

HSPICE® Signal Integrity User Guide

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SYNOPSYS®

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Contents

About This Manual

This manual describes how to use HSPICE to maintain signal integrity in your chip design.

Inside This Manual

This manual contains the chapters described below. For descriptions of the other manuals in the HSPICE documentation set, see the next section, “[The HSPICE Documentation Set](#).”

Chapter	Description
Chapter 1, Introduction	Describes some of the factors that can affect signal integrity in your design.
Chapter 2, S Parameter Modeling Using the S Element	Describes S parameter and SP modeling as well as other topics related to the S element
Chapter 3, Modeling Coupled Transmission Lines Using the W Element	Describes how to use basic transmission line simulation equations and an optional method for computing the parameters of transmission line equations.

About This Manual

The HSPICE Documentation Set

Chapter	Description
Chapter 4, Modeling Input/Output Buffers Using IBIS	Describes how to model input and output buffers using IBIS. Includes information on IBIS conventions, buffers, and the IBIS golden parser.
Chapter 5, Modeling Ideal and Lumped Transmission Lines	Describes how to model ideal and lumped transmission lines.

The HSPICE Documentation Set

This manual is a part of the HSPICE documentation set, which includes the following manuals:

Manual	Description
HSPICE Simulation and Analysis User Guide	Describes how to use HSPICE to simulate and analyze your circuit designs. This is the main HSPICE user guide.
HSPICE Signal Integrity Guide	Describes how to use HSPICE to maintain signal integrity in your chip design.
HSPICE Applications Manual	Provides application examples and additional HSPICE user information.
HSPICE Command Reference	Provides reference information for HSPICE commands.
HPSPICE Elements and Device Models Manual	Describes standard models you can use when simulating your circuit designs in HSPICE, including passive devices, diodes, JFET and MESFET devices, and BJT devices.
HPSPICE MOSFET Models Manual	Describes standard MOSFET models you can use when simulating your circuit designs in HSPICE.

Manual	Description
HSPICE RF Manual	Describes a special set of analysis and design capabilities added to HSPICE to support RF and high-speed circuit design.
AvanWaves User Guide	Describes the AvanWaves tool, which you can use to display waveforms generated during HSPICE circuit design simulation.
HSPICE Quick Reference Guide	Provides key reference information for using HSPICE, including syntax and descriptions for commands, options, parameters, elements, and more.
HSPICE Device Models Quick Reference Guide	Provides key reference information for using HSPICE device models, including passive devices, diodes, JFET and MESFET devices, and BJT devices.

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About This Manual

Other Related Publications

Other Related Publications

For additional information about HSPICE, see:

- The HSPICE release notes, available on SolvNet (see [Accessing SolvNet on page xv](#))
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- The Synopsys MediaDocs Shop, from which you can order printed copies of Synopsys documents, at <http://mediadocs.synopsys.com>

You might also want to refer to the documentation for the following related Synopsys products:

- CosmosScope
- Aurora
- Raphael
- VCS

Conventions

The following conventions are used in Synopsys documentation.

Convention	Description
Courier	Indicates command syntax.
<i>Italic</i>	Indicates a user-defined value, such as <i>object_name</i> .
Bold	Indicates user input—text you type verbatim—in syntax and examples.
[]	Denotes optional parameters, such as <code>write_file [-f filename]</code>
...	Indicates that a parameter can be repeated as many times as necessary: <code>pin1 [pin2 ... pinN]</code>

Convention	Description
	Indicates a choice among alternatives, such as low medium high
\	Indicates a continuation of a command line.
/	Indicates levels of directory structure.
Edit > Copy	Indicates a path to a menu command, such as opening the Edit menu and choosing Copy.
Control-c	Indicates a keyboard combination, such as holding down the Control key and pressing c.

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1

Introduction

Describes some of the factors that can affect signal integrity in your design.

The performance of an IC design is no longer limited to how many million transistors a vendor fits on a single chip. With tighter packaging space and increasing clock frequencies, packaging issues and system-level performance issues (such as crosstalk and transmission lines) are becoming increasingly significant. At the same time, the popularity of multi-chip packages and increased I/O counts is forcing package design to become more like chip design.

Preparing for Simulation

To simulate a PC board or backplane, you must model the following components:

- Driver cell, including parasitic pin capacitances and package lead inductances.
- Transmission lines.

1: Introduction

Preparing for Simulation

- A receiver cell with parasitic pin capacitances and package lead inductances.
- Terminations or other electrical elements on the line.

Model the transmission line as closely as possible—that is, to maintain the integrity of the simulation, include all electrical elements exactly as they are laid out on the backplane or printed circuit board.

You can use readily-available I/O drivers from ASIC vendors, and the HSPICE device models advanced lossy transmission lines to simulate the electrical behavior of the board interconnect, bus, or backplane. You can also analyze the transmission line behavior under various conditions.

You can simulate because the critical models and simulation technology exist.

- Many manufacturers of high-speed components already use Synopsys HSPICE.
- You can hide the complexity from the system level.
- HSPICE or HSPICE RF preserves the necessary electrical characteristics with full transistor-level library circuits.

HSPICE or HSPICE RF can simulate systems by using:

- System-level behavior, such as local component temperature and independent models to accurately predict electrical behavior.
- Automatic inclusion of library components by using the `SEARCH` option.
- Lossy transmission line models that:
 - Support common-mode simulation.
 - Include ground-plane reactance.
 - Include resistive loss of conductor and ground plane.
 - Allow multiple signal conductors.
 - Require minimum CPU computation time.

Signal Integrity Problems

Table 1 lists some of the signal integrity problems that can cause failures in high-speed designs.

Table 1 High-Speed Design Problems and Solutions

Signal Integrity Problem	Causes	Solution
Noise: delta I (current)	Multiple simultaneously switching drivers; high-speed devices create larger delta I.	Adjust or evaluate location, size, and value of decoupling capacitors.
Noise: coupled (crosstalk)	Closely-spaced parallel traces.	Establish design rules for lengths of parallel lines.
Noise: reflective	Impedance mismatch.	Reduce the number of connectors, and select proper impedance connectors.
Delay: path length	Poor placement and routing; too many or too few layers; chip pitch.	Choose MCM or other high-density packaging technology.
Propagation speed	Dielectric medium.	Choose the dielectric with the lowest dielectric constant.
Delay: rise time degradation	Resistive loss and impedance mismatch.	Adjust width, thickness, and length of line.

Analog Side of Digital Logic

Circuit simulation of a digital system becomes necessary only when the analog characteristics of the digital signals become electrically important. Is the digital circuit a new design or simply a fast version of the old design? Many new digital products are actually faster versions of existing designs. For example, the transition from a 100 MHz to a 150 MHz Pentium PC might not require extensive logic simulations. However, the integrity of the digital quality of the signals might require careful circuit analysis.

1: Introduction

Preparing for Simulation

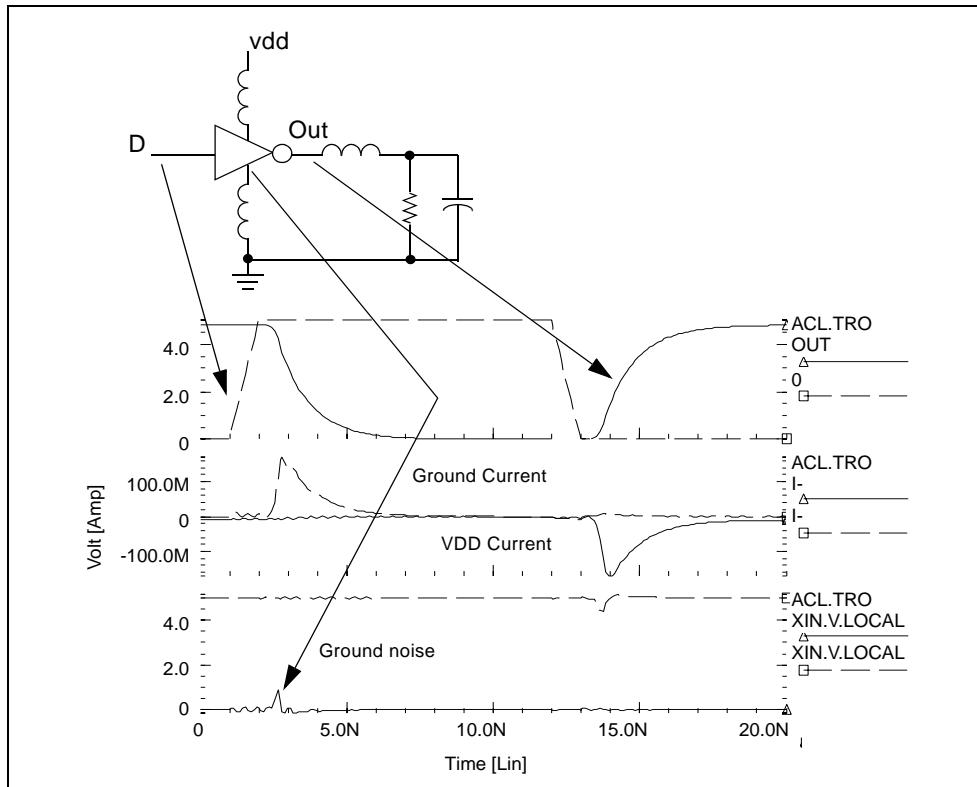
The source of a signal integrity problem is the digital output driver. A high-speed digital output driver can drive only a few inches before the noise and delay (because of the wiring) become a problem. To speed-up circuit simulation and modeling, you can create analog behavioral models, which mimic the full analog characteristics at a fraction of the traditional evaluation time.

The roadblocks to successful high-speed digital designs are noise and signal delays. Digital noise can originate from several sources. The fundamental digital noise sources are:

- Line termination noise—additional voltage reflected from the load back to the driver, which is caused by an impedance mismatch. Digital output buffers are not designed to accurately control the output impedance. Most buffers have different rising and falling edge impedances.
- Ground bounce noise—noise generated where leadframes or other circuit wires cannot form into transmission lines. The resulting inductance creates an induced voltage in the ground circuit, supply circuit, and output driver circuit. Ground bounce noise lowers the noise margins for the rest of the system.
- Coupled line noise—noise induced from lines that are physically adjacent. This noise is generally more severe for data lines that are next to clock lines.

Simulating the output buffer in Figure 1 demonstrates the analog behavior of a digital gate circuit or HSPICE RF.

Figure 1 Simulating Output Buffer with 2 ns Delay and 1.8 ns Rise/Fall Times



Circuit delays become critical as timing requirements become tighter. The key circuit delays are:

- Gate delays.
- Line turnaround delays for tristate buffers.
- Line length delays (clock skew).

Logic analysis addresses only gate delays. You can compute the variation in the gate delay from a circuit simulation only if you understand the best case and worst case manufacturing conditions.

The line turnaround delays add to the gate delays so you must add an extra margin that multiple tristate buffer drivers do not

simultaneously turn on. In most systems, the line-length delay most directly affects the clock skew.

As system cycle times approach the speed of electromagnetic signal propagation for the printed circuit board, consideration of the line length

1: Introduction

Preparing for Simulation

becomes critical. The system noises and line delays interact with the electrical characteristics of the gates, and might require circuit level simulation.

Analog details find digital systems problems. Exceeding the noise quota might not cause a system to fail. Maximum noise becomes a problem only when HSPICE accepts a digital input. If a digital systems engineer can decouple the system, HSPICE or HSPICE RF can accept a much higher level of noise.

Common decoupling methods are:

- Multiple ground and power planes on the PCB, MCM, and PGA.
- Separating signal traces with ground traces.
- Decoupling capacitors.
- Series resistors on output buffer drivers.
- Twisted-pair line driving.

In present systems designs, you must select the best packaging methods at three levels:

- printed circuit board
- multi-chip module
- pin grid array

Extra ground and power planes are often necessary to lower the supply inductance and to provide decoupling.

- Decoupling capacitors must have very low internal inductance to be effective for high-speed designs.
- Newer designs frequently use series resistance in the output drivers to lower circuit ringing.
- Critical high-speed driver applications use twisted differential-pair transmission lines.

A systems engineer must determine how to partition the logic. The propagation speed of signals on a printed circuit board is about 6 in/ns. As digital designs become faster, wiring interconnects become a factor in how you partition logic.

Note: HSPICE RF partitioning is for Operating Point (OP) only.

The critical wiring systems are:

- IC-level wiring.
- Package wiring for SIPs, DIPs, PGAs, and MCMs.
- Printed circuit-board wiring.
- Backplane and connector wiring.
- Long lines – power, coax, or twisted pair.

If you use ASIC or custom integrated circuits as part of your system logic partitioning strategy, you must make decisions about integrated circuit level wiring. The more-familiar decisions involve selecting packages and arranging packages on a printed circuit board. Large systems generally have a central backplane, which becomes the primary challenge at the system partition level.

Use the following equation to estimate wire length when transmission line effects become noticeable:

$$\text{critical length} = (\text{rise time}) * \text{velocity} / 8$$

For example, if rise time is 1 ns and board velocity is 6 in/ns, then distortion becomes noticeable when wire length is 3/4 in. The HSPICE or HSPICE RF circuit simulator automatically generates models for each type of wire to define effects of full loss transmission lines.

To partition a system, ECL logic design engineers typically used to calculate the noise quota for each line. Now, you must design most high-speed digital logic with respect to the noise quota so that the engineer knows how much noise and delay are acceptable before timing and logic levels fail.

To solve the noise quota problem, you must calculate the noise associated with the wiring. You can separate large integrated circuits into two parts:

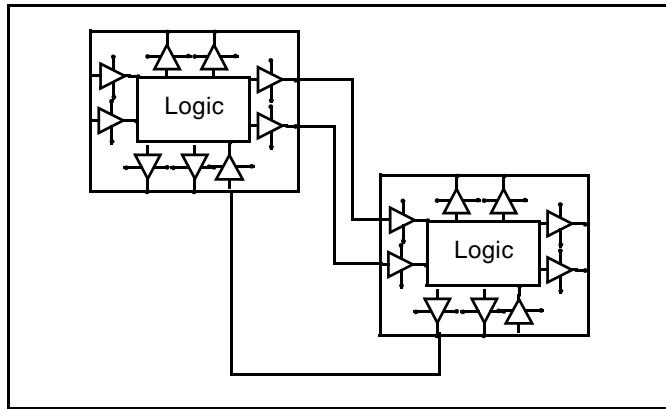
- Internal logic.
- External input and output amplifiers.

When you use mixed digital and analog tools, you can merge a complete system together with full analog-quality timing constraints and full digital representation. You can simultaneously evaluate noise-quota calculations, subject to system timing.

1: Introduction

Optimizing TDR Packaging

Figure 2 Analog Drivers and Wires



Optimizing TDR Packaging

Packaging plays an important role in determining the overall speed, cost, and reliability of a system. With today's small feature sizes, and high levels of integration, a significant portion of the total delay is the time required for a signal to travel between chips.

Multi-layer ceramic technology has proven to be well suited for high-speed GaAs IC packages.

A multi-chip module (MCM) minimizes the chip-to-chip spacing. It also reduces the inductive and capacitive discontinuity between the chips mounted on the substrate. An MCM uses a more direct path (die-bump-interconnect-bump-die), which eliminates wire bonding. In addition, narrower and shorter wires on the ceramic substrate have much less capacitance and inductance, than PC board interconnections have.

Time domain reflectometry (TDR) is the closest measurement to actual digital component functions. It provides a transient display of the impedance versus time for pulse behavior.

Using TDR in Simulation

When you use a digitized TDR file, you can use the HSPICE or HSPICE RF optimizer to automatically select design components. To extract critical points from digitized TDR files, use the .MEASURE statement, and use the results as electrical specifications for optimization. This process eliminates recurring design cycles to find component values that curve-fit the TDR files.

Figure 3 Optimization Process

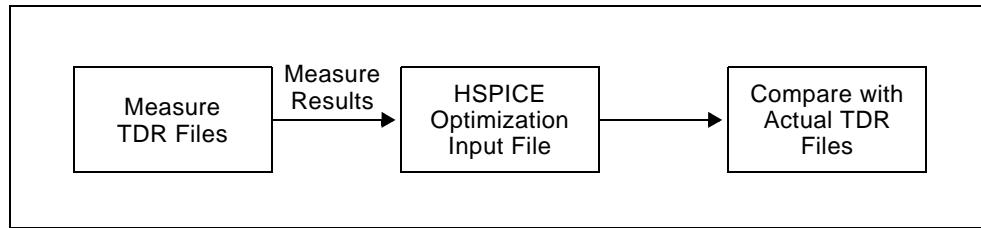
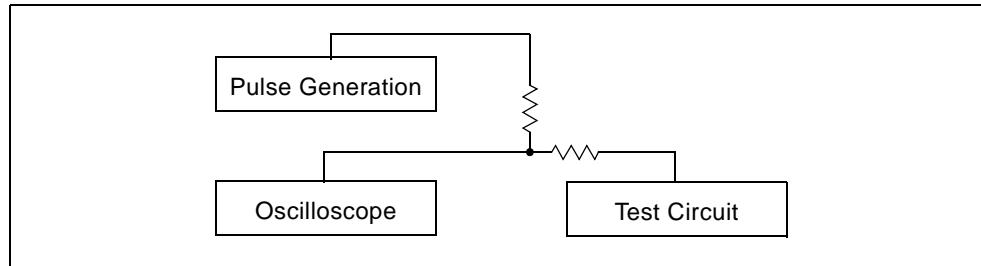


Figure 4 General Method for TDR Optimization



Use the following method for realistic high-speed testing of packaging:

- Test fixtures closely emulate a high-speed system environment.
 - A HSPICE device model uses ideal transmission lines and discrete components for measurements.

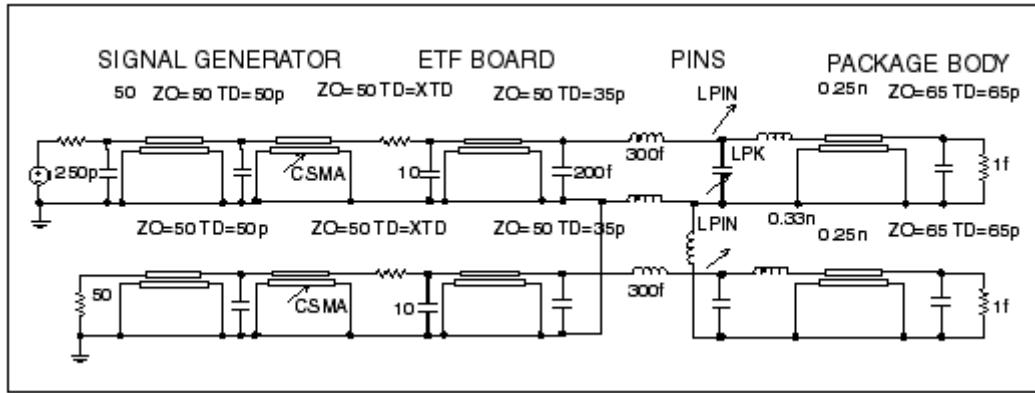
The tested circuit contains the following components:

- Signal generator.
 - Coax connecting the signal generator to ETF (engineering test fixture) board.
 - ETF board.
 - Package pins.
 - Package body.

1: Introduction

Optimizing TDR Packaging

**Figure 5 SPICE Model for Package-Plus-Test Fixture
Optimized Parameters: XTD, CSMA, LPIN, and LPK**



The package tests use a digital sampling oscilloscope to perform traditional time-domain measurements. Use these tests to observe the reflected and transmitted signals. These signals are derived from the built-in high-speed pulse generator and translated output signals into digitized time-domain reflectometer files (voltage versus time).

Use a fully-developed SPICE model to simulate the package-plus-test fixture, then compare the simulated and measured reflected/transmitted signals.

The next section shows the input netlist file for this experiment. Figure 6 through Figure 9 show the output plots.

TDR Optimization Procedure

The sample netlist for this experiment is located in the following directory:

`$installdir/demo/hspice/si/ipopt.sp`

Figure 6 Reflected Signals Before Optimization

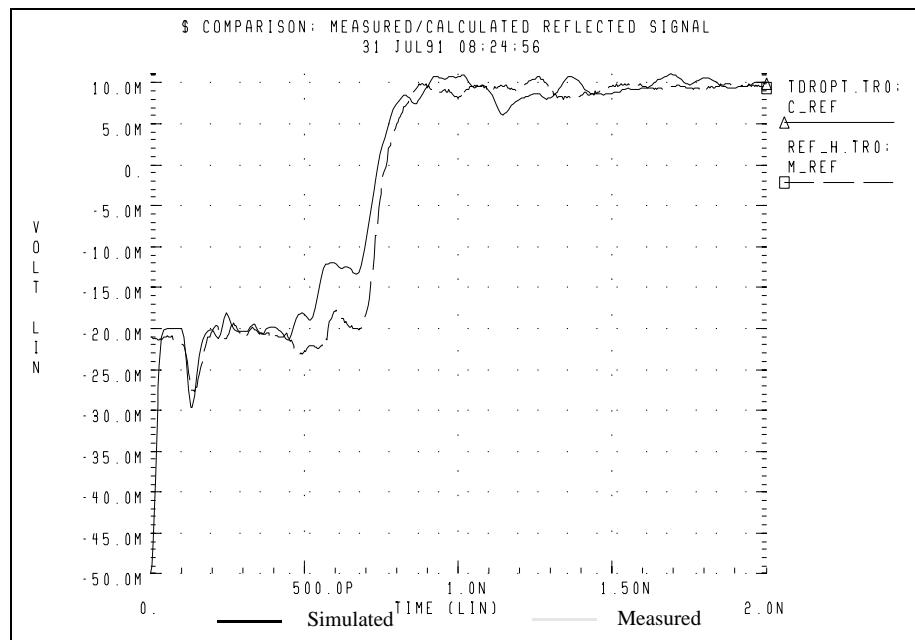
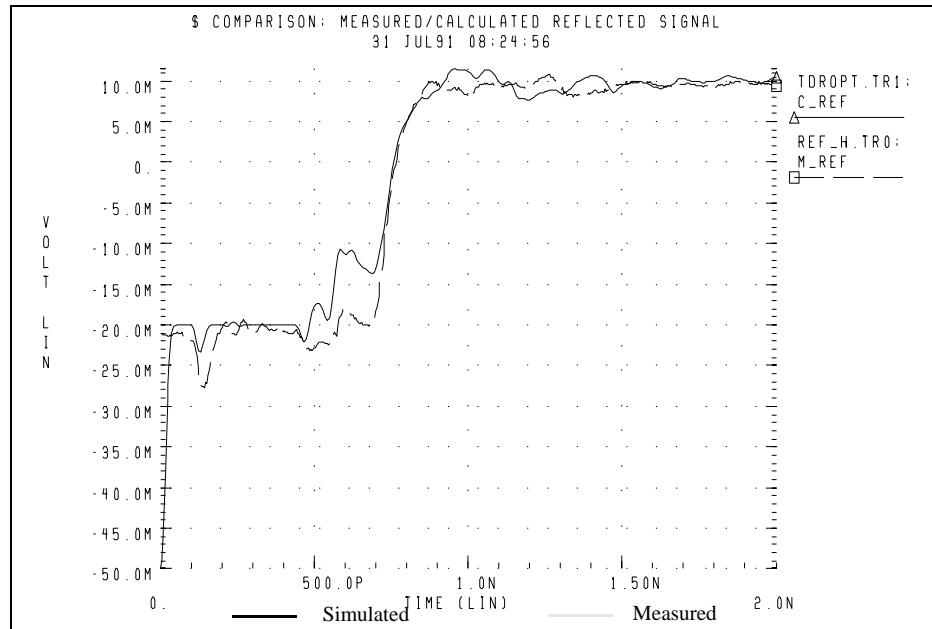


Figure 7 Reflected Signals After Optimization



1: Introduction

Optimizing TDR Packaging

Figure 8 Transmitted Signals Before Optimization

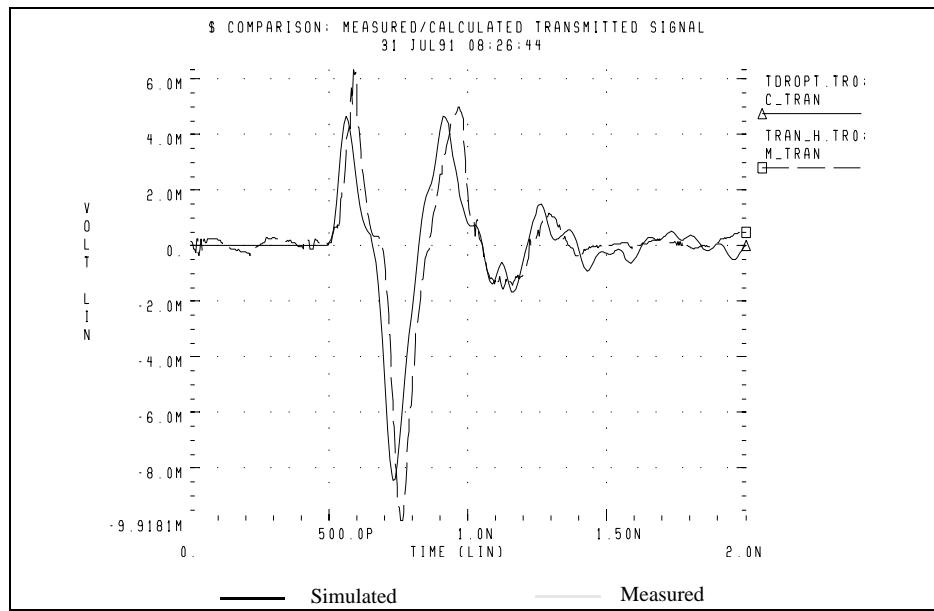
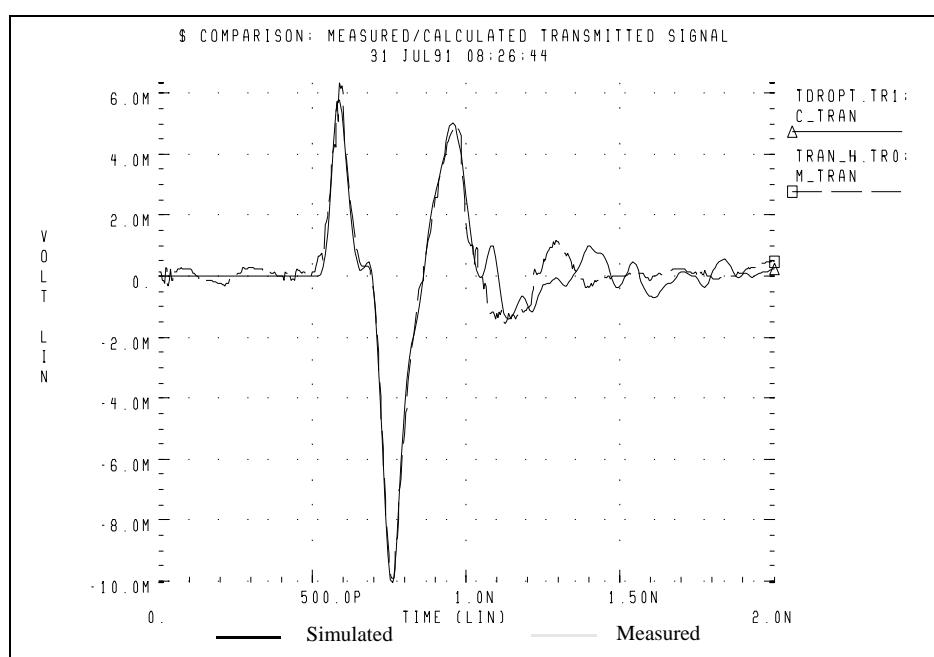


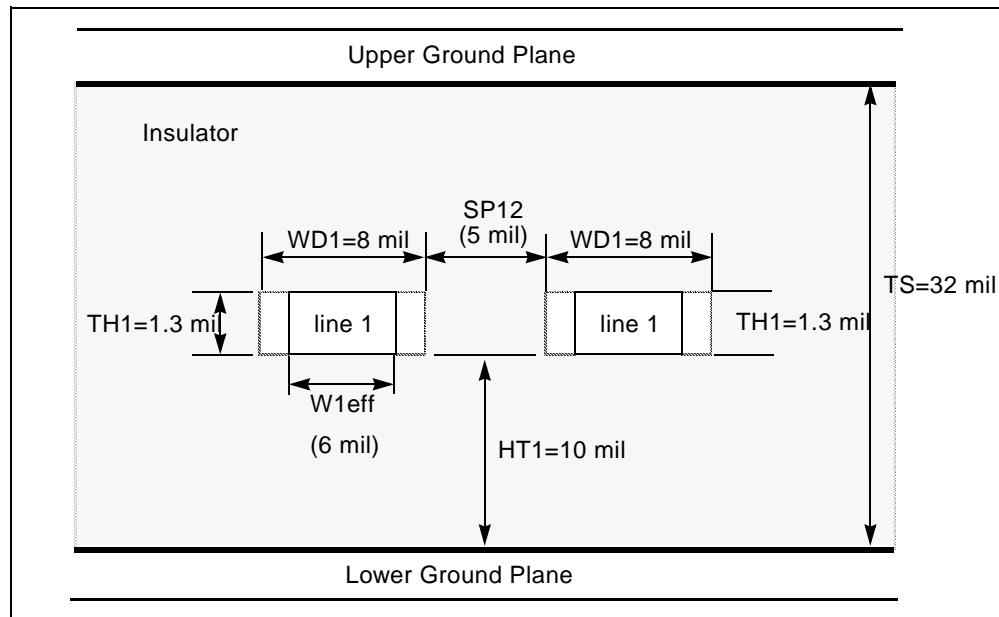
Figure 9 Transmitted Signals after Optimization



Simulating Circuits with Signetics Drivers

HSPICE or HSPICE RF includes a Signetics I/O buffer library in the \$installdir/parts/signet directory. You can use these high-performance parts in backplane design. Transmission line models describe two conductors.

Figure 10 Planar Transmission Line DLEV=2: Microstrip Sea of Dielectric

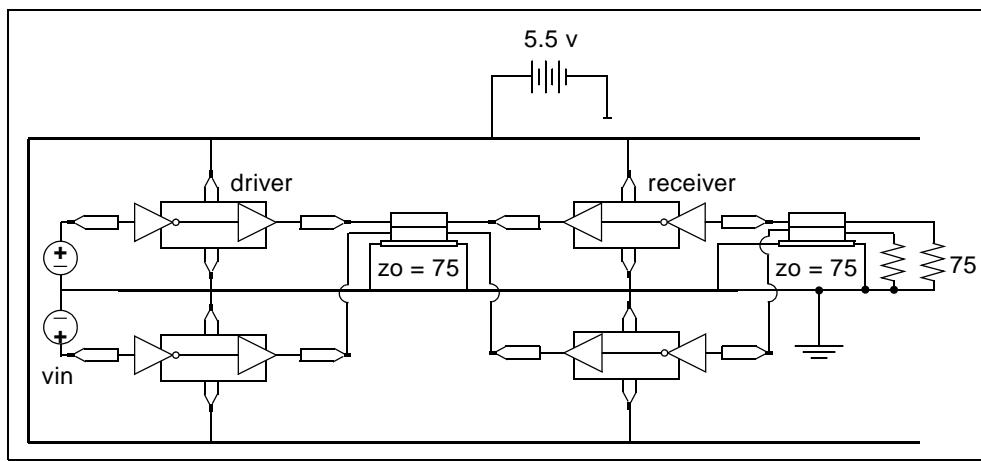


In the following application, a pair of drivers are driving about 2.5 inches of adjacent lines to a pair of receivers that drive about 4 inches of line.

1: Introduction

Simulating Circuits with Signetics Drivers

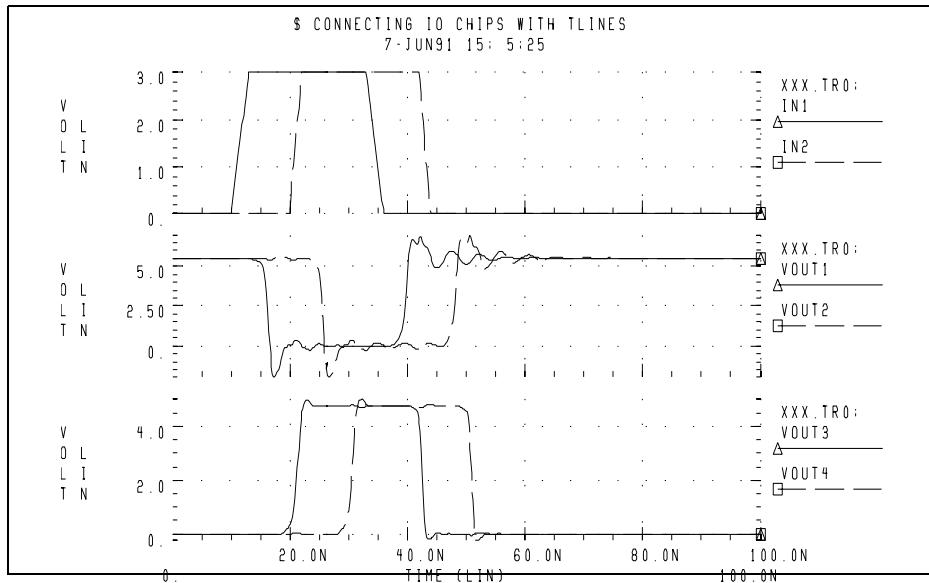
Figure 11 I/O Drivers/Receivers with Package Lead Inductance, Parallel 4" Lossy Microstrip Connectors



An example package inductance:

```
LIN_PIN IN IN1 PIN_IN  
LOUT_PIN OUT1 OUT PIN_OUT  
LVCC VCC VCC1 PIN_VCC  
LGND XGND1 XGND PIN_GND  
.ENDS  
$ TLINE MODEL - 2 SIGNAL CONDUCTORS WITH GND  
$ PLANE  
.MODEL USTRIP U LEVEL=3 ELEV=1 PLEV=1  
+ TH1=1.3mil HT1=10mil TS=32mil KD1=4.5 DLEV=0 WD1=8mil  
+ XW=-2mil KD2=4.5 NL=2 SP12=5mil  
$ ANALYSIS / PRINTS  
.TRAN .1NS 100NS  
.GRAPH IN1=V(STIM1) IN2=V(STIM2) VOUT1=V(TLOUT1)  
+ VOUT2=V(TLOUT2)  
.GRAPH VOUT3=V(TLOUT3) VOUT4=V(TLOUT4)  
.END
```

Figure 12 Connecting I/O Chips with Transmission Lines



Here's an netlist example of how I/O chips connect with transmission lines:

```
* This example connects I/O chips with transmission lines
.OPTION SEARCH='$installdir/part/signet'
.OPTION POST=2 TNOM=27 NOMOD LIST METHOD=GEAR
.TEMP 27
$ DEFINE PARAMETER VALUES
.PARAM LV=0 HV=3 TD1=10n TR1=3n TF1=3n TPW=20n
+ TPER=100n TD2=20n TR2=2n TF2=2n LNGTH=101.6m
$ POWER SUPPLY
VCC VCC 0 DC 5.5
$ INPUT SOURCES
VIN1 STIM1 0 PULSE LV HV TD1 TR1 TF1 TPW TPER
VIN2 STIM2 0 PULSE LV HV TD2 TR2 TF2 TPW TPER
$ FIRST STAGE: DRIVER WITH TLINE
X1ST_TOP STIM1 OUTPIN1 VCC GND IO_CHIP PIN_IN=2.6n
+ PIN_OUT=4.6n
X1ST_DN STIM2 OUTPIN2 VCC GND IO_CHIP PIN_IN=2.9n
+ PIN_OUT=5.6n
U_1ST OUTPIN1 OUTPIN2 GND TLOUT1 TLOUT2 GND USTRIP L=LNGTH
$ SECOND STAGE: RECEIVER WITH TLINE
X2ST_TOP TLOUT1 OUTPIN3 VCC GND IO_CHIP PIN_IN=4.0n
+ PIN_OUT=2.5n
X2ST_DN TLOUT2 OUTPIN4 VCC GND IO_CHIP PIN_IN=3.6n
+ PIN_OUT=5.1n
U_2ST OUTPIN3 OUTPIN4 GND TLOUT3 TLOUT4 GND USTRIP L=LNGTH
$ TERMINATING RESISTORS
R1 TLOUT3 GND 75
R2 TLOUT4 GND 75
```

1: Introduction

Simulating Circuits with Xilinx FPGAs

```
$ IO CHIP MODEL - SIGNETICS
.SUBCKT IO_CHIP IN OUT VCC XGND PIN_VCC=7n PIN_GND=1.8n
X1 IN1 INVOUT VCC1 XGND1 ACTINPUT
X2 INVOUT OUT1 VCC1 XGND1 AC109EQ
*Package Inductance
LIN_PIN IN IN1 PIN_IN
LOUT_PIN OUT1 OUT PIN_OUT
LVCC VCC VCC1 PIN_VCC
LGND XGND1 XGND PIN_GND
.ENDS
$ TLINE MODEL - 2 SIGNAL CONDUCTORS WITH GND
$ PLANE
.MODEL USTRIP U LEVEL=3 ELEV=1 PLEV=1
+ TH1=1.3mil HT1=10mil TS=32mil KD1=4.5 DLEV=0 WD1=8mil
+ XW=-2mil KD2=4.5 NL=2 SP12=5mil
$ ANALYSIS / PRINTS
.TRAN .1NS 100NS
.GRAPH IN1=V(STIM1) IN2=V(STIM2) VOUT1=V(TLOUT1)
+ VOUT2=V(TLOUT2)
.GRAPH VOUT3=V(TLOUT3) VOUT4=V(TLOUT4)
.END
```

Simulating Circuits with Xilinx FPGAs

Synopsys and Xilinx maintain a library of HSPICE device models and transistor-level subcircuits for the Xilinx 3000 and 4000 series Field Programmable Gate Arrays (FPGAs). These subcircuits model the input and output buffer.

The following simulations use the Xilinx input/output buffer (xil_iob.inc) to simulate ground-bounce effects for the 1.08 μ m process at room temperature and at nominal model conditions. In the IOB and IOB4 subcircuits, you can set parameters to specify:

- Local temperature.
- Fast, slow, or typical speed.
- 1.2 μ or 1.08 μ technology.

You can use these choices to perform a variety of simulations to measure:

- Ground bounce, as a function of package, temperature, part speed, and technology.
- Coupled noise, both on-chip and chip-to-chip.

- Full transmission line effects at the package level and the printed circuit board level.
- Peak current and instantaneous power consumption for power supply bus considerations and chip capacitor placement.

Syntax for IOB (xil_iob) and IOB4 (xil_iob4)

```
* EXAMPLE OF CALL FOR 1.2U PART:  
* X1 I O PAD TS FAST PPUB TTL VDD GND XIL_IOB  
*+ XIL_SIG=0 XIL_DTEMP=0 XIL_SHRINK=0  
* EXAMPLE OF CALL FOR 1.08U PART:  
* X1 I O PAD TS FAST PPUB TTL VDD GND XIL_IOB  
*+ XIL_SIG=0 XIL_DTEMP=0 XIL_SHRINK=1
```

Nodes	Description
I (IOB only)	output of the TTL/CMOS receiver
O (IOB only)	input pad driver stage
I1 (IOB4 only)	input data 1
I2 (IOB4 only)	input data 2
DRIV_IN (IOB4 only)	
PAD	bonding pad connection
TS	three-state control input (5 V disables)
FAST	slew rate control (5 V fast)
PPUB (IOB only)	pad pull-up enable (0 V enables)
PUP (IOB4 only)	pad pull-up enable (0 V enables)
PDOWN (IOB4 only)	pad pull-up enable (5 V enables)
TTL (IOB only)	CMOS/TTL input threshold (5 V selects TTL)
VDD	5-volt supply
GND	ground

1: Introduction

Simulating Circuits with Xilinx FPGAs

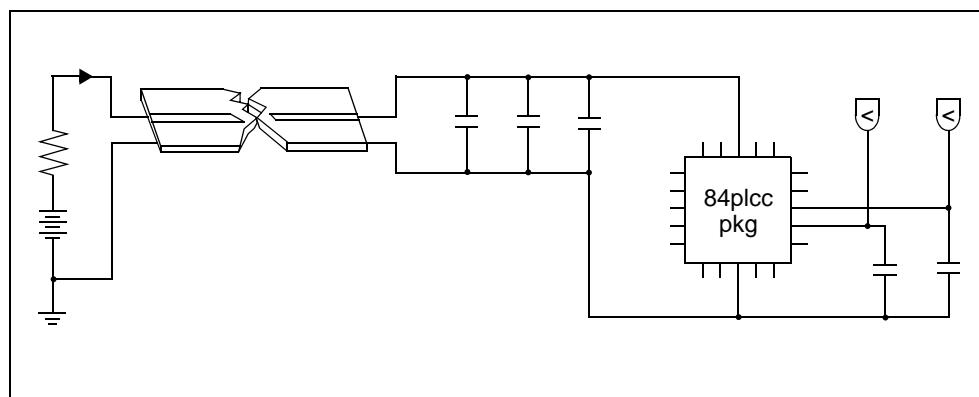
Nodes	Description
XIL_SIG	model distribution: (default 0) -3==> slow 0==> typical +3==> fast
XIL_DTEMP	Buffer temperature difference from ambient. The default = 0 degrees if ambient is 25 degrees, and if the buffer is 10 degrees hotter than XIL_DTEMP=10.
XIL_SHRINK	Old or new part; (default is new): 0==>old 1==>new

All grounds and supplies are common to the external nodes for the ground and VDD. You can redefine grounds to add package models.

Ground-Bounce Simulation

Ground-bounce simulation duplicates the Xilinx internal measurements methods. It simultaneously toggles 8 to 32 outputs. The simulation loads each output with a 56 pf capacitance. Simulation also uses an 84-pin package mode and an output buffer held at chip ground to measure the internal ground bounce.

Figure 13 Ground Bounce Simulation



HSPICE or HSPICE RF adjusts the simulation model for the oscilloscope recordings so you can use it for the two-bond wire ground. For example, the following netlist simulates ground bounce:

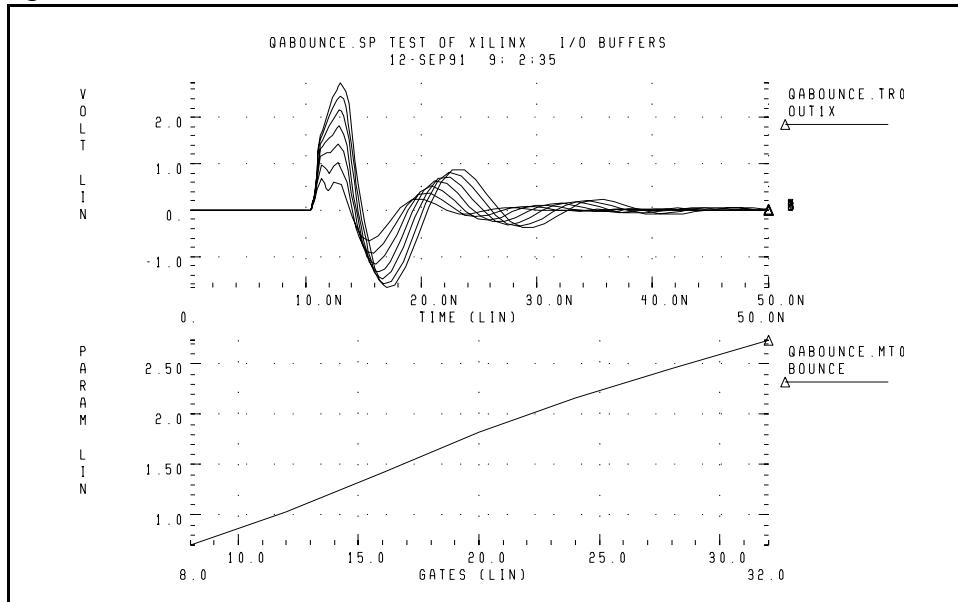
```
qbounce.sp test of xilinx i/o buffers
.OPTION SEARCH='$installdir/part/xilinx'
.op
.option post list
.tran 1ns 50ns sweep gates 8 32 4
.measure bounce max v(out1x)
*.tran .1ns 7ns
.param gates=8
.print v(out1x) v(out8x) i(vdd) power
$.param xil_dtemp=-65 $ -40 degrees c
$ (65 degrees from +25 degrees)
vdd vdd gnd 5.25
vgnd return gnd 0
upower1 vdd return iob1vdd iob1gnd pcb_power
+ L=600mil
* local power supply capacitors
xcla iob1vdd iob1gnd cap_mod cval=.1u
xclb iob1vdd iob1gnd cap_mod cval=.1u
xc1c iob1vdd iob1gnd cap_mod cval=1u
xgnd_b iob1vdd iob1gnd out8x out1x xil_gnd_test
xcout8x out8x iob1gnd cap_mod m=gates
xcout1x out1x iob1gnd cap_mod m=1
.model pcb_power u LEVEL=3 elev=1 plev=1 nl=1 lle=1
+ th=1.3mil ht=10mil kd=4.5 dlev=1 wd=500mil xw=-2mil
.macro cap_mod node1 node2 cval=56p
Lr1 node1 node1x L=2nh R=0.05
cap node1x node2x c=cval
Lr2 node2x node2 L=2nh R=0.05
.eom
.macro xil_gnd_test vdd gnd outx outref
+ gates=8
* example of 8 iobuffers simultaneously switching
* through approx. 4nh lead inductance
* 1 iob is active low for ground bounce measurements
vout drive chipgnd pwl 0ns 5v, 10ns 5v, 10.5ns 0v,
$+ 20ns 0v, 20.5ns 5v, 40ns 5v R
x8 I8 drive PAD8x TS FAST PPUB TTL chipvdd chipgnd
+ xil_iob xil_sig=0 xil_dtemp=0 xil_shrink=1 M=gates
x1 I1 gnd PAD1x TS FAST PPUB TTL chipvdd chipgnd
+ xil_iob xil_sig=0 xil_dtemp=0 xil_shrink=1 m=1
*Control Settings
rts ts chipgnd 1
rfast fast chipvdd 1
rppub ppub chipgnd 1
```

1: Introduction

Simulating Circuits with Xilinx FPGAs

```
rttl ttl chipvdd 1
* pad model plcc84 rough estimates
lvdd vdd chipvdd L=3.0nh r=.02
lgnd gnd chipgnd L=3.0nh r=.02
lout8x outx pad8x L='5n/gates' r='0.05/gates'
lout1x outref pad1x L=5nh r=0.05
c_vdd_gnd chipvdd chipgnd 100n
.eom
.end
```

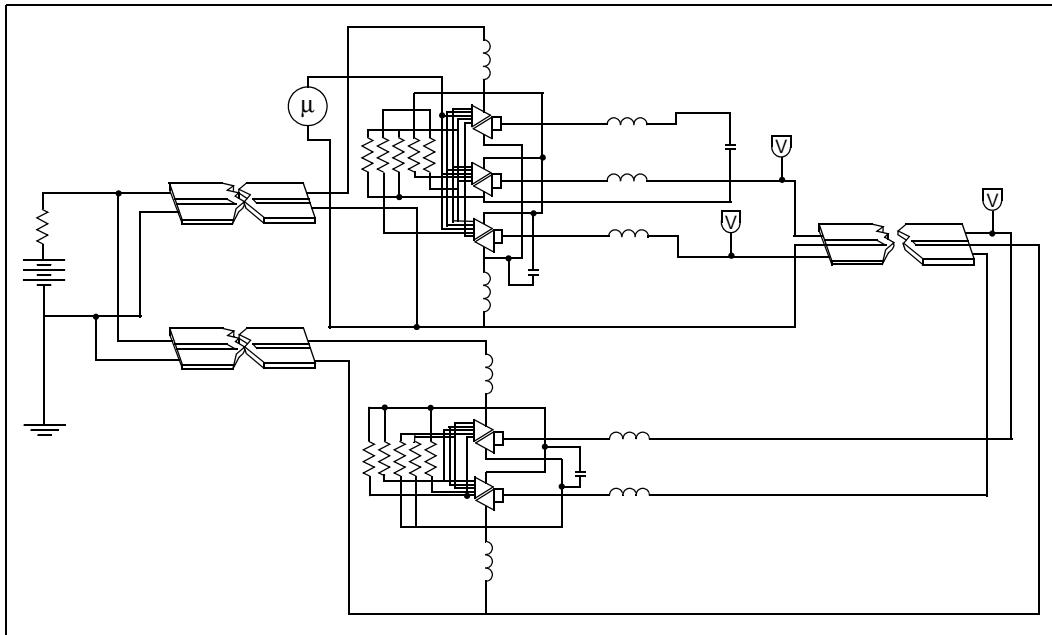
Figure 14 Results of Ground Bounce Simulation



Coupled Line Noise

This example uses coupled noise to separate IOB parts. The output of one part drives the input of the other part through 0.6 inches of PCB. This example also monitors an adjacent quiet line.

Figure 15 Coupled Noise Simulation



Here's an example netlist for coupled noise simulation:

```

Input File, for qa8.sp test of xilinx 0.8u i/o buffers
.OPTION SEARCH='$installdir/part/xilinx'
.op
.option nomod post=2
*.tran .1ns 5ns sweep xil_sig -3 3 3
.tran .1ns 15ns
.print v(out1x) v(out3x) i(vdd) v(irec)
vdd vdd gnd 5
vgnd return gnd 0
upower1 vdd return iob1vdd iob1gnd pcb_power L=600mil
upower2 vdd return iob2vdd iob2gnd pcb_power L=600mil
x4io iob1vdd iob1gnd out3x out1x outrec irec xil_iob4
cout3x out3x iob1gnd 9pf
ulx out1x outrec iob1gnd i_o_in i_o_out iob2gnd pcb_top
+ L=2000mil
xrec iob2vdd iob2gnd i_o_in i_o_out xil_rec
.ic i_o_out 0v
.model pcb_top u LEVEL=3 elev=1 plev=1 nl=2 lleve=1
+ th=1.3mil ht=10mil sp=5mil kd=4.5 dlev=1 wd=8mil xw=-2mil
.model pcb_power u LEVEL=3 elev=1 plev=1 nl=1 lleve=1
+ th=1.3mil ht=10mil kd=4.5 dlev=1 wd=500mil xw=-2mil
.macro xil_rec vdd gnd tri1 tri2
* example of 2 iobuffers in tristate
xtri1 Irec 0 pad_tri1 TSrec FAST PPUB TTL
+ chipvdd chipgnd xil_iob xil_sig=0 xil_dtemp=0 xil_shrink=1

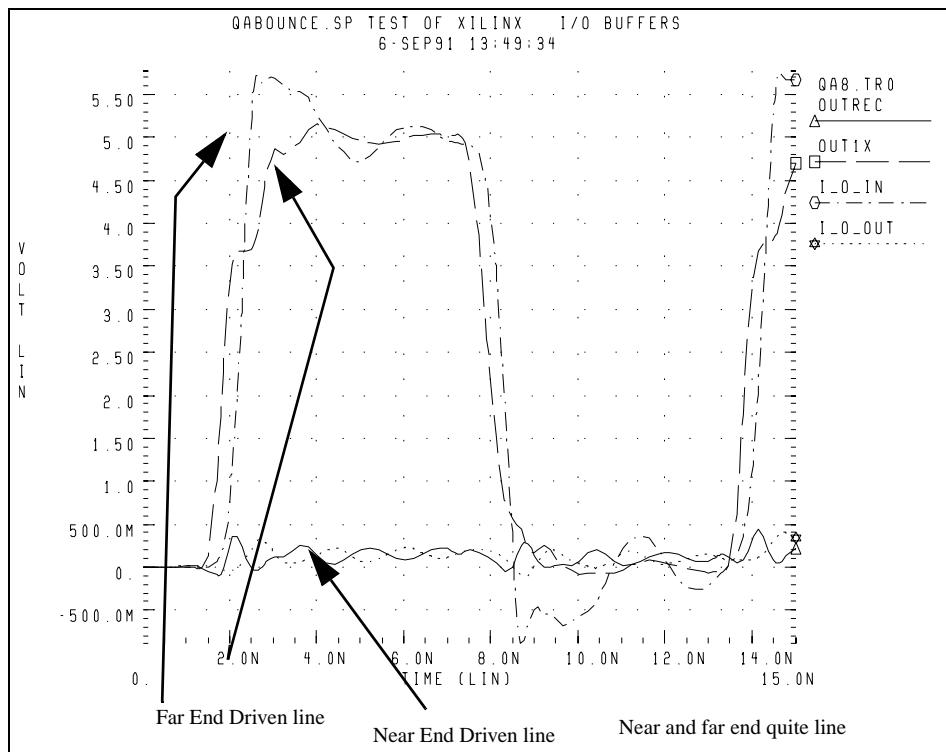
```

1: Introduction

Simulating Circuits with Xilinx FPGAs

```
+ m=1
xtri2 Irec O pad_tri2 TSrec FAST PPUB TTL
+ chipvdd chipgnd xil_iob xil_sig=0 xil_dtemp=0
+ xil_shrink=1 m=1
*Control Setting
rin_output O chipgnd 1
rtsrec tsrec chipvdd 1
rfast fast chipvdd 1
rppub ppub chipgnd 1
rttl ttl chipvdd 1
* pad model plcc84 rough estimates
lvdd vdd chipvdd L=1nh r=.01
lgnd gnd chipgnd L=1nh r=.01
ltri1 tri1 pad_tril L=3nh r=0.01
ltri2 tri2 pad_tril L=3nh r=.01
c_vdd_gnd chipvdd chipgnd 100n
.eom
.macro xil_iob4 vdd gnd out3x out1x outrec Irec
* example of 4 iobuffers simultaneously switching
* through approx. 3nh lead inductance
* 1 iob is a receiver (tristate)
vout O chipgnd pwl 0ns 0v, 1ns 0v, 1.25ns 4v, 7ns 4v,
+ 7.25ns 0v, 12ns 0v R
x3 I3 O PAD3x TS FAST PPUB TTL chipvdd chipgnd xil_iob
+ xil_sig=0 xil_dtemp=0 xil_shrink=1 m=3
x1 I1 O PAD1x TS FAST PPUB TTL chipvdd chipgnd xil_iob
+ xil_sig=0 xil_dtemp=0 xil_shrink=1 m=1
xrec Irec O PADrec TSrec FAST PPUB TTL chipvdd chipgnd xil_iob
+ xil_sig=0 xil_dtemp=0 xil_shrink=1 m=1
* control settings
rts ts chipgnd 1
rtsrec tsrec chipvdd 1
rfast fast chipvdd 1
rppub ppub chipgnd 1
rttl ttl chipvdd 1
* pad model plcc84 rough estimates
lvdd vdd chipvdd L=1nh r=.01
lgnd gnd chipgnd L=1nh r=.01
lout3x out3x pad3x L=1nh r=.0033
lout1x out1x pad1x L=4nh r=0.01
loutrec outrec padrec L=4nh r=.01
c_vdd_gnd chipvdd chipgnd 100n
.eom
.end
```

Figure 16 Results of Coupled Noise Simulation



The I/O block model description:

- * INPUT/OUTPUT BLOCK MODEL
- * PINS:
 - * I OUTPUT OF THE TTL/CMOS INPUT RECEIVER.
 - * O INPUT TO THE PAD DRIVER STAGE.
 - * PAD BONDING PAD CONNECTION.
 - * TS THREE-STATE CONTROL INPUT. HIGH LEVEL
 DISABLES PAD DRIVER.
 - * FAST SLEW RATE CONTROL. HIGH LEVEL SELECTS FAST SLEW RATE.
 - * PPUB PAD PULLL-UP ENABLE. ACTIVE LOW.
 - * TTL CMOS/TTL INPUT THRESHOLD SELECT. HIGH SELECTS TTL.
 - * VDD POSITIVE SUPPLY CONNECTION FOR INTERNAL CIRCUITRY.
 - * ALL SIGNALS ABOVE ARE REFERENCED TO NODE 0.
 - * THIS MODEL CAUSES SOME DC CURRENT TO FLOW
 INTO NODE 0, WHICH IS AN ARTIFACT OF THE MODEL.
 - * GND CIRCUIT GROUND

The buffer module description:

- * THIS SUBCIRCUIT MODELS THE INTERFACE BETWEEN XILINX
3000 SERIES PARTS AND THE BONDING PAD. IT IS NOT
USEFUL FOR PREDICTING DELAY TIMES FROM THE OUTSIDE

1: Introduction

Simulating Circuits with Xilinx FPGAs

```
* WORLD TO INTERNAL LOGIC IN THE XILINX CHIP. RATHER,  
* IT CAN BE USED TO PREDICT THE SHAPE OF WAVEFORMS  
* GENERATED AT THE BONDING PAD AS WELL AS THE RESPONSE  
* OF THE INPUT RECEIVERS TO APPLIED WAVEFORMS.  
* THIS MODEL IS INTENDED FOR USE BY SYSTEM DESIGNERS  
* WHO ARE CONCERNED ABOUT TRANSMISSION EFFECTS IN  
* CIRCUIT BOARDS CONTAINING XILINX 3000 SERIES PARTS.  
* THE PIN CAPACITANCE AND BONDING WIRE INDUCTANCE,  
* RESISTANCE ARE NOT CONTAINED IN THIS MODEL. THESE  
* ARE A FUNCTION OF THE CHOSEN PACKAGE AND MUST BE  
* INCLUDED EXPLICITLY IN A CIRCUIT BUILT WITH THIS  
* SUBCIRCUIT.  
* NON-IDEALITIES SUCH AS GROUND BOUNCE ARE ALSO A  
* FUNCTION OF THE SPECIFIC CONFIGURATION OF THE  
* XILINX PART, SUCH AS THE NUMBER OF DRIVERS WHICH  
* SHARE POWER PINS SWITCHING SIMULTANEOUSLY. ANY  
* SIMULATION TO EXAMINE THESE EFFECTS MUST ADDRESS  
* THE CONFIGURATION-SPECIFIC ASPECTS OF THE DESIGN.  
  
.SUBCKT XIL_IOB I O PAD_IO TS FAST PPUB TTL VDD GND  
+ XIL_SIG=0 XIL_DTEMP=0 XIL_SHRINK=1  
.prot FREELIB  
; ]= $.[ ;qW.261DW3Eu0  
VO\;:n[ $.[ ;qW.2'4%S+%X;:0[(3'1:67*8-:1:\[  
kp39H2J9#Yo%XpVY#O!rDI$UqhmE%:\7%(3e%:\7\50)1-5i# ;  
.ENDS XIL_IOB
```

2

S Parameter Modeling Using the S Element

Describes S parameter and SP modeling as well as other topics related to the S element

You can use the S element to describe a multi-terminal network in AC, DC and TRAN circuit analyses within either Synopsys HSPICE or HSPICE RF. This chapter describes S parameter and SP modeling as well as other topics related to the S element. For more information about using the S element (S parameter) for mixed-mode analysis, see the *HSPICE Simulation and Analysis User Guide*.

S Parameter Model

You can use small-signal parameters at the network terminals to characterize linear or non-linear networks that have sufficiently small signals. After you set the parameters, you can simulate the block in any external circuit. S parameters are widely used to characterize a linear network especially among designers of high-frequency circuits.

S parameters (S) in multi-port networks are defined as follows:

$$b = S \cdot a$$

2: S Parameter Modeling Using the S Element

S Parameter Model

In the preceding equation, a is an incident wave factor, and b is a reflected wave vector, defined as follows:

$$a = Y_r^{1/2} \cdot v_f = Z_r^{1/2} \cdot i_f$$

$$b = Y_r^{1/2} \cdot v_b = Z_r^{1/2} \cdot i_b$$

The preceding equations use the following definitions:

- v_f is the forward voltage vector.
- v_b is the backward voltage vector.
- i_f is the forward current vector.
- i_b is the backward current vector.
- Z_r is the characteristic impedance matrix of the reference system.
- Y_r is the characteristic admittance matrix.
- Z_r and Y_r satisfy the following relationship:

$$Y_r = Z_r^{-1}$$

The S parameters are frequency-dependent. When all ports are terminated with impedance matching, the forward wave is zero. This is because there is no reflection if the ports have no voltage/current source.

Using the Scattering Parameter Element

The S (scattering) Element gives you a convenient way to describe a multi-terminal network. You can use the S element in conjunction with the generic frequency-domain model (.MODEL SP), or data files that describe frequency-varying behavior of a network, and provide discrete frequency-dependent data such as a Touchstone file and CTFfile (Common Instrumentation Transfer and Interchange file).

The S element supports DC, AC, and TRAN analyses, and Y (admittance) parameters. See the *HSPICE Simulation and Analysis User Guide* for more information.

2: S Parameter Modeling Using the S Element

S Parameter Model

In particular, the S parameter in the S element represents the generalized scattering parameter (S) for a multi-terminal network, which is defined as:

$$v_{ref} = S \cdot v_{inc}$$

Where:

- Lower-case symbols denote vectors.
- Upper-case symbols denote matrices.
- v_{inc} is the incident voltage wave vector.
- v_{ref} is the reflected voltage wave vector (see [Figure 17 on page 32](#)).

The S parameter and the Y parameter satisfy the following relationship:

$$Y = Y_{rs}(I - S)(I + S)^{-1}Y_{rs}$$

where Y_r is the characteristic admittance matrix of the reference system. The following formula relates Y_r to the Z_r characteristic impedance matrix:

$$Y_r = Z_r^{-1} Y_{rs} Y_{rs} = Y_r Z_{rs} Z_{rs} = Z_r$$

Similarly, you can convert the Y parameter to the S parameter as follows:

$$S = (I - Z_{rs} Y Z_{rs})(I + Z_{rs} Y Z_{rs})^{-1}$$

S Element Syntax

Use the following S element syntax to show the connections within a circuit:

```
Sxxx nd1 nd2 ... ndN ndRef
+ <MNAME=Smode1_name> <FQMODEL=sp_model1_name>
+ <TYPE=[s|y]> <Zo=[value|vector_value]>
+ <FBASE = base_frequency> <FMAX=maximum_frequency>
+ <PRECFAC=val> <DELAYHANDLE=[1|0|ON|OFF]>
+ <DELAYFREQ=val>
+ <INTERPOLATION=STEP|LINEAR|SPLINE>
+ <INTDATTYP =[RI|MA|DBA]> <HIGHPASS=value>
+ <LOWPASS=value> <MIXEDMODE=[0|1]>
+ <DATATYPE=data_string>
+ <NOISE=[1|0]> <DTEMP=val>
```

2: S Parameter Modeling Using the S Element

S Parameter Model

Parameter	Description
nd1 nd2...ndN	Nodes of an S element (see Figure 17). Three kinds of definitions are present: <ul style="list-style-type: none">With no reference node <code>ndRef</code>, the default reference node in this situation is GND. Each node <code>ndi</code> ($i=1 \sim N$) and GND construct one of the N ports of the S element.With one reference node, <code>ndRef</code> is defined. Each node <code>ndi</code> ($i=1 \sim N$) and the <code>ndRef</code> construct one of the N ports of the S element.With an N reference node, each port has its own reference node. You can write the node definition in a clearer way as: <code>nd1+ nd1- nd2+ nd2- ... ndN+ ndN-</code> Each pair of the nodes (<code>ndi+</code> and <code>ndi-</code>, $i=1 \sim N$) constructs one of the N ports of the S element.
<code>ndRef</code>	Reference node.
<code>MNAME</code>	Name of the S model.
<code>FQMODEL</code>	Frequency behavior of the parameters.. MODEL statement of sp type, which defines the frequency-dependent matrices array.
<code>TYPE</code>	Parameter type: <code>S</code> : (scattering) (default) <code>Y</code> : (admittance) <code>Z</code> : (impedance)
<code>zo</code>	Characteristic impedance value for the reference line (frequency-independent). For multiple terminals ($N > 1$), HSPICE or HSPICE RF assumes that the characteristic impedance matrix of the reference lines is diagonal, and that you set diagonal values to <code>zo</code> . To specify more general types of reference lines, use <code>zof</code> . Default= 50Ω .

2: S Parameter Modeling Using the S Element

S Parameter Model

Parameter	Description
FBASE	<p>Base frequency to use for transient analysis. This value becomes the base frequency point for Inverse Fast Fourier Transformation (IFFT).</p> <ul style="list-style-type: none">• If you do not set this value, the base frequency is a reciprocal value of the transient period.• If you do not set this value, the reciprocal value of risetime value is taken. (See <code>.OPTION RISETIME</code> in the <i>HSPICE Command Reference</i> for more information.)• If you set a frequency that is smaller than the reciprocal value of the transient, then transient analysis performs circular convolution, and uses the reciprocal value of FBASE as its base period.
FMAX	Maximum frequency use in transient analysis. Used as the maximum frequency point for Inverse Fast Fourier Transformation (IFFT).
PRECFAC	In almost all cases, you do not need to specify a value for this parameter. This parameter specifies the precondition factor keyword used for the precondition process of the S parameter. A precondition is used to avoid an infinite admittance matrix. The default is 0.75, which is good for most cases.
DELAYHANDLE	Delay handler for transmission-line type parameters. Set <code>DELAYHANDLE</code> to ON (or 1) to turn on the delay handle; set <code>DELAYHANDLE</code> to OFF (or 0) to turn off the delay handle (default).
DELAYFREQ	Delay frequency for transmission-line type parameters. The default is FMAX. If the <code>DELAYHANDLE</code> is set to OFF, but <code>DELAYFREQ</code> is nonzero, HSPICE still simulates the S element in delay mode.
INTERPOLATION	<p>The interpolation method:</p> <ul style="list-style-type: none">• STEP: piecewise step• SPLINE: b-spline curve fit• LINEAR: piecewise linear (default)

2: S Parameter Modeling Using the S Element

S Parameter Model

Parameter	Description
INTDATTYP	Data type for the linear interpolation of the complex data. <ul style="list-style-type: none">• RI: real-imaginary based interpolation• DBA: dB-angle based interpolation• MA: magnitude-angle based interpolation (default)
HIGHPASS	Method to extrapolate higher frequency points. <ul style="list-style-type: none">• 0: cut off• 1: use highest frequency point• 2: perform linear extrapolation using the highest 2 points• 3: apply the window function to gradually approach the cut-off level (default)
LOWPASS	Method to extrapolate lower frequency points. <ul style="list-style-type: none">• 0: cut off• 1: use the magnitude of the lowest point• 2: perform linear extrapolation using the magnitude of the lowest two points
MIXEDMODE	Set to 1 if the parameters are represented in the mixed mode.
DATATYPE	A string used to determine the order of the indices of the mixed-signal incident or reflected vector. The string must be an array of a letter and a number (Xn) where: <ul style="list-style-type: none">• X = D to indicate a differential term<ul style="list-style-type: none">= C to indicate a common term= S to indicate a single (grounded) term• n = the port number

2: S Parameter Modeling Using the S Element

S Parameter Model

Parameter	Description
NOISE	Activates thermal noise. <ul style="list-style-type: none">• 1: element generates thermal noise• 0 (default): element is considered noiseless
DTEMP	Temperature difference between the element and the circuit, expressed in °C. The default is 0.0. Element temperature is calculated as: $\begin{aligned} T &= \text{Element temperature } (\text{°K}) \\ &= 273.15 \text{ (°K)} + \text{circuit temperature } (\text{°C}) \\ &\quad + \text{DTEMP } (\text{°C}) \end{aligned}$ Where circuit temperature is specified using either the .TEMP statement, or by sweeping the global TEMP variable in .DC, .AC, or .TRAN statements. When a .TEMP statement or TEMP variable is not used, the circuit temperature is set by .OPTION TNOM, which defaults to 25 °C unless you use .OPTION SPICE, which raises the default to 27 °C.

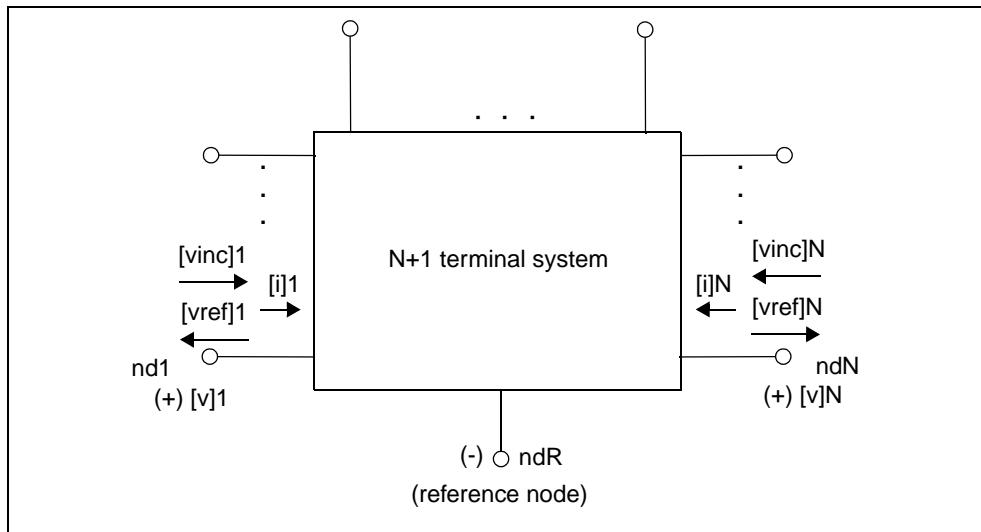
The nodes of the S element must come first. If `MNAME` is not declared, you must specify the `FQMODEL`. You can specify all the optional parameters in both the S element and S model statements, except for `MNAME` argument.

You can enter the optional arguments in any order, and the parameters specified in the element statement have a higher priority.

2: S Parameter Modeling Using the S Element

S Parameter Model

Figure 17 Terminal Node Notation



S Model Syntax

Use the following syntax to describe specific S models:

```
.MODEL Smodel_name S
+ <N=dimension>
+ [ FQMODEL=sp_model_name | TSTONEFILE=filename |
+ CITIFILE=filename ]
+ <TYPE=[s|y]> <Zo=[value | vector_value]>
+ <FBASE=base_frequency> <FMAX=maximum_frequency>
+ <HIGHPASS=[0|1|2]> <LOWPASS=[0|1|2]>
+ <PRECFAC=val> <DELAYHANDLE=[1|0|ON|OFF]>
+ <DELAYFREQ=val> <MIXEDMODE=[0|1]>
+ <DATATYPE=data_string> <XLINELENGTH=val>
```

Parameter	Description
Smodel_name	Name of the S model.
S	Specifies that the model type is an S model.
N	S model dimension, which is equal to the terminal number of an S element and excludes the reference node.

2: S Parameter Modeling Using the S Element

S Parameter Model

Parameter	Description
FQMODEL	Frequency behavior of the S,Y, or Z parameters. .MODEL statement of sp type, which defines the frequency-dependent matrices array.
TSTONEFILE	Name of a Touchstone file. Data contains frequency-dependent array of matrixes. Touchstone files must follow the .s#p file extension rule, where # represents the dimension of the network. For details, see <i>Touchstone® File Format Specification</i> by the EIA/IBIS Open Forum (http://www.eda.org).
CITIFILE	Name of the CITIfile, which is a data file that contains frequency-dependent data. For details, see <i>Using Instruments with ADS</i> by Agilent Technologies (http://www.agilent.com).
TYPE	Parameter type: S: (scattering) (default) Y: (admittance) Z: (impedance)
Zo	Characteristic impedance value of the reference line (frequency-independent). For multi-terminal lines (N>1), HSPICE assumes that the characteristic impedance matrix of the reference lines are diagonal, and their diagonal values are set to Zo. You can also set a vector value for non-uniform diagonal values. Use Zof to specify more general types of a reference-line system. The default is 50.
FBASE	Base frequency used for transient analysis. HSPICE uses this value as the base frequency point for Fast Inverse Fourier Transformation (IFFT). <ul style="list-style-type: none">• If FBASE is not set, HSPICE uses a reciprocal of the transient period as the base frequency.• If FBASE is set smaller than the reciprocal value of transient period, transient analysis performs circular convolution by using the reciprocal value of FBASE as a base period.
FMAX	Maximum frequency for transient analysis. Used as the maximum frequency point for Inverse Fast Fourier Transform (IFFT).

2: S Parameter Modeling Using the S Element

S Parameter Model

Parameter	Description
LOWPASS	Specifies low-frequency extrapolation: <ul style="list-style-type: none">• 0: Use zero in Y dimension (open circuit).• 1: Use lowest frequency (default).• 2: Use linear extrapolation with the lowest two points. This option overrides EXTRAPOLATION in .MODEL SP.
HIGHPASS	Specifies high-frequency extrapolation: <ul style="list-style-type: none">• 0: Use zero in Y dimension (open circuit).• 1: Use highest frequency.• 2: Use linear extrapolation with the highest two points.• 3: Apply window function (default). This option overrides EXTRAPOLATION in ,MODEL SP.
PRECFAC	In almost all cases, you do not need to specify a value for this parameter. This parameter specifies the precondition factor keyword used for the precondition process of the S parameter. A precondition is used to avoid an infinite admittance matrix. The default is 0.75, which is good for most cases.
DELAYHANDLE	Delay handler for transmission-line type parameters. <ul style="list-style-type: none">• 1 or ON activates the delay handler.• 0 or OFF (default) deactivates the delay handler. You must set the delay handler, if the delay of the model is longer than the base period specified in the FBASE parameter. If you set DELAYHANDLE=OFF but DELAYFQ is not zero, HSPICE simulates the S element in delay mode.
DELAYFREQ	Delay frequency for transmission-line type parameters. The default is FMAX. If the DELAYHANDLE is set to OFF, but DELAYFREQ is nonzero, HSPICE still simulates the S element in delay mode.
MIXEDMODE	Set to 1 if the parameters are represented in the mixed mode.

Parameter	Description
DATATYPE	<p>A string used to determine the order of the indices of the mixed-signal incident or reflected vector. The string must be an array of a letter and a number (Xn) where:</p> <ul style="list-style-type: none"> • X = D to indicate a differential term = C to indicate a common term = S to indicate a single (grounded) term • n = the port number
XLINELENGTH	The line length of the transmission line system where the S parameters are extracted. This keyword is required only when the S Model is used in a W Element.

The FQMODEL, TSTONEFILE, and CITIFILE parameters describe the frequency-varying behavior of a network. Only specify one of the parameters in an S model card. If more than one method is declared, only the first one is used and HSPICE issues a warning message.

FQMODEL can be set in S element and S model statements, but both statements must refer to the same model name.

S Element Data File Model Examples

The S model statement samples shown in Example 1 and Example 2 generate the same results.

Example 1 S Model Statement Code Sample

```
s1 n1 n2 n3 n_ref mname=smodel
.model smodel s n=3 fqmodel=sfqmodel zo=50 fbase=25e6 fmax=1e9
s1 n1 n2 n3 n_ref fqmodel=sfqmodel zo=50 fbase=25e6 fmax=1e9
```

In Example 2, the S model statement has the characteristic impedance equal 100 instead of the 50 as defined in smodel. The impedance changes because the parameters defined in the S element statement have higher priority than the parameters defined in the S Model statement.

Example 2 S Model Statement with Character Impedance of 100

```
s1 n1 n2 n3 n_ref mname=smodel zo=100
.model smodel s n=3 fqmodel=sfqmodel zo=50 fbase=25e6 fmax=1e9
```

2: S Parameter Modeling Using the S Element

S Parameter Model

In Example 3, `fqmodel`, `tstonefile`, and `citifile` are all declared in `smodel`. HSPICE accepts `tstonefile`, ignores both `fqmodel` and `citifile`, and issues a warning message. It is illegal to define a `tstonefile` and `CITIfile smodel` in the same statement. This prevents conflicts in the frequency-varying behavior description of the network. From the `tstonefile` file extension `.s3p`, you can tell that the network has three ports.

Example 3 S Model Statement with fqmodel, tstonefile, and citifile

```
s1 n1 n2 n3 n_ref mname=smodel
.model smodel s tstonefile=exp1.s3p fqmodel=sfqmodel
    citifile=exp1.citi0
```

In Example 4, `fqmodel` is declared both in the S element statement and the S Model statement. Each statement refers to a different `fqmodel`, which is not allowed.

Example 4 S Model Statement with fqmodel declared in both the S element statement and the S Model statement

```
s1 n1 n2 n3 n_ref mname=smodel fqmodel=sfqmodel_1
.model smodel s n=3 fqmodel=sfqmodel_2
```

A generic S parameter statement is shown in Example 5.

Example 5 S Parameter Example

```
**S-parameter example
.option sim_mode=hspice
.OPTION post=2
.probe v(n2)
V1 n1 0 ac=1v PULSE 0v 5v 5n 0.5n 0.5n 25n
.ac lin 500 1Hz 30MegHz
.tran 0.1ns 10ns
* reference node is set
S1 n1 n2 0 mname=s_model
* S parameter
.model s_model S TSTONEFILE = ss_ts.s2p
Rt1 n2 0 50
.end
```

In Example 6, the option line and noise parameters of a Touchstone file are shown.

Example 6 Touchstone Example

```
!
! touchstone file example
!
# Hz S MA R 50.0000
0.00000 0.637187 180.000 0.355136 0.00000
0.355136 0.00000 0.637187 180.000
.....
! # HZ S DB R 50.0000
! 0.00000 -3.91466 180.000 -8.99211 0.00000
! -8.99211 0.00000 -3.91466 180.000
!
!
!# Hz S RI R 50.0000
! 0.00000 -0.637187 0.00000 0.355136 0.00000
! 0.355136 0.00000 -0.637187 0.00000
!
!
! 2-port noise parameter
! frequency[Hz] Nfmin[dB] GammaOpt(M) GammaOpt(P) RN/Zo
0.0000 0.29166 0.98916 180.00 0.11055E-03
0.52632E+08 6.2395 0.59071 -163.50 0.32868
0.10526E+09 7.7898 0.44537 175.26 0.56586
!
!
! end of file
```

In Example 7, a S parameter statement and its referenced CITIfile are shown.

Example 7 S Parameter with CITIfile

```
**S-parameter
.option sim_mode=hspice
.OPTION post=2
.probe v(n2)
V1 n1 0 ac=1v PULSE 0v 5v 5n 0.5n 0.5n 25n
.ac lin 500 1Hz 30MegHz
.tran 0.1ns 10ns
* reference node is set
*S1 n1 n2 0 mname=s_model
* use default reference node
S1 n1 n2 mname=s_model
* S parameter
.model s_model S CITIFILE = ss_citi.citi Zo=50
Rt1 n2 0 50
.end

#
# citifile example "ss_citi.citi"
#
```

2: S Parameter Modeling Using the S Element

S Parameter Model

```
#  
CITIFILE A.01.00  
NAME test  
VAR FREQ MAG 1  
DATA S[1,1] DB  
DATA S[1,2] DB  
DATA S[2,1] DB  
DATA S[2,2] DB  
SEG_LIST_BEGIN  
SEG 1000 1000 1  
SEG_LIST_END  
#  
BEGIN  
#0.333333333 0.0  
-9.54242510308 0.0  
END  
BEGIN  
#0.666666667 0.0  
-3.52182518107 0.0  
END  
BEGIN  
#0.666666667 0.0  
-3.52182518107 0.0  
END  
BEGIN  
#0.333333333 0.0  
-9.54242510308 0.0  
END  
# end of file
```

S Element Noise Model

This section describes how the S element supports two-port noise parameters and multiport passive noise models.

Two-Port Noise Parameter Support in Touchstone Files

The S element is capable of reading in two-port noise parameter data from Touchstone data files and then transform the raw data into a form used for .NOISE and .lin 2pnoise analysis.

For example, you can represent a two-port system with an S element and then perform a noise analysis (or any other analysis). The S element noise model supports both normal and two-port noise analysis (.NOISE and .LIN noisecalc=1).

Input Interface

The frequency-dependent two-port noise parameters are provided in a network description block of a Touchstone data file following the S parameter data block.

The noise parameter data is typically organized by using the following syntax:

```
frequency[Hz] Nfmin[dB] GammaOpt(M) GammaOpt(P) RN/Zo
{ ...data... }
```

Where:

- frequency = frequency in units
- Nfmin[dB] = minimum noise figure (in dB)
- GammaOpt(M) = magnitude of reflection coefficient needed to realize Fmin
- GammaOpt(P) = phase (in degrees) of reflection coefficient needed to realize Fmin
- RN/Zo = normalized noise resistance
- ! = indicates a comment line

For example:

```
! 2-port noise parameter
! frequency[Hz] Nfmin[dB] GammaOpt(M) GammaOpt(P) RN/Zo
0.0000 0.29166 0.98916 180.00 0.11055E-03
0.52632E+08 6.2395 0.59071 -163.50 0.32868
0.10526E+09 7.7898 0.44537 175.26 0.56586
```

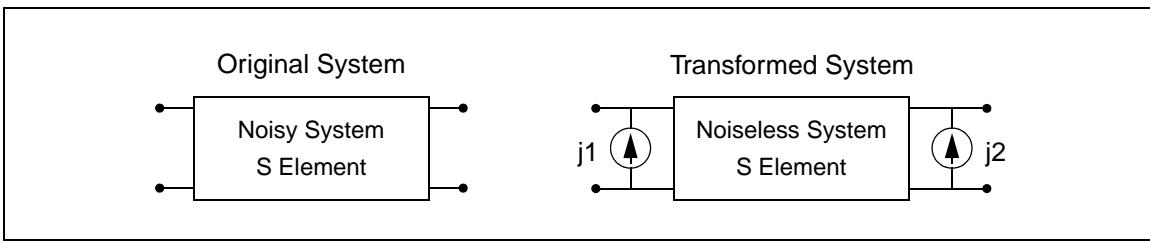
Both GammaOpt and RN/Zo values are normalized with respect to the characteristic impedance, Z_o , specified in the header of the Touchstone data file. HSPICE reads this raw data and converts it to a coefficient of the noise-current correlation matrix. This matrix can be stamped into an HSPICE noise analysis as two correlated noise current sources: j_1 and j_2 , as shown here:

$$C = \begin{bmatrix} \overline{|j_1|^2} & \overline{j_1 j_2^*} \\ \overline{j_2 j_1^*} & \overline{|j_2|^2} \end{bmatrix}$$

The noise-current correlation matrix represents the frequency-dependent statistical relationship between two noise current sources, j_1 and j_2 , as illustrated in the following figure.

2: S Parameter Modeling Using the S Element

S Parameter Model



Output Interface

HSPICE creates a `.lis` output list file that shows the results of a noise analysis just as any other noisy elements. The format is as following:

```
**** s element squared noise voltages (sq v/Hz)
element      0:s1
  N11        data
  r(N11)     data
  N12        data
  r(N12)     data
  N21        data
  r(N21)     data
  N22        data
  r(N22)     data
  total       data
```

Where:

- N_{11} = contribution of j_1 to the output port
- $r(N_{11})$ = transimpedance of j_1 to the output port
- $N_{12} = N_{21}^*$ = contribution of $j_1j_2^*$ to the output port
- $r(N_{12}) = r(N_{21})$ = transimpedance of j_1 to the output port
- $N_{21} = N_{12}^*$ = contribution of $j_2j_1^*$ to the output port
- $r(N_{21}) = r(N_{12})$ = transimpedance of j_2 to the output port
- $N_{22} = N_{11}^*$ = contribution of j_2 to the output port
- $r(N_{22}) = r(N_{11})$ = transimpedance of j_2 to the output port
- total = contribution of total noise voltage of the S element to the output port.

Notifications and Limitations

Because Touchstone files currently provide only two-port noise parameters, this type of noise model only supports two-port S parameter noise analysis for both passive and active systems.

Multiport Noise Model for Passive Systems

Multiport passive and lossy circuits, such as transmission lines and package parasitics, can exhibit considerable thermal noise. The passive noise model is used to present such thermal noise for the S element representing such circuits. The S element passive noise model supports both normal and two-port noise analysis (.NOISE and .LIN noisecalc=1).

Input Interface

To trigger a passive multiport noise model, the NOISE and DTEMP keywords in an S element statement are used:

```
Sxxx n1...nN
+
+ ...
+ <NOISE=[ 1 | 0 ]> <DTEMP=value>
```

Parameter	Description
NOISE	Activates thermal noise. <ul style="list-style-type: none">• 1: element generates thermal noise• 0 (default): element is considered noiseless

2: S Parameter Modeling Using the S Element

S Parameter Model

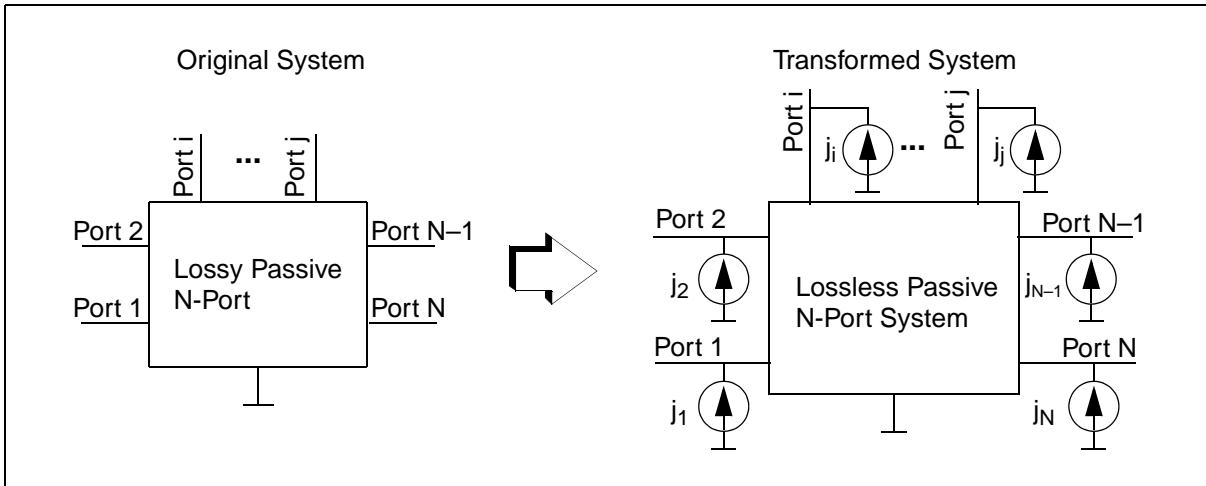
Parameter	Description
DTEMP	<p>Temperature difference between the element and the circuit, expressed in °C. The default is 0.0.</p> <p>Element temperature is calculated as:</p> $\begin{aligned} T &= \text{Element temperature } (\text{°K}) \\ &= 273.15 \text{ (°K)} + \text{circuit temperature } (\text{°C}) \\ &\quad + \text{DTEMP } (\text{°C}) \end{aligned}$ <p>Where circuit temperature is specified using either the .TEMP statement, or by sweeping the global TEMP variable in .DC, .AC, or .TRAN statements.</p> <p>When a .TEMP statement or TEMP variable is not used, the circuit temperature is set by .OPTION TNOM, which defaults to 25 °C unless you use .OPTION SPICE, which raises the default to 27 °C.</p>

When NOISE=1, HSPICE generates a NxN noise-current correlation matrix from the NxN S parameters according to Twiss' Theorem. The result can be stamped into an HSPICE noise analysis as N-correlated noise current sources: j_i ($i=1 \sim N$), as shown below:

$$C = 2kT(Y + Y^*) = \begin{bmatrix} \overline{|j_1|^2} & \overline{j_1 j_2^*} & \dots & \overline{j_1 j_N^*} \\ \overline{j_2 j_1^*} & \overline{|j_2|^2} & \dots & \overline{j_2 j_N^*} \\ \dots & \dots & \dots & \dots \\ \overline{j_N j_1^*} & \overline{j_N j_2^*} & \dots & \overline{|j_N|^2} \end{bmatrix}$$

Where $Y = Y_c(I - S)(I + S)^{-1}$

The noise-current correlation matrix represents the frequency-dependent statistical relationship between N noise current sources, j_i ($i=1 \sim N$), shown in the following figure.



Output Interface

HSPICE creates a *.lis* output list file that shows the results of a noise analysis just as any other noisy elements. The format is as following:

```
***** s element squared noise voltages (sq v/Hz)
```

```
element          0:s1
    N(i,j)      data
    r(N(i,j))   data
    ... i,j = 1~N ...
    total        data
```

Where:

- $N(i, j)$ = contribution of $j_i j_j^*$ to the output port
- $r(N(i, j))$ = transimpedance of j_i to the output port
- total = contribution of total noise voltage of the S element to the output port.

Notifications and Limitations

Because the S element can support two kinds of noise models, the priority is:

- For multisport ($N \neq 2$) S elements, only passive noise models are considered in noise analysis. If NOISE=0, the system is considered as noiseless.

2: S Parameter Modeling Using the S Element

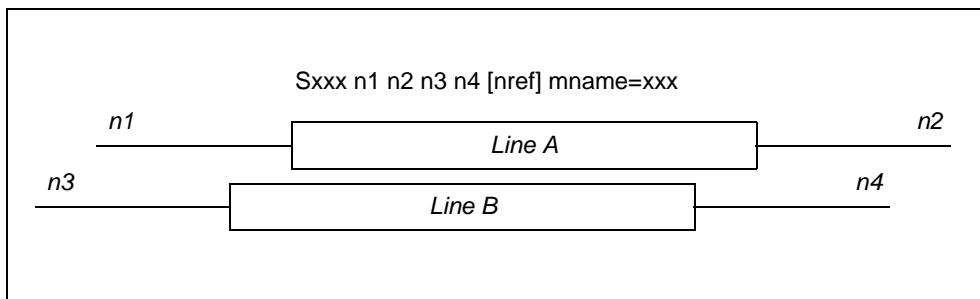
Mixed-Mode S Parameters

- For two-port S elements, if two-port noise parameters are provided in a Touchstone file, the noise model is generated from those two-port noise parameters. If two-port noise parameters are not provided and NOISE=1, then a passive noise model is triggered. Otherwise, the system is considered as noiseless.

Mixed-Mode S Parameters

Mixed-mode refers to a combination of Differential and Common mode characteristics in HSPICE linear network analysis by using the S element.

Figure 18 Node Indexing Convention



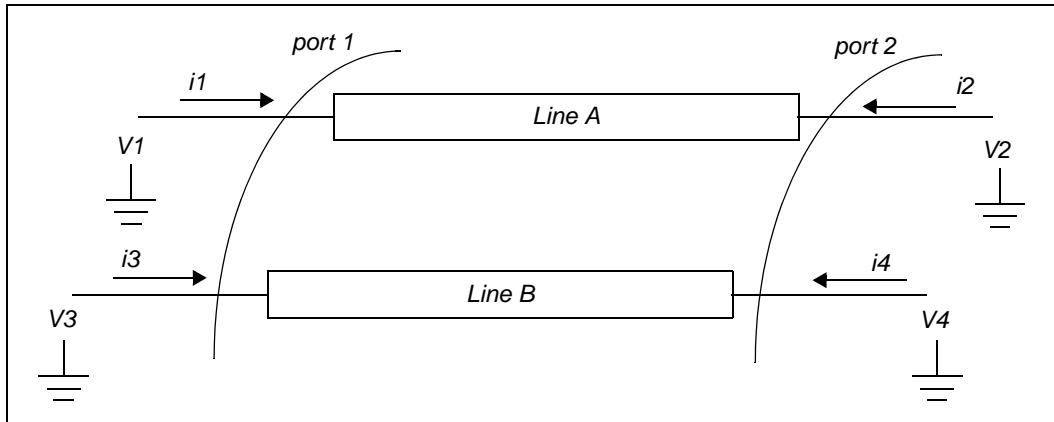
- You can use mixed-mode S parameters only with a single pair of transmission lines (4 ports).
- Nodes 1 and 3 are the ports for one end of the transmission-line pair.
- Nodes 2 and 4 are the ports for the opposite end of the transmission-line pair.

Relating Voltage and Current Waves to Nodal Waves

The following figure and set of equations include common and differential mode voltage and current waves, relating them to nodal waves. Although you can apply mixed-mode data propagation to an arbitrary number of pairs of transmission lines, a single pair model is used here.

Figure 19 shows a schematic of symmetric coupled pair transmission lines commonly used for the differential data transfer system.

Figure 19 Schematic of Symmetric Coupled-Pair Transmission Line



Solving the telegrapher's equation, you can represent nodal voltage and current waves of the data transfer system as:

$$\begin{aligned}
 v_1 &= A_1 e^{-\gamma_e x} + A_2 e^{\gamma_e x} + A_3 e^{-\gamma_o x} + A_4 e^{\gamma_o x} \\
 v_3 &= A_1 e^{-\gamma_e x} + A_2 e^{\gamma_e x} - A_3 e^{-\gamma_o x} - A_4 e^{\gamma_o x} \\
 i_1 &= \frac{A_1}{Z_e} e^{-\gamma_e x} - \frac{A_2}{Z_e} e^{\gamma_e x} + \frac{A_3}{Z_o} e^{-\gamma_o x} - \frac{A_4}{Z_o} e^{\gamma_o x} \\
 i_3 &= \frac{A_1}{Z_e} e^{-\gamma_e x} - \frac{A_2}{Z_e} e^{\gamma_e x} + \frac{A_3}{Z_o} e^{-\gamma_o x} + \frac{A_4}{Z_o} e^{\gamma_o x}
 \end{aligned} \tag{1}$$

Where:

- γ_e is the propagation constant for even mode waves.
- γ_o is the propagation constant for odd mode waves.
- Z_e is the characteristic impedance for even mode waves.
- Z_o is the characteristic impedance for odd mode waves.
- A_1 and A_3 represent phasor coefficients for the forward propagating modes.
- A_2 and A_4 represent phasor coefficients for the backward propagating modes.

2: S Parameter Modeling Using the S Element

Mixed-Mode S Parameters

Each voltage and current pair at each node represents a single propagating signal wave referenced to the ground potential. This type of expression is called *nodal wave representation*.

Characterizing Differential Data Transfer Systems

The following equations use differential and common mode waves to characterize differential data transfer systems. The difference of the nodal wave defines the voltage and current of the differential wave:

$$v_{dm} \equiv v_1 - v_3$$

$$i_{dm} \equiv \frac{1}{2}(i_1 - i_3)$$

Common mode voltage and current are defined as:

$$v_{cm} \equiv \frac{1}{2}(v_1 + v_3)$$

$$i_{cm} \equiv i_1 + i_3$$

Deriving a Simpler Set of Voltage and Current Pairs

In the following example, substituting equations 2 and 3 into equation 1 derives a simpler set of voltage and current pairs:

$$v_{dm} = 2(A_3 e^{-\gamma_o x} + A_4 e^{-\gamma_o x})$$

$$v_{cm} = A_1 e^{-\gamma_e x} + A_2 e^{\gamma_e x}$$

$$i_{dm} = \frac{A_3}{Z_o} e^{-\gamma_o x} - \frac{A_4}{Z_o} e^{\gamma_o x}$$

$$i_{cm} = 2\left(\frac{A_1}{Z_e} e^{-\gamma_e x} - \frac{A_2}{Z_e} e^{\gamma_e x}\right)$$

You can also relate characteristic impedances of each mode to the even and odd mode characteristic impedances:

$$Z_{dm} \equiv 2Z_o$$

$$Z_{cm} \equiv \frac{Z_e}{2}$$

Having defined a generalized parameter power wave in this example, you can now define differential normalized waves at port 1 and port 2:

$$\begin{aligned} a_{dm1} &\equiv \left. \frac{v_{dm} + Z_{dm} i_{dm}}{2\sqrt{Z_{dm}}} \right|_{x=0} & a_{dm2} &\equiv \left. \frac{v_{dm} + Z_{dm} i_{dm}}{2\sqrt{Z_{dm}}} \right|_{x=L} \\ b_{dm1} &\equiv \left. \frac{v_{dm} - Z_{dm} i_{dm}}{2\sqrt{Z_{dm}}} \right|_{x=0} & b_{dm2} &\equiv \left. \frac{v_{dm} - Z_{dm} i_{dm}}{2\sqrt{Z_{dm}}} \right|_{x=L} \end{aligned} \quad (2)$$

Similarly, you can define common mode normalized waves as:

$$\begin{aligned} a_{cm1} &\equiv \left. \frac{v_{cm} + Z_{cm} i_{cm}}{2\sqrt{Z_{cm}}} \right|_{x=0} & a_{cm2} &\equiv \left. \frac{v_{cm} + Z_{cm} i_{cm}}{2\sqrt{Z_{cm}}} \right|_{x=L} \\ b_{cm1} &\equiv \left. \frac{v_{cm} - Z_{cm} i_{cm}}{2\sqrt{Z_{cm}}} \right|_{x=0} & b_{cm2} &\equiv \left. \frac{v_{cm} - Z_{cm} i_{cm}}{2\sqrt{Z_{cm}}} \right|_{x=L} \end{aligned} \quad (3)$$

2: S Parameter Modeling Using the S Element

Mixed-Mode S Parameters

You can then specify S-parameters for mixed-mode waves as ratios of these waves:

$$\begin{bmatrix} b_{dm1} \\ b_{dm2} \\ b_{cm1} \\ b_{cm2} \end{bmatrix} = \mathbf{S}_{\text{mixed}} \begin{bmatrix} a_{dm1} \\ a_{dm2} \\ a_{cm1} \\ a_{cm2} \end{bmatrix}, \quad \mathbf{S}_{\text{mixed}} = \begin{bmatrix} \mathbf{S}_{dd} & \mathbf{S}_{dc} \\ \mathbf{S}_{cd} & \mathbf{S}_{cc} \end{bmatrix} \quad (4)$$

Where:

- S_{dd} is the differential-mode S parameter
- S_{cc} is the common-mode S parameter
- S_{cd} and S_{dc} represent the mode-conversion or cross-mode S parameters

Based on these definitions, you can linearly transform nodal wave (standard) S-parameters and mixed mode S-parameters:

$$M \cdot S_{\text{standard}} \cdot M^{-1} = S_{\text{mixed}} \quad (5)$$

The M transformation matrix is:

$$M = \frac{1}{\sqrt{2}} \begin{bmatrix} 1 & 0 & -1 & 0 \\ 0 & 1 & 0 & -1 \\ 1 & 0 & 1 & 0 \\ 0 & 1 & 0 & 1 \end{bmatrix} \quad (6)$$

Using the Mixed-Mode S Parameters (S Element)

The S element can recognize and parse the mixed-mode S parameters when the `mixedmode=1` keyword is set. Any other keywords besides `mixedmode` and `datatype` remain the same. Use the following syntax for a mixed-mode S parameter.

```
Sxxx p1+ <p1-> p2+ <p2-> p3+ <p3->... [n_ref] mname=Smodel  
.MODEL Smodel S ...  
[+ mixedmode=<0 | 1>]  
[+ datatype=XiYjZk...]
```

The p_{n+} and p_{n-} are the positive and negative terminals of the port n, respectively. If the port is in mixed mode (balanced) one, both positive and negative terminal names are required in series; if the port is single-ended, only one terminal name is required. The port numbers must be in increasing order corresponding to the S matrices notation.

Table 2 Mixed-Mode S Parameter Keywords

Parameter	Description
mixedmode	When <code>mixedmode=1</code> , the element knows that the S parameters are defined in mixed mode. The default is 0 (<code>standardmode</code>)
datatype	A string that determines the order of indices of the incident or reflected vectors (a and b) in Equation 8. The string must be an array of pairs that consists of a letter and a number (for example, Xn), where X= <ul style="list-style-type: none"> • D or d to indicate differential term • C or c to indicate common term • S, s, G or g to indicate single (grounded) term and n = port number.

The definition `datatype = D1D2C1C2` is the default for a 2-balanced port network and specifies the nodal relationship of the following equation:

$$a_{\text{standard}} = [a_{1+} \ a_{1-} \ a_{2+} \ a_{2-}]^T \Leftrightarrow a_{\text{mixed}} = [a_{d1} \ a_{d2} \ a_{c1} \ a_{c2}]^T$$

Where:

- a_{1+} is the incident wave goes into positive terminal of the port 1
- a_{1-} is the incident wave goes into negative terminal of the port 1
- a_{2+} is the incident wave goes into positive terminal of the port 2
- a_{2-} is the incident wave goes into negative terminal of the port 2

You can also derive the nodal relationship of the reflection wave in the same way. Nodes are assigned from the given s-matrices to the S element in the order of a_{standard} . For example, incident and reflected waves at the positive terminal of the 1(a_{1+}, b_{1+}) port appear at the first node of the S element.

2: S Parameter Modeling Using the S Element

Small-Signal Parameter Data-Table Model

The definition `datatype = D1C1S2` specifies the nodal relationship of the following equation:

$$a_{\text{standard}} = [a_{1+} \ a_{1-} \ a_2]^T \Leftrightarrow a_{\text{mixed}} = [a_{d1} \ a_{c1} \ a_{s2}]^T$$

The default of `nodemap` is `nodemap=D1D2...DnC1C2...Cn`, which is available for systems with mixed-mode (balanced) ports only.

Mixed-Mode S Parameter Netlist Examples

Example 8 Differential Transmission Line Pair

You can find an example netlist for a differential transmission line pair in the following directory:

```
$installdir/demo/hspice/sparam/mixedmode_s.sp
```

Example 9 Differential Amplifier

You can find an example netlist for a differential amplifier in the following directory:

```
$installdir/demo/hspice/sparam/diffamp_s.sp
```

Small-Signal Parameter Data-Table Model

The Small-Signal Parameter Data-Table Model (SP model) is a generic model that describes frequency-varying behavior.

SP Model Syntax

```
.MODEL name sp [N=val FSTART=val FSTOP=val NI=val  
+ SPACING=val MATRIX=val VALTYPE=val INFINITY=matrixval  
+ INTERPOLATION=val EXTRAPOLATION=val] [DATA=(npts ...)]  
+ [DATAFILE=filename]
```

Note: Interpolation and extrapolation occur after the simulator internally converts the Z and S parameter data to Y parameter data.

Parameter	Specifies
name	Model name.
N	Matrix dimension (number of signal terminals). Default is 1. If you use a value other than the default, you must specify that value before you set INFINITY and DATA.
FSTART	Starting frequency point for data. Default=0.
FSTOP	Final frequency point for data. Use this parameter only for the LINEAR and LOG spacing formats.
NI	Number of frequency points per interval. Use this parameter only for the DEC and OCT spacing formats. Default=10.
SPACING	Data sample spacing format: <ul style="list-style-type: none"> • LIN (LINEAR): uniform spacing with frequency step of (FSTOP-FSTART)/(npts-1). The default. • OCT: octave variation with FSTART as the starting frequency, and NI points per octave. npts sets the final frequency. • DEC: decade variation with FSTART as the starting frequency, and NI points per decade. npts sets the final frequency. • LOG: logarithmic spacing. FSTART and FSTOP are the starting and final frequencies. • POI: non-uniform spacing. Pairs data (NONUNIFORM) points with frequency points.
MATRIX	Matrix (data point) format: <ul style="list-style-type: none"> • SYMMETRIC: symmetric matrix. Specifies only lower-half triangle of a matrix (default). • HERMITIAN: similar to SYMMETRIC; off-diagonal terms are complex-conjugates of each other. • NONSYMMETRIC: non-symmetric (full) matrix.

2: S Parameter Modeling Using the S Element

Small-Signal Parameter Data-Table Model

Parameter	Specifies
VALTYPE	Data type of matrix elements: <ul style="list-style-type: none">• REAL: real entry.• CARTESIAN: complex number in real/imaginary format (default).• POLAR: complex number in polar format. Specify angles in radians.
INFINITY	Data point at infinity. Typically real-valued. This data format must be consistent with MATRIX and VALTYPE specifications. npts does not count this point.
INTERPOLATION	Interpolation scheme: <ul style="list-style-type: none">• STEP: piecewise step. This is the default.• LINEAR: piecewise linear.• SPLINE: b-spline curve fit.
EXTRAPOLATION	Extrapolation scheme during simulation: <ul style="list-style-type: none">• NONE: no extrapolation is allowed. Simulation terminates if a required data point is outside of the specified range.• STEP: uses the last boundary point. The default.• LINEAR: linear extrapolation by using the last two boundary points. If you specify the data point at infinity, then simulation does not extrapolate and uses the infinity value.
npts	Number of data points.
DC	Data port at DC. Normally real-valued. This data format must be consistent with MATRIX and VALTYPE specifications. npts does not count this point. You must specify either the DC point or the data point at frequency=0.

Parameter	Specifies
DATA	<p>Data points.</p> <ul style="list-style-type: none"> • Syntax for LIN spacing: .MODEL name sp SPACING=LIN [N=dim] FSTART=f0 + DF=f1 DATA=npts d1 d2 ... • Syntax for OCT or DEC spacing: .MODEL name sp SPACING=DEC or OCT [N=dim] + FSTART=f0 NI=n_per_intval DATA=npts d1 d2 ... • Syntax for POI spacing: .MODEL name sp SPACING=NONUNIFORM [N=dim] + DATA=npts f1 d1 f2 d2 ...
DATAFILE	<p>Data points in an external file. This file must contain only raw numbers without any suffixes, comments or continuation letters. The order of data must be the same as in the DATA statement. This data file has no limitation on line length so you can enter a large number of data points.</p>

Examples

```

.MODEL fmod SP N=2 FSTOP=30MegHz
+ DATA = 2
* matrix at f=0
+ 0.02      0.0
* Re(Y11) Im(Y11)
+ -0.02     0.0          0.02    0.0
* Im(Y21) Im(Y21) (= Y21) Re(Y22) Im(Y22)
* matrix at f=30MHz
+ 0.02      0.0
* Re(Y11) Im(Y11)
+ -0.02     0.0          0.02    0.0
* Im(Y21) Im(Y21) (= Y21) Re(Y22) Im(Y22)

.MODEL fmod SP N=2 FSTOP=30MegHz MATRIX=NONSYMMETRIC
+ DATA = 2
* matrix at f=0
+ 0.02      0.0      -0.02    0.0
* Re(Y11) Im(Y11) Re(Y12) Im(Y12)
+ -0.02     0.0       0.02    0.0
* Im(Y21) Im(Y21) Re(Y22) Im(Y22)
* matrix at f=30MHz
+ 0.02      0.0      -0.02    0.0
* Re(Y11) Im(Y11) Re(Y12) Im(Y12)
+ -0.02     0.0       0.02    0.0

```

2: S Parameter Modeling Using the S Element

Small-Signal Parameter Data-Table Model

```
* Im(Y21) Im(Y21) Re(Y22) Im(Y22)

.MODEL fmod SP N=2 SPACING=POI
+ DATA = 1
+ 0.0 * first frequency point
* matrix at f=0
+ 0.02      0.0
* Re(Y11) Im(Y11)
+ -0.02      0.0          0.02      0.0
* Im(Y21) Im(Y21) (= Y21) Re(Y22) Im(Y22)
+ 30e+6 * second frequency point
* matrix at f=30MHz
+ 0.02      0.0
* Re(Y11) Im(Y11)
+ -0.02      0.0          0.02      0.0
* Im(Y21) Im(Y21) (= Y21) Re(Y22) Im(Y22)

.MODEL fmod SP N=2 FSTOP=30MegHz VALTYPE=REAL
+ DATA = 2
* matrix at f=0
+ 0.02 -0.02
* Y11     Y12
+ -0.02 0.02
* Y21     Y22
* matrix at f=30MHz
+ 0.02 -0.02
* Y11     Y12
+ -0.02 0.02
* Y21     Y22

**S-parameter example
.option sim_mode=hspice
.OPTION post=2
.probe v(n2)
V1 n1 0 ac=1v PULSE 0v 5v 5n 0.5n 0.5n 25n
.op
.ac lin 500 1Hz 30MegHz
.tran 0.1ns 10ns
*S1 n1 n2 0 mname=s_model
S1 n1 n2 0 mname=s_model
.model s_model S fqmodel=fmod Zo=50 50
*.model s_model S fqmodel=fmod2 Zo=50 100
* S parameter for Zo=(50 50)
.MODEL fmod SP N=2 FSTOP=30MegHz DATA = 1
+ 0.333333333 0.0 0.666666667 0.0 0.333333333 0.0
* S parameter for Zo=(50 100)
.MODEL fmod2 SP N=2 FSTOP=30MegHz MATRIX=NONSYMMETRIC
```

```
+ DATA = 1
+ 0.5 0.0      0.5 0.0
+ 1.0 0.0      0.0 0.0
Rt1 n2 0 50
.end
```

Example 10 Transmission Line Using Resistive Termination

Figure 20 illustrates a transmission line that uses a resistive termination, and Table 3 shows a corresponding input file listing. In this example, the two outputs from the resistor and S parameter modeling must match exactly.

Figure 20 Transmission Line with Resistive Termination

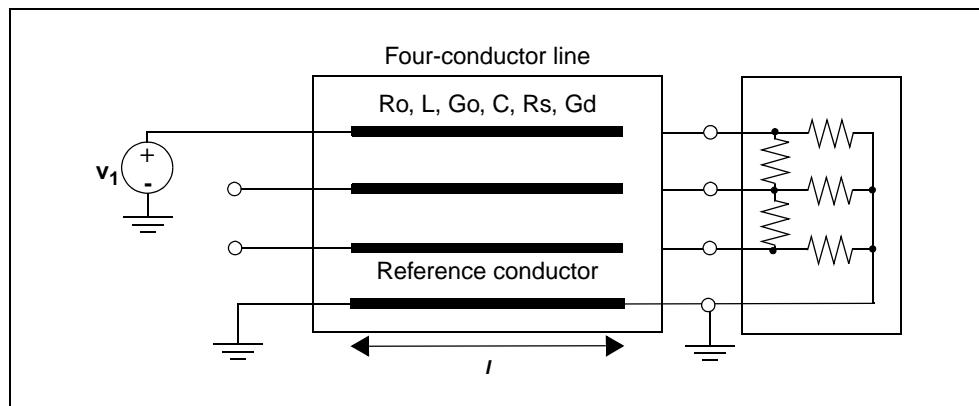


Table 3 Input File Listing

Header, options, and sources	*S-parameter x-line with a resistive positive termination .OPTION POST V1 i1 0 ac=1v
Termination	x1 o1 o2 o3 0 terminator
Transmission line (W Element)	W1 i1 i2 i3 0 o1 o2 o3 0 RLGCMODEL=wrlgc N=3 + L=0.97 .MODEL wrlgc W MODELTYPE=RLGC N=3 + Lo = 2.78310e-07 + 8.75304e-08 3.29391e-07 + 3.65709e-08 1.15459e-07 3.38629e-07 + Co = 1.41113e-10 + -2.13558e-11 9.26469e-11 + -8.92852e-13 -1.77245e-11 8.72553e-11

2: S Parameter Modeling Using the S Element

Small-Signal Parameter Data-Table Model

Frequency model definition	.MODEL fmod sp N=3 FSTOP=30MegHz + DATA= 1 + -0.270166 0.0 + 0.322825 0.0 -0.41488 0.0 + 0.17811 0.0 0.322825 0.0 -0.270166 0.0
Resistor elements	.SUBCKT terminator n1 n2 n3 ref R1 n1 ref 75 R2 n2 ref 75 R3 n3 ref 75 R12 n1 n2 25 R23 n2 n3 25 .ends terminator
Analysis	.AC lin 500 0Hz 30MegHz .DC v1 0v 5v 1v
Equivalent S parameter element	.ALTER S parameter case .SUBCKT terminator n1 n2 n3 ref S1 n1 n2 n3 ref + FQMODEL=fmod .ENDS terminator .END

Example 11 Transmission Line Using Capacitive Network Termination

The transmission line example shown here uses capacitive network termination. The two outputs from the resistor and S parameter modeling in Example 10 differ slightly due to the linear frequency dependency relative to

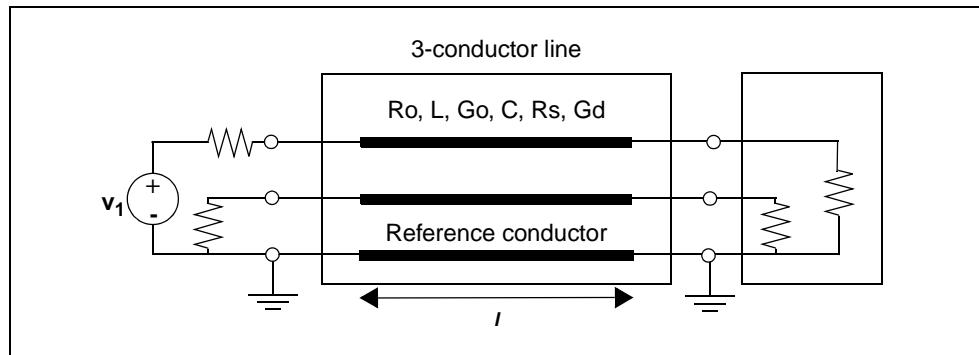
the capacitor. To remove this difference, use the linear interpolation scheme in .MODEL.

Frequency model definition	.MODEL fmod sp N=3 FSTOP=30MegHz + DATA= 2 + 1.0 0.0 + 0.0 0.0 1.0 0.0 + 0.0 0.0 0.0 0.0 1.0 0.0 + 0.97409 -0.223096 + 0.00895303 0.0360171 0.964485 -0.25887 + -0.000651487 0.000242442 0.00895303 + 0.0360171 0.97409 -0.223096
Using capacitive elements	.SUBCKT terminator n1 n2 n3 ref C1 n1 ref 10pF C2 n2 ref 10pF C3 n3 ref 10pF C12 n1 n2 2pF C23 n2 n3 2pF .ENDS terminator

Example 12 Transmission Line Using S Parameter

Figure 21 and Table 4 show an example of a transmission line that uses the S parameter.

Figure 21 3-Conductor Transmission Line



2: S Parameter Modeling Using the S Element

Small-Signal Parameter Data-Table Model

Table 4 Input File Listing

Header, options, and sources	*S parameter ex3: modeling x-line by using + S parameter .OPTION POST vin in0 0 ac=1
Analysis	.AC lin 100 0 1000meg .DC vin 0 1v 0.2v
Transmission line	W1 in1 in2 0 out1 out2 0 N=2 RLGCMODEL=m2
Termination	R1 in0 in1 28 R2 in2 0 28 R3 out1 0 28 R4 out2 0 28
W Element RLGC model definition	.MODEL m2 W ModelType=RLGC, N=2 + Lo= 0.178e-6 0.0946e-7 0.178e-6 + Co= 0.23e-9 -0.277e-11 0.23e-9 + Ro= 0.97 0 0.97 + Go= 0 0 0 + Rs= 0.138e-3 0 0.138e-3 + Gd= 0.29e-10 0 0.29e-10

2: S Parameter Modeling Using the S Element
Small-Signal Parameter Data-Table Model

Frequency model definition	.MODEL SM2 sp N=4 FSTART=0 FSTOP=1e+09 + SPACING=LINEAR + DATA= 60 + 0.00386491 0 + 0 0 0.00386491 0 + 0.996135 0 0 0 0.00386491 0 + 0 0 0.996135 0 0 0 0.00386491 0 + -0.0492864 -0.15301 + 0.00188102 0.0063569 -0.0492864 + -0.15301 0.926223 -0.307306 0.000630484 + -0.00154619 0.0492864 -0.15301 + 0.000630484 -0.00154619 0.926223 + -0.307306 0.00188102 0.0063569 + -0.0492864 -0.15301 -0.175236 -0.241602 + 0.00597 0.0103297 -0.175236 -0.241602 + 0.761485 -0.546979 0.00093508 + -0.00508414 -0.175236 -0.241602 + 0.00093508 -0.00508414 0.761485 + -0.546979 0.00597 0.0103297 -0.175236 + -0.241602 + ...
Equivalent S parameter element	.SUBCKT terminator n1 n2 n3 ref S1 n1 n2 n3 ref FQMODEL=SM2 .ENDS terminator .END

2: S Parameter Modeling Using the S Element

Small-Signal Parameter Data-Table Model

3

Modeling Coupled Transmission Lines Using the W Element

Describes how to use basic transmission line simulation equations and an optional method for computing the parameters of transmission line equations.

A transmission line is a passive element that connects any two conductors, at any distance apart. One conductor sends the input signal through the transmission line and the other conductor receives the output signal from the transmission line. The signal that transmits from one end of the pair to the other end is voltage between the conductors.

Examples of transmission lines include:

- Power transmission lines
- Telephone lines
- Waveguides
- Traces on printed circuit boards and multi-chip modules (MCMs)
- Bonding wires in semiconductor IC packages
- On-chip interconnections

This chapter describes the basic transmission line simulation equations. It explains how to use these equations as an input to the transmission line model,

3: Modeling Coupled Transmission Lines Using the W Element

Equations and Parameters

the W Element. (For more information about the W Element, see Dmitri Kuznetsov, "Optimal Transient Simulation of Transmission Lines," IEEE Trans., Circuits Syst., vol.43, pp. 110-121, Feb., 1996.)

This chapter also shows you an optional method for computing the parameters of the transmission line equations using the *field solver* model.

The W Element is a versatile transmission line model that you can apply to efficiently and accurately simulate transmission lines, ranging from a simple lossless line to complex frequency-dependent lossy-coupled lines. Unlike the U Element, the W Element can output accurate simulation results without fine-tuning optional parameters. For more information on U Elements, see [Chapter 5, "Modeling Ideal and Lumped Transmission Lines."](#)

Transmission line simulation is challenging and time-consuming, because extracting transmission line parameters from physical geometry requires a significant effort. To minimize this effort, you can use a simple (but efficient and accurate) 2-D electromagnetic field solver, which calculates the electrical parameters of a transmission line system, based on its cross-section.

Equations and Parameters

Maxwell's equations for the transverse electromagnetic (TEM) waves on multi-conductor transmission lines, reduce to the telegrapher's equations. The general form of the telegrapher's equation in the frequency domain is:

$$-\frac{\partial}{\partial z}v(z, \omega) = [R(\omega) + j\omega L(\omega)]i(z, \omega)$$
$$-\frac{\partial}{\partial z}i(z, \omega) = [G(\omega) + j\omega C(\omega)]v(z, \omega)$$

The preceding equations use the following definitions:

- Lower-case symbols denote vectors.
- Upper-case symbols denote matrices.
- v is the voltage vector across the lines.
- i is the current vector along the lines.

For the TEM mode, the transverse distribution of electromagnetic fields at any instant of time is identical to that for the static solution.

From a static analysis, you can derive the four parameter matrices for multi-conductor TEM transmission lines:

- resistance matrix, R
- inductance matrix, L
- conductance matrix, G
- capacitance matrix, C

The telegrapher's equations, and the four parameter matrices from a static analysis, completely and accurately describe TEM lines.

Unfortunately, not all transmission lines support pure TEM waves; some multi-conductor systems inherently produce longitudinal field components. In particular, waves propagating in either the presence of conductor losses or the absence of dielectric homogeneity (but not dielectric losses), must have longitudinal components.

However, if the transverse components of the fields are significantly larger than the longitudinal components, the telegrapher's equations (and the four parameter matrices obtained from a static analysis) still provide a good approximation. This is known as a quasi-static approximation.

Multi-conductor systems in which this approximation is valid, are called quasi-TEM lines. For typical micro-strip systems, the quasi-static approximation holds up to a few gigahertz.

Frequency-Dependent Matrices

The static (constant) L and C matrices are accurate for a wide range of frequencies. In contrast, the static (DC) R matrix applies to only a limited frequency range, mainly due to the skin effect. A good approximate expression of the R resistance matrix with the skin effect, is:

$$R(f) \cong R_o + \sqrt{f(1+j)}R_s$$

Where:

- R_o is the DC resistance matrix.
- R_s is the skin effect matrix.

3: Modeling Coupled Transmission Lines Using the W Element

Frequency-Dependent Matrices

The imaginary term depicts the correct frequency response at high frequency; however, it might cause significant errors for low-frequency applications. In the W Element, you can optionally exclude this imaginary term:

```
Wxxx i1 i2 ... iN iR o1 o2 ... oN oR N=val L=val INCLUDERSIMAG=NO
```

In contrast, the G (loss) conductance matrix is often approximated as:

$$G(f) \cong G_o + \frac{f}{\sqrt{1 + (f/f_{gd})^2}} G_d$$

Where:

- G_o models the shunt current due to free electrons in imperfect dielectrics.
- G_d models the power loss due to the rotation of dipoles under the alternating field (C. A. Balanis, Advanced Engineering Electromagnetics, New York: Wiley, 1989).
- f_{gd} is a cut-off frequency.

If you do not set f_{gd} , or if you set f_{gd} to 0, then $G(f)$ keeps linear dependency on the frequency. In the W Element, the default f_{gd} is zero (that is, $G(f)$ does not use the f_{gd} value).

You can specify an alternate value in the W Element statement:

```
Wxxx i1 i2 ... iN iR o1 o2 ... oN oR N=val L=val fgd=val
```

If you prefer to use the previous linear dependency, set f_{gd} to 0.

Determining Matrix Properties

All matrices in [Frequency-Dependent Matrices](#) are symmetric.

- The diagonal terms of L and C are positive, non-zero.
- The diagonal terms of R_o , R_s , G_o , and G_d are non-negative (can be zero).
- Off-diagonal terms of the L, R_o impedance matrices are non-negative.

R_o can have negative off-diagonal terms, but a warning appears. Negative off-diagonal terms normally appear when you characterize R_o at a frequency higher than zero. Theoretically, R_o should not contain negative off-diagonal terms, because these might cause errors during analysis.

- Off-diagonal terms of admittance matrices C , G_o , and G_d are non-positive.
- Off-diagonal terms of all matrices can be zero.

The elements of admittance matrices are related to the self/mutual admittances (such as those that the U Element generates):

$$Y_{ii} = \sum_{j=1}^N Y_{ij}^{(self)/(mutual)}$$

$$Y_{ij} = -Y_{ij}^{mutual}, i \neq j$$

In the preceding equations, Y stands for either C , G_o , or G_d .

A diagonal term of an admittance matrix is the sum of all self and mutual admittance in this row. This term is larger (in absolute value) than the sum of all off-diagonal terms in its row or column. Admittance matrices are strictly diagonally dominant (except for a zero matrix).

You can obtain loop impedance matrix terms from the partial impedance matrix:

$$Z_{ij}^{(loop)} = Z_{ij}^{(partial)} - Z_{io}^{(partial)} - Z_{jo}^{(partial)} + Z_{oo}^{(partial)}$$

In the preceding equation, the o index denotes a reference node.

Wave Propagation

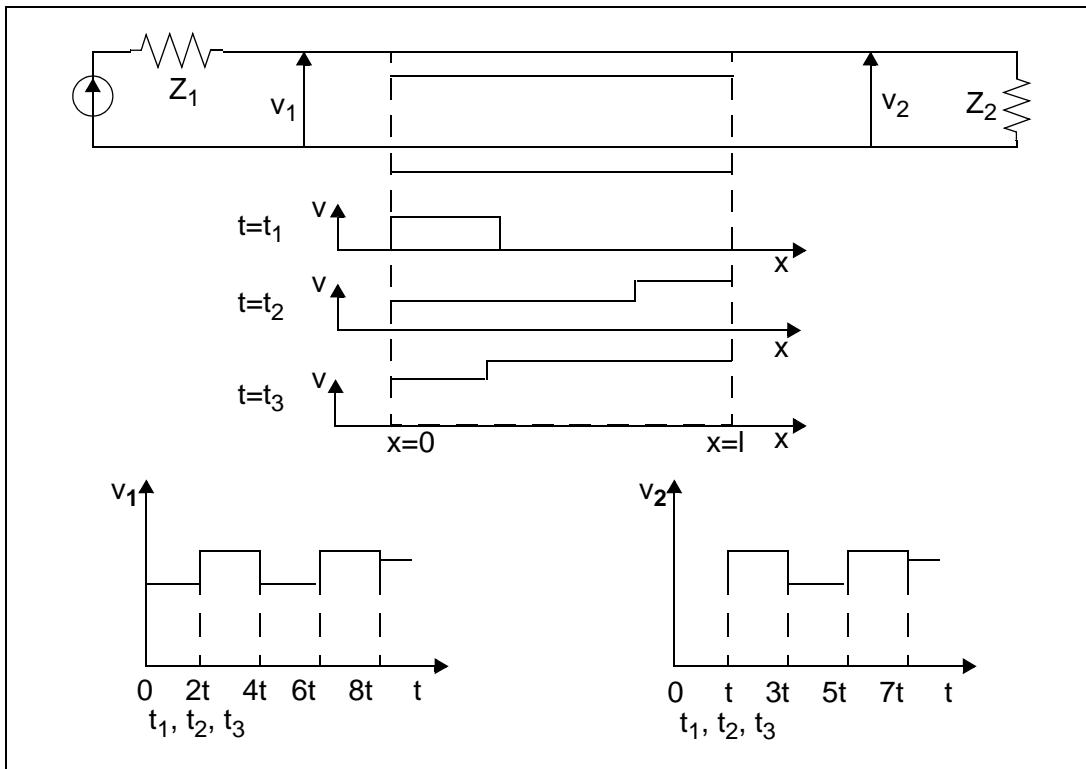
To illustrate the physical process of wave propagation and reflection in transmission lines, Figure 22 shows lines where the voltage step excites simple termination.

- At the time $t=t_1$, a voltage step from the e_1 source, attenuated by the Z_1 impedance, propagates along the transmission line.
- At $t=t_2$, the voltage wave arrives at the far end of the transmission line, is reflected, and propagates in the backward direction. The voltage at the load end is the sum of the incident and reflected waves.
- At $t=t_3$, the reflected wave arrives back at the near end, is reflected again, and again propagates in the forward direction. The voltage at the source end is the sum of attenuated voltage from the e_1 source, the backward wave, and the reflected forward wave.

3: Modeling Coupled Transmission Lines Using the W Element

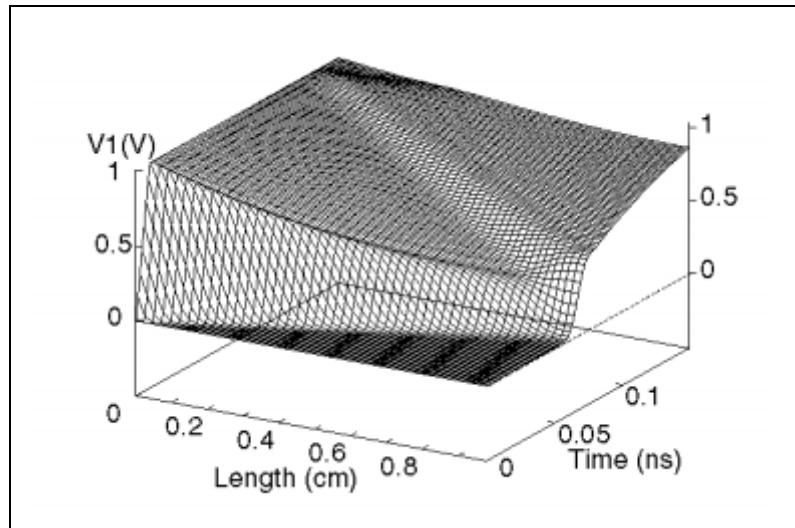
Wave Propagation

Figure 22 Propagation of a Voltage Step in a Transmission Line



The surface plot in Figure 23 shows voltage at each point in the transmission line. The input incident propagates from the left ($\text{length} = 0$) to the right. You can observe both reflection at the end of the line ($\text{length} = 1$), and a reflected wave that goes backward to the near end.

Figure 23 Surface Plot for the Transmission Line Shown in Figure 22



You can find more information about transmission lines in this resource: H.B. Bakoglu, *Circuits, Interconnections and Packaging for VLSI*. Reading, MA: Addison-Wesley, 1990.

Propagating a Voltage Step

This section is a summary of the process in Figure 22 to propagate a voltage step in a transmission line.

- Signals from the excitation source spread-out in the termination networks, and propagate along the line.
- As the forward wave reaches the far-end termination, it does the following:
 - Reflects.
 - Propagates backward.
 - Reflects from the near-end termination.
 - Propagates forward again.
 - Continues in a loop.
- The voltage at any point along the line, including the terminals, is a superposition of the forward and backward propagating waves.

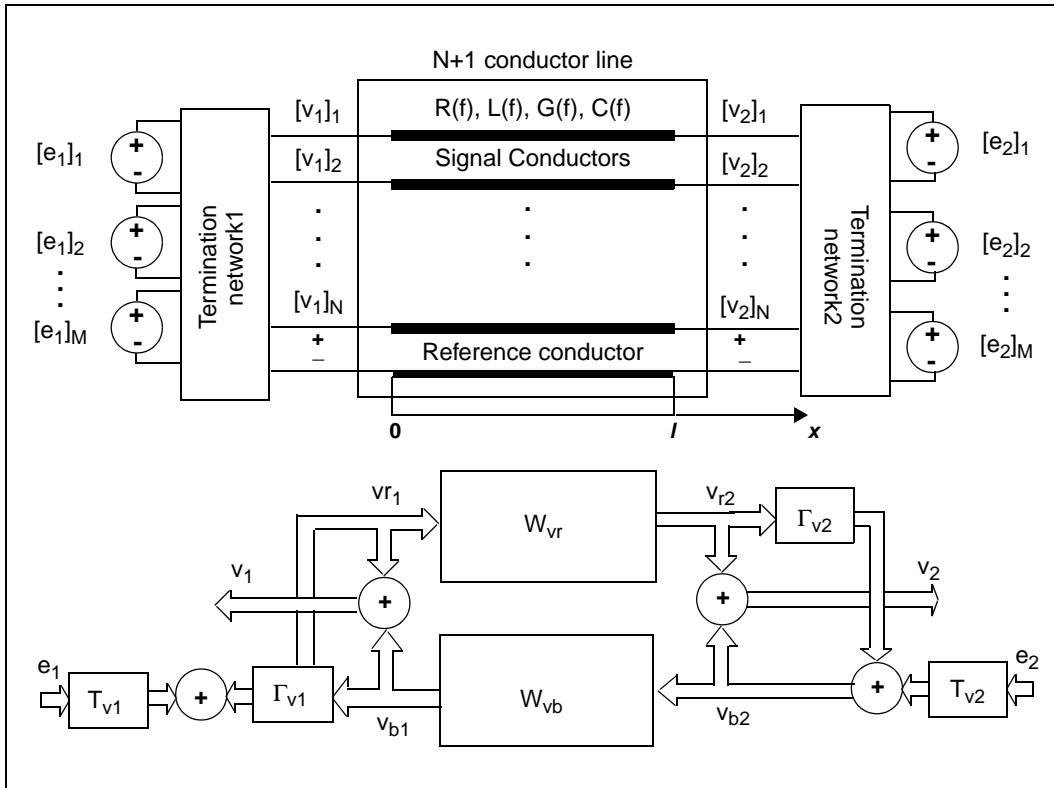
3: Modeling Coupled Transmission Lines Using the W Element

Wave Propagation

Figure 24 shows the system diagram for this process, where:

- W_{vr} and W_{vb} are forward and backward matrix propagation functions for voltage waves.
- T_1, T_2 stand for the near-end matrix transmission and reflection coefficients.
- Γ_1, Γ_2 ($\text{Gamma}_1, \text{Gamma}_2$) stand for the far-end matrix transmission and reflection coefficients.

Figure 24 System Model for Transmission Lines



This model reproduces the general relationship between the physical phenomena of wave propagation, transmission, reflection, and coupling in a distributed system. It can represent an arbitrarily-distributed system, such as:

- Transmission line
- Waveguide
- Plane-wave propagation

You can use this model for:

- System analysis of distributed systems, or
- Writing a macro solution for a distributed system without complicated mathematical derivations.

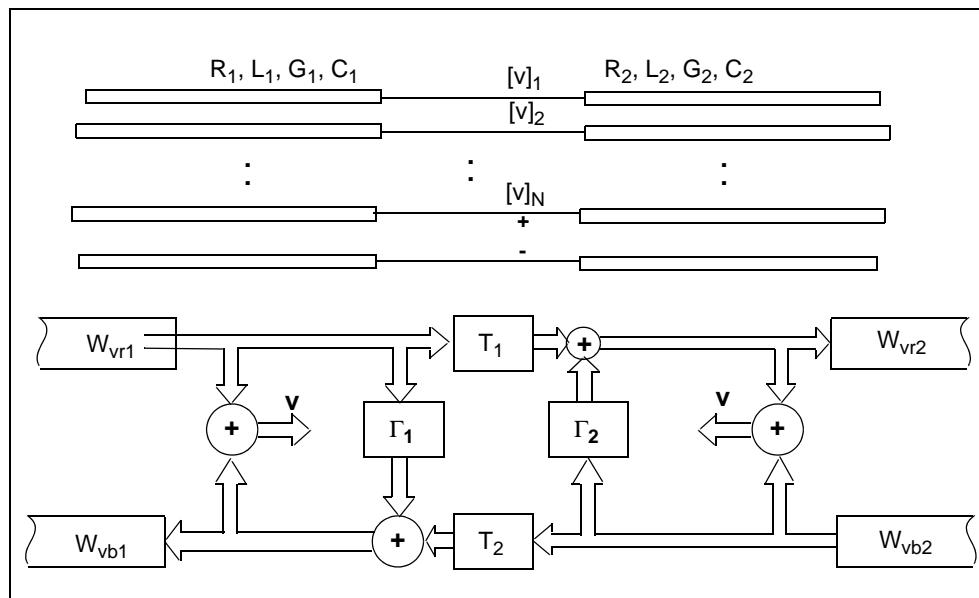
As shown in the figure, transmission lines and terminations form a feedback system. Because the feedback loop contains a delay, both the phase shift, and the sign of the feedback change periodically with the frequency. This causes oscillations in the frequency-domain response of the transmission lines, such as those shown in [Example 30 on page 81](#).

Handling Line-to-Line Junctions

A special case occurs when the line terminates in another line. Figure 25 shows the system diagram for a line-to-line junction. You can use this diagram to:

- Solve multi-layered plane-wave propagation problems.
- Analyze common waveguide structures.
- Derive generalized transmission and reflection coefficient formulas.
- Derive scattering parameter formulas.

Figure 25 System Model for a Line-to-Line Junction



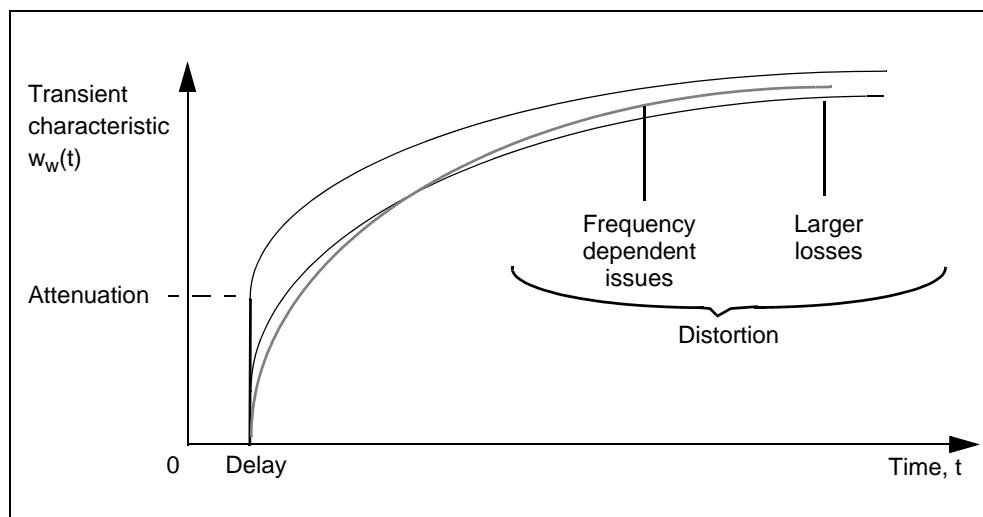
3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

The W_{vr} and W_{vb} propagation functions describe how propagation (from one termination to another) affects a wave. These functions are equal for the forward (W_{vr}) and backward (W_{vb}) directions. The off-diagonal terms of the propagation functions represent the coupling between conductors of a multi-conductor line.

As a wave propagates along the line, it experiences delay, attenuation, and distortion (see Figure 26). Lines with frequency-dependent parameters (that is, all real lines) do not contain the frequency-independent attenuation component.

Figure 26 Propagation Function Transient Characteristics (unit-step response)



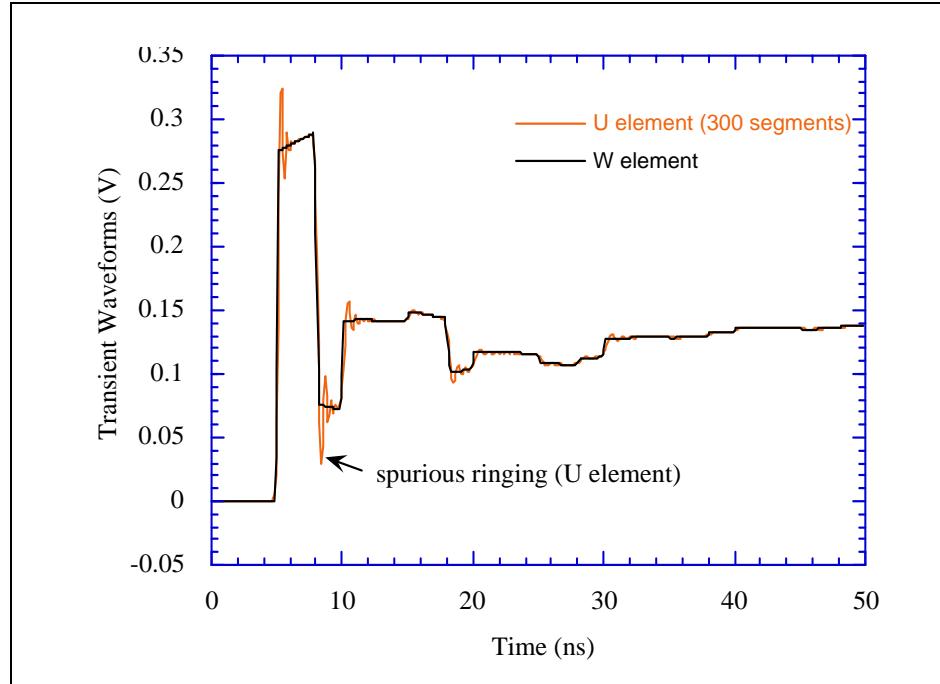
Using the W Element

The W Element is a multi-conductor lossy frequency-dependent transmission line. It provides advanced modeling capabilities for transmission lines. The W Element provides:

- Ability to extract analytical solutions for AC and DC.
- No limit on the number of coupled conductors.
- No restriction on the structure of RLGC matrices; all matrices can be full.
- No spurious ringing, such as the lumped model produces (see [Figure 27 on page 71](#)).
- Accurate modeling of frequency-dependent loss in the transient analysis.

- Built-in 2D field solver, which you can use to specify a physical line shape.

Figure 27 Spurious Ringing in U Element



The W Element supports the following types of analysis:

- DC
- AC
- Transient
- RF analyses (HB, HPAC, HPACNOISE, PHASENOISE, LIN)
- Parameter sweeps
- Optimization
- Monte-Carlo

Control Frequency Range of Interest for Greater Accuracy

This section describes the keywords you can use for achieving greater accuracy of the W Element by controlling the frequency of interest.

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

.OPTION RISETIME Setting

The W Element uses the .OPTION RISETIME parameter to estimate the frequency range of interest for the transient analysis of the W Element.

Depending on the value of this parameter, analysis uses one of the following methods to determine the maximum frequency:

- Positive value: The maximum frequency is the inverse of the value that you specify.
- No setting (recommended): Automatically determines the rise time from source statements. This method works for most cases. However, if the netlist contains the dependent source (which scales or shifts the frequency information), then you must explicitly set the rise time.
- Zero: The internal W Element-bound algorithm computes the maximum frequency for each individual transmission line, and does not use the frequency information contained in source statements.

Note: If you specify `DELAYOPT=3`, then do not use the `RISETIME` option. When `DELAYOPT=3`, the W Element automatically takes a broader frequency range.

Use DELAYOPT Keyword for Higher Frequency Ranges

Long transmission lines fabricated in a high polymer insulator, such as PCB traces, show high losses in high frequencies due to dielectric loss. In such cases, the propagation delay of the system becomes a non-constant function of frequency. To take this phenomenon accurately, beginning with the 2003.09 release of HSPICE, a novel pre-process function was introduced for constructing W Element transient (recursive convolution) model with a higher level of accuracy. To activate this new function, you can add the `DELAYOPT` keyword to the W Element instance line. You can use `DELAYOPT=0 | 1 | 2` to deactivate, activate, and automatic determination, respectively. The default value is 0 (deactivate). If this function is deactivated, the W Element behaves identical to the previous versions.

Beginning with the 2004.03 release, `DELAYOPT=3` was introduced, which achieves a higher level of accuracy up to a tens of GHz operation and involves harmonics up to THz order. With this option, line length limits are removed, which frees the simulation from segmenting, and allows independence in the behavior of the risetime option setting. A setting of `DELAYOPT=3` automatically detects whether or not frequency-dependent phenomena need to be recorded, which makes it identical to the `DELAYOPT=0` option if it produces a high enough accuracy.

Note: The `DELAYOPT=3` option activates additional evaluation functions in transient analysis, which might take longer CPU time.

Use DCACC Keyword for Lower Frequency Ranges

Beginning with the 2005.03 release, The W Element takes an additional step in making a time domain model check the accuracy of low frequency and DC coverage. And it automatically adds a few rational function terms if necessary. This process may cause slight additional computational cost and slight difference in element behavior in DC offset than in previous versions. Should you choose to use this conventional behavior, set `DCACC=0` in the W Element instance or model line to deactivate this process.

W Element Time-Step Control in Time Domain

This section describes using static and dynamic time-step controls in the time domain.

Using Static Time-Step Control

The W Element provides accurate results with just one or two time steps per excitation transient (0.1 ns in [Figure 27 on page 71](#)). Like the T Element, the W Element supports the `TLINLIMIT` option. The `TLINLIMIT=0` default setting enables special breakpoint building, which limits the maximum time step by the smallest transmission line delay in the circuit. This improves transient accuracy for short lines, but reduces efficiency. Setting `TLINLIMIT=1` disables this special breakpoint building.

Longer transmission lines might experience prolonged time intervals when nothing happens at the terminals, while the wave propagates along the line. If you increase the time step, the accuracy of the simulation decreases when the wave reaches the terminal. To prevent this for longer lines excited with short pulses, set `.OPTION DELMAX` to limit the time step to between 0.5 and 1 of the excitation transient.

Using Dynamic Time-Step Control

Static time step control achieves certain accuracy by setting static breakpoints. The `TLINLIMIT=0` option limits the maximum time step by the minimum transmission line delay, which results in poor performance for the cases with ultra-short delay transmission lines. In this case, too many redundant time

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

points are calculated, especially when the transmission line terminal signals do not vary rapidly. The same problem exists with the DELMAX option where time steps are evenly set in spite of terminal signal variation. This is inefficient.

In the 2004.09 release, the WACC option was added to solve this problem by providing dynamic step control of W Element transient analysis. Setting WACC to a positive value removes the static breakpoints and the necessary time points are set dynamically according to the variations in terminal currents and voltages.

The WACC option has the following syntax:

```
.OPTION WACC=value
```

Where WACC is a non-negative real value. It can be set between 0.0 and 10.0. When WACC is positive, the new method is activated. The default value is 0.0.

Larger values result in higher performance with lower accuracy, while smaller values result in lower performance with better accuracy. Use WACC=1.0 for normal simulation and WACC=0.1 for an accurate simulation. When WACC=0.0, the conventional step control method is used.

The WACC option has a higher priority than the TLINLIMIT option. It is only when WACC=0.0 can the TLINLIMIT option limit the maximum time step by the minimum transmission line delay. The DELMAX option has a higher priority than the WACC option. You can further limit the time step by setting the DELMAX option in addition to the WACC option.

Input Syntax for the W Element

Syntax:

```
WXXX i1 i2 ... iN iR o1 o2 ... oN oR N=val L=val
+ <RLGCMODEL=name or RLGCFILe=name or UMODEL=name>
+ FSMODEL=name or TABLEMODEL=name or SMODEL=name>
+ [ INCLUDERSIMAG=YES | NO FGD=val ] [ DELAYOPT=0 | 1 | 2 ]
+ <NODEMAP=XiYj...> <NOISE=[1 | 0]> <DTEMP=val>
```

Parameter	Description
N	Number of signal conductors (excluding the reference conductor).
i1...iN	Node names for the near-end signal-conductor terminal (Figure 28 on page 77).
iR	Node name for the near-end reference-conductor terminal.
o1... oN	Node names for the far-end signal-conductor terminal (Figure 28 on page 77).
oR	Node name for the far-end reference-conductor terminal.
L	Length of the transmission line.
RLGCMODEL	Name of the RLGC model.
RLGCFILe	Name of the external file with RLGC parameters. (See Input Model 1: W Element, RLGC Model on page 78 .)
UMODEL	Name of the U model. (See Input Model 2: U Element, RLGC Model on page 84 .)
FSMODEL	Name of the field solver model.
TABLEMODEL	Name of the frequency-dependent tabular model.
SMODEL	Name of the S model. (See Input Model 5: S Model on page 92 .)
INCLUDERSIMAG	Imaginary term of the skin effect to be considered. The default value is YES. (See Frequency-Dependent Matrices on page 63 .)

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

Parameter	Description
FGD	Specifies the cut-off frequency of dielectric loss. (See Handling the Dielectric-loss Matrix on page 85 .)
DELAYOPT	Deactivates (0), activates (1) or determines automatically(2). The default is 0.
NODEMAP	String that assigns each index of the S parameter matrix to one of the W Element terminals. This string must be an array of pairs that consists of a letter and a number, (for example, Xn), where <ul style="list-style-type: none">• X= I, i, N, or n to indicate near end (input side) terminal of the W element• X= O, o, F, or f to indicate far end (output side) terminal of the W element. The default value is NODEMAP = I1I2I3...InO1O2O3...On.
NOISE	Activates thermal noise. <ul style="list-style-type: none">• 1: element generates thermal noise• 0 (default): element is considered noiseless
DTEMP	Temperature difference between the element and the circuit, expressed in °C. The default is 0.0. Element temperature is calculated as: $\begin{aligned} T &= \text{Element temperature } (^{\circ}\text{K}) \\ &= 273.15 \text{ } (^{\circ}\text{K}) + \text{circuit temperature } (^{\circ}\text{C}) \\ &\quad + \text{DTEMP } (^{\circ}\text{C}) \end{aligned}$ Where circuit temperature is specified using either the .TEMP statement, or by sweeping the global TEMP variable in .DC, .AC, or .TRAN statements. When a .TEMP statement or TEMP variable is not used, the circuit temperature is set by .OPTION TNOM, which defaults to 25 °C unless you use .OPTION SPICE, which raises the default to 27 °C.

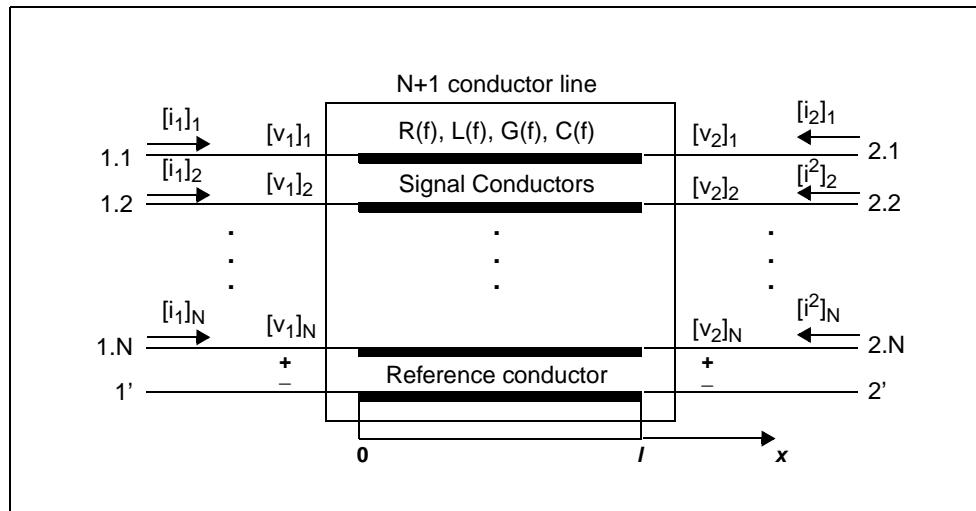
3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

The W Element supports four different formats to specify the transmission line properties:

- Model 1: RLGC-Model specification
 - Internally specified in a .MODEL statement.
 - Externally specified in a different file.
- Model 2: U-Model specification
 - RLGC input for up to five coupled conductors
 - Geometric input (planer, coax, twin-lead)
 - Measured-parameter input
 - Skin effect
- Model 3: Built-in field solver model
- Model 4: Frequency-dependent tabular model.
- Model 5: S model specification
 - S parameters specified by an S model
 - Valid only for transmission line-based S parameters.

Figure 28 Terminal Node Numbering



Normally, you can specify parameters in the W Element card in any order. Specify the number of signal conductors, N , after the list of nodes. You can intermix the nodes and parameters in the W Element card.

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

You can specify only one RLGCMODEL, FSMODEL, UMODEL, or RLGCFILe in a single W Element card.

Input Model 1: W Element, RLGC Model

[Equations and Parameters on page 62](#) describes the inputs of the W Element per unit length matrices:

- R_o
- L
- G
- C
- R_s (skin effect)
- G_d (dielectric loss)

The W Element does not limit any of the following parameters:

- Number of coupled conductors.
- Shape of the matrices.
- Line loss.
- Length or amount of frequency dependence.

The RLGC text file contains frequency-dependent RLGC matrices per unit length.

The W Element also handles frequency-independent RLGC, and lossless (LC) lines. It does not support RC lines.

Because RLGC matrices are symmetrical, the RLGC model specifies only the lower triangular parts of the matrices. The syntax of the RLGC model for the W Element is:

```
.MODEL name W MODELTYPE=RLGC N=val Lo=matrix_entries
+ Co=matrix_entries [ Ro=matrix_entries Go=matrix_entries
+ Rs=matrix_entries Gd=matrix_entries Rognd=val
+ Rsgnd=val Lgnd=val ]
```

3: Modeling Coupled Transmission Lines Using the W Element
Using the W Element

Parameter	Description
N	Number of conductors (same as in the element card).
L	DC inductance matrix, per unit length $\left[\frac{H}{m}\right]$.
C	DC capacitance matrix, per unit length $\left[\frac{F}{m}\right]$.
R_o	DC resistance matrix, per unit length $\left[\frac{\Omega}{m}\right]$.
G_o	DC shunt conductance matrix, per unit length $\left[\frac{S}{m}\right]$.
R_s	Skin effect resistance matrix, per unit length $\left[\frac{\Omega}{m\sqrt{Hz}}\right]$.
G_d	Dielectric loss conductance matrix, per unit length $\left[\frac{S}{m \cdot Hz}\right]$.
L_{gnd}	DC inductance value, per unit length for grounds $\left[\frac{H}{m}\right]$ (reference line).
R_{ognd}	DC resistance value, per unit length for ground $\left[\frac{\Omega}{m}\right]$.
R_{sgnd}	Skin effect resistance value, per unit length for ground $\left[\frac{\Omega}{m\sqrt{Hz}}\right]$.

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

The following input netlist file shows RLGC input for the W Element:

```
* W-Element example, four-conductor line
W1 N=3 1 3 5 0 2 4 6 0 RLGCMODEL=example_rlc l=0.97
V1 1 0 AC=1v DC=0v pulse(4.82v 0v 5ns 0.1ns 0.1ns 25ns)
.AC lin 1000 0Hz 1GHz
.DC v1 0v 5v 0.1v
.tran 0.1ns 200ns

* RLGC matrices for a four-conductor lossy
.MODEL example_rlc W MODELTYPE=RLGC N=3
+ Lo=
+ 2.311e-6
+ 4.14e-7 2.988e-6
+ 8.42e-8 5.27e-7 2.813e-6
+ Co=
+ 2.392e-11
+ -5.41e-12 2.123e-11
+ -1.08e-12 -5.72e-12 2.447e-11
+ Ro=
+ 42.5
+ 0 41.0 + 0 0 33.5
+ Go= + 0.000609
+ -0.0001419 0.000599
+ -0.00002323 -0.00009 0.000502
+ Rs=
+ 0.00135
+ 0 0.001303
+ 0 0 0.001064
+ Gd=
+ 5.242e-13
+ -1.221e-13 5.164e-13
+ -1.999e-14 -7.747e-14 4.321e-13
.end
```

The following three figures show plots of the simulation results:

- Figure 29 shows DC sweep
- Figure 30 shows AC response
- Figure 31 shows transient waveforms.

These figures also demonstrate that the transmission line behavior of interconnects has a significant and complicated effect on the integrity of a signal. This is why it is very important to accurately model transmission lines when you verify high-speed designs.

3: Modeling Coupled Transmission Lines Using the W Element Using the W Element

Figure 29 Simulation Results: DC Sweep

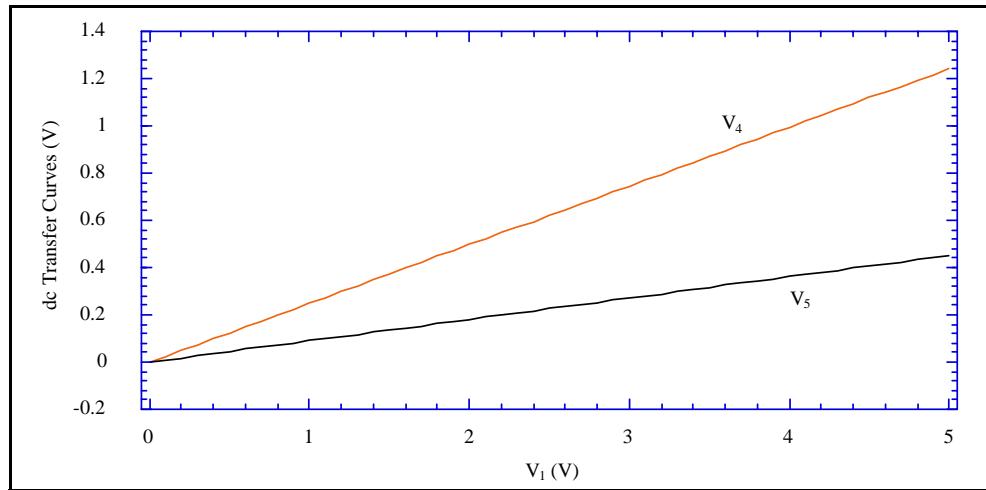
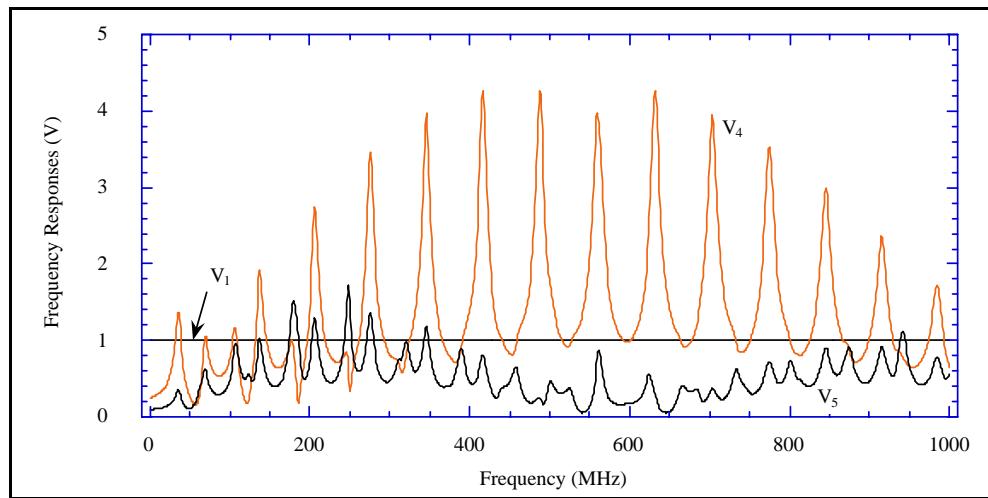


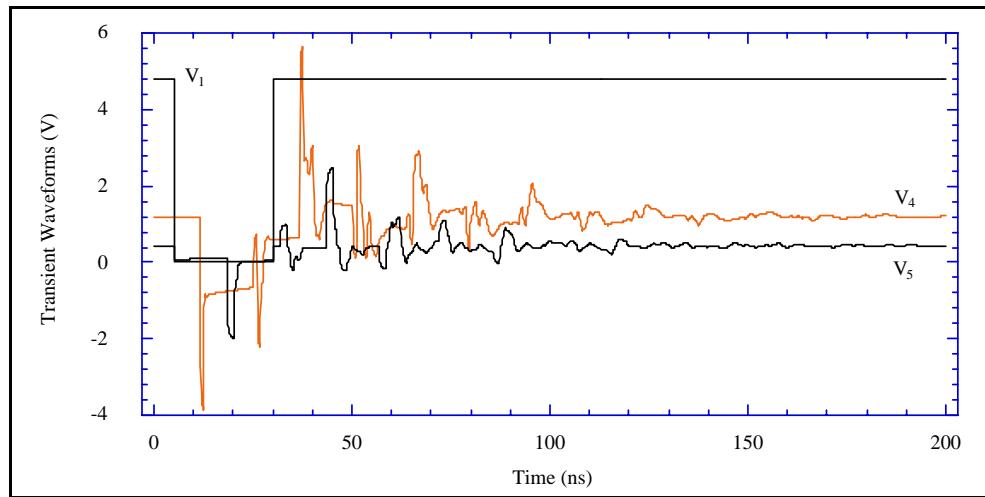
Figure 30 Simulation Results: AC Response



3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

Figure 31 Simulation Results: Transient Waveforms



Specifying the RLGC Model in an External File

You can also specify RLGC matrices in a RLGC file. Its file format is more restricted than the RLGC model; for example:

- You cannot include any parameters.
- The file does not support ground inductance and resistance.

Note: This format does not provide any advantage over the RLGC model so do not use it unless you already have an RLGC file. It is supported for backward-compatibility.

The RLGC file only specifies the lower-triangular parts of the matrices and is order-dependent. Its parameters are in the following order:

Table 5 Parameters in RLGC File for W Element

Parameter	Description
N	Number of conductors (same as in the element card).
L	DC inductance matrix, per unit length $\left[\frac{H}{m}\right]$.
C	DC capacitance matrix, per unit length $\left[\frac{F}{m}\right]$.

Table 5 Parameters in RLG File for W Element

R_o (Optional)	DC resistance matrix, per unit length $\left[\frac{\Omega}{m}\right]$.
G_o (Optional)	DC shunt conductance matrix, per unit length $\left[\frac{S}{m}\right]$.
R_s (Optional)	Skin effect resistance matrix, per unit length $\left[\frac{\Omega}{m\sqrt{Hz}}\right]$.
G_d (Optional)	Dielectric loss conductance matrix, per unit length $\left[\frac{S}{m \cdot Hz}\right]$.

Note: You can skip the optional parameters, because they default to zero. But if you specify an optional parameter, then you must specify all preceding parameters, even if they are zero.

An asterisk (*) in an RLG file comments out everything until the end of that line. You can use any of the following characters to separate numbers:

space tab newline , ; () [] { }

This RLG file is for the same netlist example used for the RLG model in the previous section:

```
* W- Element example, four-conductor line

W1 N=3 1 3 5 0 2 4 6 0 RLGfile=example.rlc l=0.97
V1 1 0 AC=1v DC=0v pulse(4.82v 0v 5ns 0.1ns 0.1ns 25ns)

.AC lin 1000 0Hz 1GHz
.DC v1 0v 5v 0.1v
.tran 0.1ns 200ns

.end
```

Calls this example.rlc file:

```
* RLG parameters for a four-conductor lossy
* frequency-dependent line
* N (number of signal conductors)
```

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

```
* Lo
2.311e-6
4.14e-7 2.988e-6
8.42e-8 5.27e-7 2.813e-6

* Co
2.392e-11
-5.41e-12 2.123e-11
-1.08e-12 -5.72e-12 2.447e-11

* Ro
42.5
0 41.0
0 0 33.5

* Go
0.000609
-0.0001419 0.000599
-0.00002323 -0.00009 0.000502

* Rs
0.00135
0 0.001303
0 0 0.001064

* Gd
5.242e-13
-1.221e-13 5.164e-13
-1.999e-14 -7.747e-14 4.321e-13
```

The RLGC file format does not support scale suffixes, such as:

n (10⁻⁹) or p (10⁻¹²)

Input Model 2: U Element, RLGC Model

The W Element accepts the U model as an input to provide backward compatibility with the U Element. It also uses the geometric and measured-parameter interfaces of the U model.

To use the W Element with the U model on the W Element card, specify:

Umodel=U-*model_name*

The W Element supports all U model modes, including:

- geometric, `Elev=1`
 - planar geometry, `Plev=1`
 - coax, `Plev=2`
 - twin-lead, `Plev=3`
- RLGC, `Elev=2`
- measured parameters, `Elev=3`
- skin-effect, `Nlay=2`

The only exception is `Llev=1`, which adds the second ground plane to the U model. The W Element does not support this. To model the extra ground plane, add an extra conductor to the W Element in `Elev=2`, or use an external lumped capacitor in `Elev=1` or `Elev=3`. For information about the U model, see [Chapter 5, “Modeling Ideal and Lumped Transmission Lines.”](#)

Using RLGC Matrices

RLGC matrices in the RLGC model of the W Element are in the Maxwellian format. In the U model, they are in self/mutual format. For conversion information, see [Determining Matrix Properties on page 64](#). When you use the U model, the W Element performs the conversion internally. [Table 7 on page 86](#) shows how the RLGC matrices in the U model are related to the RLGC matrices in the W Element, and how the W Element uses these matrices.

Handling the Dielectric-loss Matrix Because the U model does not input the G_d dielectric loss matrix, the W Element defaults G_d to zero when it uses the U model input.

Handling the Skin-effect Matrix The U and W Elements use the R_s skin-effect resistance in different ways.

- In a W Element, the R_s matrix specifies the square-root dependence of the frequency-dependent resistance:

$$R(f) \cong R_o + \sqrt{f}(1+j)R_s$$

- In a U Element, R is the value of skin resistance at the frequency:

$$R \cong R_c + R_s$$

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

In the preceding equation, the core resistance (R_c) is equivalent to the DC resistance (R_o) in the W Element. The frequency at which the U Element computes the R matrix is:

$$f_{skin} = \frac{1}{15 \cdot RISETIME}$$

Table 6 RLGC Matrices for U and W Elements

For U models with	W Element
RLGC input; Elev=2	Uses the R_s values that you specify in the <i>U</i> model.
Geometric input; Elev=1	Divides the R_s (which the <i>U</i> model computes internally), by $\sqrt{f_{skin}}$ to obtain the R_s value. For Elev=1, the R_s value in the <i>U</i> model printout is not the same as the R_s value in the <i>W</i> Element.
Measured-parameter input; Elev=3	Does not support the skin effect.

If you do not specify the *RISETIME* option, the *U* Element uses *Tstep* from the *.TRAN* card.

Table 7 RLGC Matrices in the W Element and the U Model

W Element Parameters	U Model Parameters
$L, C \begin{bmatrix} L_{11} & & \\ L_{12} & L_{22} & \\ L_{13} & L_{23} & L_{33} \end{bmatrix}$	$\begin{bmatrix} C_{r1} + C_{12} + C_{13} & & \\ -C_{12} & C_{r2} + C_{12} + C_{23} & \\ -C_{13} & -C_{23} & C_{r3} + C_{13} + C_{23} \end{bmatrix}$
$G_o, G_d \begin{bmatrix} G_{r1} + G_{12} + G_{13} & & \\ -G_{12} & G_{r2} + G_{12} + G_{23} & \\ -G_{13} & -G_{23} & G_{r3} + G_{13} + G_{23} \end{bmatrix}$	$\begin{bmatrix} 0 & & \\ 0 & 0 & \\ 0 & 0 & 0 \end{bmatrix}$

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

Nlay=1 (no skin effect)

$$Ro \begin{bmatrix} R_{11} + R_{rr} & & \\ R_{rr} & R_{22} + R_{rr} & \\ & R_{rr} & R_{33} + R_{rr} \end{bmatrix} \quad Nlay=2 \text{ (skin effect present)} \begin{bmatrix} R_{1c} + R_{rc} & & \\ R_{rc} & R_{2c} + R_{rc} & \\ R_{rc} & R_{rc} & R_{3c} + R_{rc} \end{bmatrix}$$

Nlay=1 (no skin effect)

$$Rs \begin{bmatrix} 0 & & \\ 0 & 0 & \\ 0 & 0 & 0 \end{bmatrix} \quad \frac{1}{\sqrt{f_{\text{skin}}}} \begin{bmatrix} R_{1s} + R_{rs} & & \\ R_{rs} & R_{2s} + R_{rs} & \\ R_{rs} & R_{rs} & R_{3s} + R_{rs} \end{bmatrix}$$

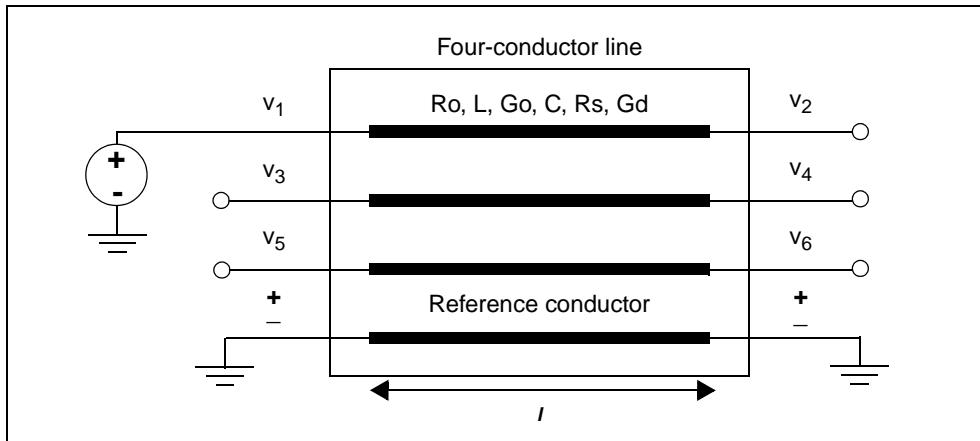
The following netlist is for a 4-conductor line as shown in Figure 32.

```
* W Element example, four-conductor line, U model
W1 1 3 5 0 2 4 6 0 Umodel=example N=3 l=0.97
.MODEL example U LEVEL=3 NL=3 Elev=2 Llev=0 Plev=1 Nlay=2
+ L11=2.311uH
+ L12=0.414uH L22=2.988uH
+ L13=84.2nH L23=0.527uH L33=2.813uH
+ Cr1=17.43pF
+ C12=5.41pF Cr2=10.1pF
+ C13=1.08pF C23=5.72pF Cr3=17.67pF
+ R1c=42.5 R2c=41.0 R3c=33.5
+ Gr1=0.44387mS
+ G12=0.1419mS Gr2=0.3671mS
+ G13=23.23uS G23=90uS Gr3=0.38877mS
+ R1s=0.00135 R2s=0.001303 R3s=0.001064
V1 1 0 AC=1v DC=0v pulse(4.82v 0v 5ns 0.1ns 0.1ns 25ns)
.AC lin 1000 0Hz 1GHz
.DC v1 0v 5v 0.1v
.TRAN 0.1ns 200ns
.END
```

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

Figure 32 4-Conductor Line



Input Model 3: Built-in Field-Solver Model

Instead of RLGC matrices, you can directly use geometric data with the W Element by using a built-in field solver. To use the W Element with a field solver, specify `FSmodel=<model_name>` on the W Element card. For a description of the built-in field solver, see [.end on page 94](#).

Input Model 4: Frequency-Dependent Tabular Model

You can use the tabular RLGC model as an extension of the analytical RLGC model to model any arbitrary frequency-dependent behavior of transmission lines (this model does not support RC lines).

You can use this extension of the W Element syntax to specify a table model (use a `.MODEL` statement of type w). To accomplish this, the `.MODEL` statement refers to `.MODEL` statements where the “type” is SP (described in [Small-Signal Parameter Data-Table Model on page 50](#)), which contain the actual table data for the RLGC matrices.

Notation Used

- Lower-case variable: Scalar quantity
- Upper-case variable: Matrix quantity
- All upper-case words: Keyword
- Parentheses and commas: Optional

Table Model Card Syntax

```
.MODEL name W MODELTYPE=TABLE N=val
+ LMODEL=l_freq_model CMODEL=c_freq_model
+ [ RMODEL=r_freq_model GMODEL=g_freq_model ]
```

Parameter	Description
N	Number of signal conductors (excluding the reference conductor).
LMODEL	SP model name for the inductance matrix array.
CMODEL	SP model name for the capacitance matrix array.
RLMODEL	SP model name for the resistance matrix array. By default, it is zero.
GMODEL	SP model name for the conductance matrix array. By default, it is zero.

The following is an example netlist of a two-line system.

```
.MODEL ex1 W MODELTYPE=TABLE N=2 LMODEL=lmod1
+ CMODEL=cmod1 RMODEL=rmod1 GMODEL=gmod1
.MODEL lmod1 sp N=2 SPACING=NONUNIFORM VALTYPE=REAL
+ DATA=( 1,
+ (0.000000e+00 5.602360e-11 -7.047240e-12)
+ )
.MODEL lmod1 N=2 SPACING=NONUNIFORM VALTYPE=REAL
+ INFINITY=(3.93346e-7 4.93701e-8 3.93346e-7)
+ DATA=( 34,
+ (0.000000e+00 3.933460e-07 4.937010e-08 3.933460e-07)
+ (3.746488e+06 4.152139e-07 4.937010e-08 4.151959e-07)
. ....
+ (4.000000e+09 3.940153e-07 4.937010e-08 3.940147e-07)
+ )
```

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

```
.MODEL rmod1 N=2 SPACING=NONUNIFORM VALTYPE=REAL
+ DATA=( 34,
+ (0.000000e+00 8.779530e-02 6.299210e-03 8.779530e-02)
+ (3.746488e+06 6.025640e-01 6.299210e-03 6.021382e-01)

.....
+
+ (4.000000e+09 1.690795e+01 6.299210e-03 1.689404e+01)
+ )

.MODEL gmod1 N=2 SPACING=NONUNIFORM VALTYPE=REAL
+ DATA=( 34,
+ (0.000000e+00 5.967166e-11 0.000000e+00 5.967166e-11)
+ (3.746488e+06 1.451137e-05 -1.821096e-06 1.451043e-05)

.....
+
+ (4.000000e+09 1.549324e-02 -1.944324e-03 1.549224e-02)
+ )
```

SP .MODEL Syntax

To look at SP .MODEL syntax, see [Small-Signal Parameter Data-Table Model on page 50](#).

Table 8 is an example of a four-conductor transmission line system, and Table 9 is a list of a tabular RLGC model.

Table 8 Input File Listing

Listing Type	W Element Tabular Model Example
Header, options and sources	.OPTION POST V1 7 0 ac=1v dc=0.5v pulse(0.5v 1.5v 0ns 0.1ns) V2 8 0 dc=1v
Analysis	.DC v1 0.5v 5.5v 0.1v SWEEP length POI 2 1.2 2 .AC lin 200 0Hz 1GHz SWEEP Ro POI 3 400 41.6667 400 .TRAN 0.1ns 50ns

3: Modeling Coupled Transmission Lines Using the W Element
Using the W Element

Table 8 Input File Listing

Listing Type	W Element Tabular Model Example
Termination	<pre>R1 7 1 50 R2 4 0 450 R3 5 0 450 R8 6 0 450 R5 4 5 10800 R6 5 6 10800 R7 4 6 1393.5</pre>
Analytical RLGC model (W Element)	<pre>.SUBCKT sub 1 2 3 4 5 6 7 8 W1 1 2 3 4 5 6 7 8 l=0.1 fgd=5e6 RLGCMODEL=analymod n=3 .MODEL analymod W MODELTYPE=RLGC N=3 + Lo=2.41667e-6 + 0.694444e-6 2.36111e-6 + 0.638889e-6 0.694444e-6 2.41667e-6 + Co=20.9877e-12 + -12.3457e-12 29.3210e-12 + -4.01235e-12 -12.3457e-12 20.9877e-12 + Ro=41.6667 + 0 41.6667 + 0 0 41.6667 + Go=0.585937e-3 + 0 0.585937e-3 + 0 0 0.585937e-3 + Rs=0.785e-5 + 0 0.785e-5 + 0 0 0.785e-5 + Gd=0.285e-6 + 0 0.285e-6 + 0 0 0.285e-6 .ENDS sub</pre>
Tabular RLGC model (W Element)	<pre>.ALTER Tabular Model .SUBCKT sub 1 2 3 4 5 6 7 8 W1 n=3 1 2 3 4 5 6 7 8 l=0.1 fgd=5e6 tablem odel=trmod .INCLUDE table.txt .ENDS sub</pre>

3: Modeling Coupled Transmission Lines Using the W Element

Using the W Element

Table 9 Tabular RLGC Model

Listing Type	W Element Tabular Model Example
RLGC table model definition	.MODEL trmod W MODELTYPE=TABLE N=3 + LMODEL=lmod CMODEL=cmod RMODEL=rmod GMODEL=gmod
C model	.MODEL cmod sp N=3 VALTYPE=REAL INTERPOLATION=LINEAR + DATA=(1 2.09877e-11 -1.23457e-11 2.9321e-11 + -4.01235e-12 -1.23457e-11 2.09877e-11)
L model	.MODEL lmod sp N=3 VALTYPE=REAL INTERPOLATION=LINEAR + INFINITY= 2.41667e-06 6.94444e-07 2.36111e-06 + 6.38889e-07 6.94444e-07 2.41667e-06 FSTOP=1e+07 + DATA=(25 2.41667e-06 6.94444e-07 2.36111e-06 + 6.38889e-07 6.94444e-07 2.41667e-06 2.41861e-06 + 6.94444e-07... 2.41707e-06 6.94444e-07 2.36151e-06 + 6.38889e-07 6.94444e-07 2.41707e-06)
R model	.MODEL rmod sp N=3 VALTYPE=REAL INTERPOLATION=LINEAR + FSTOP=1e+10 DATA=(200 41.6667 0 41.6667 0 0 41.6667 + 41.7223 0 41.7223 0 0 41.7223 ... + 42.4497 0 42.4497 0 0 42.4497 42.4517 0 42.4517 0 0 + 42.4517)
G model	.MODEL gmod sp N=3 VALTYPE=REAL INTERPOLATION=LINEAR + FSTOP=1e+08 + DATA=(100 0.000585937 0 0.000585937 + 0 0 0.000585937 0.282764 0 0.282764 0 0 0.282764 + ... 1.42377 0 1.42377 0 0 1.42377 1.42381 0 1.42381 + 0 0 1.42381)

Input Model 5: S Model

The W Element can accept the transmission line-based S parameters as input. To use the W Element with the S model on the W Element card specify the following line:

SMODEL=Smodel_name NODEMAP=XiYj...

Where:

- `Smodel_name` is an S model, which is normally used for an S Element. Use the `XLINELENGTH` keyword in the S Model statement to indicate the line length of the system where the S Parameters are extracted. This keyword is required only when you use an S Model with a W Element. See [S Element Syntax on page 27](#) for more information.
- `NODEMAP` is a string that assigns each index of the S parameter matrix to one of the W Element terminals. This string must be an array of pairs that consists of a letter and a number, (for example, `Xn`), where
 - `X= I, i, N, or n` to indicate near end (input side) terminal of the W element;
 - `X= O, i, F, or f` to indicate far end (output side) terminal of the W element.

For example, `NODEMAP = I1I2O1O2` represents that the

- 1st port of the s-matrix corresponds to the 1st near end terminal of the W Element.
- 2nd port of the s-matrix corresponds to the 2nd near end terminal of the W Element.
- 3rd port of the s-matrix corresponds to the 1st far end terminal of the W Element.
- 4th port of the s-matrix corresponds to the 2nd far end terminal of the W Element.

`NODEMAP = I1I2I3...Ino1o2o3...On` is the default setting.

S Model Conventions

When specifying an S model, you must adhere to the following rules and conventions:

- The size of the NODEMAP array must be the same as twice the line number of the W Elements and also must be the same as the port count of the S parameter matrices.
- If the W Element input model is `SMODEL`, an S model definition accompany that input model.
- S parameters must have even number of terminals.
- S parameters must be symmetric.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

- S parameters must be passive.
- Transmission-line based S Parameters can be used with different lengths of a system when the varying length keyword (L) in a W Element instance statement is present.
- The XLINELENGTH keyword must be set when used in S Models that use W Elements.

S Model Example

The following input netlist file shows S model input for the W Element:

```
***** W Element Example: S Model ***
rout out 0 50
vin in gnd LFSR (1 0 0 0.1n 0.1n 1g 1 [5,2] rout=50)
*+ pulse(0 1 0 0.1n 0.1n 0.9n 2n)

W1 in gnd out gnd SMODEL=smodel N=1 l=0.3
+ NODEMAP=I1O1
.MODEL smodel S TSTONEFILE=w.s2p
+ XLINELENGTH=0.3

.opt accurate post
.tran .01n 20n

.end
```

Extracting Transmission Line Parameters (Field Solver)

The built-in 2-D electromagnetic field solver is highly-optimized for interconnects in stratified media. This field solver uses the W Element, and it supports optimization and statistical analysis within transient simulation.

The solver is based on:

- An improved version of the boundary-element method, and
- The filament method that is also implemented in Raphael.

See K. S. Oh, D. B. Kuznetsov, and J. E. Schutt-Aine, "Capacitance computations in a multi-layered dielectric medium using closed-form spatial Green's functions," IEEE Trans. Microwave Theory and Tech., vol. 42, pp. 1443-1453, August 1994 for more information on the boundary-element method.

To learn more about BEM and Green's Function, see the *Raphael Reference Manual*.

Filament Method

This section describes the filament method for the skin-effect resistance and inductance solver. The 2D filament method uses data about magnetic coupling when it extracts frequency-dependent resistance and inductance. To use this solver, set COMPUTERS=yes in a .FSOPTION statement.

The following process explains the filament method:

1. The filament method divides the original conductor system into thin filaments.
2. From the coupling of these filaments, this method then derives the distributed magnetic coupling of the inside and outside of the conductor.
3. After dividing the conductors into thin filaments, this method creates the impedance matrix of the filament system:

$$Z_f = R_f + j\omega L_f$$

4. This method use the following equation to solve the current matrix (if):

$$v_f = Z_f i_f$$

In the preceding equation, the vf vector excites the filament system.

5. The filament method uses the result of this equation to calculate the partial current matrix of the conductor system ip as a sum of all filament currents:

$$i_{p(j, k)} = \sum_{\text{filaments in conductor } j} i_f \quad (@ \text{ k-th excitation vector})$$

6. The filament method use the following equation to solve the partial impedance matrix (Zp):

$$v_p = Z_p i_p$$

7. From the components of the partial impedance matrix, the filament method uses the following relationship to calculate the components of the loop $Z_{p(j, k)[j, k:0 \sim n]}$ impedance matrix:

$$z_{l(j, k)} = z_{p(j, k)} - z_{p(j, 0)} - z_{p(k, 0)} + z_{p(0, 0)}$$

In the preceding equation, n is the number of signal (non-reference) conductors in the system.

Note: W Element analysis uses these loop impedance components.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Modeling Geometries

In geometry modeling:

- The number of dielectric layers is arbitrary.
- You can arbitrarily shape the conductor cross-section, including an infinitely-thin strip.
- The number of conductors is unlimited.
- The current dielectric region must be planar.
- Conductors must not overlap each other.
- Magnetic materials are not supported.

Geometric modeling outputs the Maxwellian (short-circuit) transmission line matrices: C, L, Ro, Rs, Go, and Gd. (See [Equations and Parameters on page 62.](#))

Solver Limitation

When the field solver computes the conductance matrices (Go and Gd), if the media are not homogeneous, then the solver uses the arithmetic average values of conductivities and loss tangents.

Field-Solver Statement Syntax

The netlist input syntax contains five statements that specifically relate to the field solver:

Table 10 Field-Solver Statement Syntax

Statement	Defines
.MATERIAL	Material properties.
.LAYERSTACK	Stacking of materials.
.SHAPE	Material shapes.
.FSOPTIONS	Field solver options.
.MODEL W MODELTYPE=FieldSolver	Type of transmission-line model.

Defining Material Properties

Use the .MATERIAL statement to define the properties of a material. For the syntax and examples of the .MATERIAL statement, see the *HSPICE Command Reference*.

Creating Layer Stacks

A layer stack defines a stack of dielectric or metal layers. For the syntax and examples of the .LAYERSTACK statement, see the *HSPICE Command Reference*.

Defining Shapes

Use the .SHAPE statement to define a shape. The Field Solver uses the shape to describe a cross-section of the conductor. For the syntax and examples of the .SHAPE statement, see the *HSPICE Command Reference*.

Field-Solver Options

Use the .FSOPTIONS statement to set various options for the field solver. For the syntax and examples of the .FSOPTIONS statement, see the *HSPICE Command Reference*.

Using the Field Solver Model

```
.MODEL mname W MODELTYPE=FieldSolver
+ LAYERSTACK=name <FSOPTIONS=name>
+ <RLGCFIELD=name> <COORD=0|DESCART|1|POLAR>
+ <OUTPUTFORMAT=RLGC|RLGCFIELD>
+ CONDUCTOR=( SHAPE=name <MATERIAL=name>
+ <ORIGIN=(x,y)> <TYPE=SIGNAL|REFERENCE|FLOATING> ) ...
```

Parameter	Specifies
mname	Model name.
LAYERSTACK	Name of the associated layer stack.
FSOPTIONS	Associated option name. If you do not specify this entry, the field solver uses the default options.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Parameter	Specifies
RLGCFILE	Use the output file for RLGC matrices, instead of the standard error output device. If the specified file already exists, then the Field Solver appends the output. To generate output, you must set PRINTDATA in .FSOPTIONS to YES (which is the default).
COORD	The polar field solver is invoked only when COORD=1 or COORD=POLAR.
OUTPUTFORMAT	Model syntax format for RLGC matrices in the W Element. Specified in the RLGC file. Default format is an RLGC model.
SHAPE	Shape name.
x y	Coordinates of the local origin.
MATERIAL	Conductor material name. If you do not specify this entry, the Field Solver uses PEC by default.
ORIGIN	The (radius, degree) of the polar field solver.
TYPE	One of the following conductor types: SIGNAL: a signal node in the W Element (the default). REFERENCE: the reference node in the W Element. FLOATING: floating conductor, no reference to W Element.

Use the field-solver model to specify a geometry model for the W Element transmission line. In the field-solver model:

- The list of conductors must appear last.
- Conductors cannot overlap each other.
- The Field Solver assumes that floating conductors are electrically disconnected, and does not support non-zero fixed charges. Because the field solver is designed as 2D, it ignores displacement current in floating conductors.
- The Field Solver treats metal layers in the layer stack as the reference node.
- Conductors defined as REFERENCE are all electrically-connected, and correspond to the reference node in the W element.

- You must place signal conductors in the same order as the terminal list in the W Element statement. For example, the i th signal conductor (not counting reference and floating conductors), is associated with the i th input and output terminals specified in the corresponding W Element.
- Floating and reference conductors can appear in any order.

Field Solver Examples

The following examples show you how to use the field solver. All of the examples shown in this section run with the HIGH accuracy mode and with GRIDFACTOR = 1.

Example 1: Cylindrical Conductor Above a Ground Plane

This is an example of a copper cylindrical conductor above an ideal (lossless) ground plane.

With these formulas, you can derive the exact analytical formulas for all transmission line parameters:

$$L = \frac{1}{\mu\epsilon} C^{-1}$$

$$G = \frac{\sigma_d}{\epsilon} C = \omega \cdot \tan(\delta) \cdot C$$

$$R = \frac{1}{\sigma_c \delta \pi d} \left[\frac{2H/d}{\sqrt{(2H/d)^2 - 1}} \right] = \sqrt{\frac{\pi \mu}{\sigma_c \pi d}} \left[\frac{2H/d}{\sqrt{(2H/d)^2 - 1}} \right]$$

See S. Ramo, J. R. Whinnery, and T. V. Duzer, *Fields and Waves in Communication Electronics*, 2nd ed. New York: Wiley, 1984, for further information.

Figure 33 shows the geometry of a copper cylindrical conductor above an ideal ground plane.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Figure 33 Cylindrical Conductor Above a Ground Plane

$$C = \frac{2\pi\epsilon}{\operatorname{acosh}\left(\frac{2H}{d}\right)}$$

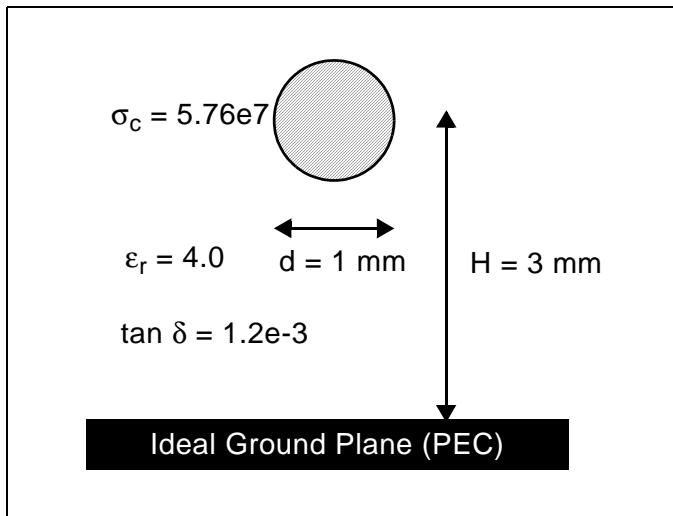


Table 11 lists the corresponding netlist.

Table 11 Input File Listing

Listing Type	Field Solver Cylindrical Example
Header, options and sources	* Example: cylindrical conductor .OPTION PROBE POST VIMPULSE in1 gnd PULSE 4.82v 0v 5n 0.5n 0.5n 25n
W Element	W1 in1 gnd out1 gnd FSmodel=cir_trans N=1 l=0.5
Materials	.MATERIAL diel_1 DIELECTRIC ER=4, LOSSSTANGENT=1.2e-3 .MATERIAL copper METAL CONDUCTIVITY=57.6meg
Shapes	.SHAPE circle_1 CIRCLE RADIUS=0.5mm
Defines a half-space	.LAYERSTACK halfSpace BACKGROUND=diel_1, LAYER=(PEC,1mm)
Option settings	.FSOPTIONS opt1 PRINTDATA=YES, + COMPUTERS=yes, COMPUTEGD=yes

3: Modeling Coupled Transmission Lines Using the W Element
 Extracting Transmission Line Parameters (Field Solver)

Table 11 Input File Listing

Listing Type	Field Solver Cylindrical Example
Model definition	<pre>.MODEL cir_trans W MODELTYPE=FieldSolver + LAYERSTACK=halfSpace, FSOPTIONS=opt1, RLGCFIELD=ex1.rlgc + CONDUCTOR=(SHAPE=circle_1, ORIGIN=(0,4mm), + MATERIAL=copper)</pre>
Analysis, outputs and end	<pre>.TRAN 0.5n 100n .PROBE v(out1) .END</pre>

Compare the computed results with the analytical solutions in Table 12. The Field Solver computes the resistance and conductance at the frequency of 200 MHz, but does not include the DC resistance (R_o) and conductance (G_o) in the computed values.

Table 12 Comparison Result

Value	Exact	Computed
C (pF/m)	89.81	89.66
L (nH/m)	494.9	495.7
G (mS/m)	0.1354	0.1352
R (Ω /m)	1.194	1.178

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Example 2: Stratified Dielectric Media

This is an example of three traces immersed in a stratified dielectric media (see Figure 34).

Figure 34 Three Traces Immersed in Stratified Dielectric Media

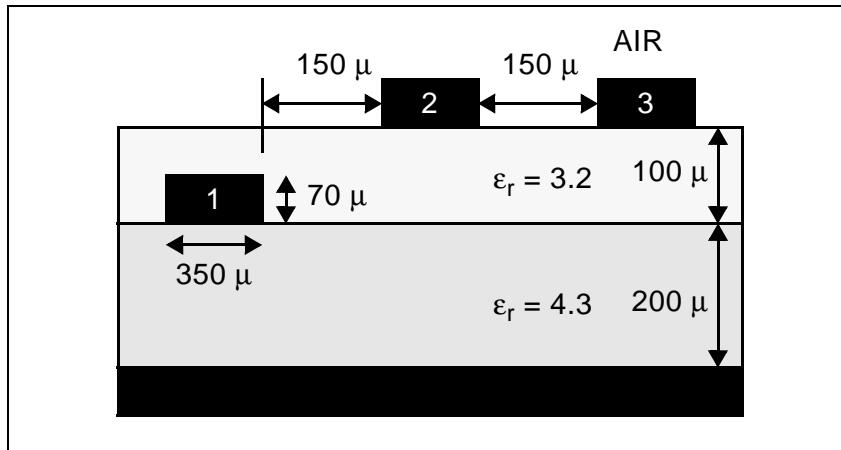


Table 13 shows the input file.

Table 13 Input File for Three Traces Immersed in Stratified Dielectric Media

Listing Type	Field Solver Stratified Dielectric Example
Header, options and sources	* Example: three traces in dielectric .OPTION PROBE POST VIMPULSE in1 gnd PULSE 4.82v 0v 5n 0.5n 0.5n 25n
W Element	W1 in1 in2 in3 gnd out1 out2 out3 gnd + FSmodel=cond3_sys N=3 l=0.5
Materials	.MATERIAL diel_1 DIELECTRIC ER=4.3 .MATERIAL diel_2 DIELECTRIC ER=3.2
Shapes	.SHAPE rect_1 RECTANGLE WIDTH=0.35mm, HEIGHT=0.07mm
Uses the default AIR background	.LAYERSTACK stack_1 + LAYER=(PEC,1um), LAYER=(diel_1,0.2mm), + LAYER=(diel_2,0.1mm)

3: Modeling Coupled Transmission Lines Using the W Element
 Extracting Transmission Line Parameters (Field Solver)

Table 13 Input File for Three Traces Immersed in Stratified Dielectric Media (Continued)

Listing Type	Field Solver Stratified Dielectric Example
Option settings	.FSOPTIONS opt1 PRINTDATA=YES
Three conductors share the same shape	.MODEL cond3_sys W MODELTYPE=FieldSolver, + LAYERSTACK=stack_1, FSOPTIONS=opt1, RLGCFILe=ex2.rlgc + CONDUCTOR=(SHAPE=rect_1,ORIGIN=(0,0.201mm)), + CONDUCTOR=(SHAPE=rect_1,ORIGIN=(0.5mm,0.301mm)), + CONDUCTOR=(SHAPE=rect_1,ORIGIN=(1mm,0.301mm))
Analysis, outputs and end	.TRAN 0.5n 100n .PROBE v(out1) .END

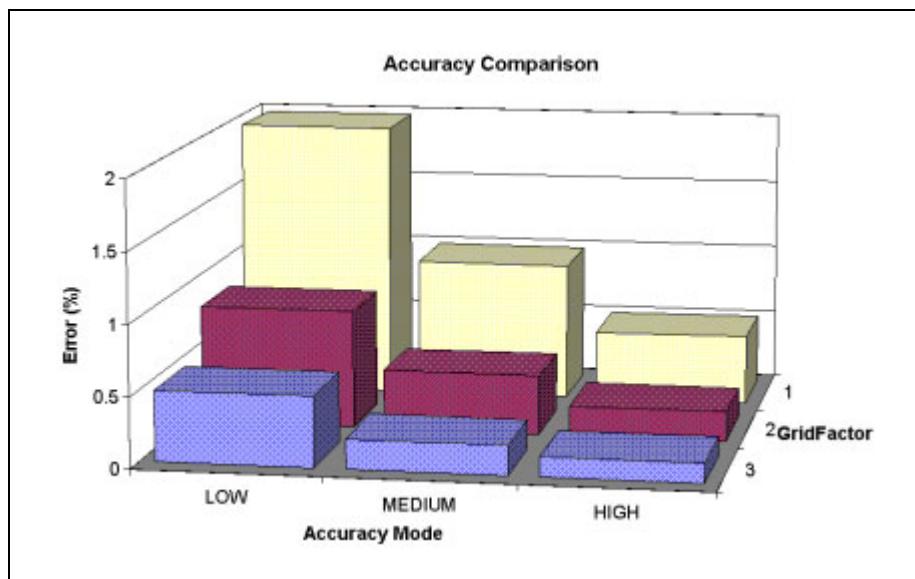
Note: W. Delbare and D. D. Zutter, "Space-domain Green's function approach to the capacitance calculation of multi-conductor lines in multi-layered dielectrics with improved surface charge modeling," IEEE Trans. Microwave Theory and Tech., vol. 37, pp. 1562-1568, October 1989.

Figure 35 shows the results of convergence analysis, based on the total capacitance of the first conductor with respect to the GRIDFACTOR parameter.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Figure 35 -Convergence of Accuracy Modes



Example 3: Two Traces Between Two Ground Planes

This is an example of two traces between two ground planes (in other words, a coupled strip line) (see Figure 36).

Figure 36 Example of a Coupled Strip Line

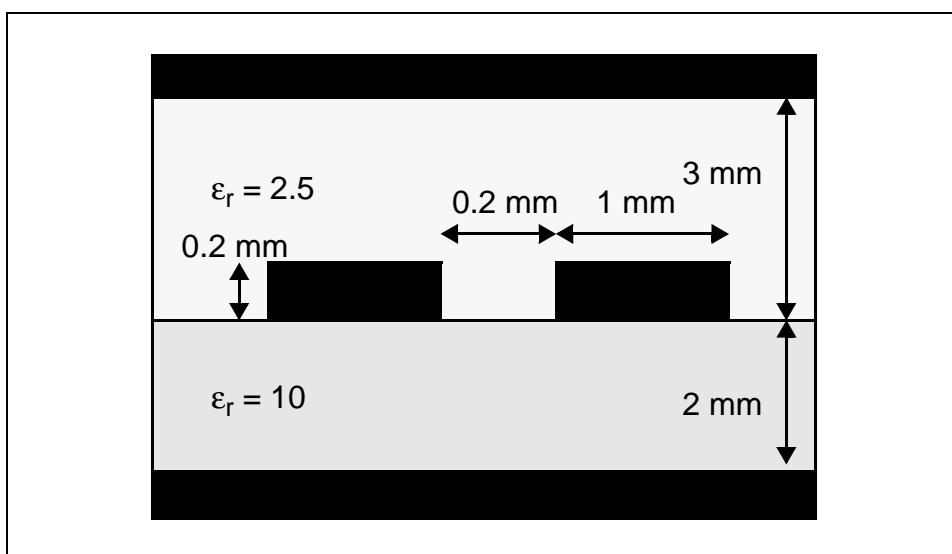


Table 14 lists the complete input netlist.

3: Modeling Coupled Transmission Lines Using the W Element
 Extracting Transmission Line Parameters (Field Solver)

Table 14 Input Netlist for Two Traces Between Two Ground Planes

Listing Type	Field Solver Ground Planes Example
Header, options and sources	* Example: two traces between gnd planes .OPTION PROBE POST VIMPULSE in1 gnd PULSE 4.82v 0v 5n 0.5n 0.5n 25n
W Element	W1 in1 in2 gnd out1 out2 gnd FSmodel=cond2_sys +N=2 l=0.5
Materials	.MATERIAL diel_1 DIELECTRIC ER=10.0 .MATERIAL diel_2 DIELECTRIC ER=2.5
Shapes	.SHAPE rect RECTANGLE WIDTH=1mm, + HEIGHT=0.2mm,
Top and bottom ground planes	.LAYERSTACK stack_1, + LAYER=(PEC,1mm), LAYER=(diel_1,2mm), + LAYER=(diel_2,3mm), LAYER=(PEC,1mm)
Option settings	.FSOPTIONS opt1 PRINTDATA=YES
Two conductors share the same shape	.MODEL cond2_sys W MODELTYPE=FieldSolver, + LAYERSTACK=stack_1, FSOPTIONS=opt1 RLGCFILe=ex3.rlgc + CONDUCTOR=(SHAPE=rect, ORIGIN=(0,3mm)), + CONDUCTOR=(SHAPE=rect, ORIGIN=(1.2mm,3mm))
Analysis, outputs and end	.TRAN 0.5n 100n .PROBE v(out1) .END

Table 15 compares the computed result with the Finite Element (FEM) solver result.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Table 15 Comparison Between Computed and FEM Solver Results

Computed	$\begin{bmatrix} 214.1 & -105.2 \\ -105.2 & 214.1 \end{bmatrix}$ (pF/m)
FEM Solver	$\begin{bmatrix} 217.7 & -108.2 \\ -108.2 & 217.7 \end{bmatrix}$ (pF/m)

Example 4: Using Field Solver with Monte Carlo Analysis

The following example shows how to use Monte Carlo transient analysis to model variations in the manufacturing of a microstrip.

The transient output waveforms are show in Figure 37.

Figure 37 Monte Carlo Analysis with Field Solver and W Element

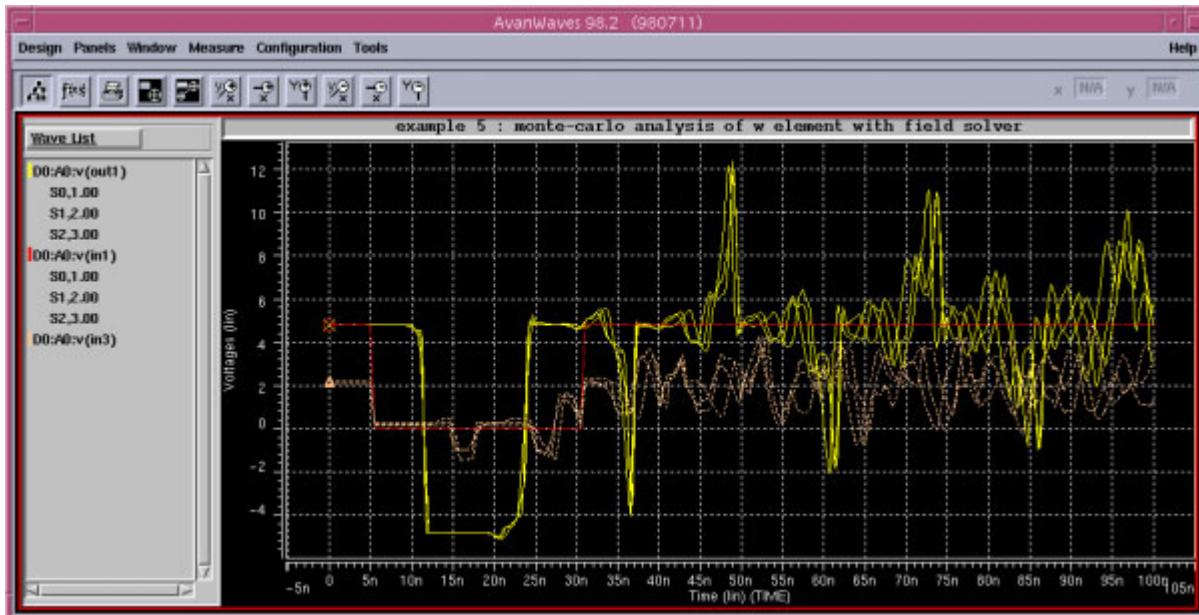


Table 16 shows the input listing with the W Element.

3: Modeling Coupled Transmission Lines Using the W Element
 Extracting Transmission Line Parameters (Field Solver)

Table 16 Input File Listing with the W Element

Listing Type	Field Solver Monte Carlo Example
Header, options and sources	<pre>*PETL Example: with Monte Carlo .OPTION PROBE POST + VIMPULSE in1 gnd AC=1v PULSE 4.82v 0v 5ns + 0.5ns 0.5ns 25ns</pre>
Parameter definitions	<pre>.PARAM x1=Gauss(0,0.02,1) x2=Gauss(0.5mm,0.02,1) + x3=Gauss(1mm,0.02,1) .PARAM dRef=1u dY1=Gauss(2mm,0.02,1) + dY2=Gauss(1mm,0.02,1)</pre>
W Element	<pre>W1 in1 in2 in3 0 out1 out2 out3 0 + FSMODEL=cond3_sys N=3 l=0.5</pre>
Materials	<pre>.MATERIAL diel_1 DIELECTRIC ER=4.3 .MATERIAL diel_2 DIELECTRIC ER=3.2</pre>
Shapes	<pre>.SHAPE r1 RECTANGLE WIDTH=0.35mm, HEIGHT=0.070mm</pre>
Uses the default AIR background	<pre>.LAYERSTACK stack_1 LAYER= (PEC,dRef),LAYER=(diel_1,dY1), + LAYER= (diel_2,dY2)</pre>
Three conductors share the same shape	<pre>.MODEL cond3_sys W MODELTYPE=FieldSolver, + LAYERSTACK=stack1, + CONDUCTOR=(SHAPE=r1,ORIGIN=(x1,'dRef+dY1')), + CONDUCTOR=(SHAPE=r1,ORIGIN=(x2,'dRef+dY1+dY2')), + CONDUCTOR=(SHAPE=r1,ORIGIN=(x3,'dRef+dY1+dY2'))</pre>
Analysis, outputs and end	<pre>.PROBE TRAN v(in1) v(out1) v(in3) .PROBE AC v(out1) v(out3) .PROBE DC v(in1) v(out1) v(out3) .AC LIN 200 0Hz 0.3GHz .DC VIMPULSE 0v 5v 0.01v .TRAN 0.5ns 100ns SWEEP MONTE=3 .END</pre>

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Additional Monte Carlo examples: coax and shield twin-lead lines.

Coax Line

```
*PETL Example: Coaxial Line
.OPTION PROBE POST
VIMPULSE in1 gnd AC=1v PULSE 4.82v 0v 5ns
+0.5ns 0.5ns 25ns

*W element
W1 in1 gnd out1 gnd FSMODEL=coax N=1, L=1
R1 out1 gnd 50

* [[ Material List ]]
.MATERIAL diel_1 DIELECTRIC ER=4
.MATERIAL copper METAL CONDUCTIVITY=57.6meg

* [[ Shape List ]]
.SHAPE circle_1 CIRCLE RADIUS=0.5m

* [[ Layer Stack ]]
.LAYERSTACK coaxial LAYER=(diel_1 11m) $ only one

* [[ Field solver option ]]
.FSOPTIONS myOpt printdata=yes computers=yes computeqd=yes
computeego=yes

* [[ Field solver model ]]
.MODEL coax W MODELTYPE=FIELDSOLVER FSOPTIONS=myOpt COORD=polar
+ LAYERSTACK=coaxial, RLGCFIle=coax.rlgc
+ CONDUCTOR = ( SHAPE=circle_1, MATERIAL=copper, ORIGIN=(0, 0) )

.TRAN 0.5n 100n
.PROBE v(in1) v(out1)
.END
```

Shield Twin-Lead Line

```
*PETL Example: Shield twin-lead lines
.OPTION PROBE POST
VIMPULSE in1 gnd AC=1v PULSE 4.82V 0v 5ns
+0.5ns 0.5ns 25ns

*W element
W1 in1 in2 0 out1 out2 0 FSMODEL=twin, N=2, L=1
R1 out1 gnd 50
R2 out2 gnd 50
R3 in2 gnd 50
```

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

```
* [[ Material List ]]
.MATERIAL diel_1 DIELECTRIC ER=4
.MATERIAL copper METAL CONDUCTIVITY=57.6meg

* [[ Shape List ]]
.SHAPE circle_1 CIRCLE RADIUS=0.5m

* [[ Layer Stack ]]
.LAYERSTACK coaxial LAYER=(diel_1 11m) $ only one

* [[ Field solver option ]]
.FSOPTIONS myOpt printdata=yes computers=yes computegd=yes
    computego=yes
* [[ Field solver model ]]
.MODEL twin W MODELTYPE=FIELDSOLVER FSOPTIONS=myOpt COORD=polar
+ LAYERSTACK=coaxial, RLGCFIELD=twin.rlgc
+ CONDUCTOR = ( SHAPE=circle_1, MATERIAL=copper,
    ORIGIN=(4.5m, 0) )
+ CONDUCTOR = ( SHAPE=circle_1, MATERIAL=copper,
    ORIGIN=(4.5m, 180) )

.TRAN 0.5n 100n
.PROBE v(in1) v(out1) v(out2)
.END
```

W Element Passive Noise Model

The W element is a passive transmission line model. When the transmission lines are lossy, they generate thermal noise. The W element passive noise model is used to describe these noise effects. The W element passive noise model supports both normal and two-port noise analysis (.NOISE and .LIN noisecalc=1).

Input Interface

To trigger a passive noise model, the NOISE and DTEMP keywords in an W element statement are used:

```
W i1 i2 ... iN iR o1 o2 ... oN oR N=val L=val
+ ...
+ <NOISE=[1|0]> <DTEMP=value>
```

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Parameter	Description
$i1\dots iN$	Node names for the near-end signal-conductor terminal (Figure 28 on page 77).
iR	Node name for the near-end reference-conductor terminal.
$o1\dots oN$	Node names for the far-end signal-conductor terminal (Figure 28 on page 77).
oR	Node name for the far-end reference-conductor terminal.
N	Number of signal conductors (excluding the reference conductor).
L	Length of the transmission line.
NOISE	Activates thermal noise. <ul style="list-style-type: none">• 1: element generates thermal noise• 0 (default): element is considered noiseless
DTEMP	Temperature difference between the element and the circuit, expressed in °C. The default is 0.0. Element temperature is calculated as: $\begin{aligned} T &= \text{Element temperature } (\text{°K}) \\ &= 273.15 \text{ (°K)} + \text{circuit temperature } (\text{°C}) \\ &\quad + \text{DTEMP } (\text{°C}) \end{aligned}$ Where circuit temperature is specified using either the .TEMP statement, or by sweeping the global TEMP variable in .DC, .AC, or .TRAN statements. When a .TEMP statement or TEMP variable is not used, the circuit temperature is set by .OPTION TNOM, which defaults to 25 °C unless you use .OPTION SPICE, which raises the default to 27 °C.

3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

When NOISE=1, HSPICE generates a $2N \times 2N$ noise-current correlation matrix from the N-conductor W element admittance matrix according to Twiss' Theorem. The result can be stamped into an HSPICE noise analysis as $2N$ -correlated noise current sources: j_i ($i=1 \sim 2N$), as shown below:

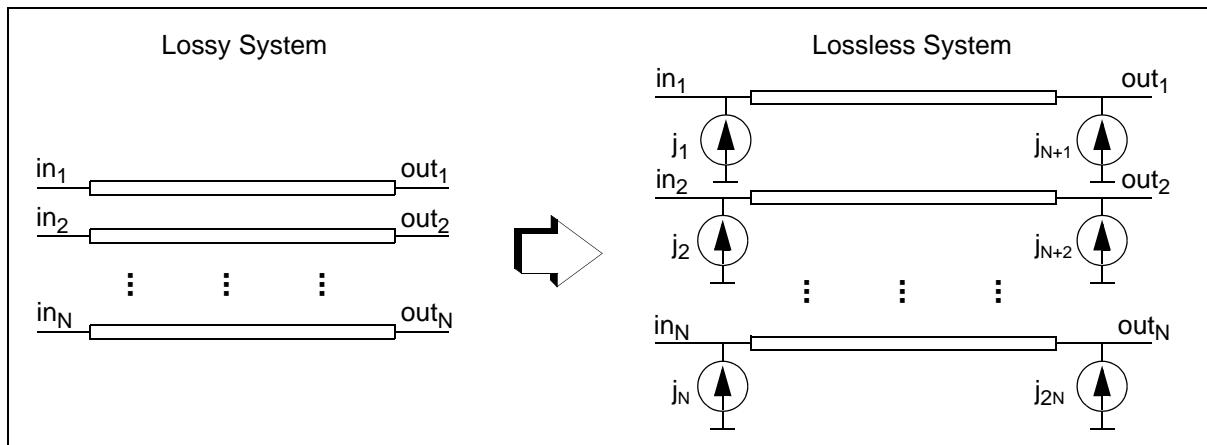
$$C = 2kT(Y + Y^*T) = \begin{bmatrix} |j_1|^2 & \overline{j_1 j_2^*} & \dots & \overline{j_1 j_{2N}^*} \\ \overline{j_2 j_1^*} & |j_2|^2 & \dots & \overline{j_2 j_{2N}^*} \\ \dots & \dots & \dots & \dots \\ \overline{j_{2N} j_1^*} & \overline{j_{2N} j_2^*} & \dots & |j_{2N}|^2 \end{bmatrix}$$

Where:

$i=1 \sim N$ corresponding to N input terminals

$i=N+1 \sim 2N$ corresponding to N output terminals.

The noise-current correlation matrix represents the frequency-dependent statistical relationship between $2N$ noise current sources, j_i ($i=1 \sim 2N$), shown in the following figure.



3: Modeling Coupled Transmission Lines Using the W Element

Extracting Transmission Line Parameters (Field Solver)

Output Interface

HSPICE creates a `.lis` output list file that shows the results of a noise analysis just as any other noisy elements. The format is as following:

```
**** w element squared noise voltages (sq v/Hz)
```

```
element          0:w1
    N(i,j)        data
    r(N(i,j))     data
    ... i,j = 1~N ...
    total         data
```

Where:

- $N(i, j)$ = contribution of $j_1 j_j^*$ to the output port
- $r(N(i, j))$ = transimpedance of j_i to the output port
- $total$ = contribution of total noise voltage of the W element to the output port.

List of Transmission Line Models

Table 17 lists the Transmission Line models that you can use in HSPICE.

Search path: `$installdir/parts/tline`

Table 17 Transmission Line Model Names

rcfilt	rg11_u	rg11a_u	rg15_u	rg180b_u
rg188a_u	rg53_u	rg54a_u	rg58a_u	rg58c_u
rg59b_u	rg62_u	rg62b_u	rg71_u	rg71b_u
rg9_u	rg9b_u	tw_sh_u	tw_un_u	

3: Modeling Coupled Transmission Lines Using the W Element

List of Transmission Line Models

3: Modeling Coupled Transmission Lines Using the W Element
List of Transmission Line Models

3: Modeling Coupled Transmission Lines Using the W Element

List of Transmission Line Models

4

Modeling Input/Output Buffers Using IBIS

Describes how to model input and output buffers using IBIS. Includes information on IBIS conventions, buffers, and the IBIS golden parser.

The Input/Output Buffer Information Specification (IBIS) specifies a standard ASCII format for presenting information describing the behavior of various I/O buffers that send electrical signals outside the silicon chip or receive such signals. IBIS specifies formats for the following types of information:

- Output I-V curves for output buffers in LOW and HIGH states
- V(t) curves describing the exact form of transitions from LOW to HIGH states and from HIGH to LOW states for a given load
- Values for die capacitance
- Electrical parameters of the packages

The IBIS standard was developed by the IBIS Open Forum, affiliated with the Electronic Industries Alliance (EIA). IBIS specifies only the “form” for the information; it does not specify how the information is processed or used by the simulator.

4: Modeling Input/Output Buffers Using IBIS

Verifying IBIS Files with the Golden Parser

Verifying IBIS Files with the Golden Parser

The IBIS standard contains a section devoted to recommendations on how to derive information from either the simulation or silicon measurement. The IBIS Open Forum has sponsored development of a parser for IBIS files—called the golden parser. The golden parser is freely available as an executable and should be used for verification of IBIS files. The golden parser is incorporated into Synopsys circuit simulators. When processing an IBIS file, the golden parser produces warnings or error messages that appear in the HSPICE output by default.

Using Buffers

The I/O buffer element type is called “buffer.” The name of this element starts with the letter “b”. Using buffers is similar to using other simulation elements, such as transistors: specify a name for the buffer, specify a list of nodes that connect the buffer to the rest of the circuit, and specify parameters. Only parameters that specify a model for the buffer (file name and model name) are required.

Two significant differences from the use of other elements are:

- You can specify a total of 4 to 8 external nodes depending on the buffer type
- If nodes are supposed to connect to power or ground rails, do not connect them in the netlist because the simulation connects the nodes by default.

This chapter is not intended to introduce the IBIS standard, because it is a large document; familiarity with the standard is assumed. A significant amount of information is available on the Internet.

The official IBIS Open Forum web site is located at:

<http://www.eigroup.org/ibis/>

This site contains articles introducing IBIS, text of the IBIS standard, examples of IBIS files, and tools such as the golden parser. The site also links to other web sites devoted to IBIS.

Three types of analysis are supported for input/output buffers:

- DC analysis
- Transient analysis
- AC analysis

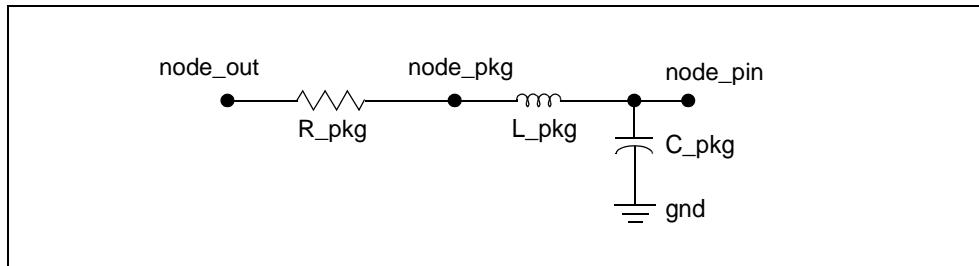
IBIS Conventions

The general syntax of an element card for I/O buffers is:

```
bxxx node_1 node_2 ... node_N
+ file='filename' model='model_name'
+ keyword_1=value_1 ... [keyword_M=value_M]
```

Parameter	Description
bname	Buffer element name. The name must begin with B, which can be followed by up to 1023 alphanumeric characters.
node_1 node_2 ... node_N	List of I/O buffer external nodes. The number of nodes and corresponding rules are specific to different buffer types (see later sections in this chapter).
file='filename'	Name of the IBIS file.
model='model_name'	Name of the model.
keyword_i=value_i	Assigns the <i>value_i</i> value to the <i>keyword_i</i> keyword. Specify optional keywords in brackets ([]) (see Specifying Common Keywords on page 144 for more information).

Figure 38 Circuit Diagram for Package



The *gnd* node on the circuit diagram for buffers denotes the ideal SPICE ground node (the node 0 [zero] notation is also used). This node is always available in the simulation device models. Do not include this node in the node list on the buffer card. If the *gnd* node appears on a circuit diagram, simulation connects the node to the ideal ground. The *gnd* node on circuit diagrams explains the connection of individual parts inside buffers.

4: Modeling Input/Output Buffers Using IBIS

IBIS Conventions

In some cases, buffer nodes have different rules than nodes for other elements. Some nodes might already be connected to voltage sources (simulation makes such connections) so do not connect a voltage source to such nodes. Conversely, some nodes should be connected to voltage sources and you need to connect voltage sources to these nodes.

Note: See [Specifying Common Keywords on page 144](#) and the sections about individual buffer types for detailed explanations on how to use these nodes.

Buffers correspond to models in IBIS files and do not include packages. In this case, you need to manually add the corresponding packages. For example, if node_out and node_pin are nodes for output of the output buffer and corresponding pin, then add the following lines to the netlist:

```
R_pkg node_out node_pkg R_pkg_value  
L_pkg node_pkg node_pin L_pkg_value  
C_pkg node_pin gnd C_pkgvalue
```

The preceding lines use the IBIS file to find the R_pkg, L_pkg, and C_pkg values (see [Figure 38 on page 119](#) for the circuit diagram).

Terminology

The following terms are frequently used in this chapter:

Table 18 Terminology Used in This Chapter

Term	Definition
card, buffer card	Denote lines from the netlist that specifies the buffer name (should begin with the letter b), a list of external nodes, required keyword, and optional keywords.
buffer, I/O buffer, input/output buffer	One of 14 IBIS models as specified in the standard, version 3.2, and implemented in the Synopsys IBIS device models.
RWF, FWF	Rising waveform, falling waveform
I/O	Input/Output
I/V curve	Current-voltage curve

Table 18 Terminology Used in This Chapter (Continued)

Term	Definition
PU, PD	Pullup, pulldown
PC, GC	Power clamp, ground clamp

Buffers

This section describes buffers as used in the Synopsys IBIS device models. Refer to [Specifying Common Keywords on page 144](#) for details about how to use keywords that are in the syntax examples in the following sections.

Input Buffer

The syntax of an input buffer element card is:

```
B_INPUT nd_pc nd_gc nd_in nd_out_of_in
+ file='filename' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={1|input}]
+ [interpol={1|2}]
+ [nowarn]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
```

In the preceding syntax, the total number of external nodes is 4.

If you specify the power=on keyword (default), the *nd_pc* and *nd_gc* nodes are connected to voltage sources with values taken from the IBIS file. Do not connect these nodes to voltage sources. Names for these nodes are provided so you can print out the voltage values if required.

For example:

```
.PRINT V(nd_pc) V(nd_gc)
```

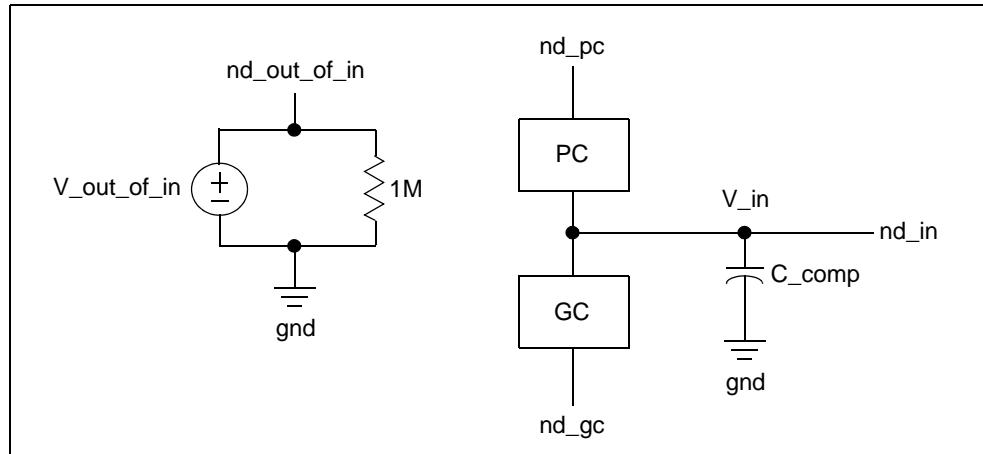
If you specify the power=off keyword, the simulation does not connect these nodes to voltage sources. You need to connect the nodes to voltage sources directly through an RLC network, or through a transmission line.

4: Modeling Input/Output Buffers Using IBIS

Buffers

You can connect node_in to I, E, F, G, and H elements. The buffer measures and processes the voltage on this node and sends a response to the nd_out_of_in node. The nd_out_of_in node is connected to the voltage source as shown in [Figure 39 on page 122](#). It is an error to connect this node to a voltage source. If power=off, you can connect the nd_pc and nd_gc nodes to the ground, which sets the voltage to zero on these nodes.

Figure 39 Input Buffer



V_out_of_in is a digital signal that assumes values of either 0 or 1 depending on the V_in, Vinh, Vinl, and Polarity voltages. The simulation processes V_out_of_in according to the following rules.

Table 19 IBIS Input Buffer

If:	Then:
Polarity=Non-Inverting	Initially V_out_of_in is set to 0 if V_in < (Vinh+Vinl)/2 and to 1 in the opposite case.
and if V_out_of_in=1	It goes to 0 only if V_in < Vinl
and if V_out_of_in=0	It goes to 1 only if V_in>Vinh
Polarity=Inverting	Initially V_out_of_in is set to 0 if V_in > (Vinh+Vinl)/2 and to 1 in the opposite case
and if V_out_of_in=1	It goes to 0 only if V_in > Vinh
and if V_out_of_in=0	It goes to 1 only if V_in < Vinl

[Figure 39 on page 122](#) shows a single circuit specified on a single element card. *V_out_of_in* is a voltage source whose value is a function of *V_in* (and of *Vinl*, *Vinh* thresholds, and *Polarity* parameter). You can use it to drive other circuits.

If you specify *pc_scal* or *gc_scal* arguments, and *pc_scal_value* or *gc_scal_value* do not equal 1.0, then HSPICE uses the *pc_scal_value* or *gc_scal_value* to adjust the PC or GC iv curve.

Output Buffer

The syntax for an output buffer element card is:

```
B_OUTPUT nd_pu nd_pd nd_out nd_in [nd_pc nd_gc]
file='file_name' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={2|output}]
+ [xv_pu=state_pu] [xv_pd=state_pd]
+ [interp={1|2}]
+ [ramp_fwf={0|1|2}] [ramp_rwf={0|1|2}]
+ [fwf_tune=fwf_tune_value] [rwf_tune=rwf_tune_value]
+ [nowarn]
+ [c_com_pu=c_com_pu_value]
+ [c_com_pd=c_com_pd_value]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pu_scal=pu_scal_value]
+ [pd_scal=pd_scal_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
+ [rwf_scal=rwf_scal_value]
+ [fwf_scal=fwf_scal_value]
+ [spu_scal=spu_scal_value]
+ [spd_scal=spd_scal_value]
```

The *nd_pc* and *nd_gc* nodes are optional. However, you can specify both nodes or none of them. The total number of external nodes is either 4 or 6; any other number is an error. If you do not specify the *nd_pc* and *nd_gc* nodes on the element card, but Power_Clamp or Ground_Clamp I-V curves are present in the model in question, then the simulator simply connects Power_Clamp or Ground_Clamp to the corresponding *nd_pu* (pullup) and/or *nd_pd* (pulldown).

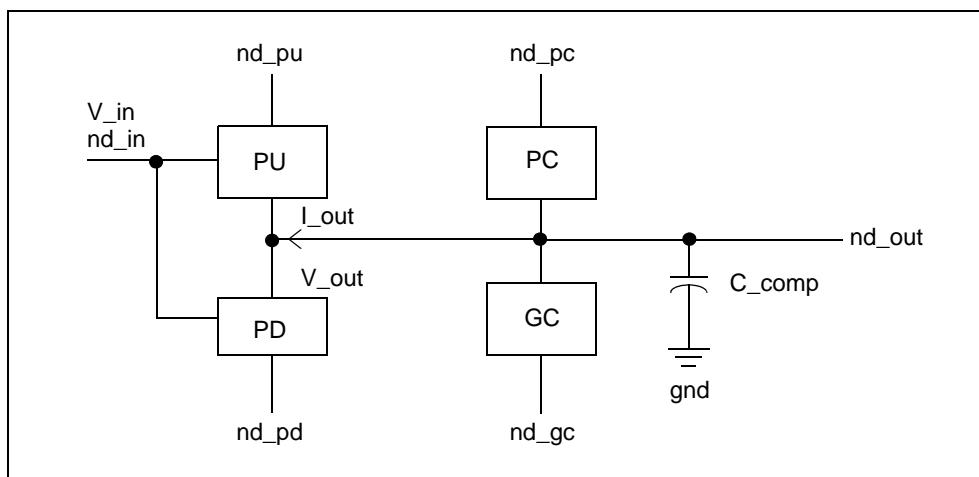
4: Modeling Input/Output Buffers Using IBIS Buffers

However, you need the optional *nd_pc* and *nd_gc* nodes are needed if:

- The POWER Clamp Reference and GND Clamp Reference IBIS keywords are present in the IBIS model and have different values than the IBIS keywords Pullup Reference and Pulldown Reference, or
- The Pullup Reference and Pulldown Reference IBIS keywords do not exist and POWER Clamp Reference and GND Clamp Reference have different values than those determined by the Voltage Range IBIS keyword.

If your circuit needs the *nd_pc* and *nd_gc* optional nodes, but they are not in the element card, the simulation issues a warning and connects *nd_pc* to *nd_pu* and *nd_gc* to *nd_pd*.

Figure 40 Output Buffer



If you specify the `power=on` (default) keyword, then the *nd_pu* and *nd_pd* nodes, and if specified, the *nd_pc* and *nd_gc* nodes, are connected to voltage sources with values taken from the IBIS file. You should not connect these nodes to voltage sources. Specify names for these nodes so you can print out the voltage values if required. For example:

```
.PRINT V(nd_pu) V(nd_pd)
```

If you specify the `power=off` keyword, the simulation does not connect these nodes to voltage sources. Connect the nodes to voltage sources directly, through an RLC network, or through a transmission line.

No special rules apply for the *nd_out* node. The voltage on this node is controlled by the digital signal on the *nd_in* node. You can connect any voltage source, current source, voltage controlled voltage source, voltage controlled

current source, current controlled voltage source, or current controlled current source to the *nd_in* node as shown in the following example:

```
V_in nd_in gnd 0V pulse(0V 1V 1n 0.1n 0.1n 7.5n 15n)]
```

If *power=off*, you can connect the *nd_pu*, *nd_pd*, *nd_pc*, and *nd_gc* nodes to the ground if you want zero voltage on these nodes.

V_in is a controlling signal that represents a digital signal with values 0 and 1. However, the simulation can use any signal and process, according to the following rules:

Table 20 IBIS Output Buffer

If:	Then:
Polarity=Non-inverting	<p>At t=0 for transient analysis (or for DC analysis), the buffer goes to HIGH state if <i>V_in</i> > 0.5 and to LOW in the opposite case.</p> <p>Next, if the buffer is in HIGH state, it goes to LOW state if <i>V_in</i> < 0.2. If the buffer is in LOW state, it goes to HIGH state if <i>V_in</i> > 0.8.</p>
Polarity=Inverting	<p>At t=0 for transient analysis (or for DC analysis), the buffer goes to HIGH state if <i>V_in</i> < 0.5 and to LOW in the opposite case.</p> <p>Next, if the buffer is in HIGH state, it goes to LOW state if <i>V_in</i> > 0.8. If the buffer is in LOW state, it goes to HIGH state if <i>V_in</i> < 0.2.</p>

If the *pc_scal* (or *gc_scal*, *pu_scal*, *pd_scal*) argument exists and the *pc_scal_value* (or *gc_scal_value*, *pu_scal_value*, *pd_scal_value*) does not equal 1.0, then the simulation adjusts the PC (or GC, PU, PD) iv curve using the *pc_scal_value* (or *gc_scal_value*, *pu_scal_value*, *pd_scal_value*).

If the *rwf_scal* (or *fwf_scal*) argument exists and *rwf_scal_value* (or *fwf_scal_value*) does not equal 1.0, then the simulation adjusts the rising and falling vt curves using the *rwf_scal_value* (or *fwf_scal_value*).

If the `spu_scal` (or `spd_scal`) argument exists and `spu_scal_value` (or `spd_scal_value`) is greater than 0 and `power=off` and $(V(nd_pu) - V(nd_pd))$ does not equal the corresponding value in the .ibs file, then the simulation adjusts the iv curves of PU (or PD) using the `spu_scal_value` (or `spd_scal_value`).

Tristate Buffer

The syntax for a tristate buffer element card is:

```
B_3STATE nd_pu nd_pd nd_out nd_in nd_en [nd_pc nd_gc]
+ file='file_name' model='model1_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={4|three_state}]
+ [xv_pu=state_pu] [xv_pd=state_pd]
+ [interpol={1|2}]
+ [ramp_fwf={2|1|0}] [ramp_rwf={2|1|0}]
+ [fwf_tune=fwf_tune_value] [rwf_tune=rwf_tune_value]
+ [nowarn]
+ [c_com_pu=c_com_pu_value]
+ [c_com_pd=c_com_pd_value]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pu_scal=pu_scal_value]
+ [pd_scal=pd_scal_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
+ [rwf_scal=rwf_scal_value]
+ [fwf_scal=fwf_scal_value]
+ [spu_scal=spu_scal_value]
+ [spd_scal=spd_scal_value]
```

The `nd_pc` and `nd_gc` nodes are optional, and you can specify either both nodes or none of them. The total number of external nodes is either 5 or 7; any other number is an error. If the element card does not specify the `nd_pc` and `nd_gc` nodes, but the model contains Power_Clamp or Ground_Clamp I-V curves, then the simulator adds Power_Clamp or Ground_Clamp I-V curves data to the corresponding Pull_Up or Pull_Down I-V curves data.

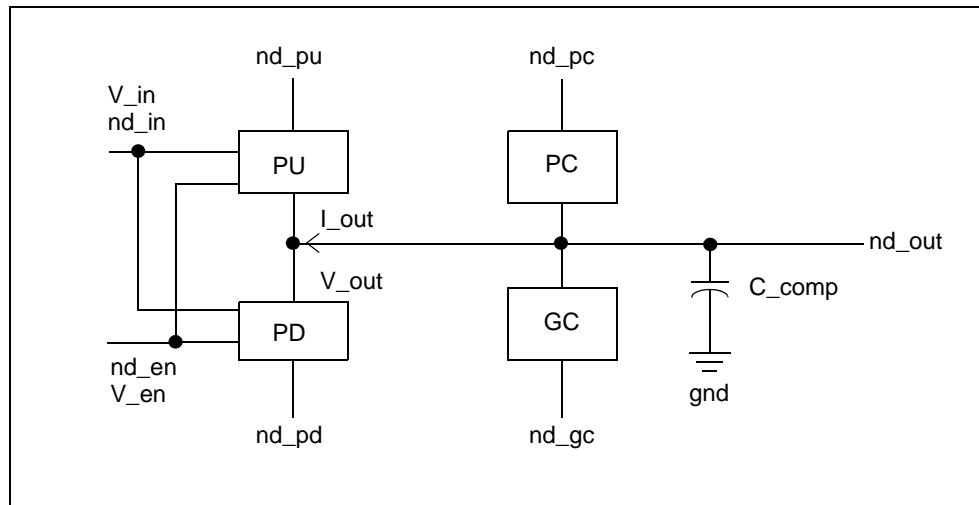
However, you need the `nd_pc` and `nd_gc` optional nodes if:

- The POWER Clamp Reference and GND Clamp Reference IBIS keywords are present in the IBIS model and have different values than the IBIS keywords Pullup Reference and Pulldown Reference, or

- The Pullup Reference and Pulldown Reference IBIS keywords do not exist and POWER Clamp Reference and GND Clamp Reference have different values than those determined by the Voltage Range IBIS keyword.

If your circuit needs *nd_pc* and *nd_gc* optional nodes, but they are not in the element card, the simulation issues a warning and connects *nd_pc* to *nd_pu* and *nd_gc* to *nd_pd*.

Figure 41 Tristate Buffer



If you specify the `power=on` (default) keyword, then the simulation connects the *nd_pu* and *nd_pd* nodes, (and if specified, *nd_pc* and *nd_gc*), are connected to voltage sources with values taken from the IBIS file. Do not connect these nodes to voltage sources.

However, specify names for these nodes in the netlist so you can print out the voltage values if required. For example:

```
.PRINT V(nd_pu) V(nd_pd)
```

If you specify the `power=off` keyword, the simulation does not connect these nodes to voltage sources. Connect the nodes to voltage sources directly through an RLC network, or through a transmission line.

No special rules apply for the *nd_out* node. The voltage on this node is controlled by the digital signal on the *nd_in* and *nd_en* nodes. Voltage sources must be connected to the nodes *nd_in*, *nd_en* as shown in the following example:

```
v_in nd_in gnd 0V pulse( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
v_en nd_en gnd 0V pulse( 0V 1V 3n 0.1n 0.1n 7.5n 15n ) ].
```

4: Modeling Input/Output Buffers Using IBIS Buffers

You can connect the *nd_pu*, *nd_pd*, *nd_pc*, and *nd_gc* nodes to the ground if you want to have zero voltage on these nodes. The *nd_in* and *nd_en* nodes cannot be connected to the ground.

V_in and *V_en* are controlling signals representing digital signals with 0 and 1 values. The simulation can use any signal and process according to the rules in Table 21. The enable signal, *V_en*, supersedes the input signal *V_in*.

Table 21 IBIS Tristate Buffer

If:	Then:
ENABLE = Active-High	At t=0 for transient analysis (or for DC analysis), the buffer goes to the ENABLE state if <i>V_en</i> > 0.5 and to DISABLE in the opposite case.
ENABLE = Active-Low	At t=0 for transient analysis (or for DC analysis), the buffer goes to ENABLE state if <i>V_en</i> < 0.5 and to DISABLE in the opposite case.
The buffer is in ENABLE state	Begins transition to DISABLE state if <i>V_en</i> < 0.2 (where Enable = Active-High) and if <i>V_en</i> > 0.8 (where Enable = Active-Low).
The buffer is in DISABLE state or in transition from ENABLE to DISABLE state	Begins transition to ENABLE state if <i>V_en</i> > 0.8 (where Enable = Active-High) and if <i>V_en</i> < 0.2 (where Enable = Active-Low).
The buffer is in ENABLE state	Response to the input signal, <i>V_in</i> , is the same as the output buffer.
Polarity=Non-Inverting	At t=0 for transient analysis (or for DC analysis), the buffer goes to HIGH state if <i>V_in</i> > 0.5 and to LOW in the opposite case. Next, if the buffer is in HIGH state, it will go to LOW state if <i>V_in</i> < 0.2. If the buffer is in LOW state, it goes to HIGH state if <i>V_in</i> > 0.8.

Table 21 IBIS Tristate Buffer (Continued)

If:	Then:
Polarity=Inverting	<p>At t=0 for transient analysis (or for DC analysis), the buffer goes to HIGH state if V_in < 0.5 and to LOW in the opposite case.</p> <p>Next, if the buffer is in HIGH state, it goes to LOW state if V_in > 0.8. If the buffer is in LOW state, it goes to HIGH state if V_in < 0.2.</p>

Note: After the buffer begins a transition from ENABLE to DISABLE state, all memory about previous HIGH/LOW states is lost. If the buffer later goes to ENABLE state, it compares the controlling signal, V_in, against the threshold 0.5 to decide whether to go to HIGH or LOW state. This is similar to the time moment t=0, rather than against the thresholds 0.2 and 0.8.

Input/Output Buffer

The syntax of an input/output buffer element card is:

```
B_IO nd_pu nd_pd nd_out nd_in nd_en V_out_of_in [nd_pc nd_gc]
+ file='file_name' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={3|input_output}]
+ [xv_pu=state_pu] [xv_pd=state_pd]
+ [interpol={1|2}]
+ [ramp_fwf={2|1|0}] [ramp_rwf={2|1|0}]
+ [fwf_tune=fwf_tune_value] [rwf_tune=rwf_tune_value]
+ [nowarn]
+ [c_com_pu=c_com_pu_value]
+ [c_com_pd=c_com_pd_value]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pu_scal=pu_scal_value]
+ [pd_scal=pd_scal_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
+ [rwf_scal=rwf_scal_value]
+ [fwf_scal=fwf_scal_value]
+ [spu_scal=spu_scal_value]
+ [spd_scal=spd_scal_value]
```

4: Modeling Input/Output Buffers Using IBIS Buffers

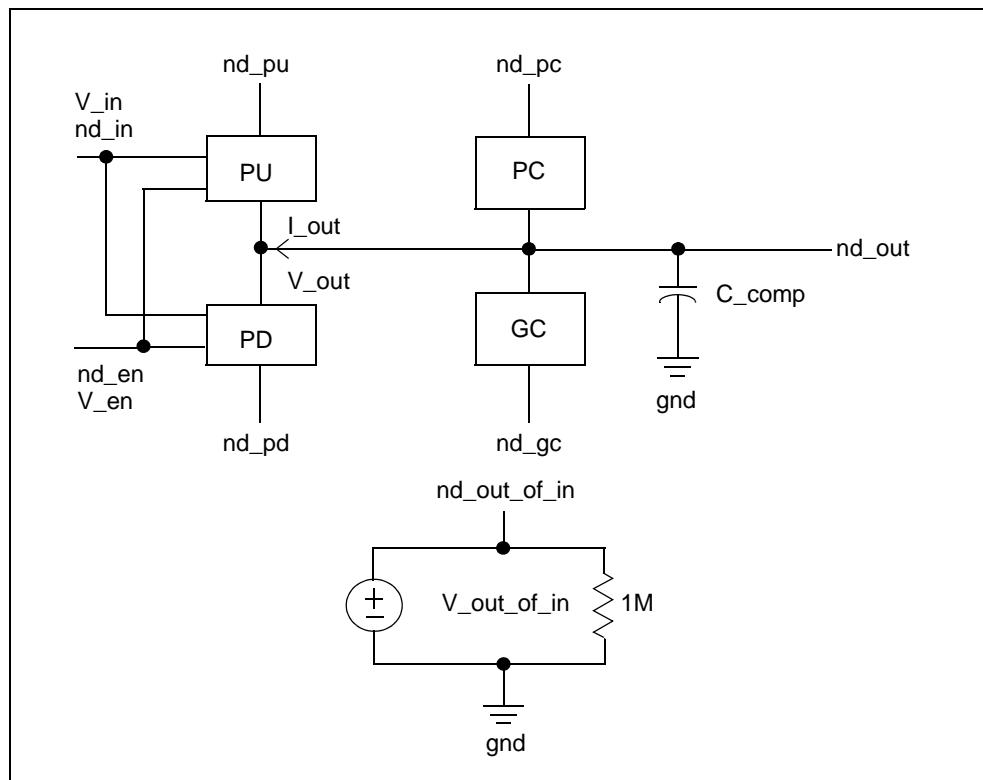
The *nd_pc* and *nd_gc* nodes are optional. However, you can specify either both nodes or none of them. The total number of external nodes is either 6 or 8; any other number is an error. If the element card does not specify the *nd_pc* and *nd_gc* nodes, but the model contains Power_Clamp or Ground_Clamp I-V curves, then the simulator adds Power_Clamp or Ground_Clamp I-V curves data to the corresponding Pull_Up or Pull_Down I-V curves data.

However, you need the *nd_pc* and *nd_gc* optional nodes if:

- The IBIS POWER Clamp Reference and GND Clamp Reference keywords are present in the IBIS model and have different values than the Pullup Reference and Pulldown Reference IBIS keywords, or
- The IBIS Pullup Reference and Pulldown Reference keywords do not exist and POWER Clamp Reference and GND Clamp Reference have different values than those determined by the Voltage Range IBIS keyword.

If you need the *nd_pc* and *nd_gc* optional nodes, and you omitted them from the element card, the simulation issues a warning and connects *nd_pc* to *nd_pu* and *nd_gc* to *nd_pd*.

Figure 42 Input-Output Buffer



If you specify the `power=on` (default) keyword, then the `nd_pu` and `nd_pd` nodes, (and if specified, `nd_pc` and `nd_gc`), connect to voltage sources with values taken from the IBIS file. Do not connect these nodes to voltage sources. However, you should specify names for these nodes in the netlist so you can print out the voltage values if required. For example:

```
.PRINT V(nd_pu) V(nd_pd)
```

If you specify the `power=off` keyword, the simulation does not connect these nodes to voltage sources. You should connect the nodes to voltage sources directly through an RLC network, or through a transmission line.

No special rules apply for the `nd_out` node. The voltage on this node is controlled by the digital signal on the `nd_in` and `nd_en` nodes. Voltage sources must be connected to the `nd_in` and `nd_en` nodes as shown in the following example:

```
V_in nd_in gnd 0V pulse (0V 1V 1n 0.1n 0.1n 7.5n 15n)
V_en nd_en gnd 0V pulse (0V 1V 3n 0.1n 0.1n 7.5n 15n).
```

You can connect the `nd_pu`, `nd_pd`, `nd_pc`, and `nd_gc` nodes to the ground if you want zero voltage on these nodes.

The `nd_out_of_in` node is connected to a voltage source (see [Figure 42 on page 130](#)). Connecting this node to a voltage source or the ground causes an error to occur.

The input-output buffer is a combination of the tristate buffer and the input buffer. See [Input Buffer on page 121](#) and [Tristate Buffer on page 126](#) for more information.

The input-output buffer can function as an input buffer. In this case, the resultant `V_out_of_in` digital signal on the `nd_out_of_in` node is controlled by the `V_out` voltage on the `nd_out` node.

For the input buffer, this controlling voltage is called `V_in` and any corresponding node is called `nd_in`.

The input-output buffer uses `V_in` and `nd_in` notations to denote the controlling voltage and controlling input node for the output part of the buffer.

If the input-output buffer is not in the DISABLE state (this includes ENABLE state and transitions to ENABLE->DISABLE and DISABLE->ENABLE), then it functions as a tristate buffer. If the input-output buffer is in the DISABLE state, it functions as an input buffer.

However, there is a difference in the digital output of the input part of the buffer (voltage `V_out_of_in`). `V_out_of_in` is not always defined (for example, if the

buffer is in ENABLE state, or $V_{inl} < V_{out} < V_{inh}$ at the time moment when the transition to DISABLE state is completed). Also, you need to preserve logical LEVELs 0 and 1 for LOW and HIGH states. Therefore, $V_{out_of_in}$ uses the value 0.5 when it is undefined.

Figure 42 on page 130 shows a single circuit specified on a single element card. The $V_{out_of_in}$ is a voltage source whose value is a function of V_{out} (of the V_{inl} and V_{inh} thresholds and the Polarity parameter). It can be used to drive other circuits.

Open Drain, Open Sink, Open Source Buffers

Open drain and open sink buffers do not include pullup circuitry. Open source buffers do not include pulldown circuitry. However, the element cards for these three buffers coincide with the element card for the output buffer. Accordingly, you should always specify names for pullup and pulldown nodes, *nd_pu* and *nd_pd*, even if the buffer does not include pullup or pulldown circuitry.

All rules in Output Buffer on page 123 apply to open drain, open sink, and open source buffers with the following exceptions:

- Because open drain and open sink buffers do not have pullup circuitry, do not specify the *xv_pu=nd_state_pu* option.
- Similarly, because open source buffers have no pulldown circuitry, do not specify the *xv_pd=nd_state_pd* option.

I/O Open Drain, I/O Open Sink, I/O Open Source Buffers

I/O open drain and I/O open sink buffers do not include pullup circuitry. I/O open source buffers do not include pulldown circuitry. However, the element cards for these three buffers coincide with the element card for the input-output buffer. Accordingly, you should always specify names for pullup and pulldown nodes, *nd_pu* and *nd_pd*, even if the buffer does not include pullup or pulldown circuitry.

All rules in Input/Output Buffer on page 129 apply to I/O open drain, I/O open sink, and I/O open source buffers with the following exceptions:

- Because I/O open drain and I/O open sink buffers do not have pullup circuitry, do not specify the *xv_pu=nd_state_pu* option.
- Similarly, because I/O open source buffers do not include pulldown circuitry, do not specify the *xv_pd=nd_state_pd* option.

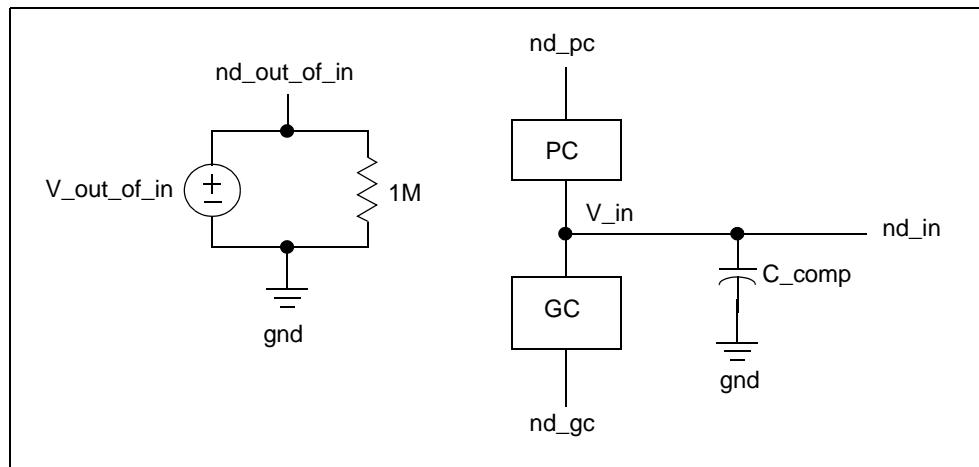
Input ECL Buffer

The syntax of the input ECL buffer element card is:

```
B_INPUT_ECL nd_pc nd_gc nd_in nd_out_of_in
+ file='file_name' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={11|input_ecl}]
+ [interp={1|2}]
+ [nowarn]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
```

The input ECL buffer is similar to the input buffer. The only difference is in default values for Vinl and Vinh.

Figure 43 Input ECL Buffer



Output ECL Buffer

The syntax of the output ECL buffer element card is:

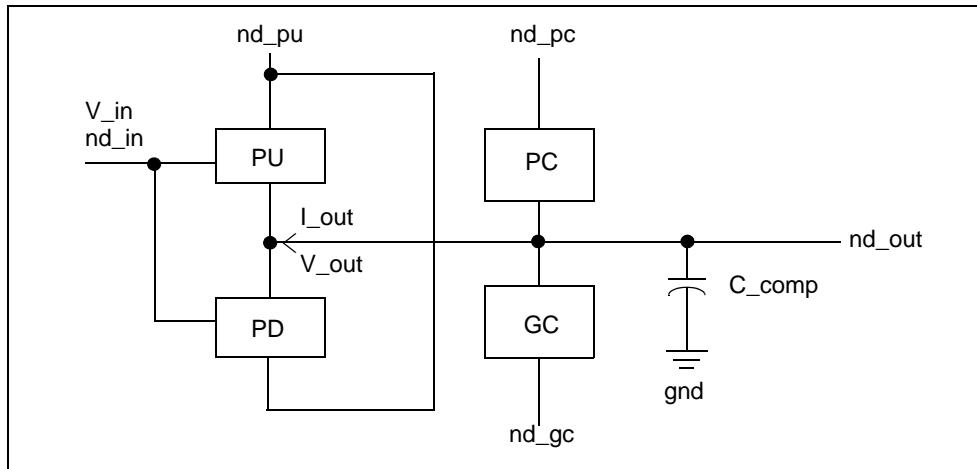
```
B_OUTPUT_ECL nd_pu nd_out nd_in [nd_pc nd_gc]
+ file='file_name' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={12|output_ecl}]
+ [xv_pu=state_pu] [xv_pd=state_pd]
+ [interpol={1|2}]
+ [ramp_fwf={0|1|2}] [ramp_rwf={0|1|2}]
+ [fwf_tune=fwf_tune_value] [rwf_tune=rwf_tune_value]
+ [nowarn]
+ [c_com_pu=c_com_pu_value]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pu_scal=pu_scal_value]
+ [pd_scal=pd_scal_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
+ [rwf_scal=rwf_scal_value]
+ [fwf_scal=fwf_scal_value]
+ [spu_scal=spu_scal_value]
+ [spd_scal=spd_scal_value]
```

The *nd_pc* and *nd_gc* nodes are optional. However, you can specify both nodes or none of them. The total number of external nodes is either 3 or 5; any other number is an error. The output ECL buffer does not have a pulldown node. The pulldown table in the IBIS file is referenced in respect to pullup voltage.

If you do not specify the *nd_pc* and *nd_gc* nodes on the element card, but the Power_Clamp or Ground_Clamp I-V curves are present in the model in question, then the simulator issues an error message (this simulator behavior is different from that for the output buffer).

In other respects, the output ECL buffer is similar to the output buffer. For more information, see [Output Buffer on page 123](#).

Figure 44 Output ECL Buffer



Tristate ECL Buffer

The syntax for the tristate ECL buffer element card is:

```
B_3STATE_ECL nd_pu nd_out nd_in nd_en [nd_pc nd_gc]
+ file='file_name' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={14|three_state_ecl}]
+ [xv_pu=state_pu] [xv_pd=state_pd]
+ [interpol={1|2}]
+ [ramp_fwf={2|1|0}] [ramp_rwf={2|1|0}]
+ [fwf_tune=fwf_tune_value] [rwf_tune=rwf_tune_value]
+ [nowarn]
+ [c_com_pu=c_com_pu_value]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pu_scal=pu_scal_value]
+ [pd_scal=pd_scal_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
+ [rwf_scal=rwf_scal_value]
+ [fwf_scal=fwf_scal_value]
+ [spu_scal=spu_scal_value]
+ [spd_scal=spd_scal_value]
```

The *nd_pc* and *nd_gc* nodes are optional. However, either both or none can be specified. The total number of external nodes is either 4 or 6, any other

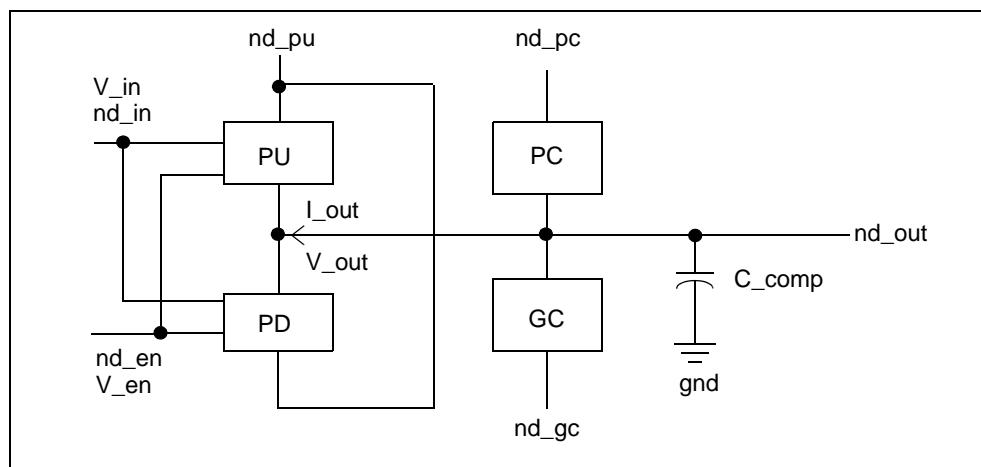
4: Modeling Input/Output Buffers Using IBIS Buffers

number is an error. The tristate ECL buffer does not have a pulldown node. The pulldown table in the IBIS file is referenced in respect to pullup voltage.

If you do not specify the *nd_pc* and *nd_gc* nodes on the element card, but the Power_Clamp or Ground_Clamp I-V curves are present in the model in question, then the simulator issues an error message (this simulator behavior is different from that for the tristate buffer).

In other respects, the tristate ECL buffer is similar to the tristate buffer. See [Tristate Buffer on page 126](#) for more information.

Figure 45 Tristate ECL Buffer



Input-Output ECL Buffer

The syntax for the input-output ECL buffer element card is:

```
B_IO_ECL nd_pu nd_out nd_in nd_en nd_out_of_in [nd_pc nd_gc]
+ file='file_name' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={13|io_ecl}]
+ [xv_pu=state_pu] [xv_pd=state_pd]
+ [interpol={1|2}]
+ [ramp_fwf={2|1|0}] [ramp_rwf={2|1|0}]
+ [fwf_tune=fwf_tune_value] [rwf_tune=rwf_tune_value]
+ [nowarn]
+ [c_com_pu=c_com_pu_value]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pu_scal=pu_scal_value]
+ [pd_scal=pd_scal_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
+ [rwf_scal=rwf_scal_value]
+ [fwf_scal=fwf_scal_value]
+ [spu_scal=spu_scal_value]
+ [spd_scal=spd_scal_value]
```

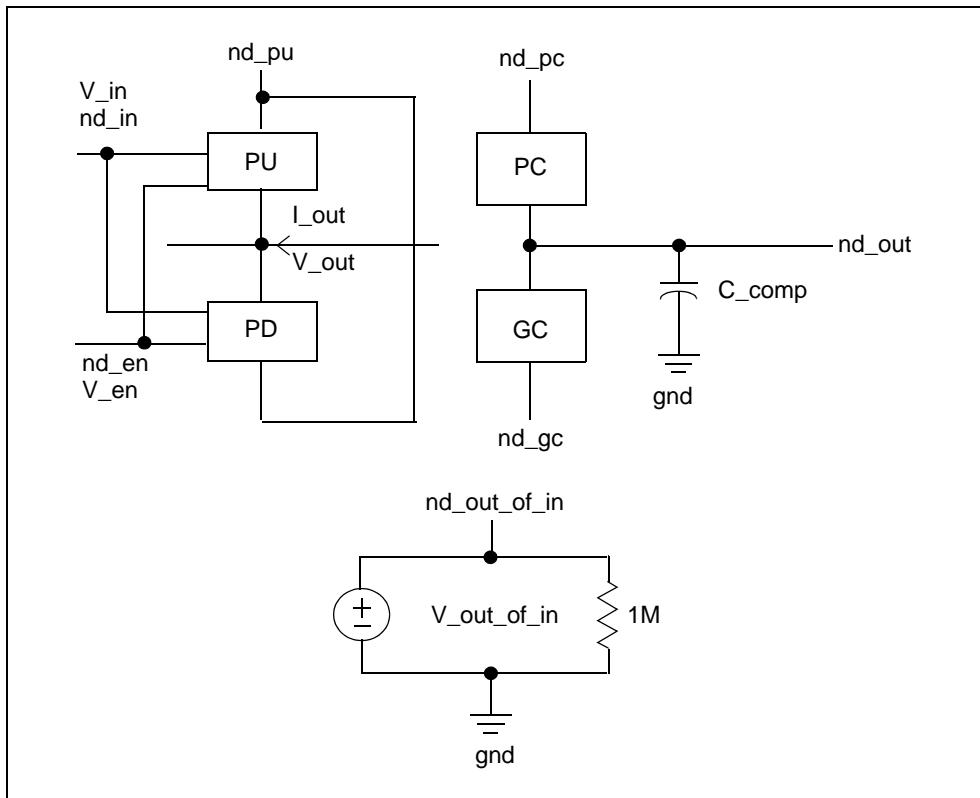
The *nd_pc* and *nd_gc* nodes are optional. However, you can specify either both nodes or none of them. The total number of external nodes is either 5 or 7; any other number is an error. The tristate ECL buffer does not include a pulldown node. The pulldown table in the IBIS file is referenced in respect to pullup voltage.

If you specify the *nd_pc* and *nd_gc* nodes on the element card but Power_Clamp or Ground_Clamp I-V curves are present in the model in question, then the simulator issues an error message (this simulator behavior is different from the Input-Output buffer).

In other respects, the input-output ECL buffer is similar to the input-output buffer. See [Input/Output Buffer on page 129](#) for more information.

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Figure 46 Input-Output ECL Buffer



Terminator Buffer

The syntax for the terminator buffer element card is:

```
b_TERMINATOR nd_pc nd_gc nd_out
+ file='filename' model='model_name'
+ [typ={typ|min|max|fast|slow}] [power={on|off}]
+ [buffer={17|terminator}]
+ [interp={1|2}]
+ [nowarn]
+ [c_com_pc=c_com_pc_value]
+ [c_com_gc=c_com_gc_value]
+ [pc_scal=pc_scal_value]
+ [gc_scal=gc_scal_value]
```

In the preceding syntax, the total number of external nodes is 3. If you specify the **power=on** keyword (default), the **nd_pc** and **nd_gc** nodes are connected to voltage sources with values taken from the IBIS file. Do not connect these

nodes to voltage sources. Names for these nodes are provided so you can print out the voltage values if required.

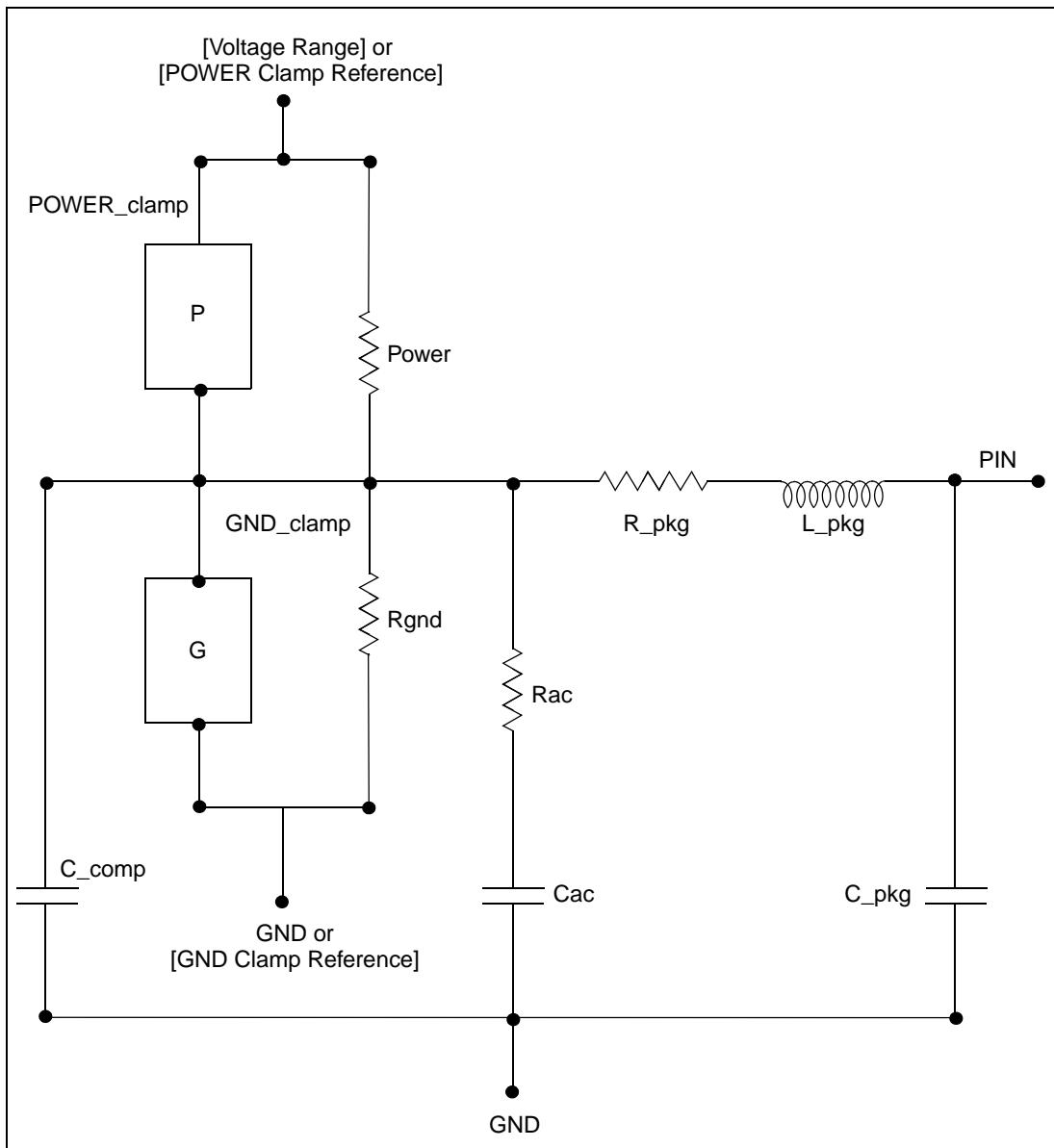
The schematic in [Figure 47 on page 140](#) shows a terminator buffer:

```
.PRINT V(nd_pc) V(nd_gc)
```

If you specify the `power=off` keyword, the simulation does not connect these nodes to voltage sources. You need to connect the nodes to voltage sources directly through an RLC network or transmission line. You can connect node_in to I, E, F, G, and H Elements.

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Figure 47 Terminator buffer schematic



Note: Rac and Cac are the resistance and capacitance values for an AC terminator.

Series Buffer

The syntax for the series buffer element card is:

```
b_SERIES nd_in nd_out
+ file='filename' model='model_name'
+ [typ={typ|min|max|fast|slow}]
+ [buffer={15|series}]
+ [interpol={1|2}]
+ [nowarn]
+ [all_sm={0|1}]
```

In the preceding syntax, the total number of external nodes is 2. This buffer type is for series models that can be described by the following model keywords:

- [R Series]
- [L Series]
- [RI Series]
- [C Series]
- [Lc Series]
- [Rc Series]
- [Series Current]
- [Series MOSFET]

[Figure 48 on page 143](#) shows a schematic for the series buffer.

Series Switch Buffer

The syntax for the series switch buffer element card is:

```
b_SER_SW nd_in nd_out
+ file='filename' model='model_name'
+ [typ={typ|min|max|fast|slow}]
+ [buffer={16|series_switch}]
+ [ss_state={on|off}]
+ [interpol={1|2}]
+ [nowarn]
+ [all_sm={0|1}]
```

4: Modeling Input/Output Buffers Using IBIS Buffers

In this syntax, the total number of external nodes is 2. This buffer type is for series switch models which can be described by the following model keywords:

- [On]
- [Off]
- [R Series]
- [L Series]
- [RI Series]
- [C Series]
- [Lc Series]
- [Rc Series]
- [Series Current]
- [Series MOSFET]

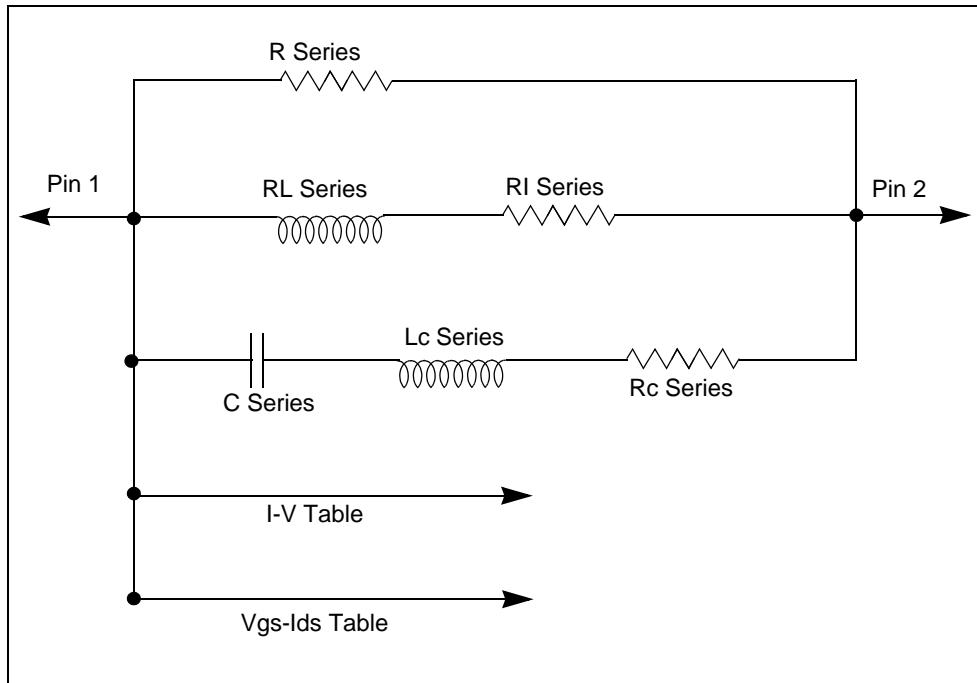
The schematic in [Figure 48 on page 143](#) is similar to a series switch buffer, except that the Vgs-Ids table is not available in the OFF state.

The all_sm subparameter is optional. It is used to control the method of the Series MOSFET. When all_sm=0, only the first Vgs-Ids table ($vds!=0$) is used. HSPICE uses the following formula to implement this method:

$$ids = Ids(vgs, Vds) * vds/Vds$$

Otherwise, when all_sm=1, all Vgs-Ids tables are used for the Series MOSFET.

Figure 48 Series buffer schematic



Multilingual Model Support

The syntax to call SPICE-formatted buffers is:

```
B_SPICE nd_pc nd_gc nd_in nd_out_of_in
+ file='ibis_filename' model='model_name'
+ [typ={typ|min|max}] [power={on|off}]
+ [nowarn]
```

In the preceding syntax,

- The list of nodes must map port names declared in [Ports] of [External Model] one for one, but they need not have the same name.
- Name of the model must be described in SPICE format [External Model].
- Specify a [Corner] in [External Circuit] from which the current simulation extracts data. If min or max [Corner] is not available, typ [Corner] is used. The default is typ=typ.

Other parameters not shown above have no affect on a SPICE-formatted buffer.

Specifying Common Keywords

This section describes how to specify the most commonly used keywords in HSPICE.

Optional Keywords

The following keywords are optional:

- buffer
- typ
- hsp_ver
- power
- interpol
- xv_pu
- xv_pd
- ramp_rwf
- ramp_fwf
- r wf_tune
- fwf_tune
- r wf_pd_dly
- fw f_pd_dly
- ss_state
- no_warn

If optional keywords are not used, the default values are selected. Optional keywords are enclosed in square brackets [] in the buffer cards. They can be set with a parameter and use the keyword=parameter_name format. The keyword={val_1|val_2|...|val_n} notation denotes that the keyword obtains a value from the set val_1, val_2, ... , val_n. The order of the keywords is not important.

You cannot sweep the typ and hsp_ver keywords during analysis.

file

Syntax

```
file = 'file_name'
```

Required. Identifies the IBIS file. The file_name must be lower case and must specify either the absolute path for the file or the relative path with respect to the directory from which you run the simulator. File path names are not restricted to 128 characters.

Example

```
file = '.ibis/at16245.ibs'  
file = '/home/oneuser/ibis/models/abc.ibs'
```

model

Syntax

```
model = 'model_name'
```

Required. Identifies the model for a buffer from the IBIS file, specified with the file='...' keyword. The model_name keyword is case-sensitive and must match one of the models from the IBIS file.

Example

```
model = 'ABC_1234_out'  
model = 'abc_1234_IN'
```

buffer

Syntax

```
buffer = {Buffer_Number | Buffer_Type}
```

4: Modeling Input/Output Buffers Using IBIS

Specifying Common Keywords

In this syntax, buffer_number is an integer within the range $1 \leq N \leq 17$. Each buffer has an assigned number.

Table 22 IBIS Buffer Types and Numbers

Buffer Type	Buffer Number	Number of nodes (nominal or min/max)	Notes
INPUT	1	4	
OUTPUT	2	4/6	
INPUT_OUTPUT	3	6/8	
THREE_STATE	4	5/7	
OPEN_DRAIN	5	4/6	
IO_OPEN_DRAIN	6	6/8	
OPEN_SINK	7	4/6	
IO_OPEN_SINK	8	6/8	
OPEN_SOURCE	9	4/6	
IO_OPEN_SOURCE	10	6/8	
INPUT_ECL	11	4	
OUTPUT_ECL	12	3/5	
IO_ECL	13	5/7	
THREE_STATE_ECL	14	4/6	was 17
SERIES	15	2	
SERIES_SWITCH	16	2	
TERMINATOR	17	3	was 14

The value of buffer_number and buffer_type must match the buffer type specified by the model='...' keyword. The buffer= {Buffer_Number |

Buffer_Type} keyword provides an extra check for the input netlist. If you omit the keyword, this extra check is not performed.

typ

Syntax

`typ = {typ|min|max|fast|slow}`

If the value of the typ buffer parameter is either `typ`, `min`, or `max`, then this value signifies a column in the IBIS file from which the current simulation extracts data. The default is `typ=typ`. If `min` or `max` data are not available, `typ` data are used instead.

If the value of the typ buffer parameter is `fast` or `slow`, then the simulation uses certain combinations of `min` and `max` data. [Table 24 on page 148](#) specifies the exact type of data used for fast and slow values.

The `typ` keyword can also be set to a number, which stands for a different typ data of an IBIS model. If you want to use a parameter for the `typ` keyword, you can only set the parameter to 0, -1, 1, 2, or -2. [Table 23 on page 147](#) shows the keywords that can be used:

Table 23 Possible Keywords for the typ Buffer Parameter

Parameter	Number
typ	0
min	-1
max	1
fast	2
slow	-2

Note: [Table 24 on page 148](#) lists all parameters and data types for all buffers. Specific buffers use relevant data only. No buffer uses all data in the table (for example, only the terminator specifies and uses the Rgnd, Rpower, Rac, Cac parameters).

4: Modeling Input/Output Buffers Using IBIS

Specifying Common Keywords

hsp_ver

Syntax

```
hsp_ver = hspice_version
```

The default is the current version of the HSPICE simulator. If you prefer the previous version of the IBIS buffer, use the following statement:

```
hsp_ver = <version number>
```

Table 24 Fast and Slow Data for IBIS Buffers

Parameter/Data	Fast	Slow
C_comp	min	max
Temp_Range	max	min
Voltage_Range	max	min
Pullup_Ref	max	min
Pulldown_Ref	min	max
POWER_Clamp_Ref	max	min
GND_Clamp_Ref	min	max
Rgnd	max	min
Rpower	max	min
Rac	max	min
Cac	min	max
Pulldown	max	min
Pullup	max	min
GND_Clamp	max	min
POWER_Clamp	max	min
Ramp	max	min

Table 24 Fast and Slow Data for IBIS Buffers (Continued)

Parameter/Data	Fast	Slow
Rising_waveform	max	min
Falling_waveform	max	min
V_fixture	max	min

power

Syntax

```
power = {on|off}
```

The default is power=on. To connect buffers to power sources that are specified in the IBIS file, use the Voltage Range, Pullup Reference, Pulldown Reference, POWER Clamp Reference, and GND Clamp Reference keywords.

By default, the simulation connects the required voltage sources for such external nodes as Pullup, Pulldown, Power_Clamp, and Ground_Clamp if applicable. Do not connect these nodes to voltage sources. However, you should specify names for these nodes so you can print out the voltage values if required.

If power=off, use internal voltage sources are not included in the buffer, and you must add external voltage sources. Use this option if the voltage source is not connected directly to buffer nodes but through a circuit to account for parasitic RLC to simulate power/ground bounce, and so on.

interpol

Syntax

```
interpol = {1|2}
```

Default is interpol=1 (recommended). The I/V curves and V(t) curves need to be interpolated. The interpol=1 keyword uses linear interpolation and interpol=2 uses quadratic bi-spline interpolation.

4: Modeling Input/Output Buffers Using IBIS

Specifying Common Keywords

xv_pu | xv_pd

Syntax

```
xv_pu = nd_state_pu  
xv_pd = nd_state_pd
```

The buffers with output function (output, input-output, tristate, and so on) are controlled by one (input) or two (input and enable) controlling signals. To describe the state of a buffer at any moment, use two state variables, St_{pu} and St_{pd}, which vary from 0 to 1. For example:

- If the output buffer is in LOW state, then St_{pu}=0, St_{pd}=1.
- If the output buffer transitions from a LOW state to HIGH state, then St_{pu} continuously changes from 0 to 1, while St_{pd} goes from 1 to 0.

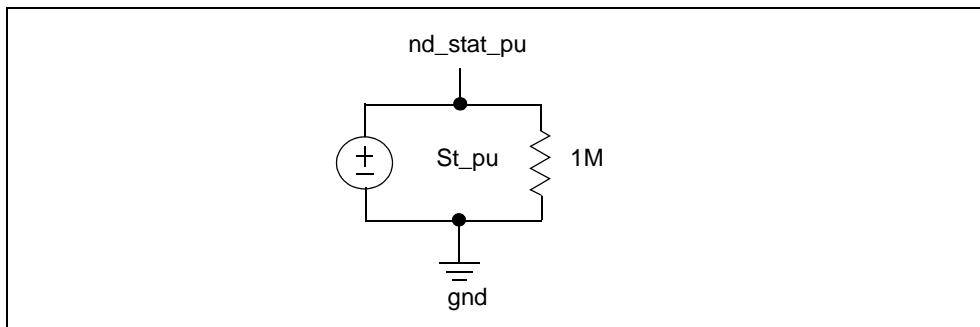
The actual time dependence for such a transition is derived from either ramp data or waveforms.

You might want to know exactly how the transition takes place. The xv_{_pu}=nd_{_state}_{_pu}, xv_{_pd}=nd_{_state}_{_pd} keywords provide such information. Here nd_{_state}_{_pu} and nd_{_state}_{_pd} are names of additional nodes (which must be unique, and are treated as any other node from the netlist, except for a 16-character limitation). If you include the keywords, then the simulation adds voltage sources (with 1MΩ parallel resistor).

The values of the voltages are St_{pu} and St_{pd}. You can print or display them as follows:

```
.PRINT V(nd_state_pu) V(nd_state_pd)
```

Figure 49 Equivalent Circuit for xv_{_pu}=nd_{_state}_{_pu} Keyword



ramp_fwf | ramp_rwf

Syntax

```
ramp_fwf = {2|1|0}  
ramp_rwf = {2|1|0}
```

Default is `ramp_fwf=2` and `ramp_rwf=2`. If ramp or waveform data are available, you can use these options choose which data to use.

The `ramp_fwf` parameter controls falling waveform/ramp. The `ramp_rwf` parameter controls rising waveforms/ramp.

- Value 0 denotes use ramp data.
- Value 1 denotes use one waveform:
 - For `ramp_fwf=1`, if more than one falling waveform is available, the simulation uses the first falling waveform for the model.
 - For `ramp_rwf=1`, if more than one rising waveform is available, the simulation uses the first rising waveform for the model.
- Value 2 (default) denotes use two waveforms:
 - For `ramp_fwf=2`, if more than two falling waveforms are available, HSPICE uses the first two falling waveforms found for the model.
 - For `ramp_rwf=2`, if more than two rising waveforms are available, HSPICE uses the first two rising waveforms found for the model.

If IC circuit simulation cannot perform a specified type of processing (for example, if you specify `ramp_fwf=2`, but only one falling waveform is found), it decrements values of `ramp_fwf` or `ramp_rwf` by one and attempts to process the new values of `ramp_fwf` and/or `ramp_rwf`. In this case, a warning is printed (unless the `nowarn` option is set).

Note: The `ramp_fwf` and `ramp_rwf` parameters are independent, and can have different values.

fwf_tune | r wf_tune

Syntax

```
fwf_tune = fwf_tune_value  
r wf_tune = r wf_tune_value
```

4: Modeling Input/Output Buffers Using IBIS

Specifying Common Keywords

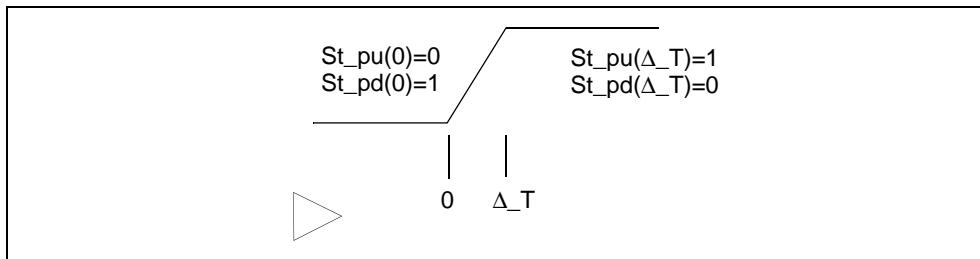
The `fwf_tune_value` and `rwf_tune_value` keywords are numbers between 0 and 1. The default is `fwf_tune=0.1` and `rwf_tune=0.1`.

The following two parameters control the algorithm for processing ramp and waveforms:

- Use `fwf_tune` only when `ramp_fwf` is 0 or 1.
- Use `rwf_tune` only when `ramp_rwf` is 0 or 1.

Figure 50 shows the effect of these parameters when switching the output buffer from LOW to HIGH.

Figure 50 Change in Values of St_pu(t) and St_pd(t) When a Buffer is Switched from LOW to HIGH



Initially, $St_{pd}=1$, $St_{pu}=0$. Both ramp data and a single rising waveform provide information about the switching process. A time interval, Δ_T occurs during the transition from LOW \rightarrow HIGH. The difference between the two data types (ramp and a single rising waveform) is that the shape of the waveform for ramp is fixed as a linearly growing function from LOW to HIGH. By contrast, an actual waveform accounts for an arbitrary time dependence.

However, this is not enough information to determine $St_{pu}(t)$ and $St_{pd}(t)$ [recall that $St_{pu}(0)=0$, $St_{pd}(0)=1$, $St_{pu}(\Delta_T)=1$, $St_{pd}(\Delta_T)=0$]. Mathematically, this represents one linear equation with two unknowns that have an infinite number of solutions. To resolve this problem, you must impose additional conditions on St_{pu} and St_{pd} (some use $St_{pu}+St_{pd}=1$).

Synopsys IBIS device models use the following approach.

The circuitry that goes from ON to OFF (for rising waveforms, pulldown circuitry) usually undergoes this transition much faster than the circuitry that goes from OFF to ON (for rising waveforms, pullup circuitry), we specify a fraction of time in units of Δ_T , during which the circuitry that goes from ON to OFF undergoes the transition.

Therefore, if `rwf_tune=0.1`, then during $0.1 \times \Delta_T$, the pulldown circuitry switches from ON to OFF. The transition is a linear function of time. After

imposing this additional condition, you can uniquely find the rate of transition for the circuitry that goes from the OFF state to ON state.

This approach is also valid for the `fwf_tune` parameter.

The `fwf_tune` and `rwf_tune` parameters are optimization parameters. The significance of these parameters strongly depends on I/V curves for pullup and pulldown circuitries. A change in `fwf_tune` and `rwf_tune` can be insignificant or very significant, depending on the I/V curves. Adjust these parameters slightly to evaluate the accuracy of the model.

If you use two waveforms, the corresponding system of equations is completely defined mathematically and the `fwf_tune` and `rwf_tune` parameters are not used (ignored if specified). However, if the data in two waveforms are inaccurate or inconsistent with other data, circuit simulation can use a single waveform or ramp data instead of two waveforms (issues a warning). If this occurs, `fwf_tune` and/or `rwf_tune` are used even if `ramp_fwf=2` and `ramp_rwf=2`.

If the two-waveform data is inconsistent or inaccurate, the results can be less accurate than ramp or one-waveform results. You can compare that two-waveform results against ramp and one-waveform results.

You can specify algorithm that finds state evolutions for ramp data and single waveform can be augmented by other algorithms, if you request it.

You can use the `xv_pu=nd_state_pu` and `xv_pd=nd_state_pd` keywords to print or view the $St_{pu}(t)$ and $St_{pd}(t)$ state evolution functions.

rwf_pd_dly | fwf_pu_dly

Syntax

```
rwf_pd_dly = rwf_pd_dly_value
fwf_pu_dly = fwf_pu_dly_value
```

The `rwf_pd_dly` and `fwf_pu_dly` parameters can improve the accuracy of one vt waveform-based IBIS buffer. They provide internal delay between external stimulus triggering and pulldown circuit turn off for rising edge, or pullup circuit turn off for falling edge.

The `rwf_pd_dly_value` and `fwf_pu_dly_value` keywords are numbers between 0 and 1. The default is `rwf_pd_dly=0` and `fwf_pu_dly=0`.

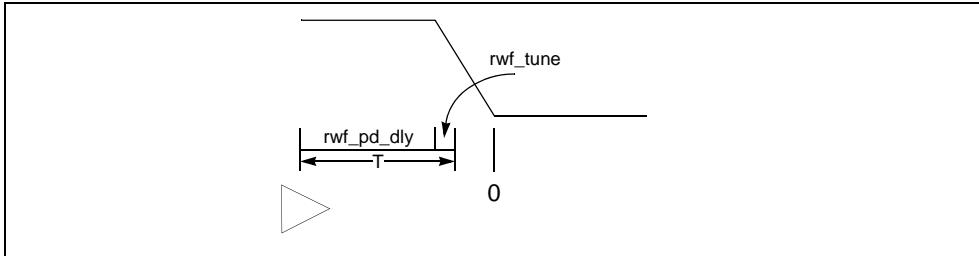
- Use `rwf_pd_dly` only when `ramp_rwf=1`
- Use `fwf_pu_dly` only when `ramp_fwf=1`

4: Modeling Input/Output Buffers Using IBIS

Specifying Common Keywords

A `rwf_pd_dly` parameter is used with a `rwf_tune` parameter to provide a more real pulldown circuit turn off transition for a rising edge, like that shown in [Figure 50 on page 152](#) for $St_{pd}(t)$. Similarly, a `fwf_pu_dly` parameter is used with a `fwf_tune` parameter to provide a more real pullup circuit turn off transition for a falling edge. In Figure 51, the internal delay will be $rwf_{pd_dly} * T$.

Figure 51 Pulldown Circuit Turn Off Transition and Internal Delay Calculation



ss_state

Syntax

```
ss_state = {on|off}
```

The `ss_state` keyword turns the state electrical models in the .ibis file on or off. The default is `ss_state=on`, but only for the series switch buffer.

When `ss_state=on`, the state electrical models are turned on in the .ibis file, which is where the series switch buffer model data is extracted. When `ss_state=off`, the state electrical models are turned off in the .ibis file, which is where the series switch buffer model data is extracted.

nowarn

Syntax

```
nowarn
```

The `nowarn` keyword suppresses warning messages from the IBIS parser. There is no equal sign “=” and value after the `nowarn` keyword. Do not use `nowarn` as the first keyword after the nodes list. Use at least one keyword followed by “=” and a value between the list of nodes and the `nowarn` keyword.

```
c_com_pu = c_com_pu_value  
c_com_pd = c_com_pd_value
```

```
c_com_pc = c_com_pc_value
c_com_gc = c_com_gc_value
```

By default (default 1) the C_comp die capacitance connects between node_out (nd_in for input buffer) and ideal ground. To simulate power bounce and ground bounce, split C_comp into several parts. Then connect between node_out (nd_in for input buffer) and some (or all) of the node_pu, node_pd, node_pc, and node_gc nodes.

If you specify at least one of the optional parameters (c_com_pu, c_com_pd, c_com_pc, and c_com_gc), then the default (1) does not apply, and unspecified parameters have a value of zero (default 2). The c_com_pu, c_com_pd, c_com_pc, and c_com_gc values are dimensionless, and denote fractions of C_comp connected between node_out (nd_in for input buffer) and respective nodes (either node_pu, node_pd, node_pc, or node_gc). For example, C_comp*c_com_pu is capacitance connected between node_out and node_pu.

Do not specify negative values for c_com_pu, c_com_pd, c_com_pc, and c_com_gc.

It is expected that $c_{com_pu} + c_{com_pd} + c_{com_pc} + c_{com_gc} = 1$. However, HSPICE-based simulators do not enforce this requirement, and warn you only if the requirement is not satisfied.

In this case, deriving the states assumes that the IBIS files specifies C_comp for the die. The simulation uses different value of C_comp, namely:

```
C_comp * (c_com_pu+c_com_pd+c_com_pc+c_com_gc)
```

Effectively, it means that some additional capacitance connects in parallel to C_comp (possibly negative).

For the output, input-output, and 3-state buffer types, if you do not specify the node_pc and node_gc nodes in the netlist, c_com_pc is added to c_com_pu and c_com_gc is added to c_com_pd. After that, c_com_pc and c_com_gc are not used anymore.

For the open drain, open sink, input-output open drain, and input-output open sink buffer types, if you do not specify the node_pc and node_gc nodes in the netlist, c_com_pc if given is ignored, and c_com_gc is added to c_com_pd. After that, c_com_gc is not used anymore.

For the open source, and input-output open source buffer types, if you do not specify the node_pc and node_gc nodes in the netlist, c_com_gc if given is ignored, and c_com_pc is added to c_com_pu. After that, c_com_pc is not used anymore.

4: Modeling Input/Output Buffers Using IBIS

Differential Pins

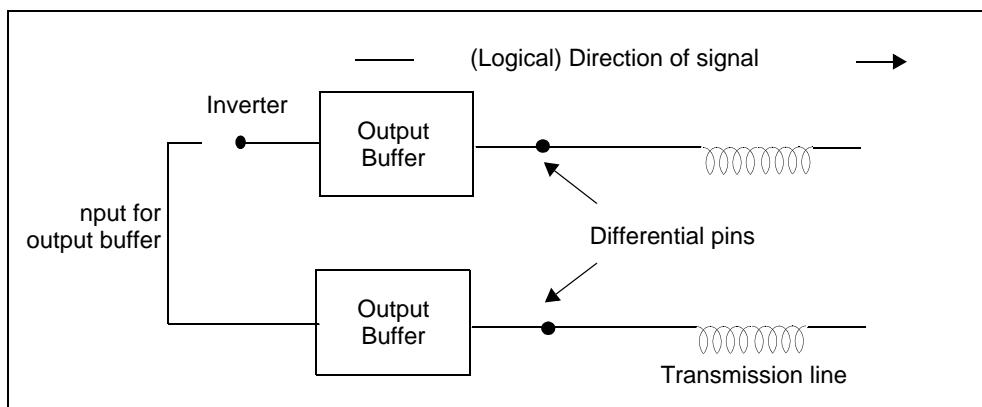
For the output ECL, input-output ECL, and 3-state ECLbuffer types, if you do not specify the node_pc and node_gc nodes in the netlist, c_com_pc and c_com_gc are ignored (assign zero values).

For the output ECL, input-output ECL, and 3-state ECLbuffer types, if c_com_pd is not zero, it is added to c_com_pu (c_com_pd is not used after that).

Differential Pins

Differential pins refer to the relationship between buffers. Specify these pins in the “Component Description” section of the IBIS standard. [Figure 52 on page 156](#) and [Figure 53 on page 157](#), and the examples that follow these figures, show how you can simulate differential pins using the Synopsys implementation of IBIS.

Figure 52 Output Buffers

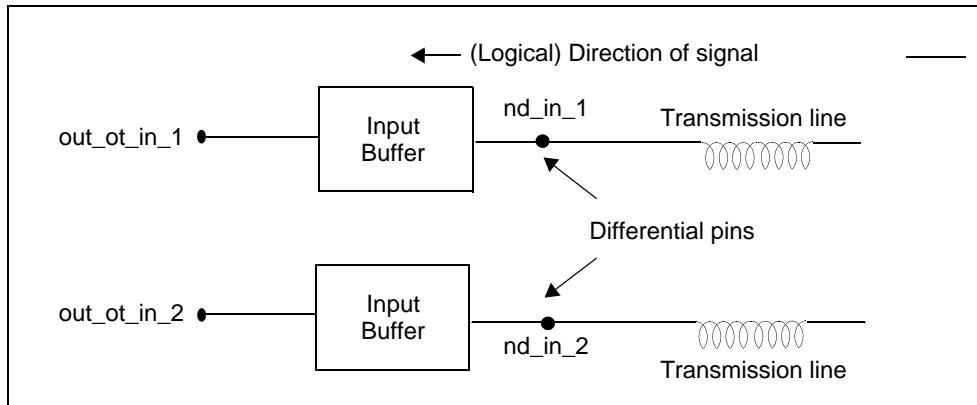


You must use two separate buffers, each specified in a separate card in the netlist. They are related only through their input, which is differential. To implement the inverter in this situation, you must specify two independent voltage sources that have opposite polarity.

You must specify the out_of_in_1, and out_of_in_2 nodes, even if they are not used. Differential input buffers probe the voltage between nd_in_1 and nd_in_2. A voltage-dependent voltage source processes the voltage.

V_diff is a differential voltage parameter from the IBIS file (default is 200 mV). Add a definition of the V_diff parameter, the E_diff_out_of_in voltage controlled voltage source, and aR_diff_out_of_in resistor.

Figure 53 Input Buffers



For example,

```
.PARAM V_diff = 0.2
E_diff_out_of_in diff_out_of_in 0 PWL(1) nd_in_1 nd_in_2
+ '- V_diff' 0 '+ V_diff' 1
R_diff_out_of_in diff_out_of_in 0 1x
Use the voltage across R_diff_out_of_in as the output of the differential
input buffer as shown below:
```

```
If V(nd_in_1) - V(nd_in_2) < V_diff, V(diff_out_of_in) = 0
if V(nd_in_1) - V(nd_in_2) > V_diff, V(diff_out_of_in) = 1
```

Buffers in Subcircuits

```
*****
* example 1 * buffers in subcircuit, power=on
*****
v_in1 nd_in1 0 pulse
+ ( 0V 1.0V CLK_Q_PRD DLT_TIME DLT_TIME CLK_H_PRD CLK_PRD )
v_en1 nd_en1 0 1V
v_in2 nd_in2 0 pulse
+ ( 1.1V 0V CLK_Q_PRD DLT_TIME DLT_TIME CLK_H_PRD CLK_PRD )
v_en2 nd_en2 0 1V
x1 nd_out1 nd_in1 nd_en1 nd_outofin1 buffer11
x2 nd_out2 nd_in2 nd_en2 nd_outofin2 buffer11

R_load nd_out1 nd_out2 50

.subckt buffer11 nd_out0 nd_in0 nd_en0 nd_outofin0
b_io_0 nd_pu0 nd_pd0 nd_out nd_in0 nd_en0 nd_outofin0 nd_pc0
+ nd_gc0
+ file = '92lv090b.ibs'
+ model = 'DS92LV090A_DOUT'
```

4: Modeling Input/Output Buffers Using IBIS

Buffers in Subcircuits

```
+ typ=typ power=on
+ buffer=3
+ interpol=1
xpin nd_out nd_out0 pin22
.ends

.subckt pin22 nd_out nd_out0
R_pin nd_out_c nd_out0 50m
C_pin nd_out_c 0 0.3p
L_pin nd_out nd_out_c 2n
.ends

In this example buffers are connected to power sources implicitly, inside the
subcircuit. Subcircuit external terminals does not need to include nd_pu,
nd_pd, nd_pc, and nd_gc.
*****
* example 2* buffers in subcircuit, power=off
*****
v_in1 nd_in1 0 pulse
+ ( 0V 1.0V CLK_Q_PRD DLT_TIME DLT_TIME CLK_H_PRD CLK_PRD )
v_en1 nd_en1 0 1V
v_in2 nd_in2 0 pulse
+ ( 1.1V 0V CLK_Q_PRD DLT_TIME DLT_TIME CLK_H_PRD CLK_PRD )
v_en2 nd_en2 0 1V

x1 nd_power 0 nd_out1 nd_in1 nd_en1 nd_outofin1 nd_power 0
+ buffer11
x2 nd_power 0 nd_out2 nd_in2 nd_en2 nd_outofin2 nd_power 0
+ buffer11

R_load nd_out1 nd_out2 50

.subckt buffer11 nd_pu0 nd_pd0 nd_out0 nd_in0 nd_en0
+ nd_outofin0 nd_pc0 nd_gc0
r_0 nd_pu0 nd_pd0 1.23456789x
b_io_0 nd_pu0 nd_pd0 nd_out nd_in0 nd_en0 nd_outofin0 nd_pc0
+ nd_gc0
+ file = '921v090b.ibs'
+ model = 'DS92LV090A_DOUT'
+ typ=typ power=off
+ buffer=3
+ interpol=1
xpin nd_out nd_out0 pin22
.ends

.subckt pin22 nd_out nd_out0
R_pin nd_out_c nd_out0 50m
C_pin nd_out_c 0 0.3p
```

```
L_pin nd_out nd_out_c 2n
.ends
```

```
V_power nd_power 0 3.3V
```

In this example, only one voltage source (`V_power`) is used to power all buffers. Specify the power nodes, `nd_pu`, `nd_pd`, `nd_pc`, and `nd_gc`.

Netlist Example with Output Buffer, Transmission Line, and Input Buffer

An example of a netlist that contains an output buffer, transmission line, and input buffer is shown below. A digital signal is supplied to the `nd_in` node. The output buffer transmits to a network, goes through a transmission line, is received by an input buffer. It is transformed into digital form and available on the `nd_out_of_in_1` node.

```
* IBIS Buffer Test
.option post
.tran 0.05n 70n
*
* input source
v1 in 0 pulse ( 0V 1V 1n 1n 1n 9n 20n )
r1 in in1 50
* tristate enable
v5 enable 0 1V

* transmission line
wline1 n1 0 n2 0 RLCGmodel=pcb N=1 L=0.3

* IBIS buffers
b1 nd_pc nd_gc n2 out_of_in
+ file = 'at16245.ibs'
+ model = 'AT16245_IN'

b4 nd_pu nd_pd n1 in1 enable
+ file = 'at16245.ibs'
+ model = 'AT16245_OUT'
+ ramp_fwf=0 ramp_rwf=0

* load
rload n2 0 50

* RLCG parameters for W-element
.model pcb w modeltype=rlgc n=1
+L0=3.94266e-7
+C0=1.12727e-10
```

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

```
+R0=5.7739  
+G0=0  
+Rs=0.00141445  
+Gd=0  
  
.end
```

Using the IBIS Buffer Component

The Input/Output Buffer Information Specification (IBIS) was developed by the IBIS Open Forum, which is affiliated with the Electronic Industries Alliance (EIA). IBIS specifies a standard form to present information in ASCII format by using special files. This information describes the behavior of various I/O buffers that send electrical signals outside the silicon chip, or receive such signals. The type of information includes:

- Output I-V curves for output buffers in LOW and HIGH states.
- V(t) curves, describing the exact form of transitions from LOW to HIGH states, and from HIGH to LOW states for a specified load.
- Values for die capacitance.
- Electrical parameters of the packages.

HSPICE device models implement buffers as a standard b element. To support simulation of IBIS models using .EBD and .PKG, HSPICE IBIS models include another component, which creates buffers for an integrated circuit.

For the syntax of the .IBIS command, see the *HSPICE Command Reference*.

Required Keywords

file='file_name'

This keyword identifies the IBIS file. The *file_name* parameter must be lower case and must specify either the absolute path for the file or the path relative to the directory from which you run the simulation.

Example

```
file = '.ibis/at16245.ibs'  
file = '/home/oneuser/ibis/models/abc.ibs'
```

component='component_name'

This keyword identifies the component for an .IBIS command from the IBIS file, specified using the `file='...'` keyword. The `component_name` keyword is case-sensitive, and it must match one of the components from the IBIS file.

Example

```
component = 'procfast'  
component = 'Virtex_SSTL_3-I_BG432'
```

Optional Keywords

package

This keyword specifies the type of package to add.

```
package = [ 0 | 1 | 2 | 3 ]
```

When package equals

- 0, then the RLC package is not added into the component.
- 1, then [Package] (in the .ibs file) is added.
- 2, then [Pin] (in the .ibs file) is added.
- 3 (default), and if [Package Model] is defined, set package with a package model. If the [Package Model] is not defined, set the package with [Pin]. If the package information is not set in [Pin], set the package with [Package] as a default. You can define the [Package Model] in IBIS or PKG files.

Example

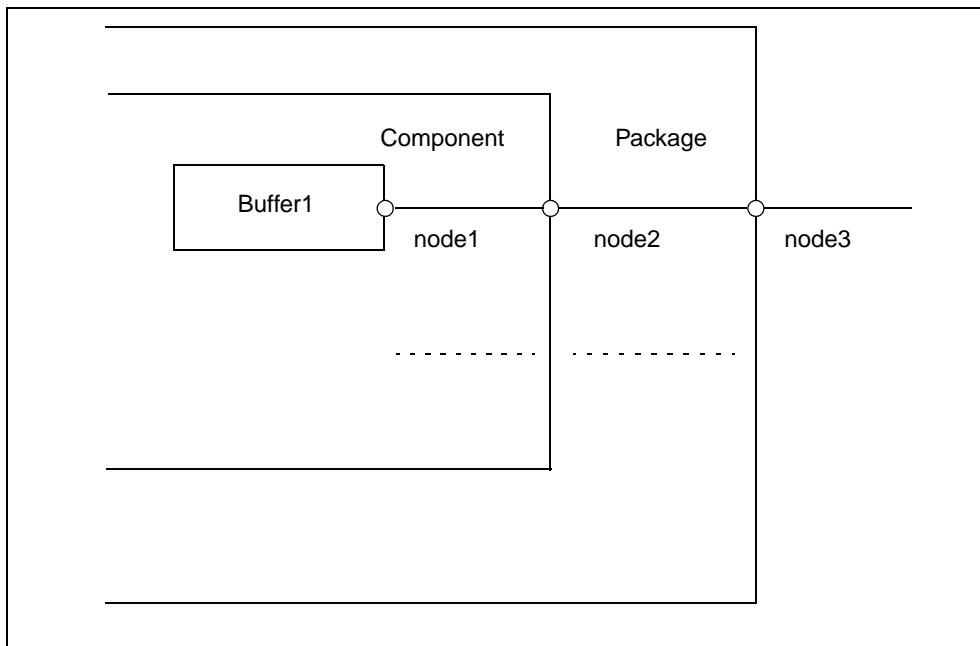
```
.ibis p_test  
+ file = 'comp.ibs'  
+ component = 'cpu_133mhz_ff'  
+ hsp_ver = 2002.4 nowarn  
+ package = 3  
+ pkgfile = 'test.pkg'
```

This card combines the .pkg and .ibis files. If you use [Package Model] in the `cpu_133mhz_ff` component, HSPICE searches for the pkg model in the `comp.ibs` and `test.pkg` files.

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

Figure 54 Package and Component Combined



pkgfile='pkg_file_name'

You can define the package model file using the `pkgfile` keyword.

```
pkgfile = 'pkg_file_name'
```

If you cannot find a package model defined within a component in both the PKG and IBIS files, HSPICE issues an error message.

Other Optional Keywords

The following keywords are the same as for the B Element (I/O buffer). For more information, see [Specifying Common Keywords on page 144](#)

```
typ  
interpo  
ramp_rwf  
ramp_fwf  
rwf_tune  
fwf_tune  
pd_scal  
pu_scal  
pc_scal
```

```
gc_scal
rwf_scal
fwf_scal
nowarn
hsp_ver
c_com_puc_com_pd
c_com_pc
c_com_gc
```

Component Calls for SPICE-Formatted Pins

The syntax to call a [Component] having SPICE-formatted [Pin] is:

```
.IBIS ibis_command_name
+ file='ibis_filename' component='component_name'
+ <package=[0|1|2|3]> <pkgfile='pkg_file_name'>
+ <nowarn>
```

In the preceding syntax,

- The *component_name* specification must involve one or more SPICE-formatted [Pin].
- Usage of the other parameters follow .ibis conventions.

Other parameters not shown above have no affect on a SPICE-formatted buffer.

How .IBIS Creates Buffers

The .IBIS command adds a buffer to the netlist for every pin, according to the `signal_name` and `model_name` defined in the [Pin] keyword in the .ibs file.

Note: The .IBIS command does not create a buffer if the pin name is a reserved model name, such as POWER, GND, or NC.

```
buffer_name = 'cname' '_' pin_name'
```

- *cname* is defined in the .ibis card in the .sp netlist.
- *pin_name* is defined in the [Pin] keyword in the .ibs file

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

HSPICE connects the new buffers that the .IBIS command creates to the following nodes:

- name of buffer 1: 'cname'_'signal_name'
 - name of node 1: 'cname'_'pin_name'_i
 - name of node 2: 'cname'_'pin_name'_o
 - name of node 3: 'cname'_'pin_name'

Or it is the outofin node for input buffer.

- 'cname'_'pin_name'_en is the enable node if the buffer has enable node.
 - 'cname'_'pin_name'_outofin is the outofin node if it is not an input buffer.

Using the Buffer Component

The buffer component creates buffers that are always connected to the power sources that you specify in the IBIS file. You can specify power sources two different ways, which is described in the following sections.

Buffer Power ON

If you did not set [Pin Mapping] in the .ibs file or hsp_ver <= 2002.2, HSPICE automatically sets the power of buffers to ON. Use the [Voltage Range], [Pullup Reference], [Pulldown Reference], [POWER Clamp Reference], and [GND Clamp Reference] keywords in the .ibs file to set the voltage source inside the buffer.

The buffer nodes expect input and output node names in this format:

```
'buffer_name' _<node_name>
    buffer_name = 'cname' _'pin_name'
```

- *cname* is defined in the *.ibis* card in the *.sp* netlist.
 - *pin_name* is defined in the [Pin] keyword in the *.ibs* file
 - *<node_name>* is different for different types of buffers as shown in the following list:

OUTPUT pu , pd , pc , gc

INPUT_OUTPUT	pu , pd , en , outofin , pc , gc
THREE_STATE	pu , pd , en , pc , gc
OPEN_DRAIN	pu , pd , pc , gc
IO_OPEN_DRAIN	pu , pd , en , outofin , pc , gc
OPEN_SINK	pu , pd , pc , gc
IO_OPEN_SINK	pu , pd , en , outofin , pc , gc
OPEN_SOURCE	pu , pd , , pc , gc
IO_OPEN_SOURCE	pu , pd , en , outofin , pc , gc
INPUT_ECL	pc , gc
OUTPUT_ECL	pu , pc , gc
IO_ECL	pu , en , outofin , pc , gc
THREE_STATE_ECL	pu , en , pc , gc

Note: For more information about nodes for different buffers, see [Buffers on page 121](#)

Table 25 shows the names of the input and output nodes for the buffers:

Table 25 Input and Output Node Names for Buffers

Buffer Type	Node Names
INPUT and INPUT_ECL buffers	‘cname’_‘pin_name’ ‘cname’_‘pin_name’_i (for outofin)
Other types of buffers	‘cname’_‘pin_name’_i (for in node) ‘cname’_‘pin_name’ (for out node)

Note: If the buffer has an enable terminal, you must create a node named `buffer_name_en` to enable the buffer.

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

You can test the following sample cases using the same method explained.

In this example, you can test the buffers with the B Element.

```
*****
.tran 50p 30n
.option post post_version=9601 probe
.subckt twobus_b out1 out2
boutput1 nd_pu1 nd_pd1 out1 nd_in1 nd_pc1 nd_gc1
+ file = 'pinmap.ibs'
+ model = 'out50v'
+ buffer=2 power_on
+ hsp_ver = 2002.4 nowarn
boutput2 nd_pu2 nd_pd2 out2 nd_in2 nd_pc2 nd_gc2
+ file = 'pinmap.ibs'
+ model = 'out50v'
+ buffer=2 power=on
+ hsp_ver = 2002.4 nowarn
Vin1_b nd_in1 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Vin2_b nd_in2 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
.ends

Xtwobus_b out1_b out2_b twobus_b

Rout1_b out1_b 0 50
Rout2_b out2_b 0 50

.probe tran
+ out1_of_output_b = v(out1_b)
+ out2_of_output_b = v(out2_b)
+ in_of_output_b = v(Xtwobus_b.nd_in1)
.end
```

In this example, you can test the buffers that the .IBIS command creates.

```
*****
.tran 50p 30n
.option post post_version=9601 probe
* add component
.ibis pcomp
+ file = 'pinmap.ibs'
+ component = 'NO_PINMAPPING'
+ hsp_ver = 2002.4 nowarn
+ package = 0
Vin1 pcomp_1_i 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Vin2 pcomp_2_i 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Rout1_1 pcomp_1 0 50
Rout2_1 pcomp_2 0 50
```

```
.probe tran
+ out1_of_nopm = v(pcomp_1)
+ out2_of_nopm = v(pcomp_2)
+ in_of_output = v(pcomp_1_i)
.end
```

The following *.ibis* file is created:

```
| ****
| IBIS file pinmap.ibs
| ****
[IBIS ver] 3.1
[File name] pinmap.ibs
[File Rev] 1.0
[Date] 5/24/2002
[Source] spice models
[Notes] This ibis file tests the pinmap
results of HSPICE .ibis command. Pinmapping
is considered only if hsp_ver > 2002.2.

| ****
| Component NO PINMAPPING
| ****
|
[Component] NO_PINMAPPING
|
[Manufacturer] TEST
|
[Package] typ min max
R_pkg 0 NA NA
L_pkg 0 NA NA
C_pkg 0 NA NA

[Pin] signal_name model_name R_pin L_pin C_pin
1 OUT1 out50v 50.0m 2.01554n 0.33960p
2 OUT2 out50v 50.0m 1.83759n 0.31097p
3 GND1 GND 50.0m 1.89274n 0.32012p
4 VCC1 POWER 50.0m 1.74394n 0.31941p
```

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

```
5 GND2      GND          50.0m      1.89274n  0.32012p
6 VCC2      POWER        50.0m      1.74394n  0.31941p
.....
|model information
.....
[END]
```

Buffer Power OFF

If you set both [Pin Mapping] in the .ibs file and hsp_ver <= 2002.2, HSPICE automatically uses the [Pin Mapping] keyword in the .ibs file to load voltage sources to the buffers. HSPICE turns OFF the power of buffers that the component created.

In this way, the nd_pc, nd_pu, nd_gc, and nd_pd nodes connect to the power and ground bus according to the information in [Pin Mapping]. All other nodes are the same as in [Buffer Power ON on page 164](#)

The following two .sp files are equivalent.

The first file uses the B Element to describe buffers:

```
* test for IO,OUTPUT,3-STATE,INPUT BUFFER in component with pin
mapping
.option post post_version=9601 probe
.tran 50p 30n
.param vhi = 2.5

.subckt io_o_3st_i_b in st gnd1 vcc1 io output
bin vcc1 gnd1 in nd_out1
+ file = 'pinmap.ibs'
+ model = 'DS92LV090A_IN1'
+ buffer=1 power=off
+ hsp_ver = 2002.4 nowarn
b3st vcc1 gnd1 st nd_in1 nd_en1 vcc1 gnd1
+ file = 'pinmap.ibs'
+ model = 'DS92LV090A_RO'
+ buffer=4 power=off
+ hsp_ver = 2002.4 nowarn
bio vcc1 gnd1 io nd_in2 nd_en2 nd_ofi vcc1 gnd1
+ file = 'pinmap.ibs'
+ model = 'DS92LV090A_DOUT'
+ buffer=3 power=off
+ hsp_ver = 2002.4 nowarn
boutput vcc1 gnd1 output nd_in3 vcc1 gnd1
+ file = 'pinmap.ibs'
```

```

+ model = 'out50v'
+ buffer=2 power=off
+ hsp_ver = 2002.4 nowarn
Vin1_b nd_in1 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Ven1_b nd_en1 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Vin2_b nd_in2 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Ven2_b nd_en2 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Vin3_b nd_in3 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Rout_b nd_out1 0 50
.ends

Xio_o_3st_i_b in_b st_b gnd1_b vcc1_b io_b output_b io_o_3st_i_b
Vvcc1_b vcc1_b 0 3.3v
Vgnd1_b gnd1_b 0 0v
Vin_b in_b 0 0V PULSE (0 vhi 1ns 0.5ns 0.5ns 5ns 10ns)
Rout1_b st_b 0 50
Rout2_b io_b 0 50
Rout3_b output_b 0 50
.probe tran
+ out_of_in_b = v(Xio_o_3st_i_b.nd_out1)
+ out_of_3st_b = v(st_b)
+ out_of_io_b = v(io_b)
+ out_of_output_b = v(output_b)
+ in_of_output_b = v(Xio_o_3st_i_b.nd_in3)
.end

```

The second file uses a component to create buffers:

```

* test with component
.option post post_version=9601 probe
.tran 50p 30n
.param vhi = 2.5
.ibis pcomp
+ file = 'pinmap.ibs'
+ component = 'IO_OUTPUT_3ST_INPUT'
+ hsp_ver = 2002.4 nowarn
+ package = 0

Vin1 pcomp_3_i 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Ven1 pcomp_3_en 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Vin2 pcomp_6_i 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Ven2 pcomp_6_en 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Vin3 pcomp_7_i 0 0V pulse ( 0V 1V 1n 0.1n 0.1n 7.5n 15n )
Rout pcomp_2_i 0 50

Vvcc1 pcomp_5 0 3.3v
Vgnd1 pcomp_4 0 0v
Vin pcomp_2 0 0V PULSE (0 vhi 1ns 0.5ns 0.5ns 5ns 10ns)
Rout1 pcomp_3 0 50

```

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

```
Rout2 pcomp_6 0 50
Rout3 pcomp_7 0 50

.probe tran
+ out_of_in = v(pcomp_in_2)
+ out_of_3st = v(pcomp_3)
+ out_of_io = v(pcomp_6)
+ out_of_output = v(pcomp_7)
+ in_of_output = v(pcomp_7_i)
.end
```

The *.ibs* file is:

```
| ****
| IBIS file pinmap.ibs
| ****
[IBIS ver] 3.1
[File name] pinmap.ibs
[File Rev] 1.0
[Date] 5/24/2002
[Source] spice models
[Notes] This ibis file tests the pinmap
results of HSPICE .ibis command. Pinmapping
is considered only if hsp_ver > 2002.2.
| ****
| Component IO,OUTPUT,3-STATE,INPUT BUFFER
| ****
```

[Component] IO_OUTPUT_3ST_INPUT[Manufacturer]

TEST

	[Package]	typ	min	max
R_pkg	0	NA	NA	
L_pkg	0	NA	NA	
C_pkg	0	NA	NA	

```
| ****
```

4: Modeling Input/Output Buffers Using IBIS Using the IBIS Buffer Component

[Pin]	signal_name	model_name	R_pin	L_pin	C_pin
1 NC	NC	50.0m	2.11433n	0.27505p	
2 IN	DS92LV090A_IN1	50.0m	2.01554n	0.33960p	
3 ST	DS92LV090A_RO	50.0m	1.94357n	0.32802p	
4 GND1	GND	50.0m	1.89274n	0.32012p	
5 VCC1	POWER	50.0m	1.74394n	0.31941p	
6 IO	DS92LV090A_DOUT	50.0m	1.83759n	0.31097p	
7 OUTPUT	out50v	50.0m	1.83759n	0.31097p	

| ****|

[Pin Mapping]	pulldown_rf	pullup_rf	gnd_clamp_rf	power_clamp_rf
1 NC	NC	NC	NC	
2 NC	NC	GND1	VCC1	
3 GND1	VCC1	GND1	NC	
5 NC	VCC1	NC	NC	
6 GND1	VCC1	GND1	VCC1	
7 GND1	VCC1	GND1	VCC1	

.....| model information
.....[END]

For information about the syntax and examples of the .PKG, .EBD, and .IBIS commands, see the *HSPICE Command Reference Manual*.

4: Modeling Input/Output Buffers Using IBIS

Using the IBIS Buffer Component

.IBIS Command

The `.IBIS` command creates a node name with a new syntax, which has the following attributes.

- The internal node connected with buffers in the component is named `buffer_name_i`.
- The pin of a component is named `buffer_name`.
- The other nodes of the buffer are named:

`buffer_name_pc`
`buffer_name_gc`
`buffer_name_pu`
`buffer_name_pd`
`buffer_name_en`
`buffer_name_outofin` (except INPUT and ECL_INPUT buffer types)

A new parameter is created when you use the `.IBIS` command, which has the following syntax:

```
.IBIS ..... package = [0|1|2|3] (default = 3)
```

- if `package=0`, then RLC is not added into component.
- if `package=1`, then [Package](in .ibs file) is added.
- if `package=2`, then [Pin](in .ibs file) is added.
- if `package=3`, the set package with a package model if [Package Model] is defined. Set package with [Pin] if the package information is set in [Pin]. Set package with [Package] as the default package parameter if package information is not set in [Pin].

For example,

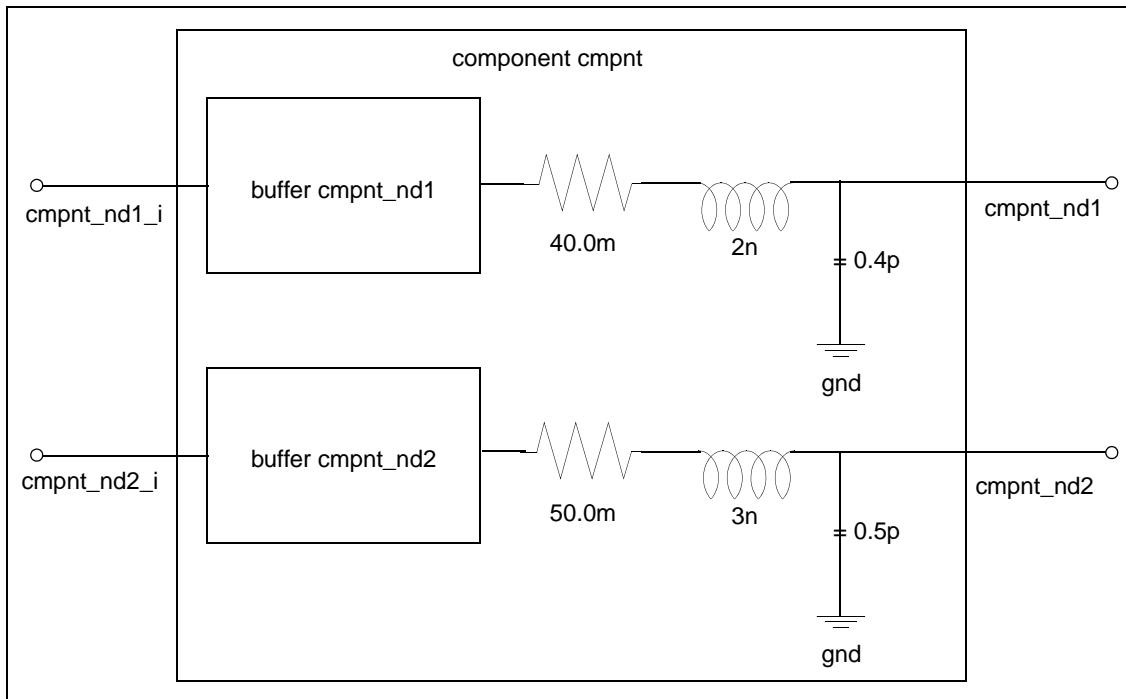
```
.ibis cmpnt
+ file = 'ebd.ibs'
+ component = 'SIMM'
+ hsp_ver = 2002.4 nowarn package = 2
```

In the ebd.ibs file:

[Component]	SIMM		
[Manufacturer]	TEST		
[Package]			
R_pkg	200m	NA	NA
L_pkg	7.0nH	NA	NA

C_pkg	1.5pF	NA	NA		
[Pin]	signal_name	model_name	R_pin	L_pin	C_pin
1	ND1	ECL	40.0m	2n	0.4p
2	ND2	NMOS	50.0m	3n	0.5p
.....					

Figure 55 Equivalent Circuit for EBD Example



Using IBIS Board-Level Components

A board-level component is used to describe a printed circuit board (PCB) or substrate that can contain components or even other boards and can connect to another board through a set of user visible pins. The electrical connectivity of such a board level component is referred to as an “Electrical Board Description.” You can use the HSPICE `.EBD` command to parse these board descriptions.

The `.EBD` command is associated with `.IBIS` command, because the EBD file contains the reference designator of the component. HSPICE search paths

4: Modeling Input/Output Buffers Using IBIS

Using IBIS Board-Level Components

between the component pins and the EBD pins are displayed in the [Path Description] of the EBD file. The component pins are designated with keyword:component in the .EBD command, which automatically create Lumped RLCs and distributed RLCs (W Elements) to express those paths. HSPICE then simulates the newly-created circuit.

In the following netlist, you can see the important elements and internal nodes that are created in the naming rules of the .EBD command.

Note: In the IBIS component and EBD naming rules, “signal name” is changed to “pin name.”

```
*****
*      Analysis And Options
*****
.op
.tran 10p 30n

.option post=2 probe
*****
*      Stimulus
*****

Vin cmp1_5_i 0 0V pulse ( 0V 3V 2n 0.1n 0.1n 7.5n 15n )

Vpu cmp1_1 0 2.5v
vpc cmp1_2 0 2.5v
vpd cmp1_3 0 0v
vgc cmp1_4 0 0

*****
*      Rload
*****

Rd1 ebd1_a3 0 50
Rd2 ebd1_a3 0 50

*****
*      Define Component
*****
.ibis cmp1
+ file = 'pinmap.ibs'
+ component = 'Component1'
+ hsp_ver = 2003.3
+ package = 0
```

```
*****
* Define EBD
*****

.ebd ebd1
+ file = 'pinmap.ebd'
+ model = 'Board1'
+ component = 'cmp1:u21'

*****
* Output
*****


.probe tran
+ cmp1_5_out = v(cmp1_5)      $ buf_5(Output): cmp1_5
+ cmp1_5_in  = v(cmp1_5_i)    $ no package , so the out node is
cmp1_5,
                           $ not cmp1_5_o

+ ebd1_a3     = v(ebd1_a3)
+ ebd1_a4     = v(ebd1_a4)

.end
```

.EDB and .IBIS Command Syntax

Use the following syntax when using IBIS board-level components:

```
.EBD 'ebd_name'
+ file = 'ebd_file_name' $ case-sensitive
+ model = 'ebd_model_name' $ case-sensitive
+ component = 'ibis_name:ref_des' $ case-insensitive
+ <component = 'ibis_name:ref_des'<...>>

.IBIS 'ibis_name'
+ file = 'ibis_file_name' $ case-sensitive
+ component = 'component_name' $ case-sensitive
+ <package = 0|1|2|3>
+ <other_keyword = value<...>>
```

Note: Using `component='ibis_name:ref_des'` to replace the function of the [Reference Designator Map] keyword and the [Reference Designator Map] keyword in EBD file is not valid.

4: Modeling Input/Output Buffers Using IBIS

Using IBIS Board-Level Components

Note: Parameters surrounded by single quotes (' ') are not required.

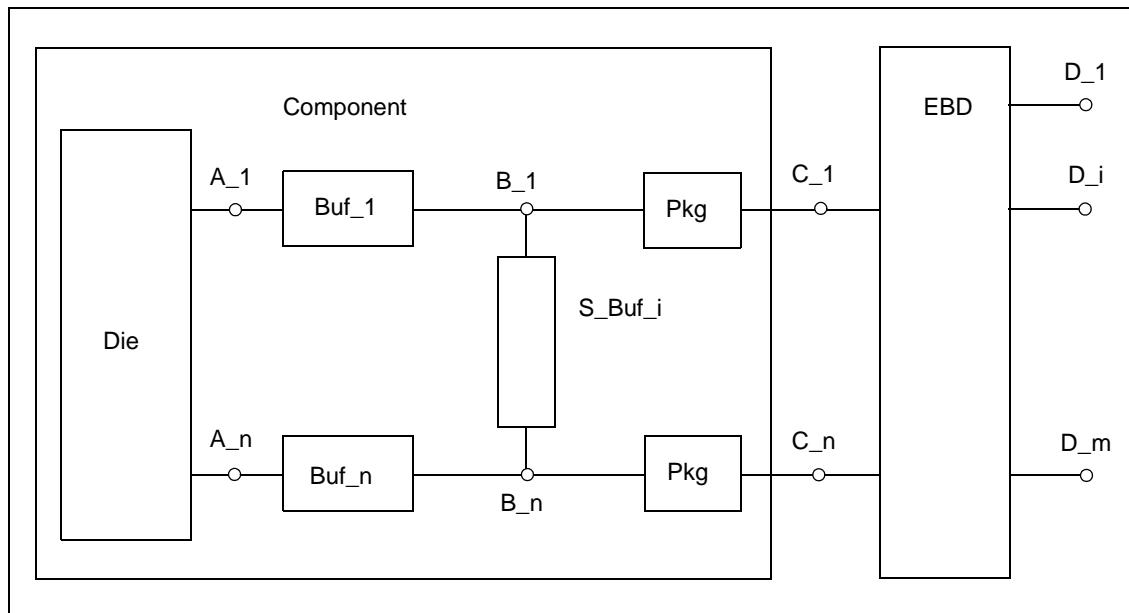
Table 26 .EBD/.IBIS Required Argument Descriptions

Parameter	Description
ebd_name	Specifies the name of the .EBD command. This argument is case-insensitive.
ibis_name	Specifies the name of associated .IBIS command. This argument is case-insensitive.
ebd_file_name	Identifies the EBD file. You must specify either the absolute path for the file or the path relative to the directory from where you run the simulation. This argument is case-sensitive. For example: <pre>file = './ebd/test.ebd' file = '/home/usr/ebd/test.ebd'</pre>
ebd_model_name	Identifies the Board-Level Component. Visible in the [Begin Board Description] keyword in the EBD file. This argument is case-sensitive.
ibis_name:ref_des	Maps an IBIS buffer component to a reference designator. <ul style="list-style-type: none">• ibis_name: Name of the associated .IBIS command to identify IBIS buffer component.• ref_des: Reference designator. Visible in the Node sub-parameter of the [Path Description] keyword in the EBD file. For example: <pre>component = 'cmp2:u22'</pre>

Circuit Topology Created by the .EBD and .IBIS Commands

The circuit topology in [Figure 56 on page 177](#) is created by the .EBD and .IBIS commands:

Figure 56 Circuit Topology Created by the .EBD and .IBIS Commands



B Element Naming Rules

The following rules in Table 27 apply when naming B Elements in IBIS board-level components:

Table 27 B Element Naming Rules

Buffer	Name	Note
Buf_#	'ibis_name'_'ibis_pin_name'	If model_name shows NC/POWER/GND in the column of the [Pin] keyword in the IBIS file, no Buf_# buffer exists.
S_Buf_#	'ibis_name'_'pin1_name'_'pin2_name'	If the [Series Pin Mapping] keyword is not in the IBIS file, no S_Buf_# series/series switch buffer exists.

Table 28 Node Naming Rules

Node	Name	Corresponding Buffer Node
A_#	'ibis_name'_'ibis_pin_name'_i	Terminator buffer: No A_# nodes
		Input/Input_ecl buffer: nd_out_of_in
		Other buffers: nd_in
		If no Buf_#, no A_# nodes
B_#	'ibis_name'_'ibis_pin_name'_o	Input/input_ecl buffer: nd_in
		Other buffers: nd_out
		Note: If no package (i.e. the package keyword in the .IBIS command is set to 0 or no relative sub-parameter is given in [Pin]/[Package] in IBIS file), then no B_# nodes. The corresponding nodes are named as C_# nodes.
C_#	'ibis_name'_'ibis_pin_name'_i	
D_#	'ebd_name'_'ebd_pin_name'_i	
Enable	'ibis_name'_'ibis_pin_name'_en	Buffer that has the nd_en Enable node. Other buffers: No
Out_of_in	'ibis_name'_'ibis_pin_name'_outofin	Buffer that has out_of_in Node except. Input/Input_ECL Buffer: nd_out_of_in

4: Modeling Input/Output Buffers Using IBIS

Using IBIS Board-Level Components

Table 28 Node Naming Rules (Continued)

Node	Name	Corresponding Buffer Node
Pulldown of Buf_#	'ibis_name'_'ibis_pin_name'_pd or 'ibis_name'_'ibis_pin_pd_name' (if pin mapping is defined in the IBIS file)	Buffer that has the Pulldown nd_pd node. Other buffers: No
Pullup of Buf_#	'ibis_name'_'ibis_pin_name'_pu or 'ibis_name'_'ibis_pin_pu_name' (if pin mapping is defined in the IBIS file)	Buffer that has the Pullup nd_pu node. Other buffers: No
GND Clamp of Buf_#	'ibis_name'_'ibis_pin_name'_pd or 'ibis_name'_'ibis_pin_gc_name' (if pin mapping is defined in the IBIS file)	Buffer that has the GND Clamp nd_gc node. Other buffers: No
POWER Clamp of Buf_#	'ibis_name'_'ibis_pin_name'_pc or 'ibis_name'_'ibis_pin_pc_name' (if pin mapping is defined in the IBIS file)	Buffer that hasPOWER Clamp nd_pc node. Other buffers: No

In the node names:

- 'ibis_name': Name of .IBIS command.
- 'ebd_name': Name of .EBD command.
- 'ibis_pin_name': Pin Name, the first column in Keyword:[Pin] in IBIS file.
- 'ebd_pin_name': Pin Name, the pin name given in [Path Description] in EBD file.
- 'pin1_name': One of two pins joined by a series model, the first column in Keyword: [Series Pin Mapping] in IBIS file.
- 'Pin2_name': The other of two pins joined by a series model, the second column in Keyword: [Series Pin Mapping] in IBIS file.

- 'ibis_pin_pd_name'
 - 'ibis_pin_pu_name'
 - 'ibis_pin_gc_name'
 - 'ibis_pin_pc_name' : The first matched pin name in [Pin] which are ground/power connections given in [Pin Mapping] in IBIS file.
-

IBIS Board-Level Component Examples

The following examples show how you can use the .IBIS and .EBD commands for board-level components.

```
** HSPICE Netlist **
.ibis cmp1
+ file = 'test1.ibs'
+ component = 'Component1'
+ package = 1

.ebd ebd1
+ file = 'test.ebd'
+ model = 'Board1'
+ component = 'cmp1:u21'

** IBIS file: test1.ibs **
[Component] Component1
| ...
[Pin] signal_name model_name R_pin L_pin C_pin
|
1 RAS0 Buffer1 200.0m 5.0nH 2.0pF
2 gnd GND 209.0m NA 2.5pF
3 pwr POWER NA 6.3nH NA
|
[Pin Mapping] pulldown_ref pullup_ref gnd_clamp_ref
power_clamp_ref ext_ref
|
1 GNDBUS1 PWRBUS1 |
2 GNDBUS1 NC |
3 NC PWRBUS1
|
[Series Pin Mapping] pin_2 model_name function_table_group
2 3 CBTSeries 1 | Four independent groups
```

Here's an example EBD file:

```
[Begin Board Description] Board1
| ...
[Pin List] signal_name
A1 GND
```

4: Modeling Input/Output Buffers Using IBIS

Using IBIS Board-Level Components

```
A2 data1
A3 data2
|.....
[Path Description] CAS_2
Pin A1
Len = 0.5 L=8.35n C=3.34p R=0.01 /
Node u21.1
Len = 0.5 L=8.35n C=3.34p R=0.01 /
Node u21.2
Len = 0.5 L=8.35n C=3.34p R=0.01 / | this section is
| discarded because
| the Node u23.3
| reference
| designator:u23 is not
| designated to IBIS
| component in the .ebd
| ebd1 command.
```

Nodes Used with B Elements

The following nodes in Table 29 are used with B Elements.

Table 29 B Element Nodes

Buffer/Node	Name
A_1	cmp1_1_i
B_1	cmp1_1_o
C_1	cmp1_1
C_2	cmp1_2
C_3	cmp1_3
D_1	ebd_a1
D_2	ebd_a2
D_3	ebd_a3
Pulldown of Buf_1	cmp1_2
Pullup of Buf_1	cmp1_3

Table 29 B Element Nodes (Continued)

Buffer/Node	Name
GND Clamp of Buf_1	cmp1_1_gc
POWER Clamp of Buf_1	cmp1_1_pc
Buf_1	cmp1_1
S_Buf_1	cmp1_2_3

Additional Notes

This section provides additional notes about IBIS models to clarify technical issues. Most of this information was developed as a result of customer feedback.

Keywords

The `fwf_tune`, `rwf_tune` parameters specify transition time for circuitry (either pullup or pulldown) that goes from the ON to OFF state. This is specified as a fraction of time (`delta_T`) for a transition for the opposite circuitry (either pulldown or pullup) from OFF to ON state. The `delta_T` value for ramp data transition time is different from the value for single waveform transition time (`delta_T` depends on the `ramp_fwf` and `ramp_rwf` parameters). Consequently, the absolute values for transition time from the ON to OFF state are different for ramp data and single waveform data.

Voltage Thresholds

Voltages applied to the input and enable nodes are digital signals. They should be either 0 or 1. You can specify input voltage as:

```
V_in nd_in 0 pulse (0 3.3 0 0.5n 0.5n 4n 8n)
```

However, IC circuit simulation currently detects only two thresholds, 20% and 80% of [0,1] swing, that is, 0.2V and 0.8V. If a buffer is non-inverting and in a LOW state, it starts the transition to a HIGH state, if $V_{in} > 0.8V$. If the buffer is in HIGH state, it will start the transition to LOW state, if $V_{in} < 0.2V$. Specifying input voltage in the range [0, 3.3V] as in the above example does not make

4: Modeling Input/Output Buffers Using IBIS

Additional Notes

LOW -> HIGH transitions better in any way, but can add uncertainty over the 0.5ns time interval when the transition actually occurs.

.OPTION D_IBIS

The D_IBIS option specifies the directory containing the IBIS files. For the syntax and examples of the .OPTION D_IBIS option, see the *HSPICE Command Reference*.

Subcircuit Model

One of three modes can be set for a subcircuit model, which you should set for the IBIS model in your *.ibs file. These modes include:

- driving
- non-driving
- all

You can define the Off_delay parameter on both the rising and falling edge. You can use this parameter with both the V_trigger_r and the V_trigger_f parameters.

Driver Schedule

Driver schedule connects the buffers together to form more complicated buffer behavior. The scheduled buffer should have the same node list as the top buffer.

For example, you can use the output buffer to schedule the open_drain buffer.

The delay parameter (such as rise_on_dly) should be consistent with the polarity of the scheduled driver. If the buffer inverts, then the rising edge turns on the pulldown device, and the rise_on_dly parameter means that the pulldown device automatically turns off after the rise_on_dly-rise_off_dly period.

5

Modeling Ideal and Lumped Transmission Lines

Describes how to model ideal and lumped transmission lines.

A transmission line delivers an output signal at a distance from the point of signal input. Any two conductors can make up a transmission line. The signal that is transmitted from one end of the pair to the other end is the voltage between the conductors. Power transmission lines, telephone lines, and waveguides are examples of transmission lines. Traces on printed circuit boards and multichip modules (MCMs) in integrated circuits are other examples of transmission lines.

With current technologies that use high-speed active devices on both ends of most circuit traces, all of the following transmission line effects must be considered during circuit analysis:

- Time delay
- Phase shift
- Power, voltage, and current loss
- Distortion
- Reduction of frequency bandwidth
- Coupled line crosstalk

5: Modeling Ideal and Lumped Transmission Lines

Selecting Wire Models

Synopsys provides accurate modeling for all kinds of circuit connections, including both lossless (ideal) and lossy transmission line elements.

Selecting Wire Models

A transmission line or interconnect is one of the following:

- Wire
- Trace
- Conductor
- Line

Many applications model electrical properties of interconnections between nodes by their equivalent circuits, and integrate them into the system simulation to accurately predict system performance.

An electrical model that simulates the behavior of interconnect must consider all of the following:

- Physical nature or electrical properties of the interconnect
- Bandwidth or risetime and source impedance of signals of interest
- Interconnect's actual time delay
- Complexity and accuracy of the model, and the corresponding effects on the amount of CPU time required for simulations

You can choose from the following circuit models for interconnects:

- No model at all. Use a common node to connect two elements.
- Lumped models with R, L, and C Elements as described in the *HSPICE Simulation and Analysis User Guide*. These include a series resistor (R), a shunt capacitor (C), a series inductor and resistor (RL), and a series resistor and a shunt capacitor (RC).
- Transmission line models such as an ideal transmission line (T Element) or a lossy transmission line (U Element)

Choosing the simplest model that adequately simulates the required performance minimizes sources of confusion and error during analysis.

Generally, to simulate both low and high frequency electrical properties of interconnects, select the U Element transmission line model. For compatibility

with conventional versions of SPICE, use one of the discrete lumped models or the T Element.

The following sections explain the factors that determine the best choice of a transmission line.

Source Properties

t_{rise} = source risetime

R_{source} = source output impedance

Interconnect Properties

Z_0 = characteristic impedance

TD = time delay of the interconnection

or

R = equivalent series resistance

C = equivalent shunt capacitor

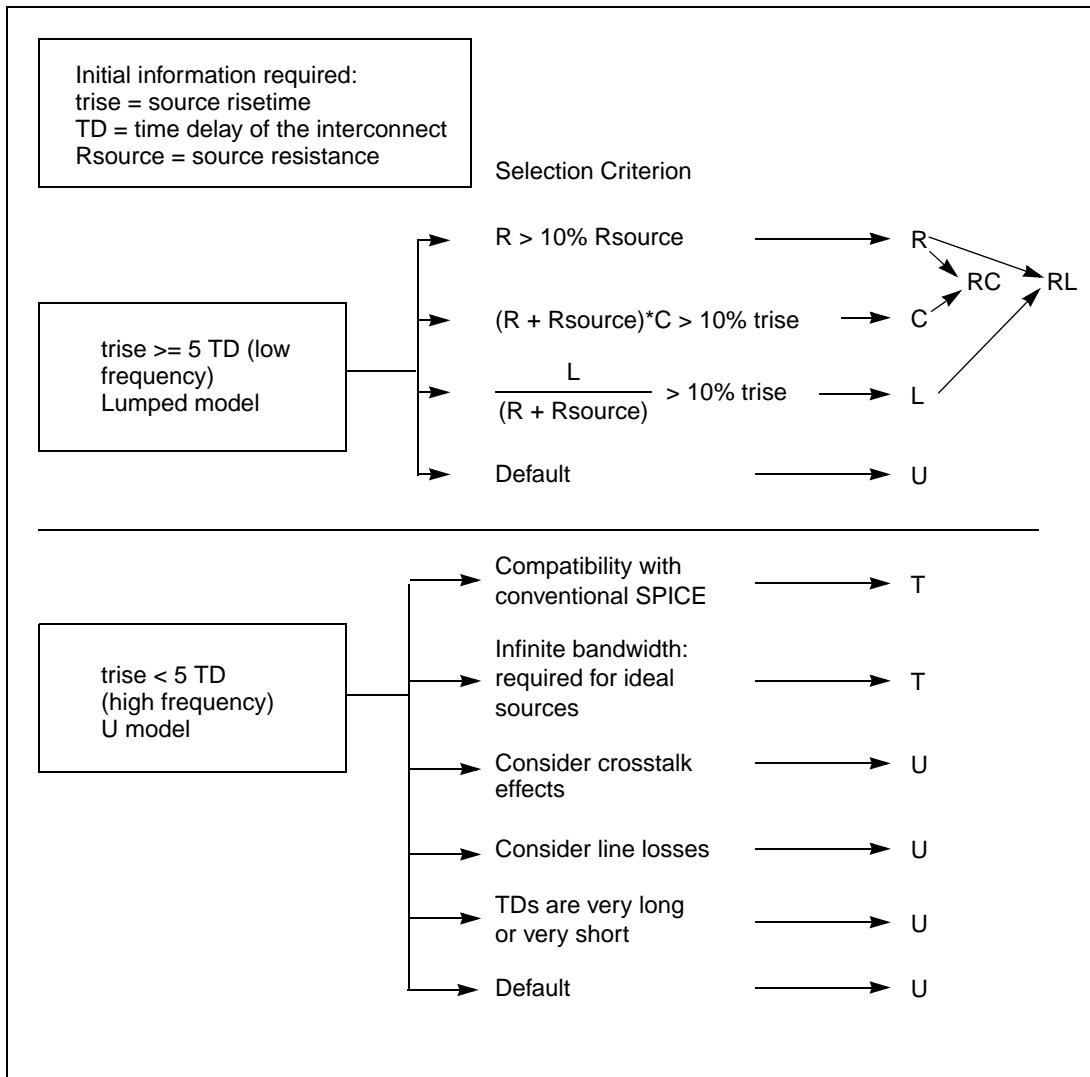
L = equivalent series inductance

Figure 57 shows you how to select a model based on source and interconnect properties.

5: Modeling Ideal and Lumped Transmission Lines

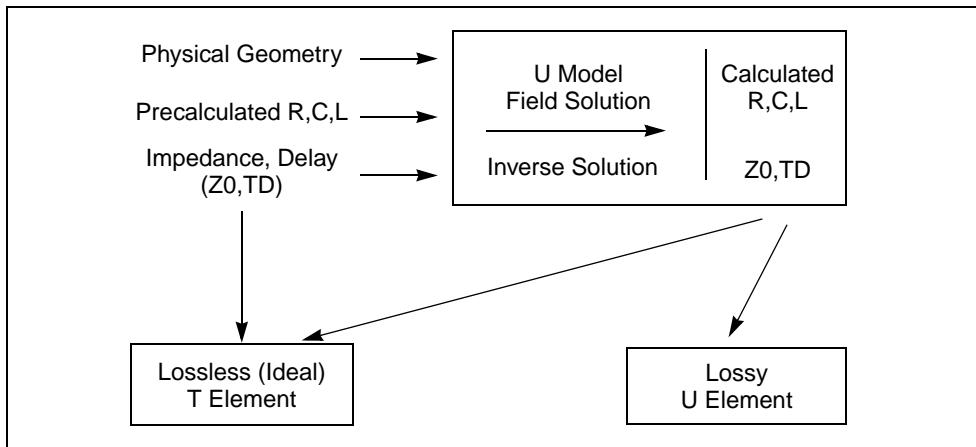
Selecting Wire Models

Figure 57 Wire Model Selection Chart



Use the U model with either the ideal T Element or the lossy U Element. You can also use the T Element alone without the U model. HSPICE offers both, a flexible definition of the conventional SPICE T Element and an accurate U Element lossy simulation.

Figure 58 U Model, T Element and U Element Relationship



The T and U Elements do not support the <M=val> multiplier function. If a U or T Element is used in a subcircuit and an instance of the subcircuit has a multiplier applied, the results are inaccurate.

A warning message similar to the following is issued in both the status file (.st0) and the output file (.lis) if the smallest transmission line delay is less than TSTOP/10e6:

```
**warning**: the smallest T-line delay (TD) = 0.245E-14 is too small
Please check TD, L and SCALE specification
```

This feature is an aid to finding errors that cause excessively long simulations.

Using Ground and Reference Planes

All transmission lines have a ground reference for the signal conductors. In this manual, the ground reference is called the reference plane so that it is not confused with SPICE ground. The reference plane is the shield or the ground plane of the transmission line element. The reference plane nodes may or may not be connected to SPICE ground.

Selecting Ideal or Lossy Transmission Line Element

The ideal and lossy transmission line models each have particular advantages, and they may be used in a complementary manner. Both model types are fully

5: Modeling Ideal and Lumped Transmission Lines

Selecting Wire Models

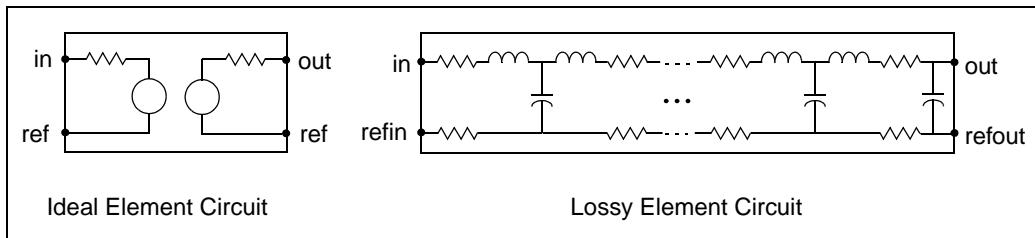
functional in AC analysis and transient analysis. Some of the comparative advantages and uses of each type of model are listed in Table 30.

Table 30 Ideal versus Lossy Transmission Line

Ideal Transmission Line	Lossy Transmission Line
lossless	includes loss effects
used with voltage sources	used with buffer drivers
no limit on input risetime	prefiltering necessary for fast rise
less CPU time for long delays	less CPU time for short delays
differential mode only	supports common mode simulation
no ground bounce	includes reference plane reactance
single conductor	up to five signal conductors allowed
AC and transient analysis	AC and transient analysis

The ideal line is modeled as a voltage source and a resistor. The lossy line is modeled as a multiple lumped filter section as shown in Figure 59.

Figure 59 Ideal versus Lossy Transmission Line Model



Because the ideal element represents the complex impedance as a resistor, the transmission line impedance is constant, even at DC values. On the other hand, you must prefilter the lossy element if ideal piecewise linear voltage sources are used to drive the line.

Selecting U Models

The U model allows three different description formats: geometric/physical, precomputed, and electrical. It provides equally natural description of vendor parts, physically described shapes, and parametric input from field solvers. The description format is specified by the required model parameter ELEV as follows:

- ELEV=1 – geometric/physical description such as width, height, and resistivity of conductors. It is used by board designers dealing with physical design rules.
- ELEV=2 – precomputed parameters. These are available with some commercial packaging, or as a result of running a field solver on a physical description of commercial packaging.
- ELEV=3 – electrical parameters such as delay and impedance, available with purchased cables. It allows one conductor and ground plane for PLEV=1.

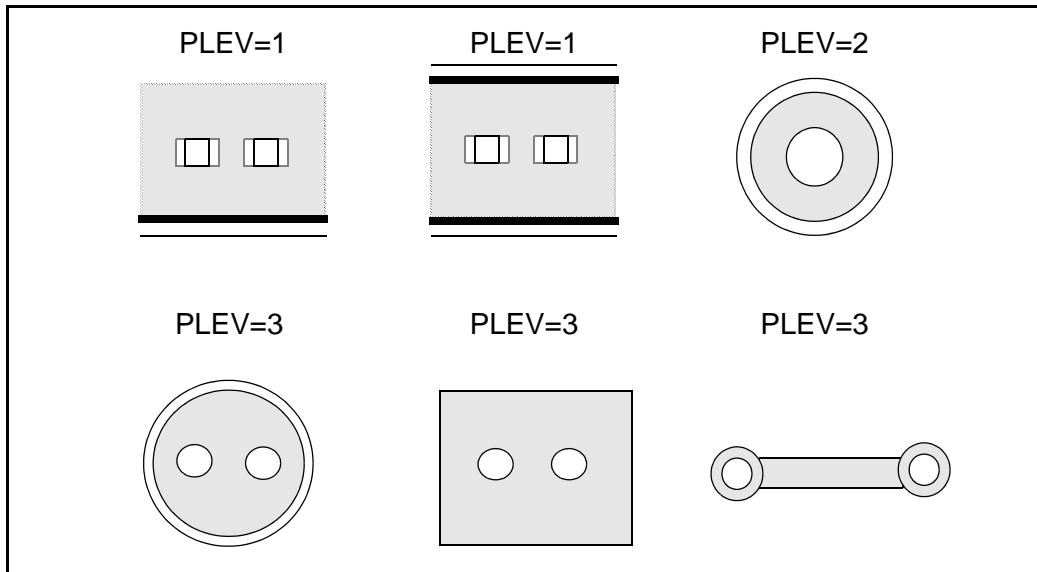
The U model explicitly supports transmission lines with several types of geometric structures. The geometric structure type is indicated by the PLEV model parameter as follows:

- PLEV=1 – Selects planar structures, such as microstrip and stripline, (the usual conductor shapes on integrated circuits and printed-circuit boards).
- PLEV=2 – Selects coax, which frequently is used to connect separated instruments.
- PLEV=3 – Selects twinlead, which is used to connect instruments and to suppress common mode noise coupling.

5: Modeling Ideal and Lumped Transmission Lines

Selecting Wire Models

Figure 60 U Model Geometric Structures



Transmission Lines: Example

The following file fragment is an example of how both T Elements and U Elements can be referred to a single U model as indicated in [Figure 58 on page 189](#). The file specifies a 200 millimeter printed circuit wire implemented as both a U Element and a T Element. The two implementations share a U model that is a geometric description (ELEV=1) of a planar structure (PLEV=1).

```
T1 in gnd t_out gnd microl L=200m  
U1 in gnd u_out gnd microl L=200m  
.model microl U LEVEL=3 PLEV=1 ELEV=1 wd=2m ht=2m th=0.25m  
+ KD=5
```

The next section provides details of element and model syntax.

Table 31 Transmission Line Parameters

Parameter	Description
T1, U1	Element names
microl	The model name
in, gnd, t_out, and u_out	Nodes

Table 31 Transmission Line Parameters (Continued)

Parameter	Description
L	The length of the signal conductor
wd, ht, th	Dimensions of the signal conductor and dielectric
KD	The relative dielectric constant

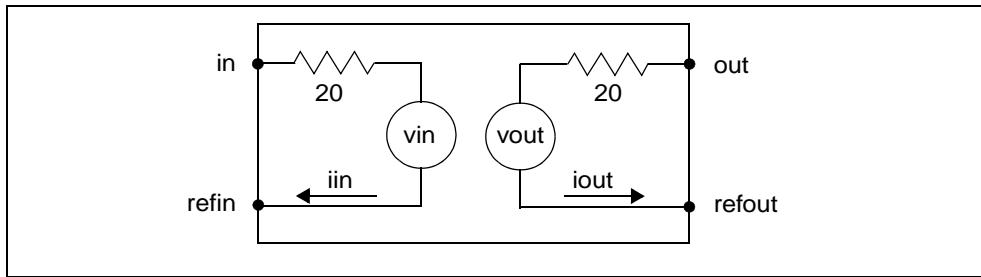
Interconnect Simulation

This section provides details of the requirements for T-line or U-line simulation.

Ideal Transmission Line

The ideal transmission line element contains the element name, connecting nodes, characteristic impedance (Z_0), and wire delay (TD), unless Z_0 and TD are obtained from a U model. In that case, it contains a reference to the U model.

Figure 61 Ideal Element Circuit



The input and output of an ideal transmission line have these relationships:

$$Vin|_t = V(out - refout)|_{t-TD} + (iout \times Z_0)|_{t-TD}$$

$$Vout|_t = V(in - refin)|_{t-TD} + (iin \times Z_0)|_{t-TD}$$

The signal delays for ideal transmission lines are specified as:

$$TDeff = TD \cdot L$$

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

If TD is given, or

$$T_{\text{Def}} = NL/F$$

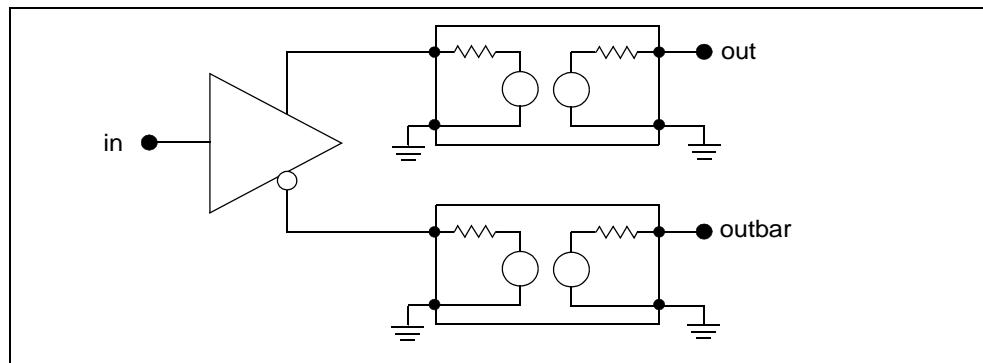
if NL and F are given, or

$$T_{\text{Def}} = TD$$

if you use a U model.

The ideal transmission line only delays the difference between the signal and the reference. Some applications, such as a differential output driving twisted pair cable, require both differential and common mode propagation. Use a U Element, if you need the full signal and reference. You can use approximately two T Elements (see Figure 62). In this figure, the two lines are completely uncoupled so that only the delay and impedance values are correctly modeled.

Figure 62 Use of Two T Elements for Full Signal and Reference



You cannot implement coupled lines with the T Element so use U Elements for applications requiring two or three coupled conductors.

Synopsys circuit simulation uses a transient timestep that does not exceed half the minimum line delay. Very short transmission lines (relative to the analysis time step) cause long simulation times. You can replace very short lines with a single R, L, or C Element (see [Figure 57 on page 188](#)).

Lossy U Element Statement

The U Element models single and coupled lossy transmission lines for various planar, coaxial, and twinlead structures. When a U Element is included in your netlist, simulation creates an internal network of R, L, C, and G Elements to represent up to five lines and their coupling capacitances and inductances. For more information, see the *HSPICE Element and Device Models Manual*.

You can specify interconnect properties in three ways:

- Specify the R, L, C, and G (conductance) parameters in a matrix form (ELEV = 2).
- Provide common electrical parameters, such as characteristic impedance and attenuation factors (ELEV = 3).
- Specify the geometry and the material properties of the interconnect (ELEV = 1).

This section initially describes how to use the third method.

The U model is optimized for typical geometries used in ICs, MCMs, and PCBs. The model's closed form expressions are optimized via measurements and comparisons with several different electromagnetic field solvers.

The U Element geometric model handles one to five uniformly spaced transmission lines, all at the same height. Also, the transmission lines can be on top of a dielectric (microstrip), buried in a sea of dielectric (buried), have reference planes above and below them (stripline), or have a single reference plane and dielectric above and below the line (overlay). Thickness, conductor resistivity, and dielectric conductivity allow for calculating loss as well.

The U Element statement contains the element name, the connecting nodes, the U model reference name, the length of the transmission line, and, optionally, the number of lumps in the element. You can create two kinds of lossy lines: lines with a reference plane inductance (LRR, controlled by the model parameter LLEV) and lines without a reference plane inductance. Wires on integrated circuits and printed circuit boards require reference plane inductance.

The reference ground inductance and the reference plane capacitance to SPICE ground are set by the HGP, CMULT, and optionally, the CEXT parameters.

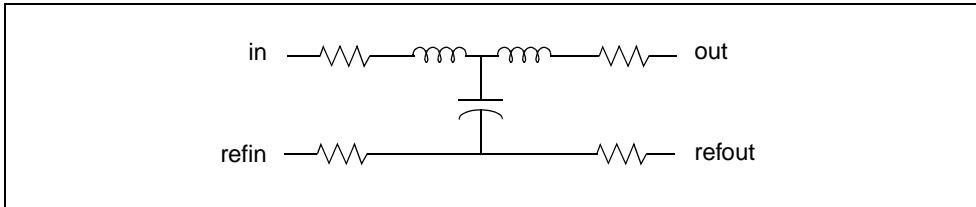
Lossy U Model Statement

The schematic for a single lump of the U model with LLEV=0, is shown in Figure 63. If LLEV is 1, the schematic includes inductance in the reference path as well as capacitance to HSPICE ground. See [Reference Planes and HSPICE Ground on page 201](#) for more information about LLEV=1 and reference planes.

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Figure 63 Lossy Line with Reference Plane



The following shows the netlist syntax for the U model.

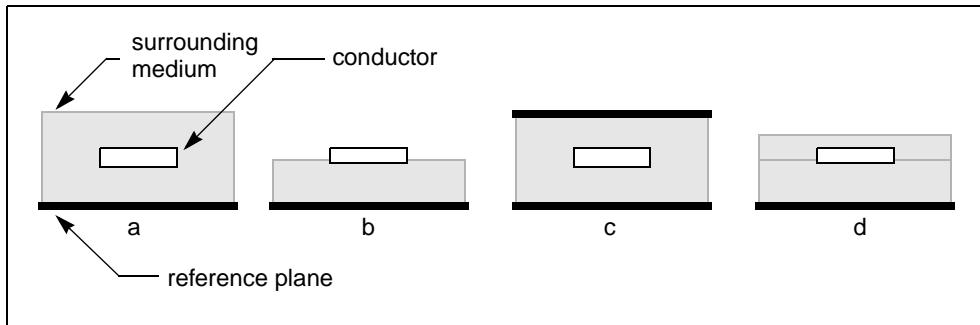
```
.MODEL mname U LEVEL=3 ELEV=val PLEV=val <DLEV=val>
+ <LLEV=val> + <Pname=val> ...
```

Parameter	Description
LEVEL=3	Selects the lossy transmission line model
ELEV=val	Selects the electrical specification format including the geometric model val=1
PLEV=val	Selects the transmission line type
DLEV=val	Selects the dielectric and ground reference configuration
LLEV=val	Selects the use of reference plane inductance and capacitance to HSPICE ground.
Pname=val	Specifies a physical parameter, such as NL or WD (see Table 32 on page 197) or a loss parameter, such as RHO or NLAY (see Table 33 on page 199).

[Table 32 on page 197](#) and [Table 33 on page 199](#) list the model parameters.

Figure 64 shows the three dielectric configurations for the geometric U model. You use the DLEV switch to specify one of these configurations. The geometric U model uses ELEV=1.

Figure 64 Dielectric and Reference Plane Configurations



In the above figure, a) sea, DLEV=0; b) microstrip, DLEV=1; c) stripline, DLEV=2; and d) overlay, DLEV=3.

Planar Geometric Models Lossy U Model Parameters

This section explains the physical, lossy, and geometric parameters of the U model.

Common Planar Model Parameters

The parameters for U models are listed in Table 32.

Table 32 U Element Physical Parameters

Parameter	Units	Default	Description
LEVEL		required	(=3) required for lossy transmission lines model
ELEV		required	Electrical model (=1 for geometry)
DLEV			Dielectric model (=0 for sea, =1 for microstrip, =2 stripline, =3 overlay; default is 1)
PLEV		required	Transmission line physical model (=1 for planar)
LLEV			Omit or include the reference plane inductance (=0 to omit, =1 to include; default is 0)
NL			Number of conductors (from 1 to 5)

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Table 32 U Element Physical Parameters (Continued)

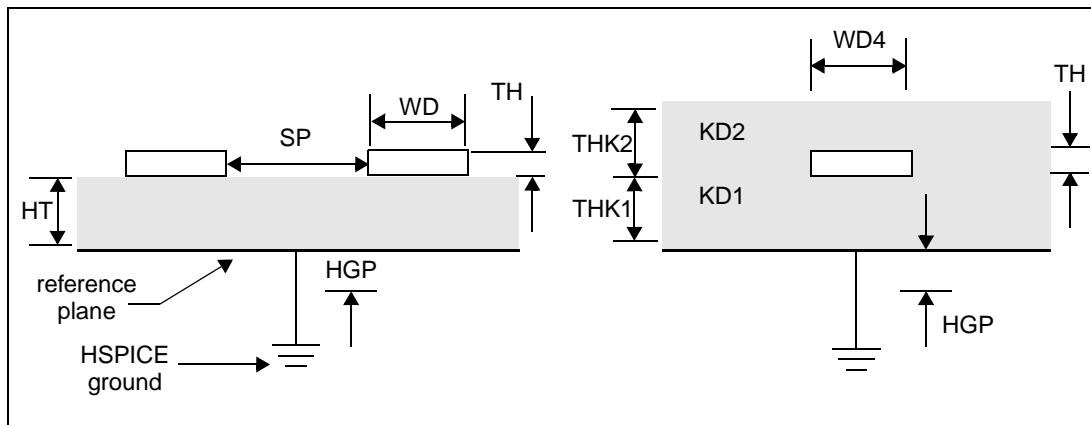
Parameter	Units	Default	Description
WD	m		Width of each conductor
HT	m		Height of all conductors
TH	m		Thickness of all conductors
THB	m		Reference plane thickness
TS	m		Distance between reference planes for stripline (default for DLEV=2 is 2 HT + TH. TS is not used when DLEV=0 or 1)
SP	m		Spacing between conductors (required if NL > 1)
KD			Dielectric constant
XW	m		Perturbation of conductor width added (default is 0)
CEXT	F/m		External capacitance between reference plane and ground. Only used when LLEV=1, this overrides the computed characteristic.
CMULT		1	Dielectric constant of material between reference plane and ground (default is 1 – only used when LLEV=1)
HGP	m		Height of the reference plane above HSPICE ground. Used for computing reference plane inductance and capacitance to ground (default is 1.5*HT – HGP is only used when LLEV=1).
CORKD			Perturbation multiplier for dielectric (default is 1)
WLUMP		20	Number of lumps per wavelength for error control
MAXL		20	Maximum number of lumps per element

The U model has two parametric adjustments: XW and CORKD. XW adds to the width of each conductor, but does not change the conductor pitch (spacing plus width). XW is useful for examining the effects of conductor etching. CORKD is a multiplier for the dielectric value. Some board materials vary more than others, and CORKD provides an easy way to test tolerance to dielectric variations.

Physical Parameters

The dimensions for one and two-conductor planar transmission lines are shown in Figure 65.

Figure 65 U Element Conductor Dimensions



Loss Parameters

Table 33 lists the loss parameters for the U model.

Table 33 U Element Loss Parameters

Parameter	Units	Description
RHO	ohm·m	Conductor resistivity (default is rho of copper, 17E-9 ohm·m)
RHOB	ohm·m	Reference plane resistivity (default value is for copper)

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Table 33 U Element Loss Parameters (Continued)

Parameter	Units	Description
NLAY		Number of layers for conductor resistance computation (=1 for DC resistance or core resistance, =2 for core and skin resistance at skin effect frequency)
SIG	mho/m	Dielectric conductivity

Losses have a large impact on circuit performance, especially as clock frequencies increase. RHO, RHOB, SIG, and NLAY are parameters associated with losses. Time domain simulators, such as SPICE, cannot directly handle losses that vary with frequency. Both the resistive skin effect loss and the effects of dielectric loss create loss variations with frequency. NLAY is a switch that turns on skin effect calculations in circuit simulation and analysis. The skin effect resistance is proportional to the conductor and backplane resistivities, RHO and RHOB.

Dielectric conductivity is included using SIG. The U model computes skin effect resistance at a single frequency and uses that resistance as a constant. The dielectric SIG computes a fixed conductance matrix, which is constant for all frequencies. To closely approximate losses, compute resistances and conductances at the frequency of maximum power dissipation. In AC analysis, resistance increases as the square root of frequency above the skin-effect frequency, and resistance is constant below the skin effect frequency.

Geometric Parameter Recommended Ranges

The U Element analytic equations compute quickly, but have a limited range of validity. The U Element equations were optimized for typical IC, MCM, and PCB applications. Table 34 lists the recommended minimum and maximum values for U Element parameter variables.

Table 34 Recommended Ranges

Parameter	Minimum	Maximum
NL	1	5
KD	1	24

Table 34 Recommended Ranges (Continued)

Parameter	Minimum	Maximum
WD/HT	0.08	5
TH/HT	0	1
TH/WD	0	1
SP/HT	0.15	7.5
SP/WD	1	5

The U Element equations lose their accuracy when you use values outside the recommended ranges. Because the single-line formula is optimized for single lines, you will notice a difference between the parameters of single lines and two coupled lines at a very wide separation. The absolute error for a single line parameter is less than 5% when used within the recommended range. The main line error for coupled lines is less than 15%. Coupling errors can be as high as 30% in cases of very small coupling. Since the largest errors occur at small coupling values, actual waveform errors are kept small.

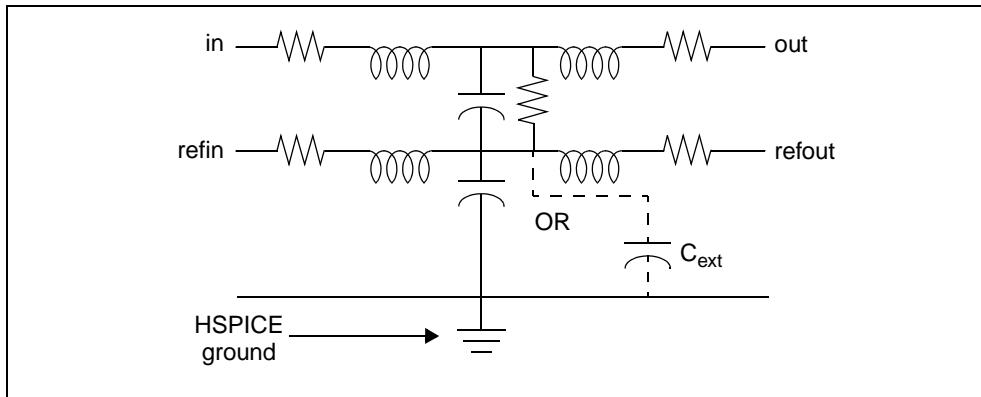
Reference Planes and HSPICE Ground

Figure 66 shows a single lump of a U model for a single line with reference plane inductance. If LLEV=1, the reference plane inductance is computed, and capacitance from the reference plane to HSPICE ground is included in the model. The reference plane is the ground plane of the conductors in the U model.

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Figure 66 Schematic of a U Element Lump when LLEV=1



The model reference plane is not necessarily the same as HSPICE ground. For example, a printed circuit board with transmission lines can have a separate reference plane above a chassis. Simulation with the U model uses either HGP, the distance between the reference plane and HSPICE ground, or C_{ext} to compute the parameters for the ground-to-reference transmission line.

If you use HGP, the capacitance per meter of the ground-to-reference line is computed based on a planar line of width $(NL+2)(WD+SP)$ and the height of HGP above the SPICE ground. CMULT is the dielectric constant of the ground-to-reference transmission line. If you specify C_{ext} , then C_{ext} is the capacitance per meter for the ground-to-reference line. The inductance of the ground-to-reference line is computed from the capacitance per meter and an assumed propagation at the speed of light.

Estimating the Skin Effect Frequency

Most of the power in a transmission line is dissipated at the clock frequency. As a first choice, simulation estimates the maximum dissipation frequency, or skin effect frequency, from the risetime parameter. The risetime parameter is set with the .OPTION statement (for example, .OPTION RISETIME=0.1ns).

Some designers use $0.35/trise$ to estimate the skin effect frequency. This estimate is good for the bandwidth occupied by a transient, but not for the clock frequency, at which most of the energy is transferred. In fact, a frequency of $0.35/trise$ is far too high and results in excessive loss for almost all applications. Simulation computes the skin effect frequency from $1/(15*trise)$. If you use precomputed model parameters (ELEV = 2), compute the resistance matrix at the skin effect frequency.

When the risetime parameter is not given, simulation uses other parameters to compute the skin effect frequency. The circuit simulator examines the .TRAN statement for *tstep* and *delmax* and examines the source statement for *trise*. If you set any one of the parameters *tstep*, *delmax*, and *trise*, simulation uses the maximum of these parameters as the effective risetime.

In AC analysis, the skin effect is evaluated at the frequency of each small-signal analysis. Below the computed skin effect frequency (ELEV=1) or FR1(ELEV=3), the AC resistance is constant. Above the skin effect frequency, the resistance increases as the square root of frequency.

Number of Lumped-Parameter Sections

The number of sections (lumps) in a transmission line model also affects the transmission line response. Simulation computes the default number of lumps from the line delay and the signal risetime. There should be enough lumps in the transmission line model to ensure that each lump represents a length of line that is a small fraction of a wavelength at the highest frequency used. It is easy to compute the number of lumps from the line delay and the signal risetime by using an estimate of $0.35/trise$ as the highest frequency.

For the default number of lumps, simulation uses the smaller of 20 or $1+(20*TDeff/trise)$, where *TDeff* is the line delay. In most transient analysis cases by using more than 20 lumps gives a negligible bandwidth improvement at the cost of increased simulation time. In AC simulations over many decades of frequency with lines over one meter long, more than 20 lumps may be needed for accurate simulation.

Ringing

Sometimes a transmission line simulation shows ringing in the waveforms as in [Figure 83 on page 225](#). If the ringing is not verifiable by measurement, it might be due to an incorrect number of lumps in the transmission line models or due to the simulator integration method. Increasing the number of lumps in the model or changing the integration method to Gear reduces the amount of ringing due to simulation errors. The default integration method is TRAP (trapezoidal), but you can change it to Gear with the statement .OPTION METHOD=GEAR.

See [Oscillations Due to Simulation Errors on page 240](#) for more information about the number of lumps and ringing.

The next section covers parameters for geometric lines. It discusses coaxial and twinlead transmission lines, and the previously-described planar type.

Geometric Parameters (ELEV=1)

Geometric parameters provide a description of a transmission line in terms of the geometry of its construction and the physical constants of each layer or other geometric shape involved.

PLEV=1, ELEV=1 Geometric Planar Conductors Planar conductors are used to model printed circuit boards, packages, and integrated circuits. The geometric planar transmission line is restricted to:

- One conductor height (HT or HT1)
- One conductor width (WD or WD1)
- One conductor thickness (TH or TH1)
- One conductor spacing (SP or SP12)
- One dielectric conductivity (SIG or SIG1)
- One or two relative dielectric constants (KD or KD1, and KD2 only if DLEV=3)

Common planar conductors include:

- DLEV=0 – microstrip sea of dielectric. This planar conductor has a single reference plane and a common dielectric surrounding conductor (see Figure 67).
- DLEV=1 – microstrip dual dielectric. This planar conductor has a single reference plane and two dielectric layers (see [Figure 69 on page 206](#)).
- DLEV=2 – stripline. This planar conductor has an upper and lower reference plane (see Figure 68). Both symmetric and asymmetric spacing are available.
- DLEV=3 – overlay dielectric. This planar conductor has a single reference plane and an overlay of dielectric material covering the conductor (see [Figure 70 on page 206](#)).

Figure 67 Planar Transmission Line, DLEV=0, Sea of Dielectric

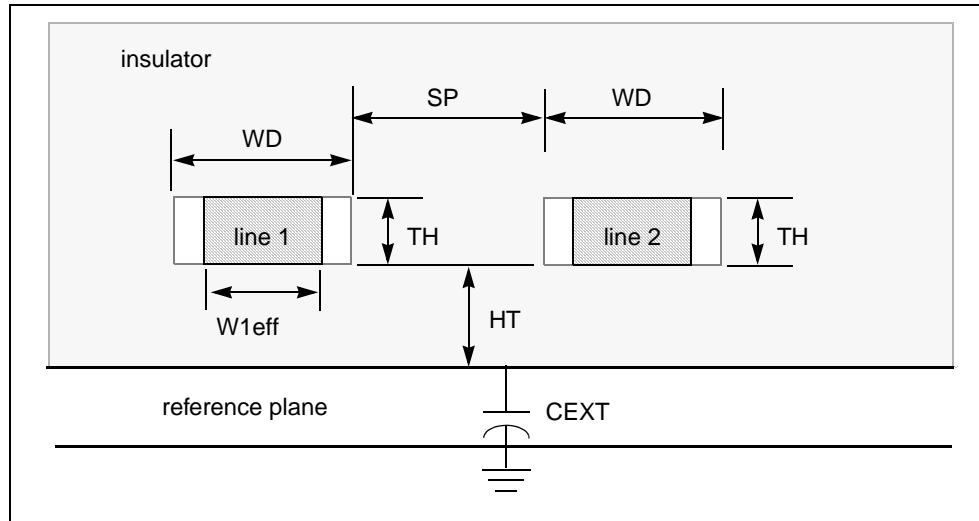
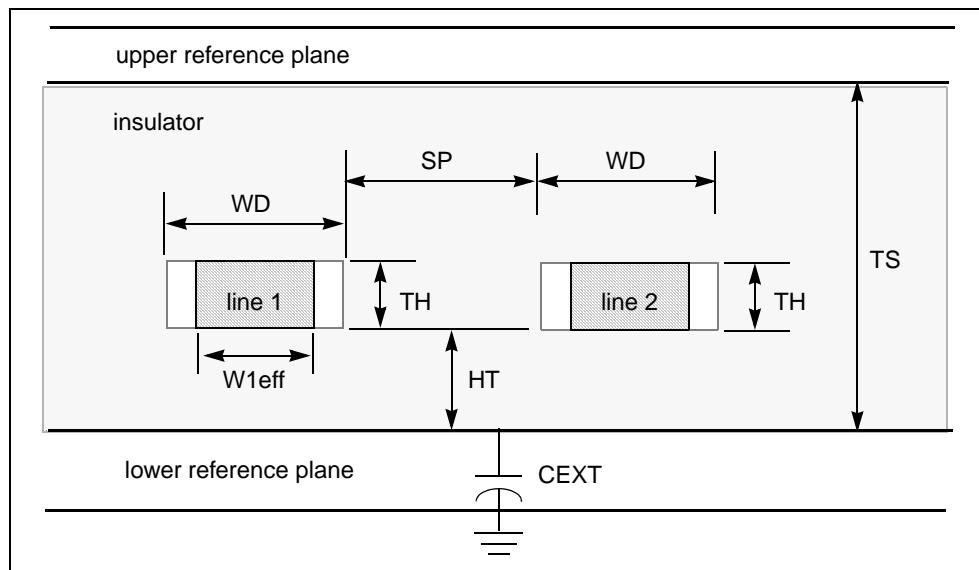


Figure 68 Planar Transmission Line, DLEV=2, Stripline



5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Figure 69 Planar Transmission Line, DLEV=1, Microstrip

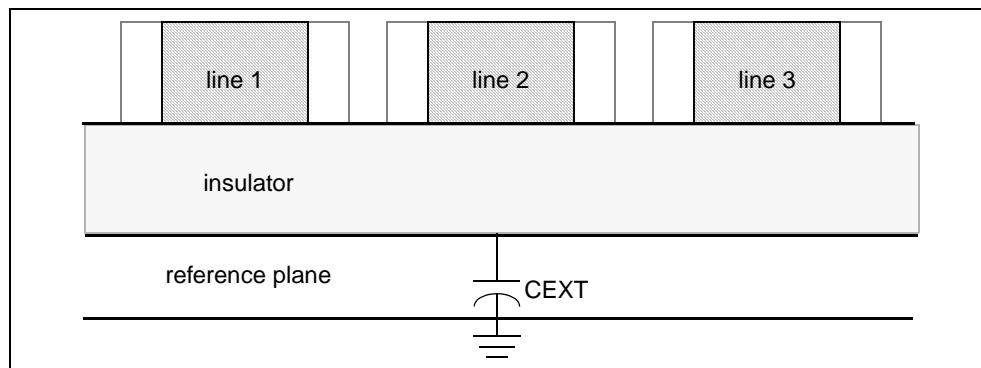


Figure 70 Planar Transmission Line, DLEV=3, Overlay Dielectric

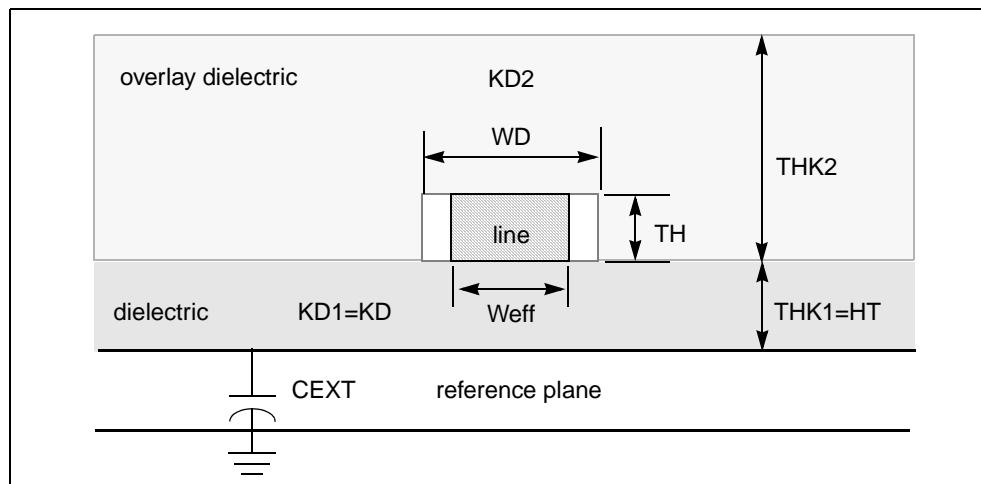


Table 35 Geometric Parameters

Name (Alias)	Units	Default	Description
DLEV	—	1.0	0: microstrip sea of dielectric 1: microstrip layered dielectric 2: stripline
NL	—	1	Number of conductors
NLAY	—	1.0	Layer algorithm: 1: DC cross section only 2: skindepth cross section on surface plus DC core

Table 35 Geometric Parameters (Continued)

Name (Alias)	Units	Default	Description
HT(HT1)	m	req	Conductor height
WD(WD1)	m	req	Conductor width
TH(TH1)	m	req	Conductor thickness
THK1	m	HT	Dielectric thickness for DLEV=3
THK2	m	0.0	Overlay dielectric thickness for DLEV=3 $0 \leq \text{THK2} < 3 \cdot \text{HT}$ (see the Note after this table)
THB	m	calc	Reference conductor thickness
SP(SP12)	m	req	Spacing: line 1 to line 2 required for $\text{nl} > 1$
XW	m	0.0	Difference between drawn and realized width
TS	m	calc	Height from bottom reference plane to top reference plane $\text{TS} = \text{TH} + 2 \cdot \text{HT}$ (DLEV=2, stripline only)
HGP	m	HT	Height of reference plane above SPICE ground – LLEV=1
CMULT	—	1.0	CPR multiplier for dielectric constant of material between shield and SPICE ground if LLEV=1 and CEXT is not present
CEXT	F/m	und	External capacitance from reference plane to <i>circuit ground point</i> – used only to override HGP and CMULT computation
RHO	ohm·m	17E-9	Resistivity of conductor material – defaults to value for copper
RHOB	ohm·m	rho	Resistivity of reference plane material
SIG1(SIG)	mho/m	0.0	Conductivity of dielectric
KD1(KD)	—	4.0	Relative dielectric constant of dielectric

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Table 35 Geometric Parameters (Continued)

Name (Alias)	Units	Default	Description
KD2		KD	Relative dielectric constant of overlay dielectric for DLEV=3 $1 < KD1 < 4 \cdot KD$
CORKD	—	1.0	Correction multiplier for KD

Note: If THK2 is greater than three times HT, simulation accuracy decreases. A warning message is issued to indicate this. A reference plane is a ground plane, but it is not necessarily at SPICE ground potential.

Lossy U Model Parameters for Geometric Coax (PLEV=2, ELEV=1)

Figure 71 Geometric Coaxial Cable

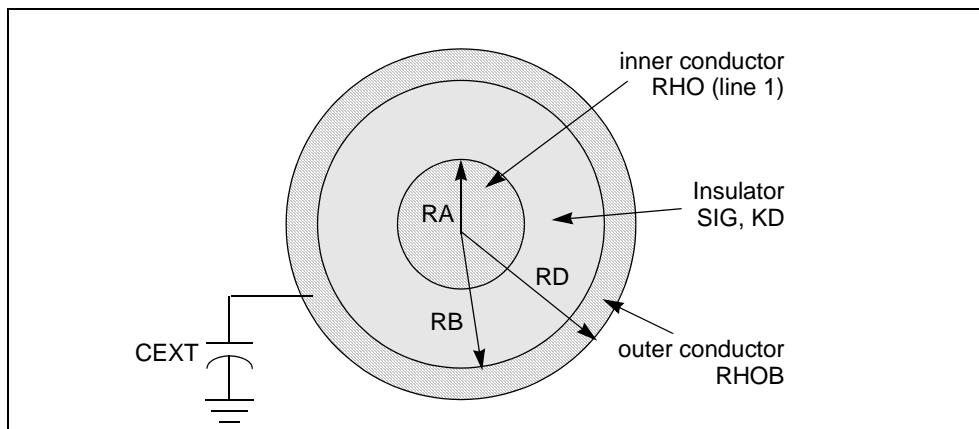


Table 36 Lossy U Model Parameters

Name (Alias)	Units	Default	Description
RA	m	req	Outer radius of inner conductor
RB	m	req	Inner radius of outer conductor (shield)

Table 36 Lossy U Model Parameters (Continued)

Name (Alias)	Units	Default	Description
RD	m	ra+rb	Outer radius of outer conductor (shield)
HGP	m	RD	Distance from shield to SPICE ground
RHO	ohm·m	17E-9	Resistivity of conductor material – defaults to value for copper
RHOB	ohm·m	rho	Resistivity of shield material
SIG	mho/m	0.0	Conductivity of dielectric
KD	—	4.0	Relative dielectric constant of dielectric
CMULT	—	1.0	Multiplier (used in defining CPR) for dielectric constant of material between shield and SPICE ground when LLEV=1 and CEXT is not present
CEXT	F/m	und.	External capacitance from shield to SPICE ground – used only to override HGP and CMULT computation
SHTHK	m	2.54E-4	Coaxial shield conductor thickness

Lossy U Model Parameters Geometric Twinlead (PLEV=3, ELEV=1)

Figure 72 Geometric Embedded Twinlead, DLEV=0, Sea of Dielectric

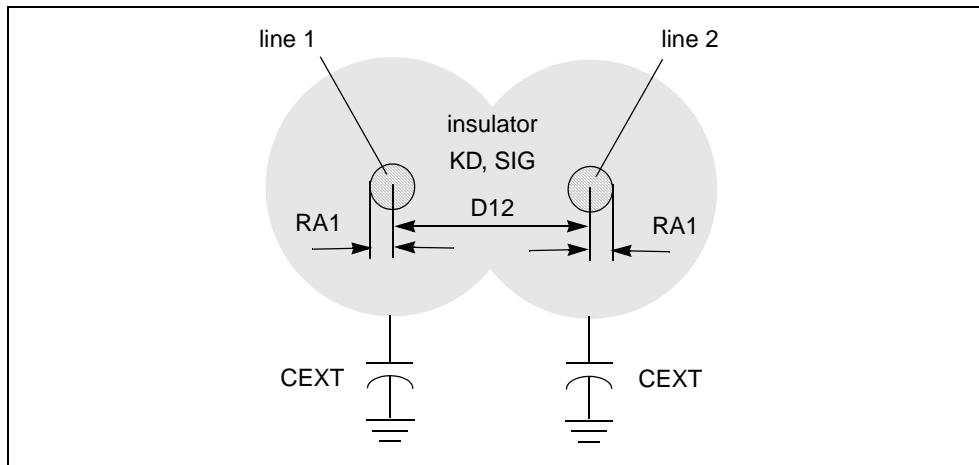


Figure 73 Geometric Twinlead, DLEV=1 with Insulating Spacer

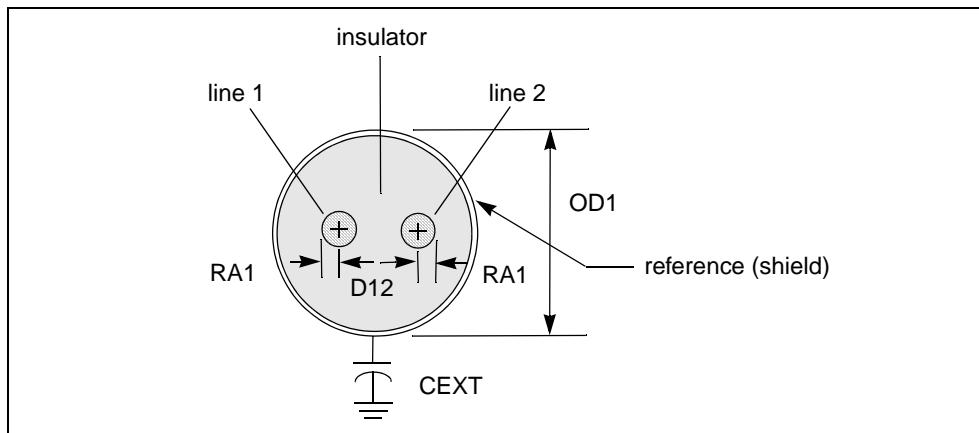


Figure 74 Geometric Twinlead, DLEV=2, Shielded

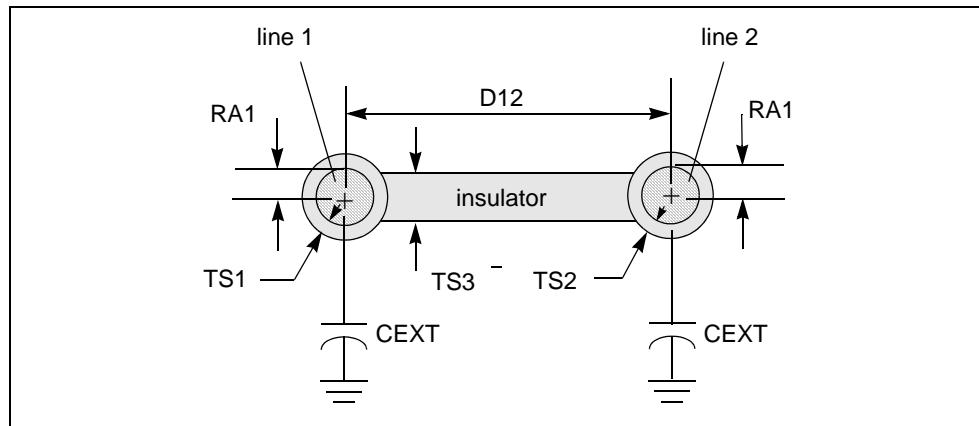


Table 37 Geometric Twinlead Parameters (ELEV=1)

Name (Alias)	Units	Default	Description
DLEV	—	0.0	0: embedded twinlead 1: spacer twinlead 2: shielded twinlead
RA1	m	req.	Outer radius of each conductor
D12	m	req.	Distance between the conductor centers
RHO	ohm·m	17E-9	Resistivity of first conductor material – defaults to value for copper
KD		4.0	Relative dielectric constant of dielectric
SIG	mho/m	0.0	Conductivity of dielectric
HGP	m	d12	Distance to reference plane
CMULT	—	1.0	Multiplier {used in defining CPR} for dielectric constant of material between reference plane and SPICE ground when LLEV=1 and CEXT is not present.
CEXT	F/m	undef.	External capacitance from reference plane to SPICE ground point (overrides LRR when present)

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Table 37 Geometric Twinlead Parameters (ELEV=1) (Continued)

Name (Alias)	Units	Default	Description
TS1	m	req.	Insulation thickness on first conductor
TS2	m	TS1	Insulation thickness on second conductor
TS3	m	TS1	Insulation thickness of spacer between conductor
The following parameters apply to shielded twinlead:			
RHOB	ohm·m	rho	Resistivity of shield material (if present)
OD1	m	req.	Maximum outer dimension of shield
SHTHK	m	2.54E-4	Twinlead shield conductor thickness

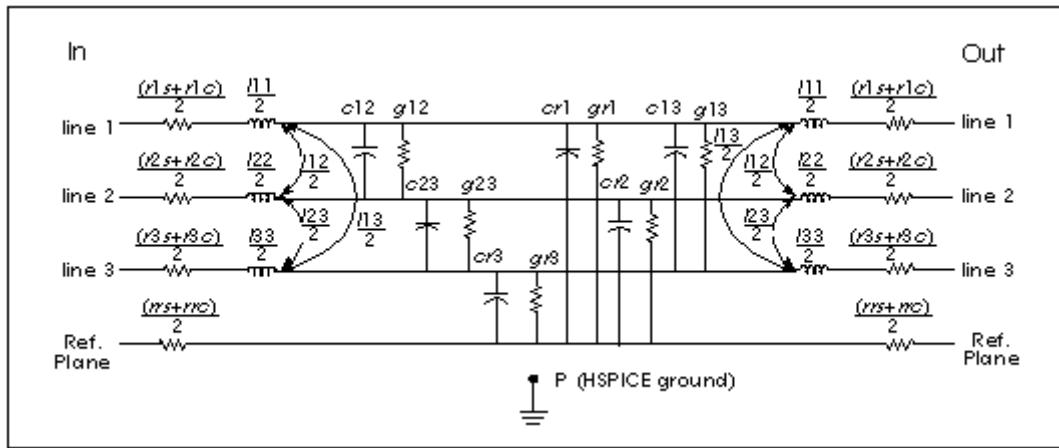
Precomputed Model Parameters (ELEV=2)

Precomputed parameters allow the specification of up to five signal conductors and a reference conductor. These parameters may be extracted from a field solver, laboratory experiments, or packaging specifications supplied by vendors. The parameters supplied include:

- Capacitance/length. Each conductor has a capacitance to all other conductors.
- Conductance/length. Each conductor has a conductance to all other conductors due to dielectric leakage.
- Inductance/length. Each conductor has a self inductance and mutual inductances to all other conductors in the transmission line.
- Resistance/length. Each conductor has two resistances, high frequency resistance due to skin effect and bent wires and DC core resistance.

Figure 75 identifies the precomputed components for a three-conductor line with a reference plane. The names for the resistance, capacitance, and conductance components for up to five lines are shown in Figure 76.

Figure 75 Precomputed Components for 3 Conductors and a Reference Plane



5: Modeling Ideal and Lumped Transmission Lines

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Figure 76 ELEV=2 Model Keywords for Conductor PLEV=1

	Ref. plane	line 1	line 2	line 3	line 4	line 5	
HSPICE ground	CPR GPR	CP1 GP1	CP2 GP2	CP3 GP3	CP4 GP4	CP5 GP5	
Ref. plane	RRR	CR1 GR1	CR2 GR2	CR3 GR3	CR4 GR4	CR5 GR5	
	LRR	LR1	LR2	LR3	LR4	LR5	
line 1		R11 L11	C12 G12 L12	C13 G13 L13	C14 G14 L14	C15 G15 L15	LLEV=1 parameter only
line 2		R22 L22	C23 G23 L23	C24 G24 L24	C25 G25 L25		
line 3			R33 L33	C34 G34 L34	C35 G35 L35		
line 4				R44 L44	C45 G45 L45		
line 5						R55 L55	

All precomputed parameters default to zero except CEXT, which is not used unless it is defined. The units are standard MKS in every case, namely:

Table 38 Precomputed Model Parameters

Parameter	Units
capacitance	F/m
inductance	H/m
conductance	mho/m
resistance	ohm/m

The following are four additional parameters, LLEV (which defaults to 0), CEXT, and GPR:

- LLEV=0. Reference plane conductor is resistive only (default).
- LLEV=1. Reference plane inductance is included as well as common mode inductance and capacitance to SPICE ground for all conductors.
- CEXT. External capacitance from the reference plane to SPICE ground. When CEXT is specified, it overrides CPR.
- GPR. Conductance to circuit ground; is zero except for immersion in a conductive medium.

Conductor Width Relative to Reference Plane Width

For the precomputed lossy U model (ELEV=2), the conductor width must be smaller than the reference plane width, which makes the conductor inductance smaller than the reference plane inductance. If the reference plane inductance is greater than the conductor inductance, simulation reports an error.

Alternative Multi-conductor Capacitance/Conductance Definitions

Three different definitions of capacitances and conductances between multiple conductors are currently used. In this manual, relationships are written explicitly only for various capacitance formulations, but they apply equally well to corresponding conductance quantities, which are electrically in parallel with the capacitances. The symbols used in this section, and where you are likely to encounter these usages, are:

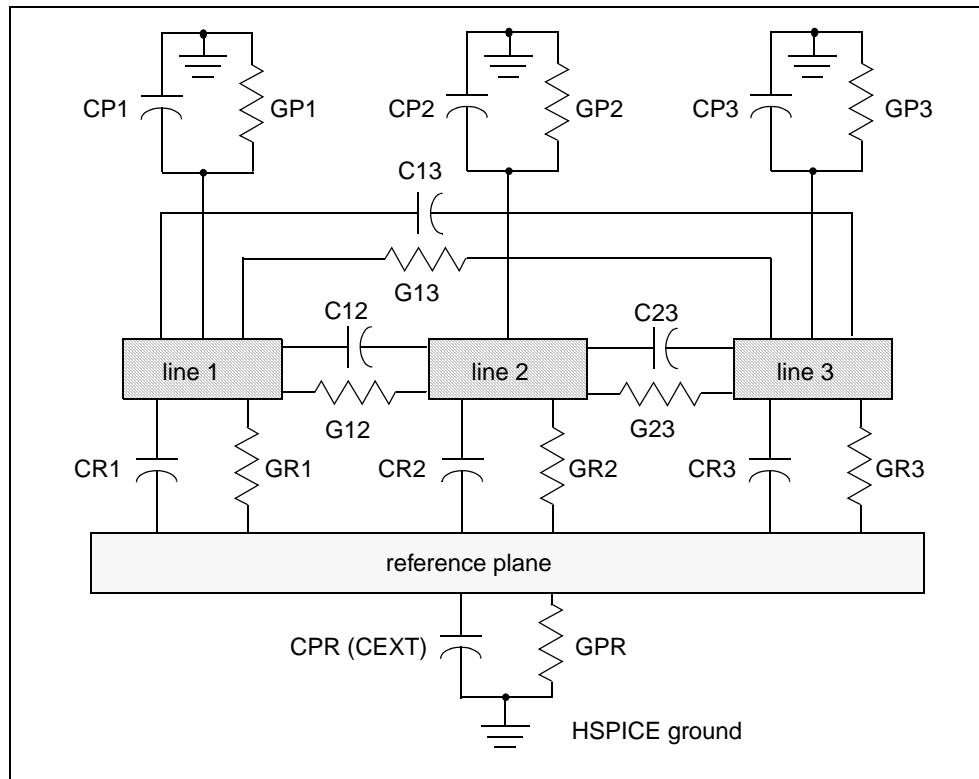
- CXY: branch capacitances, input, and circuit models.
- Cjk: Maxwell matrices for capacitance, multiple capacitor stamp for MNA (modified nodal admittance) matrix, which is a SPICE and HSPICE internal. Also the output of some field solvers.
- CX: capacitance with all conductors except X grounded. The output of some test equipment.
- GXY, Gjk, GX: conductances corresponding to above capacitances

The following example uses a multiple conductor capacitance model, a typical U model transmission line. The U Element supports up to five signal conductors plus a reference plane, but the three conductor case, Figure 77, demonstrates the three definitions of capacitance. The branch capacitances are specified in HSPICE notation.

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Figure 77 Single-Lump Circuit Capacitance



The branch and Maxwell matrices are completely derivable from each other. The “O.C.G.” (“other conductors grounded”) matrix is derivable from either the Maxwell matrix or the branch matrix. Thus:

$$CX = \sum_{X \neq Y} CX_Y$$

$$C_{jk} = CX \text{ on diagonal} \\ = -CX_Y \text{ off diagonal}$$

The matrices for the example given above provide the following “O.C.G.” capacitances:

$$C_1 = CR_1 + C_{12} + C_{13}$$

$$C_2 = CR_2 + C_{12} + C_{23}$$

$$C_3 = CR_3 + C_{13} + C_{23}$$

$$CR = CR_1 + CR_2 + CR_3 + CPR$$

Also, the Maxwell matrix is specified as:

$$C_{jk} = \begin{bmatrix} CR & -CR1 & -CR2 & -CR3 \\ -CR1 & C1 & -C12 & -C13 \\ -CR2 & -C12 & C2 & -C23 \\ -CR3 & -C13 & -C23 & C3 \end{bmatrix}$$

The branch capacitances also may be obtained from the Maxwell matrices. The off-diagonal terms are the negative of the corresponding Maxwell matrix component. The branch matrix terms for capacitance to circuit ground are the sum of all the terms in the full column of the maxwell matrix with signs intact:

```
CPR = sum (Cjk), j=R, k=R:3
CP1 = sum (C1k), j=1, k=R:3
CP2 = sum (C2k), j=2, k=R:3
CP3 = sum (C3k), j=3, k=R:3
```

CP1, ... CP5 are not computed internally with the geometric (ELEV=1) option, although CPR is. This, and the internally computed inductances, are consistent with an implicit assumption that the signal conductors are completely shielded by the reference plane conductor. This is true, to a high degree of accuracy for stripline, coaxial cable, and shielded twinlead, and to a fair degree for MICROSTRIP. If accurate values of CP1 and so forth are available from a field solver, they can be used with ELEV=2 type input.

If the currents from each of the other conductors can be measured separately, then all of the terms in the Maxwell matrix may be obtained by laboratory experiment. By setting all voltages except that on the first signal conductor equal to 0, for instance, you can obtain all of the Maxwell matrix terms in column 1.

$$\begin{bmatrix} IR \\ I1 \\ I2 \\ I3 \end{bmatrix} = \begin{bmatrix} CR & -CR1 & -CR2 & -CR3 \\ -CR1 & C1 & -C12 & -C13 \\ -CR2 & -C12 & C2 & -C23 \\ -CR3 & -C13 & -C23 & C3 \end{bmatrix} \cdot jw \cdot \begin{bmatrix} 0.0 \\ 1.0 \\ 0.0 \\ 0.0 \end{bmatrix} = jw \cdot \begin{bmatrix} -CR1 \\ C1 \\ -C12 \\ -C13 \end{bmatrix}$$

The advantage of using branch capacitances for input derives is that only one side of the off-diagonal matrix terms are input. This makes the input less tedious and provides fewer opportunities for error.

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Measured Parameters (ELEV=3)

When measured parameters are specified in the input, the program calculates the resistance, capacitance, and inductance parameters using TEM transmission line theory with the LLEV=0 option. If redundant measured parameters are given, the program recognizes the situation, and discards those which are usually presumed to be less accurate. For twinlead models, PLEV=3, the common mode capacitance is one thousandth of that for differential-mode, which allows a reference plane to be used.

The ELEV=3 model is limited to one conductor and reference plane for PLEV=1.

Table 39 Measured Parameters

Name (Alias)	Units	Default	Description
PLEV			1: planar 2: coax 3: twinlead
ZK	ohm	calc	Characteristic impedance
VREL	—	calc	Relative velocity of propagation (delen / (delay · clight))
DELAY	sec	calc	Delay for length delen
CAPL		1.0	Linear capacitance in length clen
AT1		1.0	Attenuation factor in length atlen. Use dB scale factor when specifying attenuation in dB.
DELEN	m	1.0	Unit of length for delay (for example, ft.)
CLEN	m	1.0	Unit of length for capacitance
ATLEN	m	1.0	Unit of length for attenuation
FR1	Hz	req.	Frequency at which AT1 is valid. Resistance is constant below FR1, and increases as $\sqrt{(\text{frequency})}$ above FR1.

Parameter Combinations You can use several combinations of measured parameters to compute the L and C values used internally. The full parameter set is redundant. If you input a redundant parameter set, the program discards those that are presumed to be less accurate. Table 41 shows how each of seven possible parameter combinations are reduced, if need be, to a unique set and then used to compute C and L.

Three different delays are used in discussing transmission lines:

Table 40 Delays Used with Transmission Lines

Delay	Description
DELAY	U model input parameter that is the delay required to propagate a distance “dlen”
TD	T Element input parameter signifying the delay required to propagate one meter
TD _{eff}	internal variable, which is the delay required to propagate the length of the transmission line T Element or U Element.

Table 41 Lossless Parameter Combinations

Input Parameters	Basis of Computation
ZK, DELAY, DELEN, CAPL, CLEN	redundant. Discard CAPL and CLEN.
ZK, VREL, CAPL, CLEN	redundant. Discard CAPL and CLEN.
ZK, DELAY, DELEN	VREL=DELEN/(DELAY · CLIGHT)
ZK and VREL	C=1/(ZK · VREL · CLIGHT) L=ZK/(VREL · CLIGHT)
ZK, CAPL, CLEN	C=CAPL/CLEN L=C · ZK ²
CAPL, CLEN, DELAY, DELEN	VREL=DELEN/(DELAY · CLIGHT)
CAPL, CLEN, VREL	LC=CAPL/CLEN LL=1/(C · VREL ² · CLIGHT ²)

Loss Factor Input You can specify the attenuation per unit length as either an attenuation factor or a decibel attenuation. Because the data might be available either as input/output or output/input, decibels greater than 0, or factors greater than 1 are assumed to be input/output. The following example shows the four ways that one may specify that an input of 1.0 is attenuated to an output of 0.758.

Table 42 Input Attenuation Variations

AT1 Input	Computation of attenuation factor and linear resistance
AT1 = -2.4dB	$v(\text{out})/v(\text{in}) = 0.758 = 10^{(+\text{AT1}/20)}$ (for dB < 0)
AT1 = +2.4dB	$v(\text{out})/v(\text{in}) = 0.758 = 10^{(-\text{AT1}/20)}$ (for dB > 0)
AT1 = 1.318	$v(\text{out})/v(\text{in}) = 0.758 = 1/\text{AT1}$ (for AT1 < 1)
AT1 = 0.758	$v(\text{out})/v(\text{in}) = 0.758 = \text{AT1}$ (for AT1 > 1)

The attenuation factor is used to compute the exponential loss parameter and linear resistance.

$$\alpha = \frac{\ln((v(\text{in}))/v(\text{out}))}{ATlin}$$

$$LR = 2 \cdot \alpha \cdot \sqrt{(LL)/(LC)}$$

U Element Examples

The following examples show the results of simulating a stripline geometry using the U model in a PCB scale application and in an IC scale application.

Three Coupled Lines, Stripline Configuration

Figure 78 shows three coupled lines in a stripline configuration on an FR4 printed circuit board. A simple circuit using three coupled striplines is shown in Figure 79.

Figure 78 Three Coupled Striplines (PCB Scale)

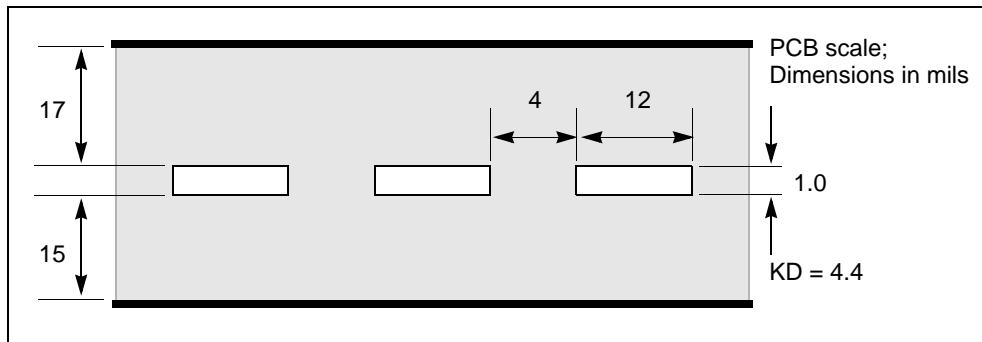
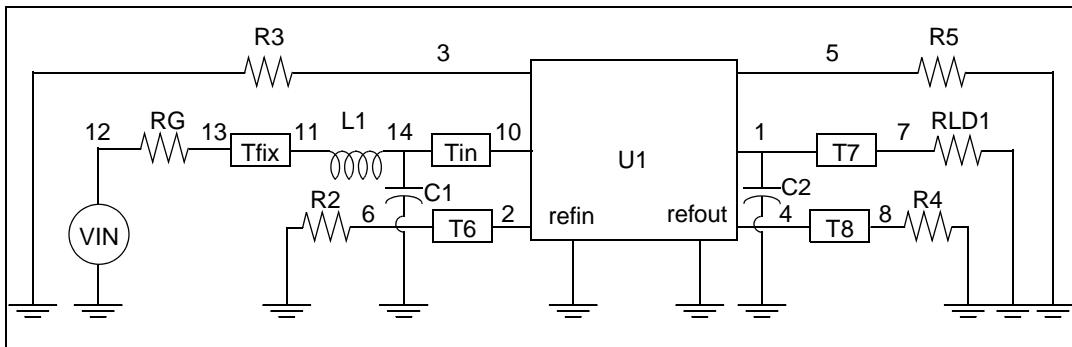


Figure 79 Schematic Using the Three Coupled Striplines U Model



The sample netlist for this example is located in the following directory:

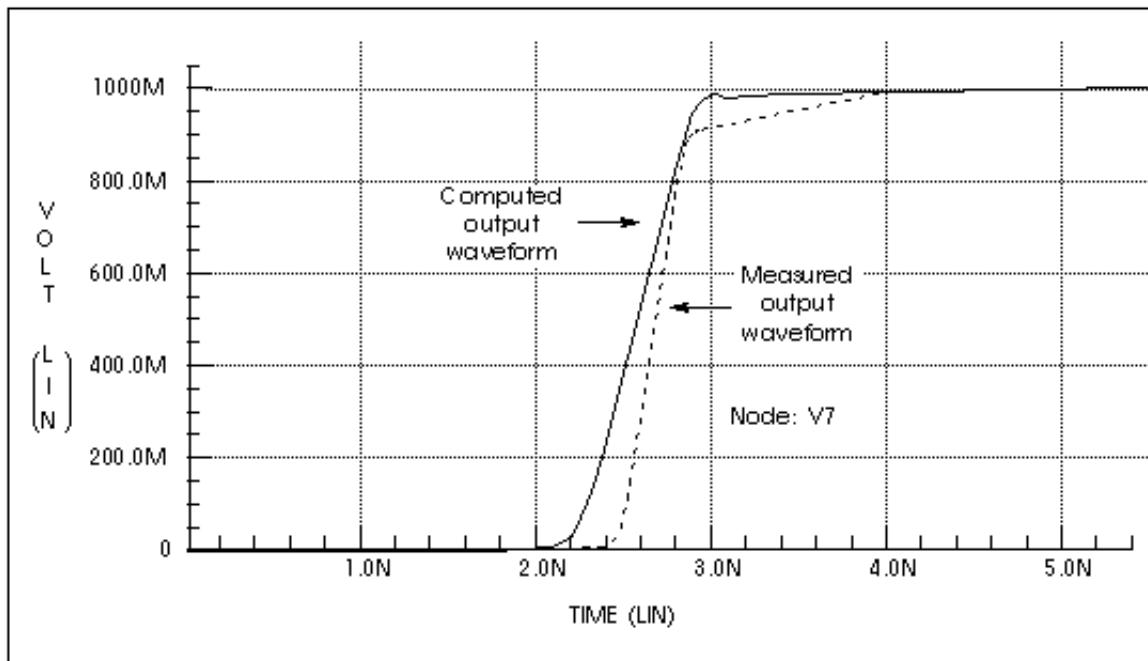
`$installdir/demo/hspice/tline/stripline.sp`

Figure 80, Figure 81, and Figure 82 show the main line and crosstalk responses. The rise time and delay of the waveform are sensitive to the skin effect frequency, since losses reduce the slope of the signal rise. The main line response shows some differences between simulation and measurement. The rise time differences are due to layout parasitics and the fixed resistance model of skin effect. The differences between measured and simulated delays are due to errors in the estimation of dielectric constant and the probe position.

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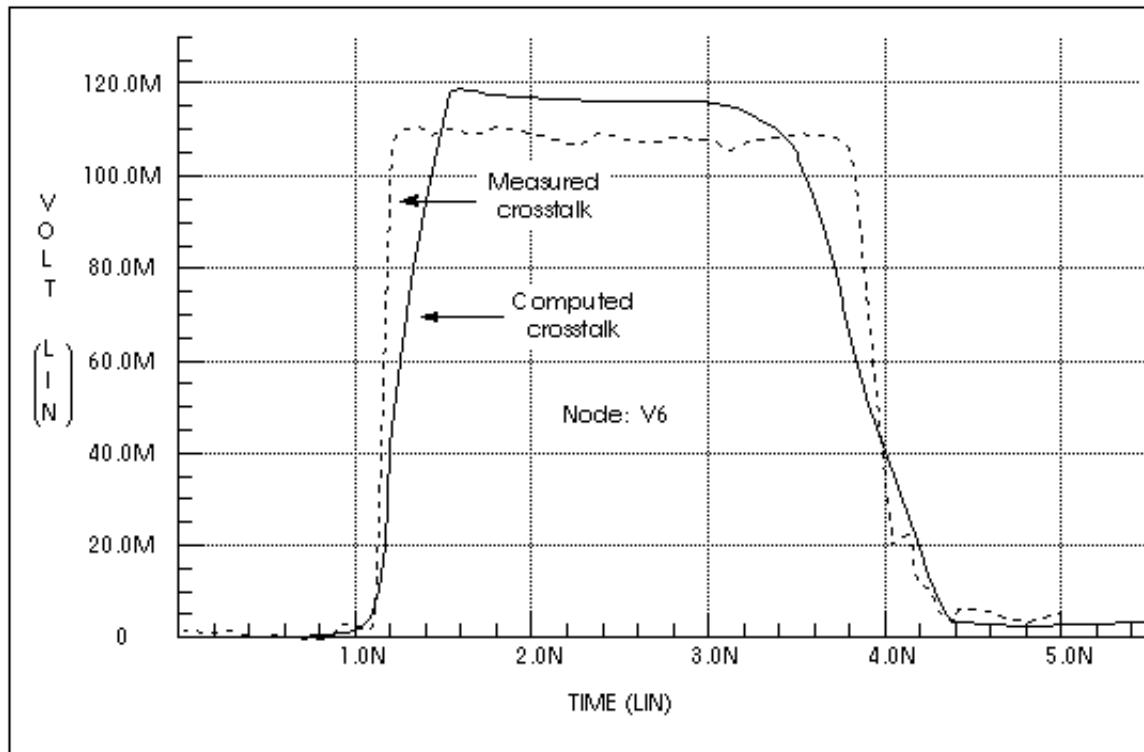
Figure 80 Measured versus Computed Through-Line Response



The gradual rise in response between 3 ns and 4 ns is due to skin effect. During this period, the electric field driving the current penetrates farther into the conductor so that the current flow increases slightly and gradually. This affects the measured response as shown for the period between 3 ns and 4 ns.

Figure 81 shows the backward crosstalk response. The amplitude and delay of this backward crosstalk are very close to the measured values. The risetime differences are due to approximating the skin effect with a fixed resistor, while the peak level difference is due to errors in the LC matrix solution for the coupled lines.

Figure 81 Measured Versus Computed Backward Crosstalk Response



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Figure 82 Measured Versus Computed Forward Crosstalk Response

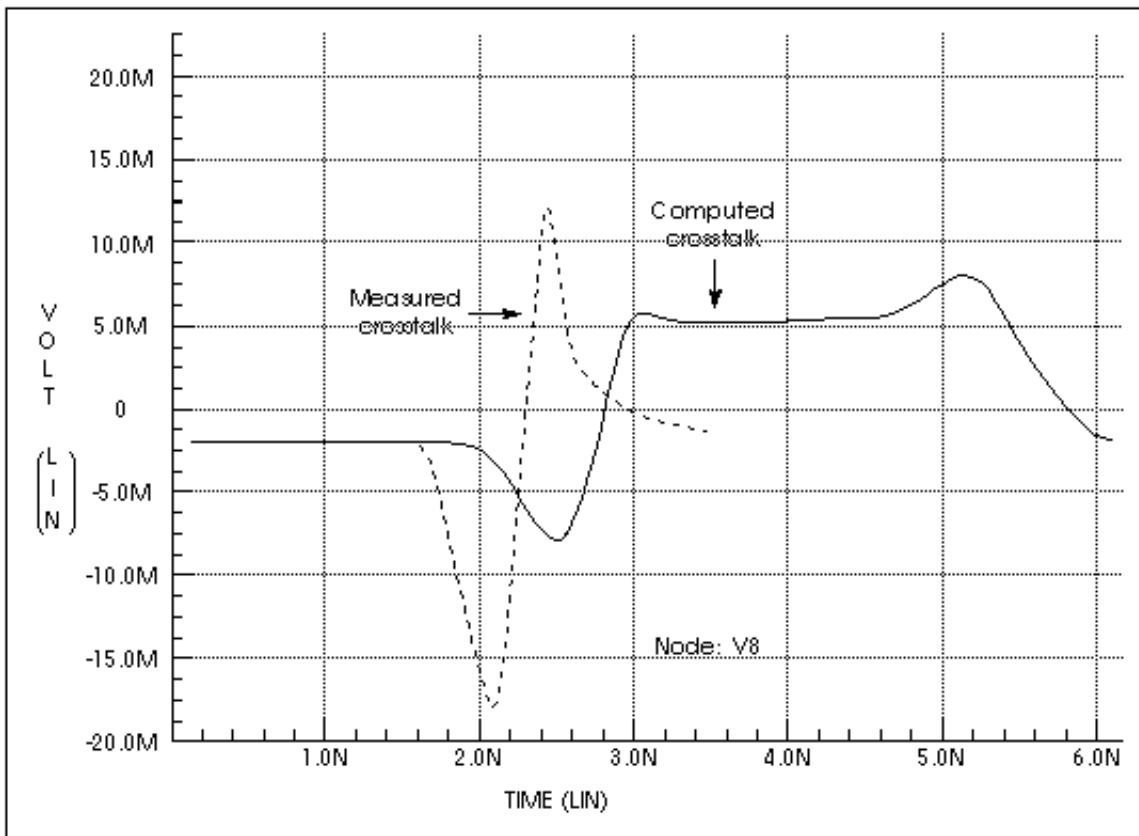
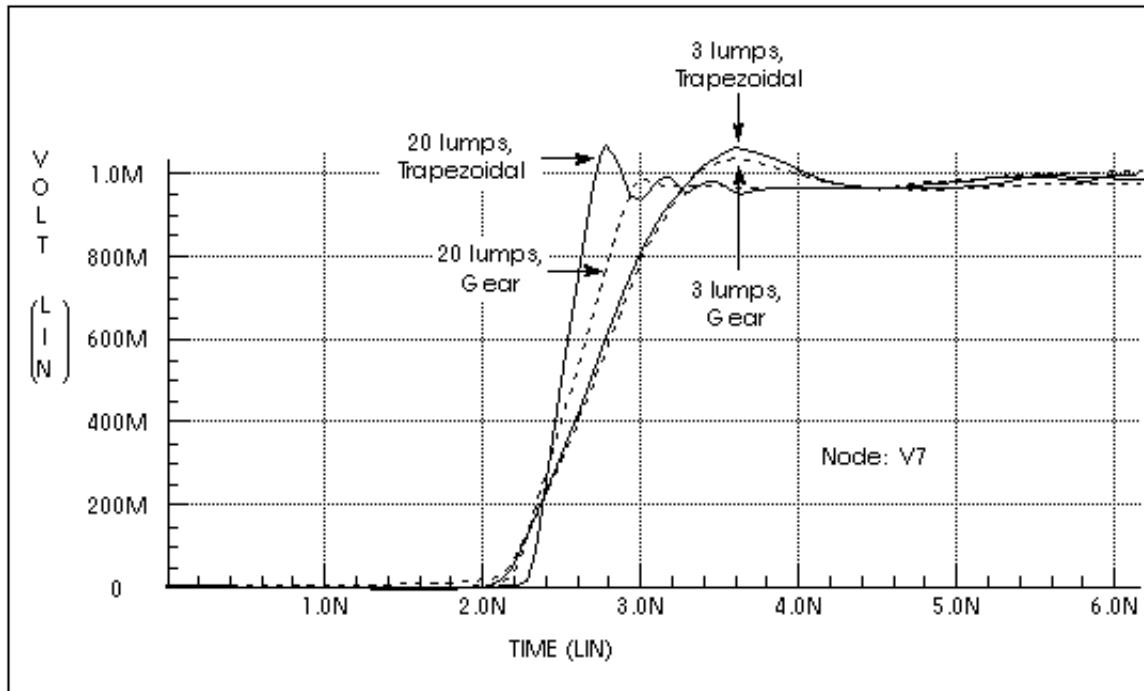


Figure 82 shows the forward crosstalk response. This forward crosstalk shows almost complete signal cancellation in both measurement and simulation. The forward crosstalk levels are about one tenth the backward crosstalk levels. The onset of ringing of the forward crosstalk has reasonable agreement between simulation and measurement. However, the trailing edge of the measured and simulated responses differ. The measured response trails off to zero after about 3 ns, while the simulated response does not trail down to zero until 6 ns. Errors in simulation at this voltage level can easily be due to board layout parasitics that have not been included in the simulation.

Simulation methods can have a significant effect on the predicted waveforms. Figure 83 shows the main line response at Node 7 of [Figure 79 on page 221](#) as the integration method and the number of lumped elements change. With the recommended number of lumps, 20, the Trapezoidal integration method shows a fast risetime with ringing.

The Gear integration method shows a fast risetime and a well damped response. When the number of lumped elements changes to 3, both Trapezoidal and Gear methods show a slow risetime with ringing. In this situation, the Gear method with 20 lumps gives the more accurate simulation.

Figure 83 Computed Responses for 20 Lumps and 3 Lumps, Gear and Trapezoidal Integration Methods



Three Coupled Lines, Sea of Dielectric Configuration

This example shows the U Element analytic equations for a typical integrated circuit transmission line application. Three 200 μ m-long aluminum wires in a silicon dioxide dielectric are simulated to examine the through-line and coupled line response.

The U model uses the transmission line geometric parameters to generate a multisection lumped-parameter transmission line model. Use a single U Element statement to create an internal network of three 20-lump circuits.

Figure 84 shows the IC-scale coupled line geometry.

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Figure 84 Three Coupled Lines with One Reference Plane in a Sea of Dielectric (IC Scale)

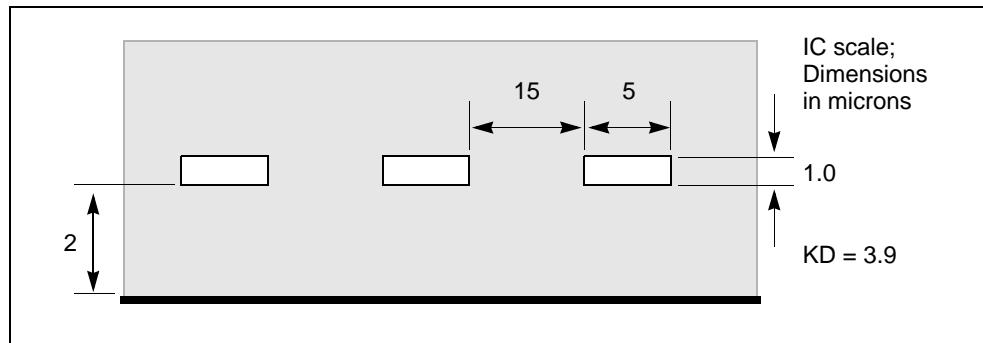


Figure 85 shows one lump of the lumped-parameter schematic for the three-conductor stripline configuration of Figure 84. This internal circuitry represents one U Element instantiation. Internal elements are described in [Simulation Output on page 229](#)

Figure 85 Schematic for Three Coupled Lines with One Reference Plane

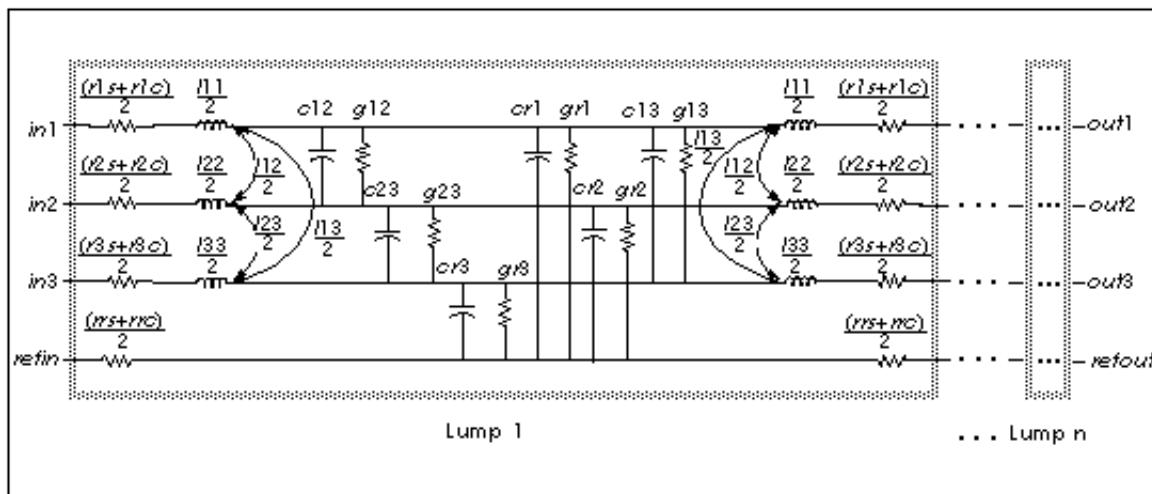
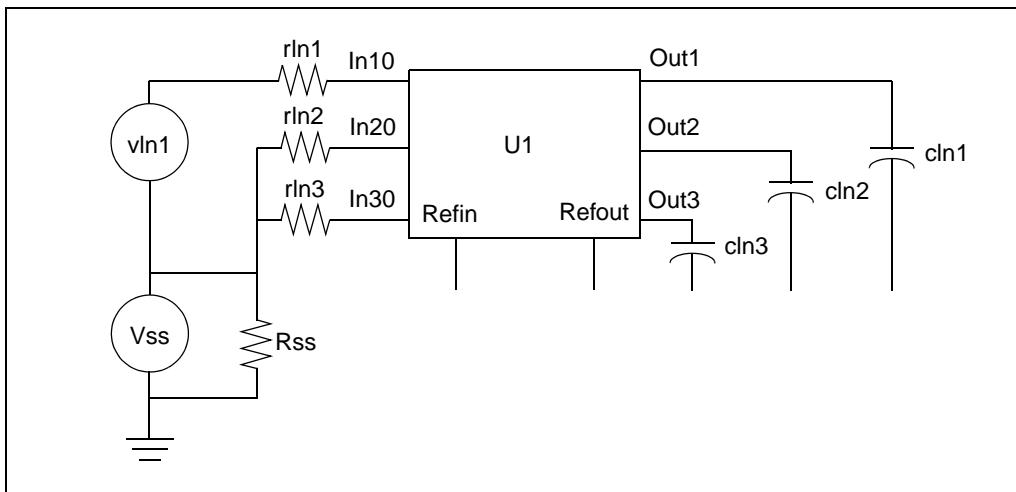


Figure 86 shows a schematic using the U Element of Figure 85. In this simple circuit, a pulse drives a three-conductor transmission line source terminated by 50Ω resistors and loaded by 1pF capacitors.

Figure 86 Schematic Using the Three Coupled Lines U Model



The input file for the U Element solution is shown below.

The sample netlist for this example is located in the following directory:

`$installdir/demo/hspice/tline/uele.sp`

The U Element uses the conductor geometry to create length-independent RLC matrices for a set of transmission lines. You can then input any length, and simulation computes the number of circuit lumps that are required.

Figure 87, Figure 88 and Figure 89 show the through and coupled responses, computed using U Element equations.

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Figure 87 Computed Through-Line Response

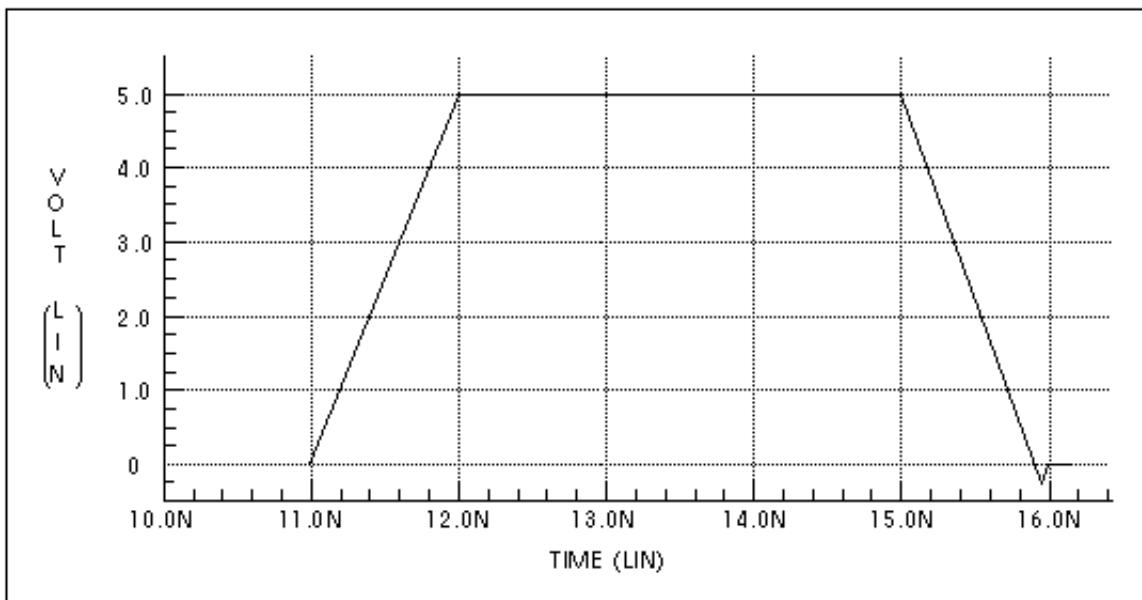


Figure 88 shows the nearest coupled line response. This response occurs only during signal transitions.

Figure 88 Computed Nearest Coupled-Line Response

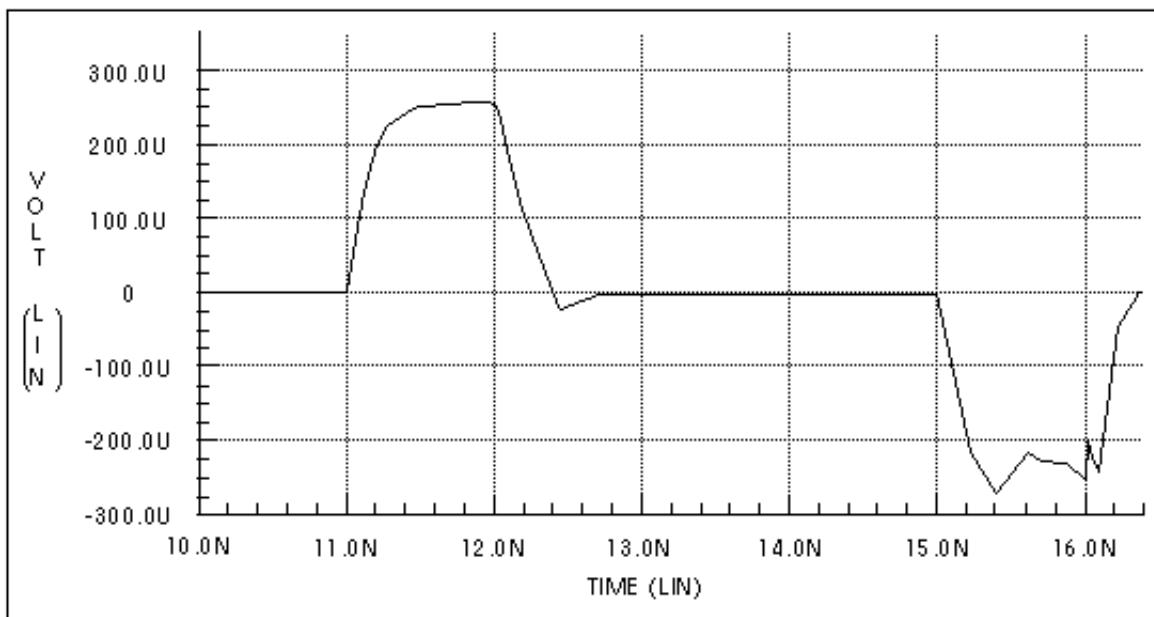
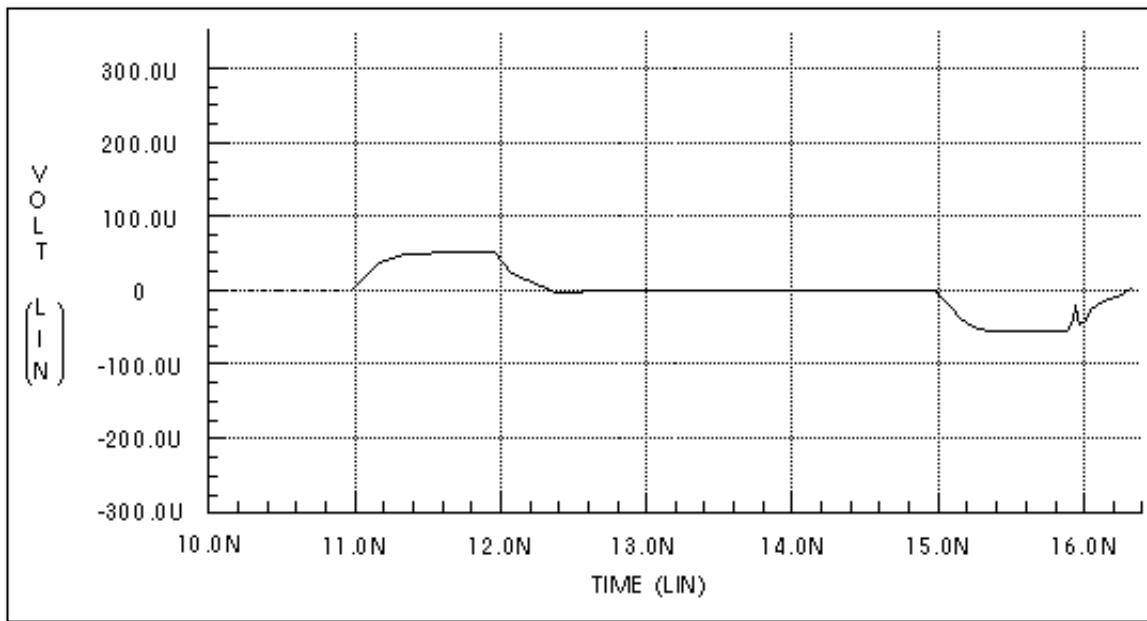


Figure 89 shows the third coupled line response. The predicted response is about 1/100000 of the main line response.

Figure 89 Computed Furthest Coupled-Line Response



By default, simulation prints the model values, including the LCRG matrices for the U Element. All of the printed LCRG parameters are identified in the following section.

Simulation Output

The listing below is part of the output from a simulation using the HSPICE input deck for the *IcWire* U model. Descriptions of the parameters specific to U Elements follows the listing. (Parameters not listed in this section are described in [Table 32 on page 197](#) and [Table 33 on page 199](#).)

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IcWire Output Section

```
*** model name: 0:icwire ****
names  values  units   names  values  units   names  values  units
--- u-model control parameters ---
maxl= 20.00 #lumps wlump= 20.00
plev= 1.00 llevel= 0.
nl= 3.00 #lines nb= 1.00 #refpl
--- begin type specific parameters ---
dlev= 0. kd= 3.90 corkd= 1.00
sig= 0. mho/m ho= 28.00 n ohm*m rhob= 28.00 n ohm*m
th= 1.00u meter thb= 1.42u meter skin= 10.31u meter
skinb= 10.31u meter wd2 5.00u meter ht2 2.00u meter
th2 1.00u meter spl 15.00u meter wd3 5.00u meter
ht3 2.00u meter th3 1.00u meter sp2 15.00u meter
cr1= 170.28p f/m gr1= 0. mho/m l11= 246.48n h/m
cr2= 168.25p f/m gr2= 0. mho/m c12= 5.02p f/m
g12= 0. mho/m l12= 6.97n h/m l22= 243.44n h/m
cr3= 170.28p f/m gr3= 0. mho/m c13= 649.53f f/m
g13= 0. mho/m l13= 1.11n h/m c23= 5.02p f/m
g23= 0. mho/m l23= 6.97n h/m l33= 246.48n h/m
--- two layer (skin and core) parameters ---
rrs= 1.12k ohm/m rrc= 0. ohm/m rls= 5.60k ohm/m
rlc= 0. ohm/m r2s= 5.60k ohm/m r2c= 0. ohm/m
r3s= 5.60k ohm/m r3c= 0. ohm/m
```

Table 43 U Element Parameters

Parameter	Description
c_{ij}	coupling capacitance from conductor i to conductor j (positive)
cr_j	self capacitance/m of conductor j to the reference plane
cpr	capacitance of the reference plane to the HSPICE ground
g_{ij}	conductance/m from conductor i to conductor j (zero if $sig=0$)
gr_j	conductance/m from conductor j to the reference plane (0 if $sig=0$)
gpr	conductance from the reference plane to the HSPICE ground, always=0

Table 43 U Element Parameters (Continued)

Parameter	Description
hti	conductor i height above reference plane (only ht is input, all heights same)
lri	inductance/m from conductor i to the reference plane
rrr	inductance/m of the reference plane
lij	inductance/m from conductor i to conductor j
lij	self inductance/m of conductor j
rrc	reference plane core resistance/m (if NLAY = 2, zero if skin depth > 90% of thb)
rrr	resistance/m of the reference plane (if NLAY = 1)
rrs	skin resistance/m of the reference plane (if NLAY = 2)
ris	skin resistance/m of conductor i (if NLAY = 2)
ric	conductor i core resistance/m (if NLAY = 2, zero if skin depth > 50% of th)
rjj	resistance/m of conductor j (if NLAY = 1)
skin	skin depth
skinb	skin depth of the reference plane
spi	spacing between conductor i and conductor $i+1$ (only sp is input, same spacings)
thi	thickness of conductor i (only th is input, all thicknesses are the same)
wdi	width of conductor i (only wd is input – all widths are the same)

The total conductor resistance is indicated by rjj when NLAY = 1, or by ris + ric when NLAY = 2.

As shown in the next section, *some difference between HSPICE and field solver results is to be expected*. Within the range of validity shown in [Table 34](#)

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on page 200 for the U model, simulation comes very close to field solver accuracy. In fact, discrepancies between results from different field solvers can be as large as their discrepancies with simulation. The next section compares some Synopsys physical circuit models to models derived using field solvers.

Capacitance and Inductance Matrices

Simulation places capacitance and inductance values for U Elements in matrix form, for example:

$$\begin{bmatrix} C_{ii} & \cdots & C_{ji} \\ \vdots & & \vdots \\ \vdots & & \vdots \\ C_{ij} & & C_{jj} \end{bmatrix}$$

Table 44 shows the capacitance and inductance matrices for the three-line, buried microstrip IC-scale example shown in [Figure 84 on page 226](#).

Table 44 Capacitance and Inductance Matrices for the Three-Line, IC-Scale Interconnect System

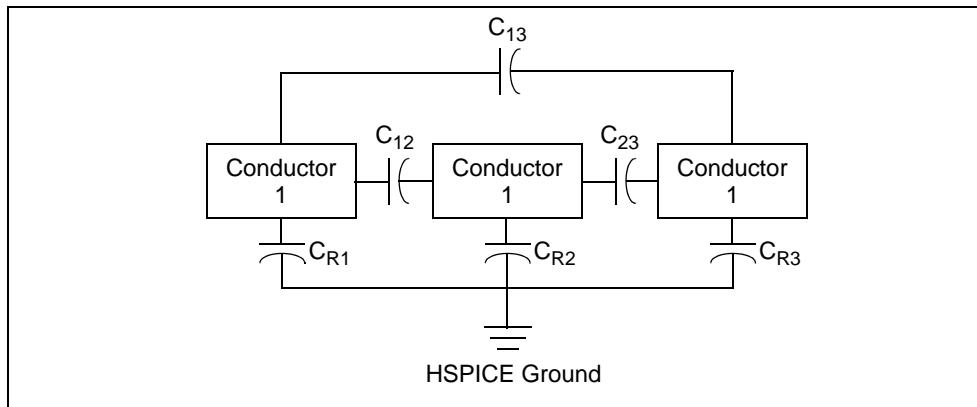
Capacitance (pF/m)	176	-5.02	-0.65
	-5.02	178	-5.02
	-0.65	-5.02	176
Inductance (nH/m)	246	6.97	1.11
	6.97	243	6.97
	1.11	6.97	246

The capacitance matrices in Table 44 are based on the admittance matrix of the capacitances between the conductors. The negative values in the capacitance matrix are due to the sign convention for admittance matrices. The inductance matrices are based on the impedance matrices of the self and mutual inductance of the conductors. Each matrix value is per meter of conductor length. The actual lumped values use a conductor length equal to the total line length divided by the number of lumps.

The above capacitance matrix can be related directly to the output of the IC-scale example. Simulation uses the branch capacitance matrix for internal

calculations. For the three-conductors in this example, Figure 90 shows the equivalent capacitances in terms of simulation device model parameters.

Figure 90 Conductor Capacitances for IC-scale Example



The capacitances of Figure 90 are those shown in [Figure 85 on page 226](#). The HSPICE nodal capacitance matrix of Table 44 is shown below by using the capacitance terms that are listed in the HSPICE output.

$$\begin{bmatrix} C_{R1} + C_{12} + C_{13} & -C_{12} & -C_{13} \\ -C_{12} & C_{R2} + C_{12} + C_{23} & -C_{23} \\ -C_{13} & -C_{23} & C_{R3} + C_{13} + C_{23} \end{bmatrix}$$

Off-diagonal terms are the negative of coupling capacitances (to conform to the sign convention).

The diagonal terms require some computation, for example:

$$\begin{aligned} C_{11} &= C_{R1} + C_{12} + C_{13} \\ &= 170.28 + 5.02 + 0.65 \\ &= 175.95, \text{ or } 176 \text{ pF/m} \end{aligned}$$

Note that the matrix values on the diagonal in Table 44 are large: they indicate self-capacitance and inductance. The diagonal values show close agreement among the various solution methods. As the coupling values become small compared to the diagonal values, the various solution methods give very different results. Third-line coupling capacitances of 0.65 pF/m, 1.2 pF/m, and 0.88 pF/m are shown in Table 44. Although the differences between these coupling capacitances seem large, they represent a negligible difference in

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waveforms because they account for only a very small amount of voltage coupling. Table 44 represents very small coupling because the line spacing is large (about seven substrate heights).

Table 45 shows the parameters for the stripline in Figure 91.

Figure 91 Stripline Geometry Used in MCM Technology

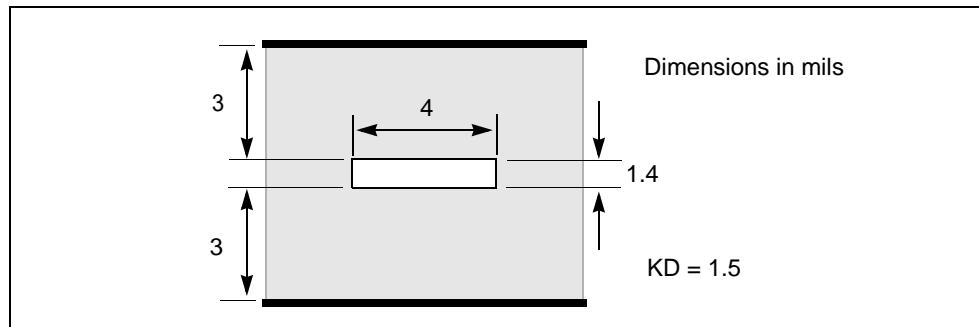


Table 45 Capacitance and Inductance for the Single Line MCM-Scale Stripline

Capacitance (pF/m)	164.4
Inductance (nH/m)	236.5

Five Coupled Lines, Stripline Configuration

This example shows a five-line interconnect system in a PCB technology. Table 46 shows the matrix parameters for the line configuration of Figure 92.

Figure 92 Five Coupled Lines on a PCB

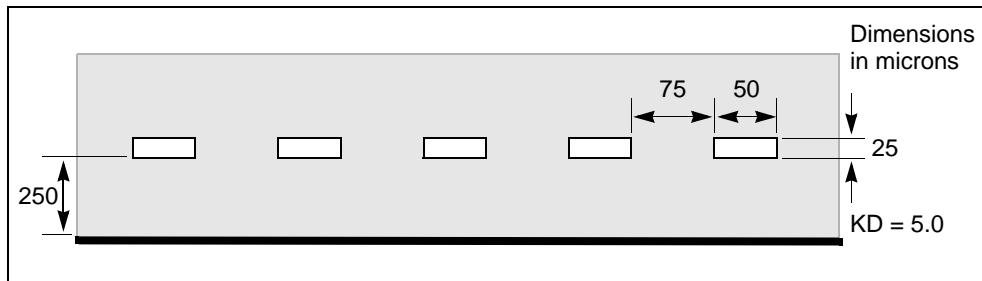


Table 46 Capacitance and Inductance for the Five-Line PCB-Scale Interconnect System

Capacitance (pF/m)	59	-19	-2.5	-0.8	-0.4
	-19	69	-18	-2.2	-0.8
	-2.5	-18	69	-18	-2.5
	-0.8	-2.2	-18	69	-19
	-0.4	-0.8	-2.5	-19	57
Inductance (nH/m)	676	309	179	116	81
	309	641	297	174	116
	179	297	637	297	179
	116	174	297	641	309
	81	116	179	309	676

U Model Applications

This section gives examples of use, and explains some of the aspects of ringing (impulse-initiated oscillation) in real and simulated transmission line circuits.

Data Entry Examples

Coax Geometry Entry (ELEV=1,PLEV=2) with ground reference (LLEV=1) and skin effect (NLAY=2):

```
uc in1 3 out1 4 wire2 l=1
.model wire2 u LEVEL=3 nlay=2 plev=2 elev=1 llev=1
+ ra=1m rb=7.22m hgp=20m rho=1.7e-8 kd=2.5
```

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

Matrix Entry (ELEV=2):

```
u1 In1 In2 In3 Vss Out1 Out2 Out3 Vss Wire3 L=0.01
.model Wire3 U LEVEL=3 NL=3 Elev=2 Llev=0
+ rrr=1.12k r11=5.6k r22=5.6k r33=5.6k c13=0.879pF
+ cr1=176.4pF cr2=172.6pF cr3=176.4pF c12=4.7pF c23=4.7pF
+ L11=237nH L22=237nH L33=237nH L12=5.52nH L23=5.52nH
+ L13=1.34nH
```

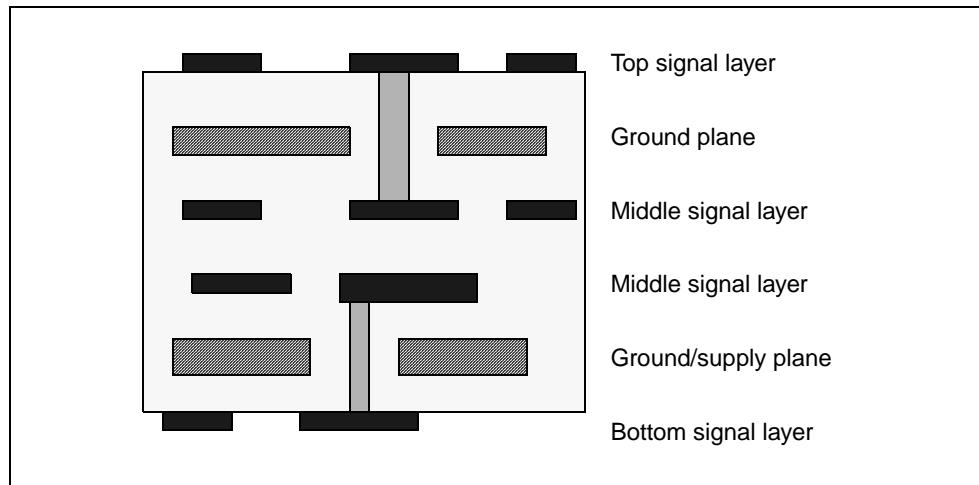
Coax Measured Data Entry (ELEV=3, PLEV=2):

```
u10 1 0 2 0 rg58 l=12
.model rg58 u LEVEL=3 plev=2 elev=3
+ zk=50 capl=30.8p clen=1ft vrel=0.66
+ frl=100meg at1=5.3db atlen=100ft
```

Printed Circuit Board Models

Figure 93 illustrates a small cross section of a six-layer printed circuit board. The top and bottom signal layers require a microstrip U model (DLEV=1), while the middle signal layers use a stripline U model (DLEV=2).

Figure 93 Six-Layer Printed Circuit Board



Important aspects of such a circuit board are:

- Trace impedance is difficult to control because of etch variation
- 6 mil effective trace widths
- 8 mil drawn widths
- 10 mil insulator thickness

- 1 ounce copper 1.3 mil thick
- Microstrip model TOP used for top and bottom
- Stripline model MID used for middle signal layers

Example:

Top and bottom layer model:

```
.MODEL TOP U LEVEL=3 ELEV=1 PLEV=1 TH=1.3mil HT=10mil KD=4.5
+ DLEV=1 WD=8mil XW=-2mil
```

Middle layer model:

```
.MODEL MID U LEVEL=3 ELEV=1 PLEV=1 TH=1.3mil HT=10mil KD=4.5
+ DLEV=2 WD=8mil XW=-2mil TS=32mil
```

Coax Models

The following examples are for standard coax. These are obtained from commonly available tables. (The parameter fr1 is the frequency at which a specific amount of attenuation, at1, occurs for a specified length of coax, atlen.) Synopsys simulators accept dB (decibel) and ft. (foot) units.

Example:

```
.model rg9/u      u          LEVEL=3      plev=2      elev=3
+             Zk=51      vrel=.66
+             fr1=100meg at1=2.1db   atlen=100ft
*
.model rg9b/u    u          LEVEL=3      plev=2      elev=3
+            Zk=50      vrel=.66
+            fr1=100meg at1=2.1db   atlen=100ft
*
.model rg11/u    u          LEVEL=3      plev=2      elev=3
+            Zk=75      vrel=.78
+            fr1=100meg at1=1.5db   atlen=100ft
*
.model rg11a/u   u          LEVEL=3      plev=2      elev=3
+            Zk=75      vrel=.66
+            fr1=100meg at1=1.9db   atlen=100ft
*
.model rg54a/u   u          LEVEL=3      plev=2      elev=3
+            Zk=58      vrel=.66
+            fr1=100meg at1=3.1db   atlen=100ft
*
.model rg15/u    u          LEVEL=3      plev=2      elev=3
+            Zk=53.5    vrel=.66
+            fr1=100meg at1=4.1db   atlen=100ft
```

5: Modeling Ideal and Lumped Transmission Lines

Interconnect Simulation

```
*  
.model rg53/u u LEVEL=3 plev=2 elev=3  
+ Zk=53.5 vrel=.66  
+ frl=100meg at1=4.1db atlen=100ft  
  
*.model rg58a/u u LEVEL=3 plev=2 elev=3  
+ Zk=50 vrel=.66  
+ frl=100meg at1=5.3db atlen=100ft  
  
*.model rg58c/u u LEVEL=3 plev=2 elev=3  
+ Zk=50 vrel=.66  
+ frl=100meg at1=5.3db atlen=100ft  
  
*.model rg59b/u u LEVEL=3 plev=2 elev=3  
+ Zk=75 vrel=.66  
+ frl=100meg at1=3.75db atlen=100ft  
  
*.model rg62/u u LEVEL=3 plev=2 elev=3  
+ Zk=93 vrel=.84  
+ frl=100meg at1=3.1db atlen=100ft  
  
.model rg62b/u u LEVEL=3 plev=2 elev=3
```

Twinlead Models

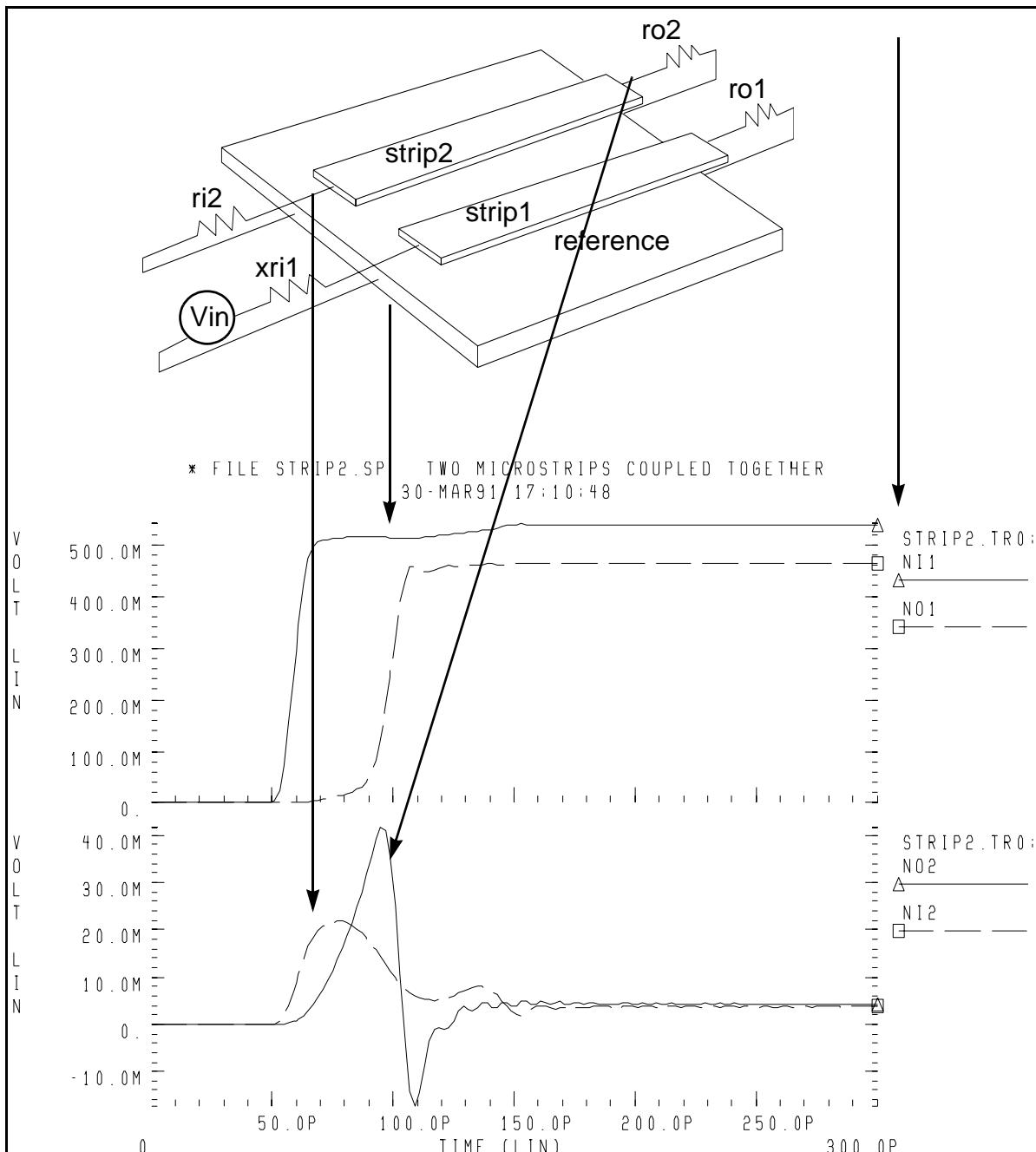
Example:

```
.model tw/sh u LEVEL=3 plev=3 elev=3  
* Shielded TV type twinlead  
+ Zk=300 vrel=.698  
+ frl=57meg at1=1.7db atlen=100ft  
  
.model tw/un u LEVEL=3 plev=3 elev=3  
* Unshielded TV type twinlead  
+ Zk=300 vrel=.733  
+ frl=100meg at1=1.4db atlen=100ft
```

Two Coupled Microstrips

Figure 94 shows two metal lines formed of the first aluminum layer of a modern CMOS process. The microstrip model assumes that the metal strips sit on top of a dielectric layer that covers the reference plane.

Figure 94 Two Coupled Microstrips Geometrically Defined as LSI Metallization



The sample netlist for this example is located in the following directory:

\$installdir/demo/hspice/tline/strip2.sp

Solving Ringing Problems with U Elements

Ringing oscillations at sharp signal edges may be produced by:

- Oscillations due to the simulator
- Oscillations due to lossy approximation of a transmission line (U Element)
- Signal reflections due to impedance mismatch

The primary reason for using a circuit simulator to measure high speed transmission line effects is to calculate how much transient noise the system contains and to determine how to reduce it to acceptable values.

Oscillations Due to Simulation Errors

The system noise results from the signal reflections in the circuit. It may be masked by noises from the simulator. Simulator noise must be eliminated in order to obtain reliable system noise estimates. The following sections describes ways to solve problems with simulator noise.

Timestep Control Error

The default method of integrating inductors and capacitors is trapezoidal integration. While this method gives excellent results for most simulations, it can lead to what is called trapezoidal ringing. This is numerical oscillations that look like circuit oscillations, but are actually timestep control failures. In particular, trapezoidal ringing can be caused by any discontinuous derivatives in the nonlinear capacitance models, or from the exponential charge expressions for diodes, BJTs, and JFETs.

Set the .OPTION METHOD=GEAR to change the integration method from trapezoidal to Gear. The gear method does not ring and, although it typically gives a slightly less accurate result, is still acceptable for transient noise analysis.

Incorrect Number of Element Lumps

It is important to use the right number of lumps in a lossy transmission line element. Too few lumps results in false ringing or inaccurate signal transmission, while too many lumps leads to an inordinately long simulation run.

Sometimes, as in verification tests, it is necessary to be able to specify the number of lumps in a transmission line element directly. The number of lumps

in a lossy transmission line element can be directly specified, defaulted to an accuracy and limit based computation, or computed with altered accuracy and limit and risetime parameters.

Default Computation

In the default computation, LUMPS=1 until a threshold of total delay versus risetime is reached:

```
TDeff = RISETIME/20
```

- TDeff = total end-to-end delay in the transmission line element
- RISETIME = the duration of the shortest signal ramp as given in the statement:
`.OPTION RISETIME = value`

At the threshold, two lumps are used. Above the threshold, the number of lumps is determined by:

```
number of lumps = minimum of 20 or [1+(TDeff/RISETIME)*20]
```

The upper limit of 20 is applied to enhance simulation speed.

If the standard accuracy-based computation does not provide enough lumps, or if it computes too many lumps for simulation efficiency, you can use one of several methods to change the number of lumps on one or more elements:

- Specify LUMPS=*value* in the element statement.
- Specify .MODEL MAXL=*value* and .MODEL WLUMP=*value*.
- Specify a different RISETIME=*value* in an .OPTION statement.
- Specify LUMPS=*value* (direct specification)

Direct specification overrides the model and limit based computation, applying only to the element specified in the element statement as in the following example:

```
U35 n1 gnd n2 oref      model lumps=31 L=5m
```

The preceding example specifies 31 lumps for an element of length 5 mm.

Specify MAXL and WLUMP (altered accuracy and limit parameters)

You can alter the default computation for all the elements that refer to a particular model by specifying the MAXL and WLUMP model parameters

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(which would otherwise default to 20). In the nondefault case the number of lumps, the threshold, and the upper limit all would be changed:

```
lumps = min{MAXL, [1+(TDef/RISETIME)*WLUMP] }
```

```
Threshold: TDef = RISETIME/WLUMP
```

```
Upper lim: MAXL
```

Specify a different “RISETIME” parameter in the .OPTION statement

You can change the threshold and number of lumps computed for all elements of all models, reduce or increase the RISETIME analysis parameter. Note that care is required if RISETIME is decreased, because the number of lumps may be limited by MAXL in some cases where it was not previously limited.

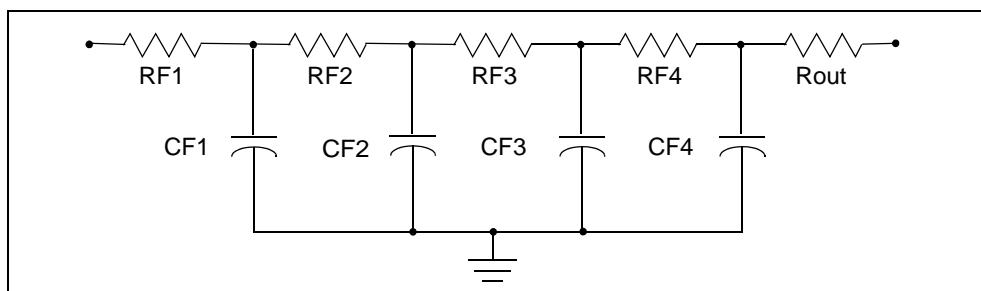
Using a Multi-stage RC Filter to Prevent Ringing

Artificial sources such as pulse and piecewise linear sources often are used to simulate the action of real output buffer drivers. Since real buffers have a finite cutoff frequency, a multistage filter can be used to give the ideal voltage source reasonable impedance and bandwidth.

You can place a multistage RC filter, shown below, between the artificial source and any U Element to reduce the unrealistic source bandwidth and, consequently, the unrealistic ringing. In order to provide as much realism as possible, the interposed RC filter and the PWL (piecewise linear) source must be designed together to meet the following criteria:

- Reduce the ringing to acceptable levels
- Preserve the realistic bandwidth of the source signal
- Provide a driver with any chosen impedance
- Provide accurately timed transient signals

Figure 95 Circuit Diagram of an RC Filter



Example:

```

.MACRO RCFNEW in out gnd_ref RFLT=50 TDFLT=100n
*
.PROT
* Begin RCFILT.inc (RC filter) to smooth and match pulse
* sources to transmission lines. User specifies impedance
* (RFLT) and smoothing interval (TDFLT). TDFLT is usually
* specified at about .1*risetime of pulse source.
*
* cutoff freq, total time delay; and frequency dependent
* impedance and signal voltage at "out" node
*
* smoothing period = TDFLT.....(equivalent boxcar filter)
* delay= TDFLT
* fc=2/(pi*TDFLT).....(cutoff frequency)
* Zo~ RFLT*(.9 + .1/sqrt( 1 + (f/fc)^2 ))
* V(out)/V(in)= [1 / sqrt( 1 + (f/fc)^2 )]^4
*
.PARAM TD1S='TDFLT/4.0'
RF1 in n1 '.00009*RFLT'
RF2 n1 n2 '.0009*RFLT'
RF3 n2 n3 '.009*RFLT'
RF4 n3 n4 '.09*RFLT'
Rout n4 out '.90*RFLT'
*
.PARAM CTD='TD1S/.9*RFLT'
CF1 n1 0 '10000*CTD'
CF2 n2 0 '1000*CTD'
CF3 n3 0 '100*CTD'
CF4 n4 0 '10*CTD'
*
.UNPROT
.EOM

```

From the comments embedded in the macro, the output impedance varies from RFLT in the DC limit to 3% less at FC and 10% less in the high frequency limit.

$$(RFLT|_{DC} = 0.99999 \cdot RFLT) \backslash$$

$$RFLT|_{FC} = 0.97 \cdot RFLT$$

Therefore, setting RFLT to the desired driver impedance gives a reasonably good model for the corrected driver impedance. TDFLT is generally set to 40% of the voltage source risetime.

```

* excitation voltage + prefilter
V1 np1 0 PWL 0.0s 0v 50ps 0v 60ps 1v

```

5: Modeling Ideal and Lumped Transmission Lines

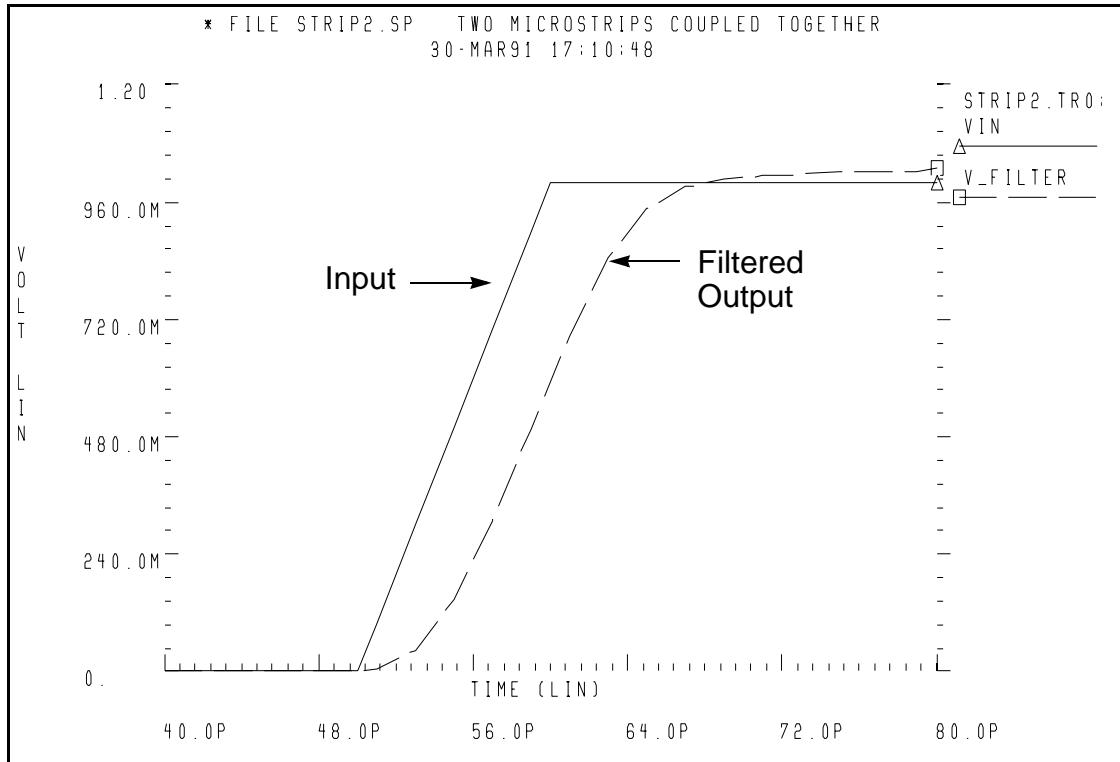
Interconnect Simulation

```
xrII1 NP1 NI1 RCFNEW rflt=rx tdflt=4ps
```

Note: RCFNEW is an automatic include file named `$installdir/parts/behave/rcfilt.inc`, where `$installdir` is the installation directory.

Figure 96 shows the input and output voltages for the filter.

Figure 96 Multistage RC Filter Input and Output



Signal Reflections Due to Impedance Mismatch

The effect of impedance mismatch is demonstrated in the following example. This circuit has a 75 ohm driver, driving 3 inches of 8 mil wide PCB (middle layer), then driving 3 inches of 16 mil wide PCB.

Figure 97, and Figure 98, and Figure 99, show operational characteristics of such a circuit. The first steady value of impedance is 75 ohms, which is the impedance of the first transmission line section. The input impedance falls to 56 ohms after about 2.5ns when the negative reflection from the nx1 node reaches nil. This TDR displays one idiosyncrasy of the U Element. The high initial value of Zin (TDR) is due to the fact that the input element of the U Element is

inductive. The initial TDR spike can be reduced in amplitude and duration by simply using a U Element with a larger number of lumped elements.

Figure 97 Mathematical Transmission Line Structure

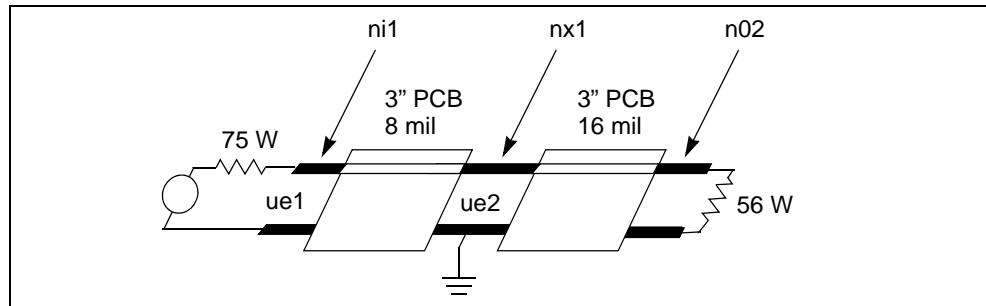
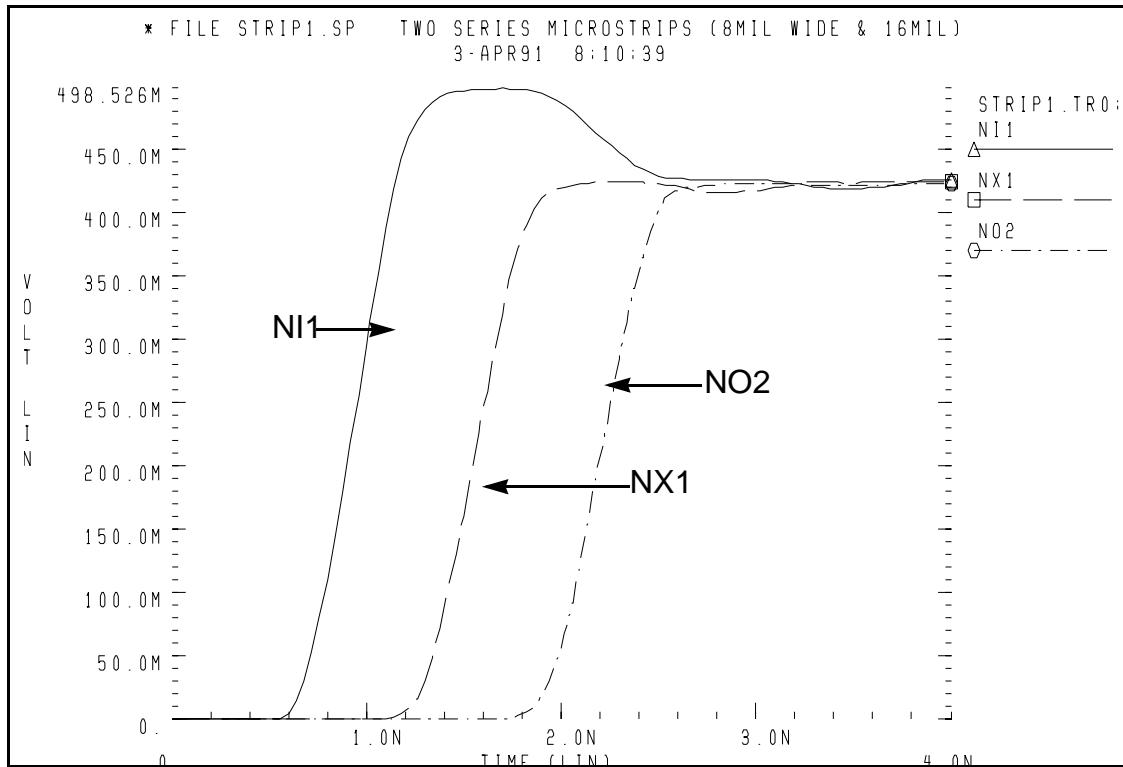


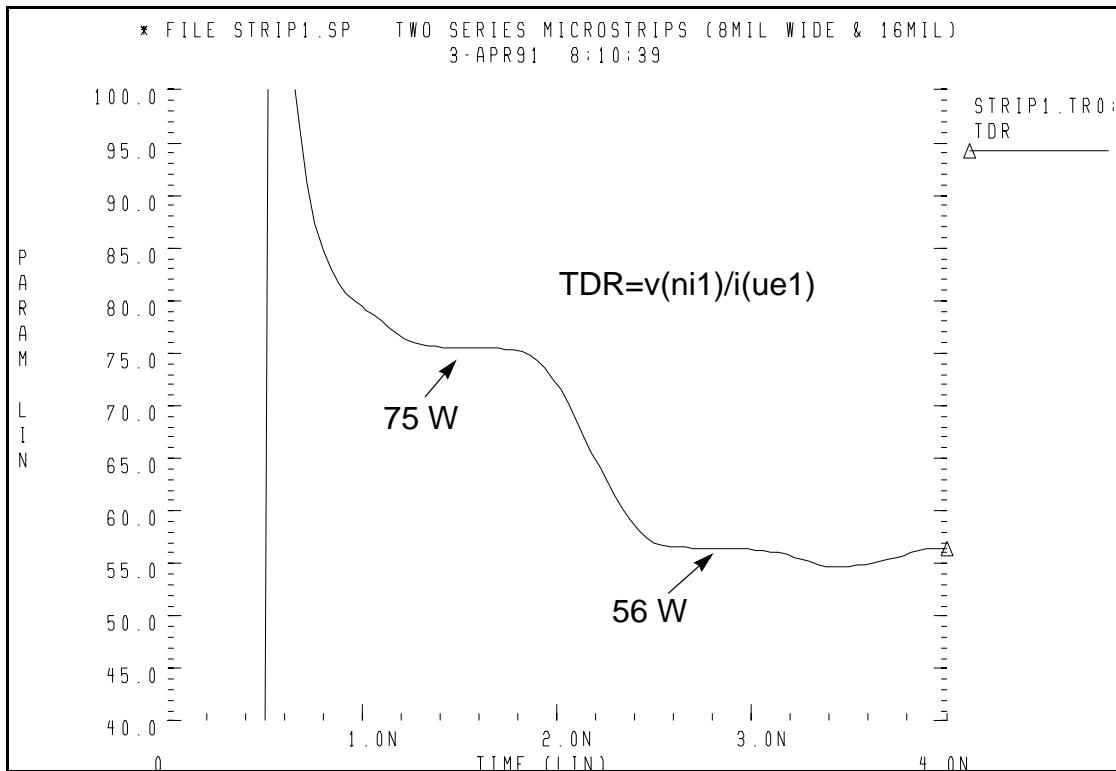
Figure 98 Waveforms in Mismatched Transmission Line Structure



5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

Figure 99 Impedance from TDR at Input



The sample netlist for this example is located in the following directory:

```
$installdir/demo/hspice/tline/strip1.sp
```

Transmission Line Theory

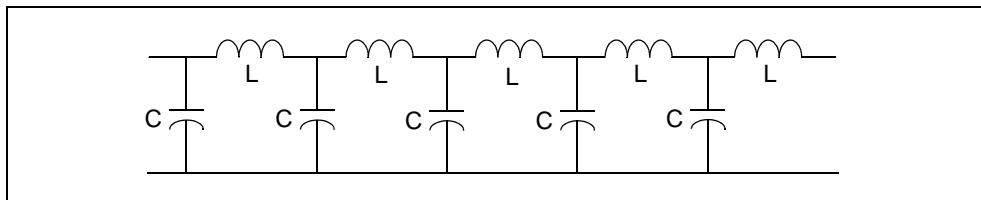
This section:

- Discusses how the discrete lumped model of the U Element transmission line explains characteristic impedance and transmission velocity.
- Uses the concepts of self and mutual inductance to explain crosstalk.
- Describes rules of thumb for various types of clock pulses.
- Discusses the sources of transmission line attenuation.

Lossless Transmission Line Model

As a signal propagates down the pair of conductors, each new section acts electrically as a small lumped circuit element. In its simplest form, called the lossless model, the equivalent circuit of a transmission line has just inductance and capacitance. These elements are distributed uniformly down the length of the line as shown in Figure 100.

Figure 100 Equivalent Circuit Model of a Lossless Transmission Line



From this electrical circuit model, the two important terms that characterize a transmission line can be derived: the velocity of a signal (v) and the characteristic impedance (Z_0).

$$v = \frac{1}{\sqrt{L_L C_L}} \quad \text{and} \quad Z_0 = \sqrt{\frac{L_L}{C_L}}$$

- L_L = inductance per length
- C_L = capacitance per length

This is the basis for the T Element. It accounts for a characteristic impedance (Z_0) and a time delay (TD). The time delay depends on the distance (d) between the two ends of the transmission line:

$$TD = \frac{d}{v}$$

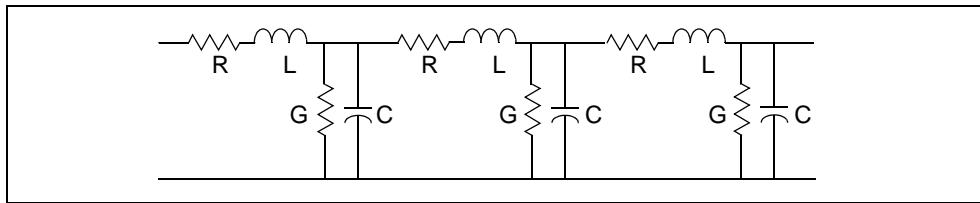
Lossy Transmission Line Model

When loss is significant, the effects of the series resistance (R) and the dielectric conductance (G) should be included. Figure 101 shows the equivalent circuit model of a lossy transmission line with distributed “lumps” of R , L , and C Elements.

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

Figure 101 Equivalent Circuit Model of a Lossy Transmission Line



The U Element is the equivalent circuit model for the lossy transmission line. In a transient simulation, the U Element automatically accounts for frequency-dependent characteristic impedance, dispersion (frequency dependence in the velocity), and attenuation.

The most common types of transmission line cross sections are microstrip, stripline, coax, wire over ground, and twisted pair. There is no direct relationship between cross section, velocity of propagation, and characteristic impedance.

In a balanced transmission line, the two conductors have similar properties and are electrically indistinguishable. For example, each wire of a twisted pair has the same voltage drop per length down the line. The circuit model for each wire has the same resistance, capacitance, and inductance per length.

This is not the case with a microstrip line or a coaxial cable. In those structures, the signal conductor has a larger voltage drop per length than the other conductor. The wide reference plane in a microstrip or the larger diameter shield in a coax have lower resistance per length and lower inductance per length than the signal line. The equivalent circuit model for unbalanced lines typically assumes the resistance and inductance per length of the ground path is zero and all the voltage drop per length is on the signal conductor. Even though the inductance of the reference plane is small, it can play a significant role when there are large transient currents.

Impedance

The impedance of a device (Z) is defined as the instantaneous ratio of the voltage across the device (V) to the current through it:

$$Z = \frac{V}{I}$$

Impedance of Simple Lumped Elements

The impedance of a device can be thought of as the quality of the device that causes it to transform a current through it into a voltage across it:

$$V = ZI$$

The admittance (Y) is less often used to characterize a device. It is the inverse of the impedance:

$$Y = \frac{1}{Z} = \frac{I}{V}$$

There are three ideal circuit elements used to describe passive components: a resistor, a capacitor, and an inductor. They are defined by how they interact with voltage across them and current through them:

Resistor with resistance (R):

$$V = IR$$

Capacitor with capacitance (C):

$$I = C \frac{dV}{dt}$$

Inductor with inductance (L):

$$V = L \frac{dI}{dt}$$

When the voltage or current signals are time dependent, the impedance of a capacitive or inductive element is a very complicated function of time. You can simulate it, but it is difficult to build an intuitive model.

The impedance of a capacitor rotates the phase of the current 90° in the negative or direction to generate the voltage across the capacitor. The impedance of an inductor rotates the current 90° in the positive direction to generate the voltage across the inductor. For a resistor, the current and voltage have the same phase.

In the frequency domain when all signals are sine waves in the time domain, the impedance of a capacitor and an inductor is frequency dependent, decreasing with frequency for a capacitor and increasing with frequency for an inductor. The impedance of a resistor is constant with frequency.

In the real world of finite dimensions and engineered materials, ideal circuit elements have associated parasitics, which cause them to behave in complex ways that are very apparent at high frequencies.

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

Characteristic Impedance

A controlled impedance transmission line is a pair of conductors that have a uniform cross section and uniform distribution of dielectric materials down their length. A short segment, Δx of the transmission line has a small capacitance associated with it, ΔC , which is the capacitance per length, C_L , times the Δx :

$$\Delta C = C_L \Delta x$$

When a voltage signal is introduced at one end, the voltage between the conductors induces an electric field that propagates the length of the line at the speed of light in the dielectric. As the voltage signal moves down the line, each new section of line charges up. The new section of line, Δx , is charged up in a time Δt :

$$\Delta t = \frac{\Delta x}{v}$$

If the voltage (V) moves down the line at a constant speed, and the capacitance per length is uniform through the line, then the constant voltage applied to the front end draws a constant charging current (I):

$$I = \frac{\Delta Q}{\Delta t} = \frac{\Delta CV}{\Delta t} = \frac{C_L \Delta x V}{\Delta t} = C_L v V$$

This constant voltage with constant current has the behavior of a constant impedance (Z):

$$Z = \frac{V}{I} = \frac{V}{C_L v V} = \frac{1}{C_L v}$$

The impedance is determined by the speed of the signal and the capacitance per length of the pair of conductors, both intrinsic properties of the line. This intrinsic impedance is termed the characteristic impedance of the line (Z_0).

If a measurement is made at one end of the line in a short time compared to the round trip time delay, the line behaves as a resistor with a resistance equal to the characteristic impedance of the line. Transmission line effects are only important when rise times are comparable or shorter than the round trip time delay.

For example, if the rise time of a device is 1 ns, and it drives an interconnect trace in FR4 which is longer than three inches, the load on the device during the risetime is purely resistive. For CMOS devices, which are used to drive high

resistance loads, the typical 50 ohm resistance they see initially can significantly distort the waveform from what is expected.

It is only during the initial surge of the voltage that a transmission line behaves as a constant impedance with a value equal to its characteristic impedance. For this reason the characteristic impedance of a line is also called the surge impedance. The surge time during which the impedance is constant is the round trip time of flight or twice the time delay. Reflections from the far end complicate the electrical behavior of the line after the surge time.

The instantaneous impedance measured at the front end of a transmission line is a complicated function of time. It depends on the nature of the terminations at the far end. When the line is shunted to ground with a resistor of value equal to the characteristic impedance of the line, there is no reflection back, and the front end of the line behaves as a resistive load. When the termination at the far end is open, the impedance at the front end starts out at the characteristic impedance and eventually, after multiple reflections, approaches an infinite impedance. During some periods the instantaneous impedance may be zero. These transient effects are fully simulated with T Elements and U Elements.

Inductance

This section gives an operation definition of inductance and explains the differences between mutual and subtle inductance.

Mutual Inductance and Self Inductance

The most confusing, subtle, and important parameter in high-speed packaging and interconnect design is inductance. It plays a key role in the origin of simultaneous switching noise, also called common ground inductance, and a key role in crosstalk between transmission line structures.

Operational Definition of Inductance

Consider an inductor to be any section of circuit element which carries current: an interconnect trace, a ground plane, a TAB lead frame, a lead in a DIP package, the lead of a resistor or a pin in a connector. An inductor does not have to be a closed circuit path, but can be a small section of a circuit path.

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

A changing current passing through an inductor generates a voltage drop. The magnitude of the voltage drop (ΔV) for an inductance (L) and change in current (dI/dt) is:

$$\Delta V = L \frac{dI}{dt}$$

This definition can always be used to evaluate the inductance of a section of a circuit. For example, with two long parallel wires, each of radius (r) and a center-to-center separation s, you can measure the voltage drop per length for one of the wires when a changing current dI/dt flows through one wire and back through the other. The induced voltage per length on one of the wires is:

$$V_L = \frac{\mu_0}{2\pi} Ln\left(\frac{s}{r} - \frac{r}{s}\right) \frac{dI}{dt} \quad [\text{V in mV/inch, I in mA, t in ns}]$$

From this expression, the effective inductance per length of a wire is:

$$L_L = \frac{\mu_0}{2\pi} Ln\left(\frac{s}{r} - \frac{r}{s}\right) \approx 5 Ln\left(\frac{s}{r}\right) (s \gg r) \quad [\text{nH/inch}]$$

Mutual Inductance

A second effect also is important: the induced voltage from currents that are adjacent to, but not in, the same circuit path. This is caused by the mutual inductance between two current elements. A section of conductor in a circuit, labeled 1, may have an induced voltage generated across it because of currents not in circuit 1, but from circuits 2, 3, and 4.

The voltage generated across the section of circuit 1, V_1 , is given in its general form by:

$$V_1 = L_{11} \frac{dI_1}{dt} + L_{12} \frac{dI_{12}}{dt} + L_{13} \frac{dI_3}{dt} + L_{14} \frac{dI_4}{dt}$$

The notation for mutual inductance (L_{ab}) is related to the induced voltage on circuit element a, from the current element, b. In some texts, the symbol used is M, rather than L. The special case of the induced voltage on a circuit element from its own current (L_{aa}) is called self inductance.

Mutual inductance relates to the magnitude of induced voltage from an adjacent current. The magnitude of this voltage depends on the flux linkages between the two circuit elements.

Self Inductance

The self inductance of an isolated single trace is a well-defined, absolute mathematical quantity, but not a measurable physical quantity. There is always a return current path somewhere, and the mutual inductance from this return current path induces a voltage on the circuit element that subtracts from the self inductance. Self inductance can never be measured or isolated, independent of a mutual inductance of a return current path.

In the example above of two long parallel wires, the measured inductance per length (L_L) of one wire is neither the self inductance nor the mutual inductance of the wire. It is a combination of these two terms. If the universe contained just the two wires, the measured voltage drop per length would be:

$$V_L = L_{11} \frac{dI_1}{dt} - L_{12} \frac{dI_2}{dt} = (L_{11} - L_{12}) \frac{dI_1}{dt} = L_L \frac{dI_1}{dt}$$

The minus sign reflects the opposite directions of the currents I_1 and I_2 . Operationally, when the inductance per length of one wire is measured, what is really measured is the difference between its self inductance and the mutual inductance of the return path. Because of this effect, it is clear that the nature of the return path greatly influences the measured inductance of a circuit element.

Reference Plane Return Paths

The capacitance per length (C_L) of any planar transmission line is:

$$C_L = \frac{85}{Z_0} \sqrt{\epsilon_r} \text{ [pF/inch]}$$

The inductance per length of the signal line (L_L) is:

$$L_L = 0.085 Z_0 \sqrt{\epsilon_r} \text{ [nH/inch]}$$

This is the self inductance of the signal line, minus the mutual inductance of the return current in the reference plane.

For example, the inductance per length of a transmission line with characteristic impedance of 50 ohms in an FR4 printed circuit board is 9.6 nH/inch. The capacitance per length is 3.8 pF/inch.

In the equivalent circuit of a lossless transmission line, the series inductance per length is 9.6 nH/inch, and the shunt capacitance to ground is 3.8 pF/inch.

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

In the notation of the U Element for an ELEV=2 (RCLK equivalent model) and a PLEV=1 (microstrip cross section), the parameters to model this lossless transmission line are

$$C_{11} = 3.8 \text{ pF/inch}, \quad L_{11} = 9.6 \text{ nH/inch}$$

The LLEV=0 parameter simplifies the inductance problem by automatically calculating the inductance of the line as the difference between the self inductance of the line and the mutual inductance of the return signal path.

In many texts, the term L11 is generically used as the self inductance. LLEV=1 assumes a circuit ground point, separate from the reference plane of the transmission line. Thus the LLEV=1 option includes an approximation to the self inductance of both the signal conductor and the reference plane, while LLEV=0 assumes a reference plane return current.

Crosstalk in Transmission Lines

When there are adjacent transmission lines, for instance line 2 and line 3, the coupling capacitance and inductance between them and the quiet line, line 1, lead to crosstalk.

In the notation of the Synopsys transmission line models, the voltage per length on transmission line 1, V₁, including the mutual inductance to lines 2 and 3 is:

$$V_1 = L_{11} \frac{dI_1}{dt} + L_{12} \frac{dI_2}{dt} + L_{13} \frac{dI_3}{dt}$$

LLEV=0 simplifies the inductance analysis by automatically including the effects of the return current path. The first inductance term (L11) is the inductance per length of the transmission line (1) including the self inductance of the line and the mutual inductance of the return ground path.

The second term, the coupling inductance of the second transmission line (L12), includes the mutual inductance of the second signal line and the mutual inductance of the return current path of the second line. Because these two currents are in opposite directions, the mutual inductance of the pair is much less than the mutual inductance of just the second signal trace alone.

The third term (L13) includes the mutual inductance of the signal path in the third transmission line and the mutual inductance of its return path through the reference plane.

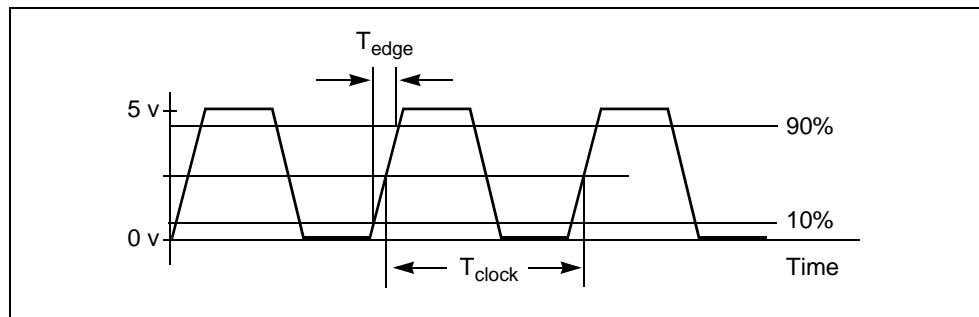
The coupling inductances (L12 and L13) include the mutual inductances of the adjacent signal lines and their associated return paths. They are more than the

mutual inductance of the adjacent traces. This is equivalent to the operational inductances that you can measure with a voltmeter and a dI/dt source.

Risetime, Bandwidth, and Clock Frequency

In the time domain, a clock waveform can be described in terms of its period (T_{clock}), its frequency (F_{clock}), and a risetime (τ_{edge}). Figure 102 illustrates these features.

Figure 102 Clock Waveform



The risetime is typically the time between the 10% to 90% points.

To describe this waveform in terms of sine wave components, the highest sine wave frequency required (the bandwidth, BW) depends on the risetime. As the bandwidth increases and higher sine wave frequency components are introduced, the risetime of the reconstructed waveform decreases. The bandwidth of a waveform is determined by the fastest risetime it contains. The risetime and bandwidth are related by:

$$BW = \frac{0.35}{\tau_{edge}} \text{ or } \tau_{edge} = \frac{0.35}{BW}$$

The risetime of a clock waveform and the clock period are only indirectly related. The risetime of a system is determined by the output driver response and the characteristics of the packaging and interconnect. In general, the risetime is made as long as possible without degrading the clock period.

Without specific information about a system, it is difficult to know the precise risetime, given just the clock frequency or period. In a fast system such as an oscillator with only one gate, the period might be two times the risetime:

$$T_{period} \approx 2\tau_{edge}$$

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

For a complex system such as a microprocessor board, the period might be 15 times as long as the risetime:

$$T_{period} \approx 15\tau_{edge}$$

In each case, the bandwidth is always related to the risetime by the first expression in this section, and the clock frequency and clock period are always related by:

$$F_{clock} = \frac{1}{T_{clock}}$$

The microprocessor example reports the worst case of the shortest risetime for a given clock period. Combining these expressions shows the relationship between clock frequency and bandwidth:

$$F_{clock} = \frac{1}{T_{clock}} = \frac{1}{15\tau_{edge}} = \frac{BW}{15 \cdot 0.35} \approx \frac{1}{5}BW \text{ or } BW \approx 5F_{clock}$$

In general, the highest sine wave frequency component contained in a clock waveform is five times the clock frequency. The important assumption is that there are about 15 risetimes in one period. If the risetime is actually faster than this assumption, the bandwidth is higher. To provide a safety margin, a package or interconnect is characterized or simulated at a bandwidth of about 10 to 20 times the clock frequency, which corresponds to roughly two to four times the bandwidth of the signal.

Definitions of Transmission Line Terms

The following table gives the definitions of transmission line terms.

Table 47 Transmission Line Terms

Term	Description
F_{clock}	Clock frequency in units of frequency such as Hz
T_{clock}	Clock period in units of time such as secs or ns
τ_{edge}	Rise or fall time in units of time such as sec or ns
BW	Bandwidth in units of frequency such as Hz or MHz

Table 47 Transmission Line Terms (Continued)

Term	Description
F	A repetitive frequency in units of Hz or MHz
<i>f</i>	A sine wave frequency in units of Hz or MHz
ω	An angular frequency in units of radians/sec
t	Time or a conductor thickness, units of sec or length
V(t)	Instantaneous voltage in units of volts
I(t)	Instantaneous current in units of amps or mA
Z(t)	Instantaneous impedance in units of ohms
Z(ω)	Frequency domain, complex impedance in units of ohms
C	Capacitance in units of Farads or microFarads
R	Resistance in units of ohms
L	Inductance in units of Henrys or nanoHenries
v	Speed of light in the medium in units of length/time
d	A length in units such as inches
TD	Time delay in units of time such as sec or nsec
C _L	Capacitance per length in units such as pF/inch
L _L	Inductance per length in units such as nH/inch
R _L	Resistance per length in units such as ohms/inch
ϵ_r	Relative dielectric constant, ϵ/ϵ_0 , dimensionless
r	Reflection coefficient, dimensionless
DZ	A small change in characteristic impedance
G _L	Conductance per length units of Mhos (Siemens)/length

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

Table 47 Transmission Line Terms (Continued)

Term	Description
$\tan(\delta)$	Dissipation factor of a material, dimensionless
d	Skin depth of a conductor, units of length such as meter
ρ	Resistivity of a conductor, units of ohm-length
μ_0	Permeability of free space = $4 \pi \times 10^{-7}$ Henry/meter
α	Attenuation per length, units of dB/len or nepers/len
w	A conductor width
n	Number of squares in a planar conductor, dimensionless
R_{sq}	Sheet resistance of a planar conductor, units: ohms/sq
ϵ_0	Permittivity of free space=0.225 pF/inch=0.0885 pF/cm
ϵ_{eff}	Effective dielectric constant due to mixed dielectrics
h	A dielectric thickness in units of length such as mils
R	Resistance in ohms

Relationships and Rules of Thumb

This section explains the rules and properties associated with transmission lines.

Time and Frequency Relationships

$$F_{clock} = \frac{1}{T_{clock}}$$

$$BW = \frac{0.35}{\tau_{edge}} \text{ or } \tau_{edge} = \frac{0.35}{BW}$$

$$T_{period} \approx 15\tau_{edge}$$

$$F_{clock} \approx \frac{1}{5}BW \text{ or } BW \approx 5F_{clock}$$

Transmission Line Effects

Transmission line analysis recommended for:

$$BW > \frac{v}{10d} = \frac{1}{10 \cdot TD}$$

$$\tau_{edge} < \frac{5d}{v} = 5 \cdot TD$$

On FR4 material:

$$BW > \frac{600}{d} \quad [\text{BW in MHz, d in inches}]$$

$$F_{clock} > \frac{120}{d} \quad [\text{Fclock in MHz, d in inches}]$$

$$\tau_{edge} < \frac{d}{7.5} \quad t_{edge} \quad [\text{in ns, d in inches}]$$

Intrinsic Properties

$$Z_0 = \frac{1}{vC_L} = \sqrt{\frac{L_L}{C_L}} \quad [\text{CL is in pF/inch}]$$

$$v = \frac{1}{\sqrt{L_L C_L}}$$

$$C_L = \frac{1}{vZ_0} = \frac{\sqrt{\epsilon_r}}{cZ_0} = \frac{85}{Z_0} \sqrt{\epsilon_r} \quad [\text{pF/inch}]$$

$$L_L = \frac{1}{C_L v^2} = \frac{7.3 \epsilon_r}{C_L} \quad [\text{LL in nH/inch, CL in pF/inch}]$$

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

Typical polymers:

$$TD = \frac{d}{6} \quad [\text{TD in ns, d in inches}]$$

$$C_L = \frac{170}{Z_0} \quad [\text{pF/inch}]$$

$$L_L = 0.172Z_0 \quad [\text{nH/inch}]$$

50 ohm lines:

$$C_L = 1.7\sqrt{\epsilon_r} \quad [\text{pF/inch} = 3.4 \text{ pF/inch (typical polymer)}]$$

$$L_L = 4.3\sqrt{\epsilon_r} \quad [\text{nH/inch} = 8.6 \text{ nH/inch (typical polymer)}]$$

Transmission line of length d:

$$C = C_L d = \frac{TD}{Z_0}$$

$$L = L_L d = Z_0 TD$$

Reflections

Reflection coefficient from Z_1 to Z_2 :

$$r = \frac{Z_2 - Z_1}{Z_2 + Z_1}$$

Reflection from a ΔZ of short length with time delay, TD, $\tau_{edge} > TD$:

$$r = \frac{\Delta Z}{2Z_0} \left(\frac{TD}{\tau_{edge}} \right)$$

Reflection from a series lumped L surrounded by a transmission line:

$$r = \frac{L}{2Z_0\tau_{edge}}$$

Reflection from a lumped C load to ground, on a transmission line:

$$r = \frac{CZ_0}{2\tau_{edge}}$$

Loss and Attenuation

Skin depth of a conductor:

$$\delta = \sqrt{\frac{\rho}{\pi\mu_0 f}} = 500 \cdot \sqrt{\frac{\rho}{f}}$$

δ in meters, ρ in ohm.meter, f in Hz (in copper), at $f = 1e+9$, and $\rho = 1.7e-8$ ohm.meter, $\delta = 2.0e-6$.

Low loss approximation for attenuation per length:

$$\alpha = \frac{1}{2} \left(\frac{R_L}{Z_0} + G_L Z_0 \right) \quad [\text{nepers/length}]$$

$$\alpha = 4.34 \left(\frac{R_L}{Z_0} + G_L Z_0 \right) \quad [\text{dB/length}]$$

Attenuation per length due to just dielectric loss:

$$\alpha = 2.3f \tan(\delta) \sqrt{\epsilon_r} \quad [\text{dB/inch}, f \text{ in GHz}]$$

$$\alpha \approx 0.05 \quad [\text{dB/inch for FR4 at 1 GHz}]$$

Attenuation per length due to metal, $t < \delta$:

$$\alpha = 43.4 \frac{\rho}{twZ_0} \quad [\text{dB/inch with } \rho \text{ in ohm.meter, } t \text{ in microns, } w \text{ in mils}]$$

For 1 ounce copper microstrip, 5 mils wide, 50 ohm:

$$\alpha = 0.01 \quad [\text{dB/inch}]$$

Attenuation per length due to metal, 50 ohm line, skin depth limited, $t > \delta$:

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

$$\alpha = 0.55 \frac{\sqrt{\rho f}}{w} \quad [\text{dB/inch with } \rho \text{ in ohm.meter, } w \text{ in mils, } f \text{ in GHz}]$$

For 1 ounce copper microstrip, 5 mils wide, 50 ohm, at 1 GHz:

$$\alpha = 0.15 \quad [\text{dB/inch}]$$

Physical Design Quantities

For a planar interconnect:

Sheet resistance:

$$R_{sq} = \frac{\rho}{t} \quad [\text{ohm/sq}]$$

Number of squares:

$$n = \frac{d}{w}$$

Resistance:

$$R_L = n \cdot R_{sq} \quad [\text{ohm/inch, Rsq in ohm/sq}]$$

Resistance per length:

$$R_L = 10 \frac{\rho}{tw} \quad [\text{ohm/inch, } \rho \text{ in ohm-meter, } t \text{ in microns, } w \text{ in mils}]$$

Parallel plate, no fringe fields:

$$C_L = 0.225 \epsilon_r \left(\frac{w}{h} \right) \quad [\text{pF/inch}]$$

Microstrip capacitance per length good to ~20%:

$$C_L = 0.45 \epsilon_r \left(\frac{w}{h} \right) \quad [\text{pF/inch}]$$

Microstrip capacitance per length, good to ~5%:

$$C_L = \frac{1.41 \epsilon_{eff}}{\ln \left(\frac{8h}{w} + \frac{w}{4h} \right)}$$

$$\epsilon_{eff} = \left(\frac{\epsilon_r + 1}{2}\right) + \left(\frac{\epsilon_r - 1}{2}\right)\left(1 + \frac{10h}{w}\right)^{-\frac{1}{2}}$$

Stripline capacitance per length good to ~20%:

$$C_L = 0.675\epsilon_r\left(\frac{w}{h}\right) \quad [\text{pF/inch}]$$

Stripline capacitance per length, good to ~5%:

$$C_L = \frac{0.9\epsilon_r}{\ln\left(1 + \frac{2h}{w}\right)} \quad [\text{pF/inch}]$$

Inductance per length of one wire in a pair of two parallel wires:

(r = radius, s = center to center spacing, s » r)

$$L_L = 5Ln\left(\frac{s}{r}\right) \quad [\text{nH/inch}]$$

Inductance per length for a circular loop:

$$L_L = 26 \quad [\text{nH/inch of perimeter}]$$

Inductance per length of controlled impedance line when the return line is a reference plane:

$$L_L = 0.086Z_0\sqrt{\epsilon_r} = \frac{7.3\epsilon_r}{C_L} \quad [\text{nH/inch with } C_L \text{ in pF/inch}]$$

Conductance per length:

$$G_L = \omega\tan(\delta)C_L$$

Attenuation in Transmission Lines

The T Element, common to most Berkeley-compatible SPICE tools, uses the lossless model for a transmission line. This model adequately simulates the dominant effects related to transmission behavior: the initial driver loading due to a resistive impedance, reflections from characteristic impedance changes, reflections introduced by stubs and branches, a time delay for the propagation

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

of the signal from one end to the other and the reflections from a variety of linear and nonlinear termination schemes.

In systems with risetimes are on the order of 1 ns, transmission line effects dominate interconnect performance.

In some high-speed applications, the series resistance seriously effects signal strength and should be taken into account for a realistic simulation.

The first-order contribution from series resistance is an attenuation of the waveform. This attenuation decreases the amplitude and the bandwidth of the propagating signal. As a positive result, reflection noise decreases so that a lossless simulation is a worst case. As a negative result, the effective propagation delay is longer because the risetimes are longer. A lossless simulation shows a shorter interconnect related delay than a lossy simulation.

The second-order effects introduced by series resistance are a frequency dependence to the characteristic impedance and a frequency dependence to the speed of propagation, often called dispersion. Both the first order and second order effects of series resistance generic to lossy transmission lines are simulated using the U model.

Physical Basis of Loss

The origin of loss is the series resistance of the conductors and the dielectric loss of the insulation. Conductor resistance is considered in two parts, the DC resistance and the resistance when skin depth plays a role. The dielectric loss of the insulation, at low frequency, is described by the material conductivity (σ) (SIG in the Synopsys U model), and at high frequency, by the dissipation factor, $\tan(\delta)$. These material effects contribute a shunt conductance to ground (G).

In a planar interconnect such as a microstrip or stripline, the resistance per length of the conductor R_L is

$$R_L = \frac{\rho}{wt}$$

ρ = bulk resistivity of the conductor

w = the line width of the conductor

t = thickness of the conductor

Example 1

FR4, 5 mil wide line, half ounce copper:

$$R_L = 0.24 \text{ ohm/inch}$$

Example 2

Cofired ceramic, 4 mil wide, 0.75 mils thick Tungsten:

$$R_L = 2.7 \text{ ohm/inch}$$

Example 3

Thin film copper, 1 mil wide, 5 microns thick:

$$R_L = 3.6 \text{ ohm/inch}$$

Skin Depth

At high frequency, the component of the electric field along the conductor, which drives the current flow, does not fully penetrate the conductor depth. Rather, its amplitude falls off exponentially. This exponential decay length is the *skin depth* (δ). When the signal is a sine wave, the skin depth depends on the conductor's resistivity (ρ), and the sine wave frequency of the current (f):

$$\delta = \sqrt{\frac{\rho}{\pi\mu_0 f}} = 500 \cdot \sqrt{\frac{\rho}{f}} \quad \delta \quad [\text{in meters, } r \text{ in ohm.meter, } f \text{ in Hz}]$$

A real signal has most of its energy at a frequency of $1/t_{\text{period}}$, where t_{period} is the average period. Because most of the loss occurs at this frequency as a first approximation \gg should be used to compute the skin depth. In practice as mentioned previously, approximating t_{period} by $15(\tau_{\text{edge}})$ works well. With a 1 ns rise time, the skin depth of copper is 8 microns, assuming $15(\tau_{\text{edge}})$ is used for $1/f_{\text{skin}}$. For half ounce copper, where the physical thickness is 15 microns, the skin depth thickness should be used in place of the conductor thickness to estimate the high frequency effects.

For thin film substrates with a physical thickness of the order of 5 microns or less, the effects of skin depth can, to the first order, be ignored. In cofired ceramic substrates, the skin depth for 1 ns edges with tungsten paste conductors is 27.6 microns. This is also comparable to the 19 micron physical thickness, and to the first order, the effects of skin depth can be ignored. At shorter rise times than 1 ns, skin depth plays an increasingly significant role.

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

Dielectric Loss

Two separate physical mechanisms contribute to conductivity in dielectrics, which results in loss: DC conduction and high frequency dipole relaxation. As illustrated in the following section, the effects from dielectric loss are in general negligible. For most practical applications, the dielectric loss from the DC conductivity and the high frequency dissipation factor can be ignored.

To be cautious, estimate the magnitude of the conductance of the dielectric and verify that, for a particular situation, it is not a significant issue. Exercise care in using these material effects in general application.

The bulk conductivity of insulators used in interconnects (σ), typically specified as between 10^{-12} and 10^{-16} siemens/cm, is often an upper limit, rather than a true value. It is also very temperature and humidity sensitive. The shunt conductance per length (G_L) depends on the geometrical features of the conductors in the same way as the capacitance per length (C_L). It can be written as:

$$G_L = \sigma \frac{C_L}{\epsilon_0 \epsilon_r}$$

At high frequencies, typically over 1 MHz, dipole relaxations begin to dominate the conduction current and cause it to be frequency dependent. This effect is described by the dissipation factor of a material, which ranges from 0.03 for epoxies down to 0.003 for polyimides and less than 0.0005 for ceramics and Teflon. The effective conductivity of a dielectric material at high frequency is:

$$\sigma = 2\pi f \epsilon_0 \epsilon_r \tan(\delta)$$

The shunt conductance per length of an interconnect when dipole relaxation dominates, is:

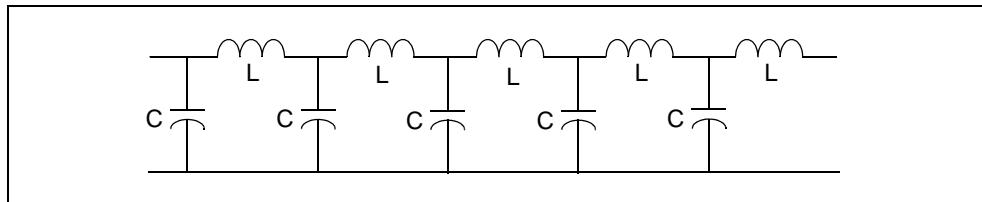
$$G_L = 2\pi f \tan(\delta) C_L$$

As a worst case, the frequency corresponding to the bandwidth of the signal can be used to estimate the high frequency conductivity of the material.

Lossy Transmission Line Model

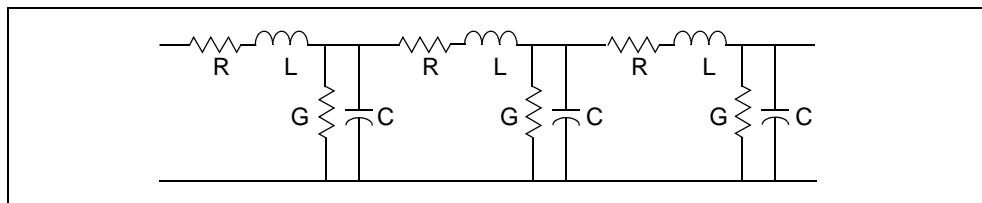
In the lossless transmission line model, only the distributed capacitance (C) and inductance (L) of the interconnect is considered:

Figure 103 Lossless Transmission Line Model



In the lossy transmission line model, the series resistance and dielectric conductance are introduced into the equivalent circuit model:

Figure 104 Lossy Transmission Line Model



These four circuit elements, normalized per unit length, can be used to describe all the high frequency properties of a transmission line. When the equivalent circuit equation is solved in the frequency domain, the characteristic impedance is modified to:

$$Z_0 = \sqrt{\frac{R_L + j\omega L_L}{G_L + j\omega C_L}}$$

and the propagation phase term, γ , is:

$$\gamma = \alpha + j\beta = \sqrt{(R_L + j\omega L_L)(G_L + j\omega C_L)}$$

In the propagation phase term, β is related to the phase velocity by:

$$v = \frac{\omega}{\beta}$$

5: Modeling Ideal and Lumped Transmission Lines

Transmission Line Theory

To first order when $R_L \ll \omega L_L$ and $G_L \ll \omega C_L$, the characteristic impedance and phase velocity (v) are unchanged from their lossless values. However, a new term, the attenuation per length (α) is introduced.

The attenuation per length is approximately:

$$\alpha = \frac{1}{2} \left(\frac{R_L}{Z_0} + G_L Z_0 \right) \quad [\text{nepers/length}]$$

$$\alpha = 4.34 \left(\frac{R_L}{Z_0} + G_L Z_0 \right) \quad [\text{dB/length}]$$

The total attenuation (αd) determines the fraction of the signal amplitude that remains after propagating the distance (d). When α has the units of dB/length, the fraction of signal remaining is:

$$10^{\left(\frac{-\alpha d}{20}\right)}$$

A 2 dB attenuation in a signal corresponds to a final amplitude of 80% of the original and 6 dB attenuation corresponds to a final amplitude of 50% of the original. Attenuation on the order of 6 dB significantly changes the signal integrity.

Attenuation Due to Conductor Resistance

In the typical case of a 50 ohm transmission line, the attenuation per length due to just the series resistance is

$$\alpha = 0.09 R_L \quad [\text{dB/length}]$$

When the resistance per length is of the order of 0.2 ohm/inch or less as is the case in typical printed circuit boards, the attenuation per length is about 0.02 dB/inch. Typical interconnect lengths of 10 inches yields only 0.2 dB, which would leave about 98% of the signal remaining. Using the lossless T Element to approximate most applications provides a good approximation.

However, in fine line substrates, such as in the previous section, the resistance per length can be on the order of 2 ohms/inch. In such a case, the attenuation is on the order of 0.2 dB/inch. So a 10 inch interconnect line then has an attenuation on the order of 2 dB, which would leave only about 80% of the signal. This is large enough that its effects should be included in a simulation.

Attenuation Due to the Dielectric

When the dielectric completely surrounds the conductors, the attenuation due to just the conductance per length of the dielectric is:

$$\alpha_{dielectric} = 2.3f\tan(\delta)\sqrt{\epsilon_{eff}} \quad [\text{dB/inch, } f \text{ in GHz}]$$

The worst case and highest attenuation per length is exhibited by FR4 boards with $\tan(\delta)$ of the order of 0.02 and a dielectric constant of 5. The attenuation at 1 GHz is about 0.1 dB/inch. For an interconnect 10 inches long, this is 1 dB of attenuation, which would leave about 90% of the signal remaining, comparable to the attenuation offered by a conductor with 1 ohm/inch resistance.

If the resistance per length is larger than 1 ohm/inch—for example in cofired ceramic and thin film substrates, and the dissipation factor is less than 0.005, the attenuation from the conductor losses can be on the order of 10 times greater than dielectric loss. In these applications, the dielectric losses can be ignored.

Integrating Attenuation Effects

All of the first-order effects of attenuation are automatically simulated with the U Element.

With ELEV=1, the inputs can be the cross sectional geometry and the material properties of the conductor, bulk resistivity (RHO), the relative dielectric constant of the insulation (KD), and the conductivity of the dielectric (SIG). From these features, the equivalent capacitance per length, inductance per length, series resistance per length, and conductance per length are calculated during simulation.

With ELEV=2, you can use estimates, measurements or third-party modeling tools to directly input the equivalent capacitance per length, inductance per length, series resistance per length, and conductance per length.

Simulation automatically generates a model for the specified net, composed of a series of lumped elements that resembles the model for a lossy transmission line. The parameter WLUMPS controls the number of lumped elements included per wavelength, based on the estimated rise time of signals in the simulation.

The attenuation effects previously described are a natural consequence of this model. The U Element allows realistic simulations of lossy transmission lines in both the AC and the transient domain.

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Handbook of Electronics Calculations for Engineers and Technicians, McGraw Hill, pages 18-29, 18-23.

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